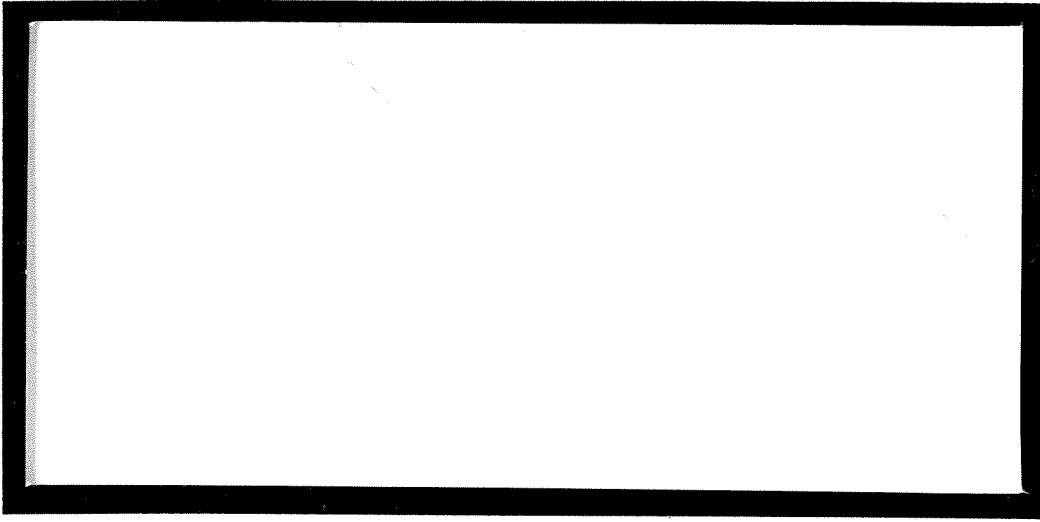


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**Electric, Electronics and Informatics Research
Grant Committee**

ACTIVE PHASED ARRAYS AND ARRAY FED ANTENNAS

AKTİF FAZ TARAMALI DİZİLER
VE
DİZİ BESLEMELİ ANTENLER

Proje No: COST 245

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ÖNSÖZ

Aktif Faz Taramalı Diziler ve Dizi Beslemeli Antenler (Active Phased Arrays and Array Fed Antennas) adlı COST 245 projesinde faz taramalı anten dizileri, monolitik mikrodalga entegre devreler (MMIC), geniş bantlı antenler ve bu tür yapıların nümerik metotlarla analizi konuları yer almıştır. Avrupa Ekonomik Topluluğu üye ülkeleriyle işbirliği içerisinde yürütülen bu proje, Orta Doğu Teknik Üniversitesi, Elektrik ve Elektronik Mühendisliği Bölümü'nde bir ekip tarafından gerçekleştirilmiş ve 1 Ocak 1994 - 1 Temmuz 1997 tarihleri arasında TÜBİTAK tarafından desteklenmiştir.

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ÖZ

COST 245 “Aktif Faz Taramalı Diziler ve Dizi Beslemeli Antenler” (Active Phased Arrays and Array Fed Antennas) Projesinin Ortak Niyet Beyanı ülkemiz adına imzalanarak, çalışmaları ODTÜ Elektrik ve Elektronik Mühendisliği Bölümünde görevli ekip tarafından yürütülmüştür. AT ülkeleriyle bilimsel işbirliği içerisinde yürütülen bu proje sonucu, diğer üye ülkelerin araştırma ve endüstriyel kuruluşlarında yapılan çalışmaları yakından izlemek ve bu üyelerin konuyla ilgili problemleri çözüm yollarını ele alış biçimleri hakkında fikir sahibi olmak imkanı elde edilmiştir.

Proje kapsamında yapılan çalışmalar A. Faz taramalı anten dizileri konusundaki çalışmalar, B. Monolitik mikrodalga entegre devrelerle (MMIC) ile ilgili çalışmalar ve C. Geniş bantlı antenler ve nümerik metotlar olarak üç ana grupta toplanmıştır. Birinci bölümde düzlemsel bir çift hüzmeli (dual beam) TVRO anteni gerçekleştirmek üzere mikroşerit faz taramalı anten dizileri üzerinde kapsamlı bir çalışma yapılmıştır. Uydu alıcı antenlerinde ortaya çıkan termal gürültünün analizi ve yüksek G/T (kazanç/eşdeğer gürültü derecesi) oranlı mikroşerit anten dizileri besleme yapıları tasarımı için özgün bir yöntem geliştirilmiştir. Bu çalışmalar sonucunda, 8x4 elemanlı (10 GHz), 32x12 elemanlı (11.3 GHz), 24x32 elemanlı aktif (9.5 GHz) ve silindirik yüzey üzerine yerleştirilmiş mikroşerit yama anten dizileri tasarımı ve üretilmiş ve ölçümleri yapılmıştır.

İkinci bölümde faz taramalı anten dizilerinde kullanımı büyük avantaj sağlayan monolitik mikrodalga entegre devrelerinden, dar ve geniş bantlı yükselteçler, voltaj kontrollü osilatör, karıştırıcı, düşük gürültülü yükselteç, alıcı/verici anahtar, güç yükselteci, geniş bantlı voltaj kontrollü zayıflatıcı ve faz kaydırıcı devrelerinin tasarımı yapılmış ve bunlardan ilk beş tanesi üretilerek performansları ölçülmüştür.

Üçüncü bölümde ise geniş bantlı Vivaldi antenler ve dairesel Vivaldi anten dizileri gerçekleştirilmiş, ayrıca, dielektrik ve ferit katmanlar içeren antenlerle elektronik hüzmeye taraması elde edilebileceği gösterilmiştir. Bunlara ilaveten, düzlemsel mikroşerit yapıların incelenmesinde kullanılan moment yöntemi entegrasyondan arındırılarak hızlı analiz yapılabilmesi sağlanmıştır. Bir başka uygulama olarak da sonlu dizi antenler için, integral denklem sistemi ile sistematik bir çözüm yöntemi geliştirilmiştir.

Anahtar sözcükler: Faz taramalı diziler, aktif anten dizileri, mikroşerit antenler, monolitik mikrodalga entegre devreler, moment metodu.

ABSTRACT

The project COST 245 "Active Phased Arrays and Array Fed Antennas" is carried out by a team of researchers at the Department of Electrical and Electronics Engineering, Middle East Technical University, after the signatures on behalf of our country were put on the memorandum of understanding. The project is conducted with the participation of member countries of EC and the coordination of the efforts is achieved through project management committee meetings held in various countries.

Within the framework of the project, the research activities are carried out in three main groups: A. Research on phased array antennas, B. Monolithic microwave integrated circuit (MMIC) designs and C. Research on wide band antennas and numerical methods. In the first group, a detailed study is carried out on microstrip phased antenna arrays in order to realize a planar dual beam TVRO antenna. An original method is developed for the analysis of the thermal noise in the satellite receiving antennas and for the design of the feeding networks for antennas with low G/T (gain/equivalent noise temperature) ratio. As a result of these studies, microstrip patch antenna arrays (8x4 element 10 GHz, 32x12 element 11.3 GHz, 24x32 element active 9.5 GHz and one placed on cylindrical surface) are designed, implemented and measured.

In the second group a number of monolithic microwave integrated circuits which offer great advantages in phased arrays are designed. These are narrow and wide band amplifiers, voltage controlled oscillator, mixer, low noise amplifier, transmit/receive switch, power amplifier, wide band voltage variable attenuator and phase shifter. First five of the circuits are manufactured and their performances are measured.

In the third group wide band Vivaldi antennas and circular Vivaldi arrays are realized and also electronic beam scanning is achieved using antennas with dielectric and ferrite layers. In addition, the numerical integration is eliminated in the method of moments whereby a fast numerical algorithm is developed for the analysis of planar microstrip structures. A systematic solution technique is also obtained for the integral equation set corresponding to planar antenna arrays.

Key words: Phased arrays, active antenna arrays, microstrip antennas, monolithic microwave integrated circuits, method of moments.

I GİRİŞ :

COST 245 Projesi, Ortak Niyet Beyanı ülkemiz adına daha önce imzalanarak çalışmaları ODTÜ Elektrik ve Elektronik Mühendisliği Bölümünde görevli ekip tarafından yürütülen “Antennas in the 1990’s: Active Array Antennas for future Satellite and Terrestrial Communications” adlı ve COST 223 No.lu projenin devamı niteliğindedir. COST 245 kapsamında AT ülkeleriyle bilimsel işbirliği içerisinde yürütülen bu proje sonucu, diğer üye ülkelerin araştırma ve endüstriyel kuruluşlarında yapılan çalışmaları yakından izlemek, bu üyelerin konuyla ilgili problemleri ve çözüm yollarını ele alış biçimleri hakkında fikir sahibi olmak imkanı elde edilmiştir. COST-245 Projesine aşağıda belirtilen 18 Avrupa ülkesi katılmıştır:

Belçika, Bulgaristan, İsviçre, Almanya, Danimarka, İspanya, Hollanda, Fransa, Yunanistan, İtalya, Norveç, Portekiz, Polonya, İsveç, Finlandiya, Türkiye, İngiltere.

Yakın geleceğin önemli teknolojilerine sahip olmak, ilgili iletişim sistemleri üzerinde çalışmalar yaparak bu konuda gelişmiş ülkelere yetişmek, en azından bu ülkelere geri kalmamak projenin ana hedefi olmuştur. İletişim uydularında, uçaklarda veya yer yüzündeki platformlarda kullanılmaları öngörülen aktif dizi anten sistemlerinin geliştirilmesi amaçlanmıştır. Aktif anten dizileri, anten elemanlarının ve bu elemanlara bağlanacak kazancı ayarlanabilir yükselteç ve faz kaydırıcı birimlerinin aynı yüzey üzerinde gerçekleştirildiği sistemlerdir. Dizi elemanlarının, daha karmaşık yapıda çoklu hüzmeye oluşturu devrelerle de beslenebilmeleri öngörülmüştür. Aktif dizi sistemlerinin kullanılmasındaki amaç, verici ve alıcı modlarında çalışırken ortaya çıkan kayıpların yükselteçler vasıtasıyla uygun şekilde telafi edilmesiyle, çakışan (overlapping) ve yeniden şekillendirilebilen (reconfigurable) hüzmelerin oluşturulmasıdır. Dizideki anten elemanlarının karakteristikleri, diziden genel olarak istenen düşük yan hüzmeye, tarama genişliği v.b. gibi özelliklerle uyum içinde olması öngörülmüştür.

COST 245 projesinin amacı, yukarıda tanımlanan özelliklere sahip bir prototipin gerçekleştirilebilmesine yönelik teorik ve pratik çalışmaların yapılması, bu doğrultudaki çeşitli araştırma-geliştirme çabalarının COST 245 çatısı altında, COST kuruluşunun ilkelerine uygun olarak, koordinasyonunun sağlanması olmuştur. Bu amaçla başlıca üç araştırma grubu oluşturulmuştur:

- WG I - Modelleme ve Analiz (Modelling and Analysis),
- WG II - Işıma Elemanları (Radiating Elements),
- WG III - Tasarım, Devreler, Elemanlar ve Ölçme (Architecture, Circuits, Components and Measurements).

Türkiye, projeye katılan ülkelerden biri olarak, projenin genel amaçlarına koordineli bir biçimde katkıda bulunmuş, aynı zamanda bağımsız, ama amaca uygun olarak ürettiği bilgileri projenin yukarıda adı geçen çalışma gruplarında tartışmıştır.

COST 245 projesinin amaçlarına uygun olarak yapılan çalışmalar üç ana grupta toplanmıştır:

- A. Faz taramalı anten dizileri konusundaki çalışmalar,
- B. Monolitik mikrodalga entegre devrelerle (MMIC) ilgili çalışmalar,
- C. Geniş bantlı antenler ve nümerik metotlarla ilgili çalışmalar.

Faz taramalı anten dizileri konusundaki çalışmalar ayrıca kendi içerisinde iki ayrı grup halinde ele alınmıştır:

- A.1 TVRO (TV Receive Only) ve ilgili faz taramalı anten dizileri,
- A.2 Akıllı Antenler (Smart Antennas).

COST 245 projesinin genel amacına uygun olarak düzlemsel bir çift hüzmeli (dual beam) TVRO anteni gerçekleştirmek üzere mikroşerit faz taramalı anten dizileri üzerinde kapsamlı bir çalışma yapılmıştır. Önce çeşitli konfigürasyonlar teorik olarak incelenmiş ve bilgisayar analiz programları geliştirilmiştir.

Uydu alıcı antenlerinde yüksek G/T (kazanç/eşdeğer gürültü derecesi) oranı istendiğinden mikroşerit anten dizilerinde ortaya çıkan termal gürültünün analizi ve yüksek G/T oranlı anten dizisi besleme yapısı tasarımı için özgün bir yöntem geliştirilmiştir.

Bir sonraki aşamada, bir mikroşerit ölçme sistemi hazırlanarak mikroşerit hatların ve çeşitli mikroşerit yama antenlerin karakteristikleri ölçülmüştür.

Son aşamada ise aşağıda sıralanan mikroşerit yama anten dizileri tasarımı yapılmış ve ölçümleri yapılmıştır.

- i - 8x4 elemanlı mikroşerit yama anten dizisi (10 GHz),
- ii - 32x12 elemanlı mikroşerit yama anten dizisi (11.3 GHz, COST 245 TVRO spesifikasyonlarına uygun),
- iii - 24x32 elemanlı aktif mikroşerit anten dizisi (9.5 GHz),
- iv - Silindirik yüzey üzerinde mikroşerit anten dizisi.

Akıllı antenler konusunda ise 7 GHz de çalışan, yön bulma ve sayısal hüzme oluşturma kapasitesine sahip doğrusal bir mikroşerit anten dizisi tasarlanıp üretilmiş ve ölçümleri yapılmıştır.

Düşük maliyet, tasarım esnekliği, yüksek güvenilirlik, üretimde tekrarlanabilirlik, küçük boyutlar ve hafiflik gibi avantajlar nedeni ile MMIC (Monolithic Microwave Integrated Circuit - tek parça mikrodalga tümleşik devre) teknolojisi ileri sanayi ülkelerinde yaygın olarak kullanılmaktadır. Monolitik sözcüğü bir mikrodalga devresindeki bütün aktif ve pasif devre elemanlarının ve bağlantılarının tek bir yarıiletken katman üzerinde gerçekleştirilmesi anlamına gelmektedir. Bu teknik, daha düşük frekanslarda kullanılan VLSI teknolojisinin mikrodalga frekanslarındaki benzer uygulaması olarak görülebilir. Yukarıda bahsedilen özellikleri nedeniyle MMIC devreleri, özellikle düzlemsel yapıdaki aktif anten dizilerinde kullanılan çok sayıdaki RF modülleri için uygun bir çözüm olmaktadır. Bu amaca yönelik olarak sekiz değişik MMIC devresinin tasarım ve ölçümleri gerçekleştirilmiştir. Bütün devrelerin tasarım ve optimizasyonları, LIBRA ve ACADEMY yazılım paketleri kullanılarak ve GEC-Marconi firmasının F20 yapım kurallarına uygun olarak yapılmıştır. Tasarınlanan bu devreler Eurochip kanalıyla üretilmiş ve karakteristikleri ölçülmüştür. Ölçüm sonuçlarıyla bilgisayar simülasyon sonuçlarının iyi bir uyum içinde oldukları görülmüştür.

Üçüncü bölümdeki çalışmalar ise projenin genel amaçlarına uygun olarak düzlemsel mikroşerit yapıların incelenmesinde kullanılan MoM metodunun nümerik entegrasyondan arındırılması, sonlu dizi antenlerin integral denklem sistemi ile sistematik çözümü, geniş bantlı dairesel Vivaldi anten dizisi tasarımı ve milimetrik dalga bandında iki ve üç katmanlı (ferit-dielektrik) antenlerle elektronik demet taraması gibi araştırmaları kapsamaktadır.

Bütün bu konularda yapılan çalışmaların tanıtımı, literatür taraması ve sonuçları Teknik Çalışmalar Bölümünde yer almıştır. Proje kapsamında ortaya çıkan yurt içi ve yurt dışı yayınlar da raporun sonunda EK I'de sunulmuştur. EK II de ise projenin uluslararası organizasyonu hakkında bilgiler verilmiştir.

II TEKNİK ÇALIŞMALAR

A- RESEARCH ON PHASED ARRAY ANTENNAS

Being the central theme of the COST 245 project, phased array antennas are thoroughly investigated by our METU-ASELSAN COST 245 team. These studies can be grouped under two subheadings: TVRO and related phased arrays, and the smart antennas having digital beamforming capabilities. In both of these fields, final theoretical designs are manufactured and measured using the facilities of METU and ASELSAN.

A.1 TVRO and Related Phased Arrays

A.1.1 Introduction and Preliminary Studies

For the coherency of the international efforts, the idea of “coordinated outputs” was put forward in the COST 245 meeting held in Ankara in October 1994. The originator of this idea was A. Roederer from ESA-ESTEC, who also offered a number of concrete problems to be worked upon. Our group showed interest particularly on the “dual beam TVRO- TV Receive Only” project (see the illustration in Fig. A.1.1) that would offer us the opportunity to get into the receiving microstrip phased arrays.

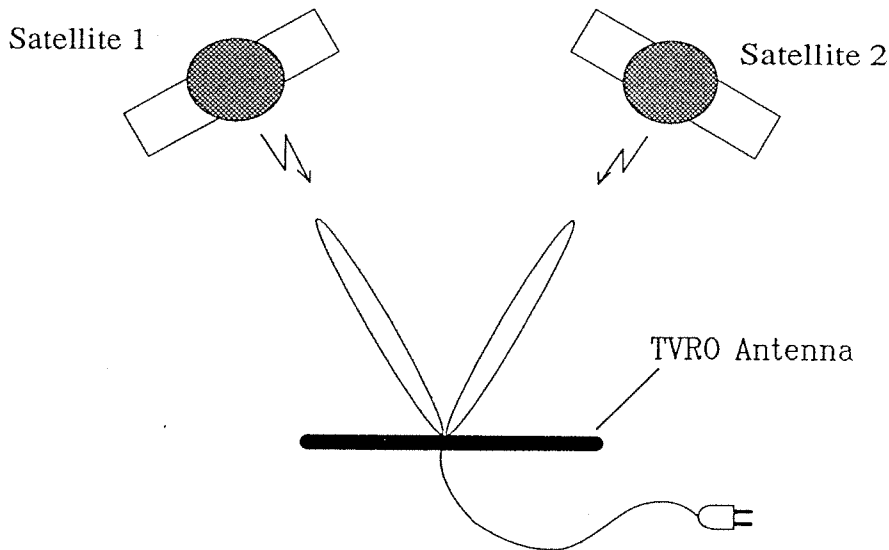


Figure A.1.1 Dual beam TVRO antenna illustration

TVRO Technical Specifications

The technical specifications of the planar dual beam TVRO antenna are listed below. Our weekly meetings were devoted to TVRO discussions for a better comprehension of the problem as well as the technical specifications; further clarifications were also requested from A. Roederer. A possible dual beam operation is illustrated in Fig. A.1.2, using a one-dimensional array for simplicity and the dots resemble the individual radiators. The basic mechanism of dual beam generation relies on the end-fed topology. In the following sections we investigate this idea more deeply. Before we embark on phased-array topologies, it is timely to explore the satellite positions as seen from Ankara.

Frequency: 10.9 - 11.7 GHz

Beam Numbers: 2 (42° East - Turksat** and 19.2° East Eutelsat 2)

Side Lobe Level: < -25 dB for $\theta \geq 3.0^\circ$ in plane of geostationary orbit

Polarization: Switchable two linear polarizations
with 1° polarization alignment accuracy
-20 dB cross-polarization level (within 1 dB contour)

G/T (Gain/Noise Temperature): 12.5 dB/K = $10\log(G/T)$

Pointing Error: < 0.4°

**In the original specs distributed by A. Roederer, Eutelsat 1 at 13° East was actually given instead of the Turksat satellite, however, this modification was made by our group based on our particular interest.

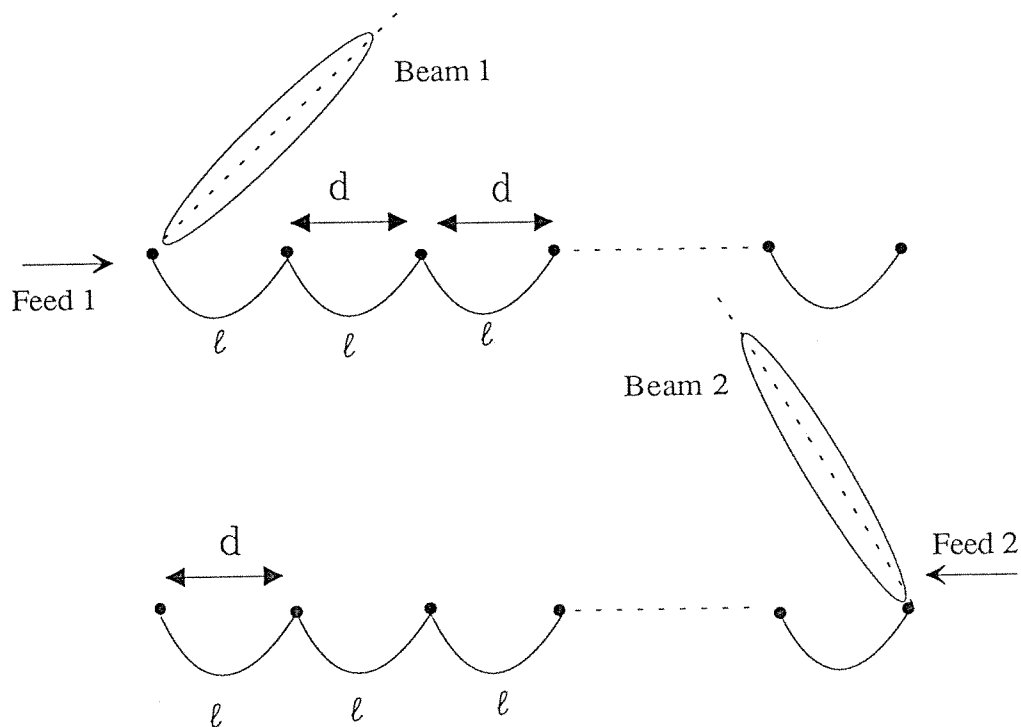


Figure A.1.2 Dual beam generation using end-fed topology

Satellite Positions

The specific radiation pattern of the dual beam TVRO antenna depends on the relative positions of the receiver and the two satellites. First we display the absolute positions of these three objects; see Fig. A.1.3 and the following illustrations.

Receiver: 32.875° East, 39.9375° North (Ankara)
 Turksat: 42° East, 0° North (Equatorial plane)
 Eutelsat 2: 19.2° East, 0° North (Equatorial plane)

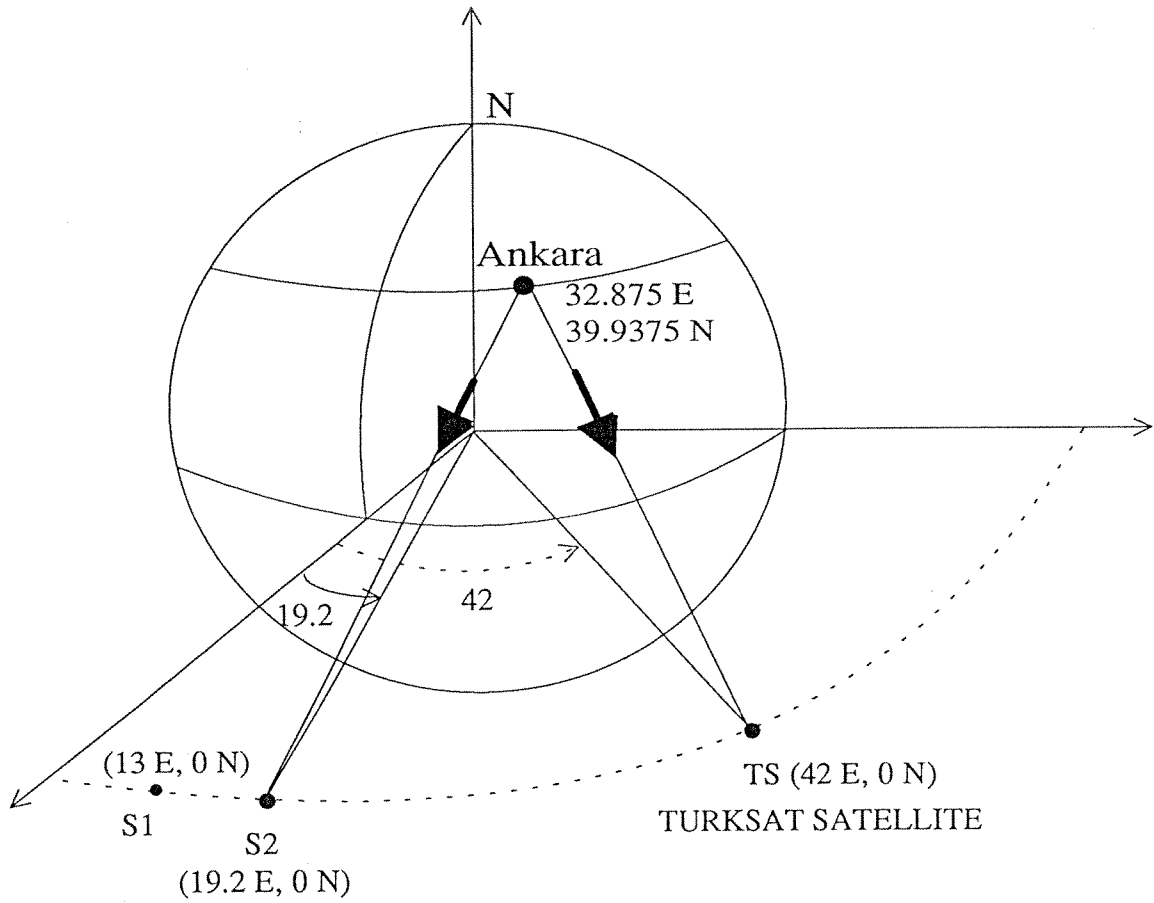


Figure A.1.3 Positions of the two satellites and Ankara

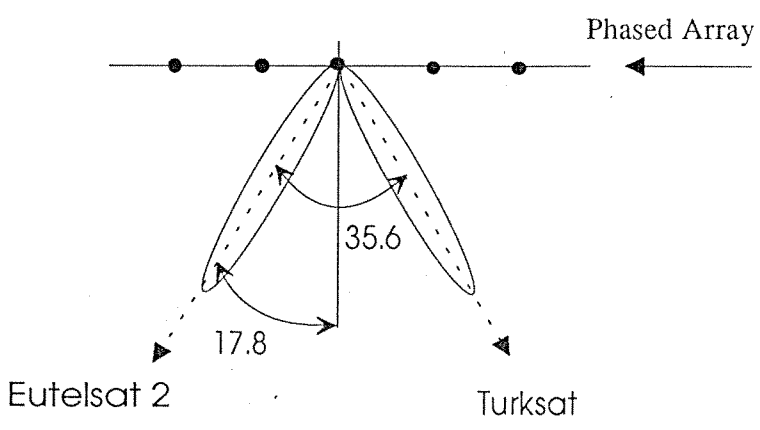
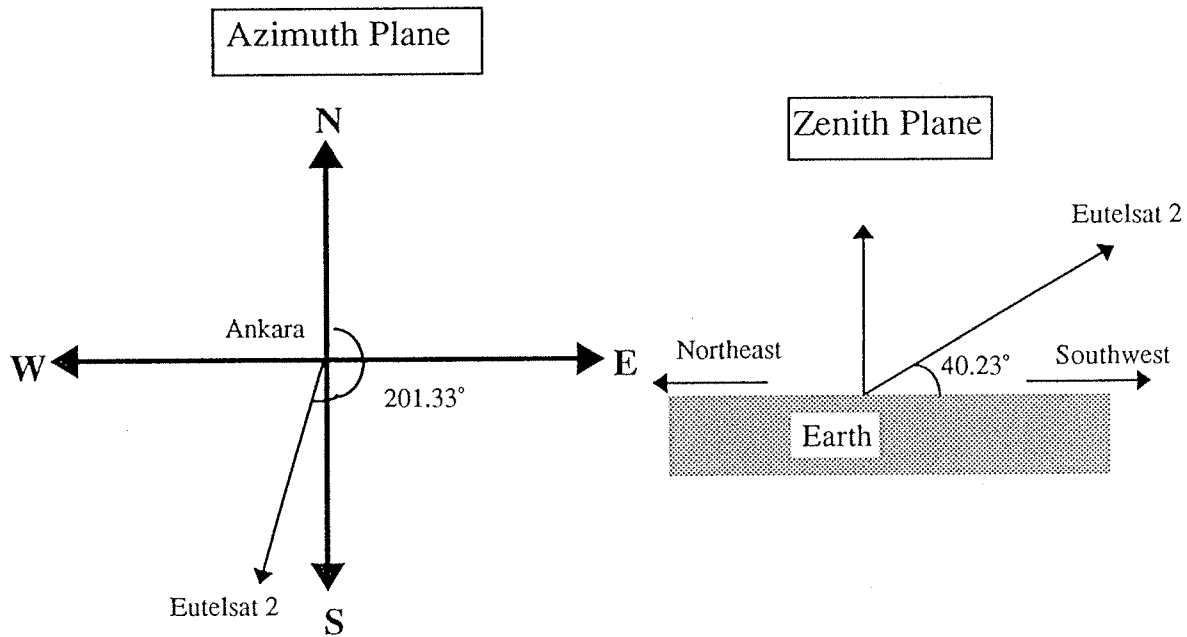
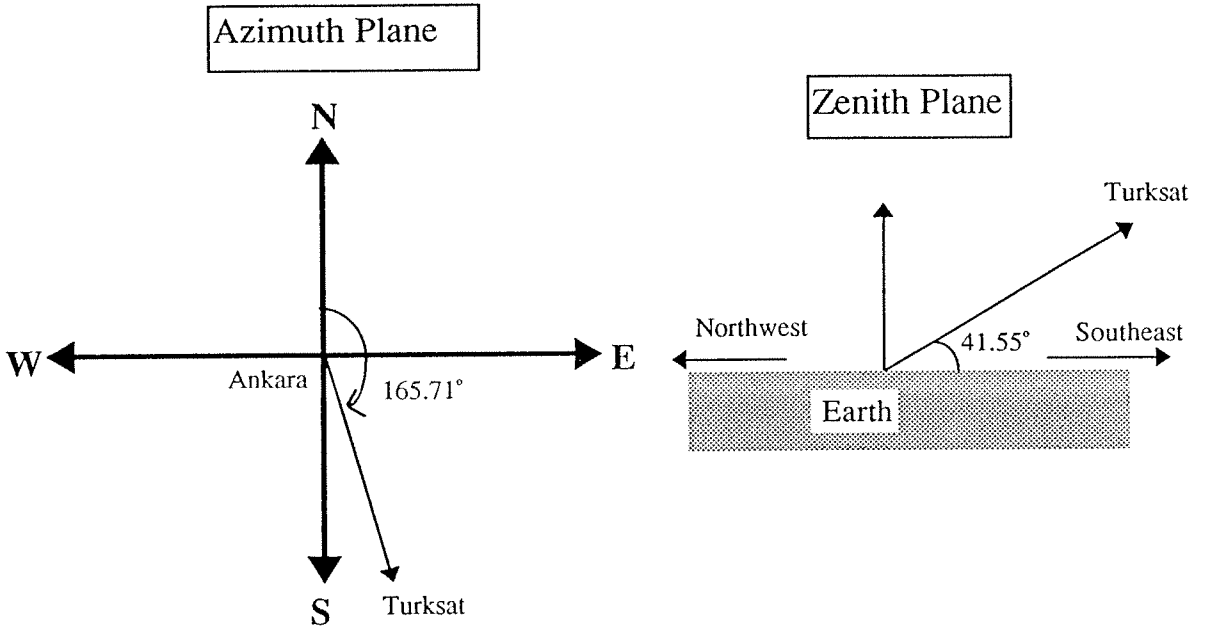


Figure A.1.4 The beam angles in the azimuth plane with the ground base chosen as Ankara

Unit Vectors:

$$r_1 = 0.7179 a_x + 0.68385 a_y - 0.13025 a_z \text{ (Ankara} \rightarrow \text{Turksat)}$$

$$r_2 = 0.95008 a_x + 0.28334 a_y - 0.13064 a_z \text{ (Ankara} \rightarrow \text{Eutelsat 2)}$$



According to the calculated satellite positions with respect to Ankara, the angle between the two beams becomes 35.6° in the azimuth plane (see Fig. A.1.4).

Preliminary Studies

After examining several types of configurations, it is decided that a microstrip patch antenna array with microstrip line feeds is feasible for the required design. A planar array with 39 elements in one direction and 18 elements in the other direction is designed to meet the high gain specifications. To provide low side lobe level, a Gaussian tapered excitation is found to be appropriate in both directions. The amount of tapering (the ratio of the largest to the lowest excitation coefficient) is dictated by the beamwidth specification. Tapering is achieved by using transmission-line transformers between the patches.

Several feeding configurations are examined, such as series and parallel; the advantages and disadvantages of each topology are summarized below.

Our first trial design is shown in Fig. A.1.5. In this array, series feeding is used in both directions.

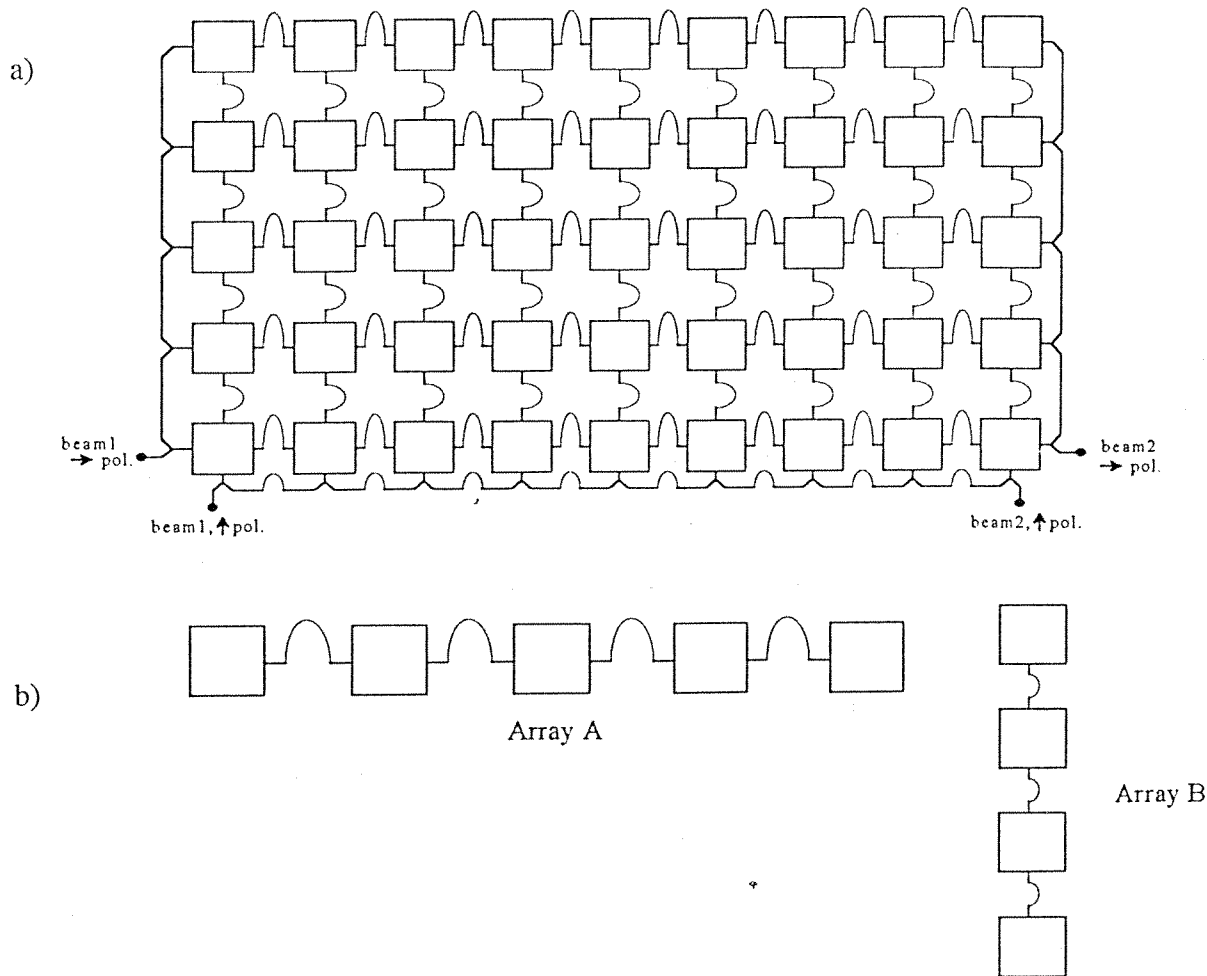


Figure A.1.5 First preliminary design a) having series fed topology, and b) individual arrays

In this design, horizontally polarized beam 1 is excited from the upper left port, whereas vertically polarized beam 1 is excited from the lower port. With this topology it is not possible to make the ends of the one-dimensional arrays open. This causes some problems in impedance calculations, since it is required to feed both of

the ends to obtain a dual beam. For this reason a new array with the same number of elements but a different feeding structure for array A is designed. As shown in Fig. A.1.6, for this case the feeding of array A is chosen to be parallel whereas the feeding of array B is kept series. For the required excitation coefficients, two-step transformers are designed between the patches. However, it is observed that when the one-dimensional array is fed from one end, the input impedances seen from the input of each patch becomes smaller and smaller as one proceeds to the input of the array. In Fig. A.1.7, the input impedances seen from the input of each patch is plotted for array B.

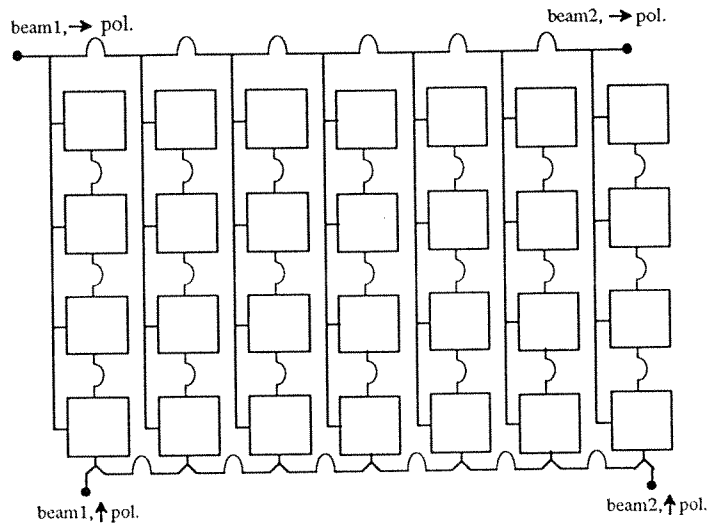


Figure A.1.6 Second preliminary topology having a parallel fed array A

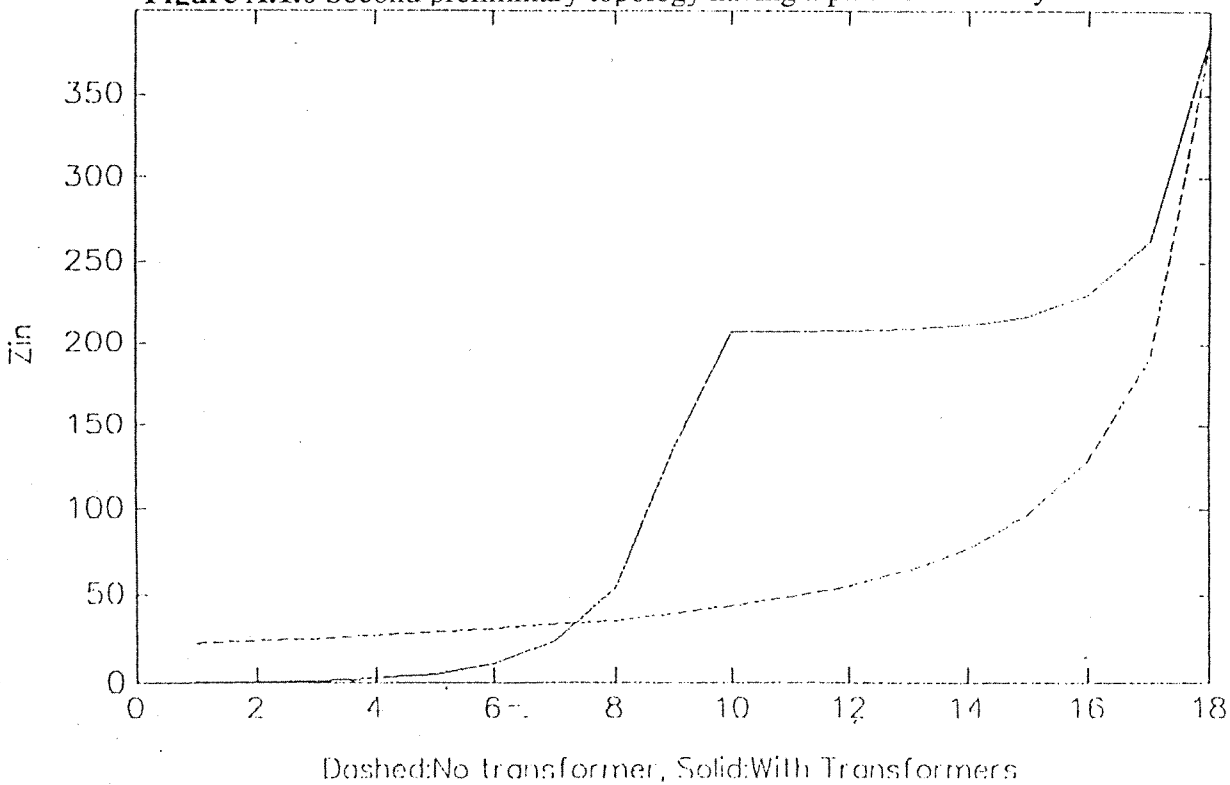


Figure A.1.7 The variation of the input impedance within the array B

As can be observed from Fig. A.1.7, the input impedance decreases drastically after the midpoint of the array since the Gaussian tapering changes direction after this point. In other words, the coefficients begin to decrease after the midpoint, whereas they increase before the midpoint. In order to eliminate this problem, it is decided to switch to a center-fed topology. Dual beam operation is not possible by using a center-fed topology. However, dual beam satellite antenna has an important drawback: the angle between the two beams depends highly on the local position of the antenna. Thus, different antennas need to be designed for different cities. In this case, a dual beam can be achieved by just adjusting the orientation of two separate antenna arrays.

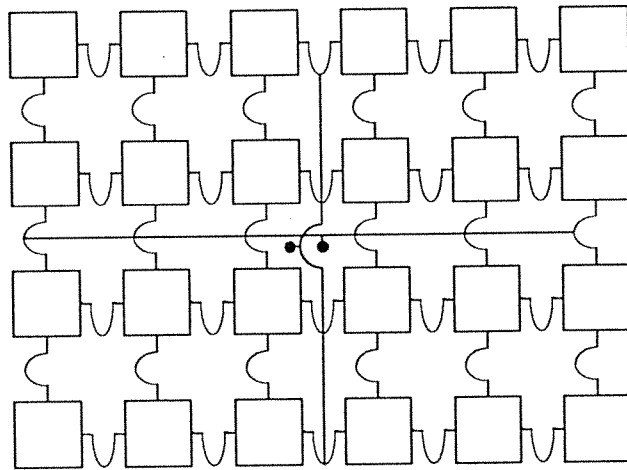


Figure A.1.8 The third preliminary antenna with center-fed topology

In Fig. A.1.8, the center-fed topology is shown. To satisfy symmetry, an even number of elements is used. Due to the symmetry of this configuration, in addition to the transmission-line transformers, losses along these lines are utilized to achieve tapering. In this way losses are used in a beneficial manner, and this advantage results in a low noise temperature. The decrease in noise temperature enables one to decrease the gain in order to meet the same G/T requirement. Consequently array dimensions are decreased from 39×18 to 32×12 .

A more detailed investigation of the last topology reveals that series feed leads to a tuning problem. The physical length of a microstrip patch antenna is generally chosen to be slightly smaller than the half of the guided wavelength for resonance. In other words, the physical resonance length of a patch is calculated by equating the imaginary part of the input impedance to zero. However, in the series feeding case, each patch is loaded by the remaining ones. Consequently, the length of each patch should be adjusted to a different value due to the different loading. On the other hand, the patches should be square in order to obtain dual polarization. Hence when the resonance is obtained for one polarization, it cannot be satisfied for the other polarization. In order to eliminate the tuning problem, a parallel feeding structure is preferred. When both array A and array B are fed in parallel, the feeding lines will cross each other. Thus, a two-layered structure must be considered to obtain dual polarization. As an initial step, we decided to complete all the calculations and analysis of an array with one polarization (see Fig. A.1.9).

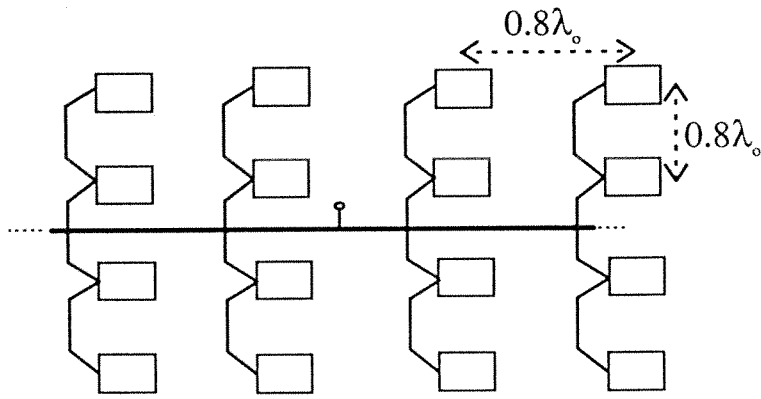


Figure A.1.9 The fourth preliminary center-fed topology (only a portion is shown)

For both array A and B, Gaussian tapering is used, and the spacing between the array elements are chosen to 0.8 of the wavelength. The associated radiation patterns are supplied in Figs. A.1.10 and A.1.11.

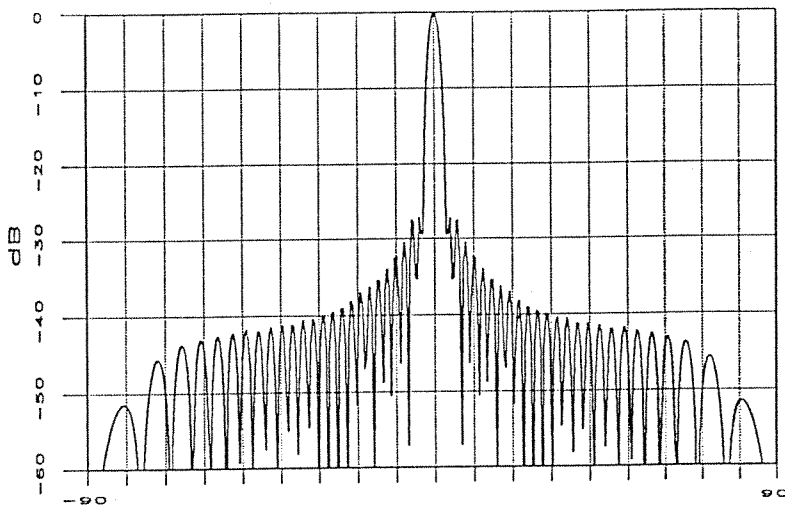


Figure A.1.10 The radiation pattern of array A

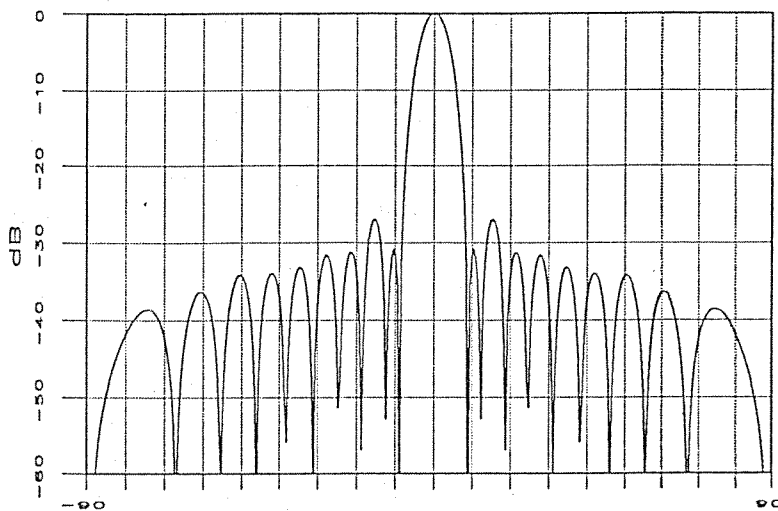


Figure A.1.11 The radiation pattern of array B

A software is developed to analyze the performance of the designed array. Patch antennas are substituted by their transmission-line equivalent models. The radiation conductance, effective permittivity, and the slot capacitance of the patch are evaluated by using the more recently developed formulas. The losses in the transmission-lines are computed by using the empirical formulas of the transmission-line model and the losses in the patch antennas are evaluated by using the cavity model. The analysis is carried out by using the ABCD matrix method. In order to obtain wideband operation, two-step transmission-line transformers are used between the array elements to achieve Gaussian tapering. A transmission-line transformer is a combination of two transmission-lines with different characteristic admittances. A two-step transformer is obtained by using two single transformers successively. Consequently, between each element, there are four pieces of transmission-lines, each having a length of quarter-wavelength. The characteristic admittance of the first and the third section (Y_s) of the transformer are chosen to be equal between each antenna and the width of this transmission-line section is fixed to 1 mm ($Y_s=0.0061$ mho). The characteristic admittance of the second and the fourth sections (Y_{sn}) are chosen to be equal and they are synthesized for each element to achieve tapering. By using Gaussian distribution, the required voltage ratio (V_m) of two adjacent array elements are calculated. Starting from the last element of the array, the initial guess of the characteristic is made by equating the ratio Y_s/Y_{sn} to the square root of the desired voltage ratio. Then the voltage ratio is calculated due to this characteristic admittance. The characteristic admittance is updated by using the error between the desired and the calculated voltage ratios and the same procedure is iterated until an acceptable error is attained. After the synthesis of the last element is finished, the same procedure is applied to the proceeding element. For array B, as there was not enough space, a single step transformer is designed at the input of the first element. By the first element it is meant the first element with respect to the symmetry axis of the array. If the input admittance seen from the first element of array B is Y_B then the elements of array A have input admittance values of $2Y_B$. Due to this fact, the transformer at the input of array B is synthesized in such a way that Y_B is equated to the half of Y_s in order to minimize the mismatches. The desired voltage ratios and the synthesized characteristic admittances for array B and A are given in Tables A.1.1 and A.1.2, respectively.

n	voltage ratio(V_{rn})	Y_{cn} of the line
1	0.442387	1.37766E-02
2	0.890899	6.44989E-03
3	0.824861	6.70618E-03
4	0.763712	6.97185E-03
5	0.707104	7.24762E-03
6	0.654691	7.53462E-03

Table A.1.1 Voltage ratios and synthesized characteristic admittances for array B

n	voltage ratio(V_{rn})	Y_{cn} of the line
1	0.994589	6.05976E-03
2	0.983879	6.09936E-03
3	0.973283	6.13807E-03
4	0.962800	6.17613E-03
5	0.952429	6.21372E-03
6	0.942170	6.25099E-03
7	0.932022	6.28803E-03
8	0.921982	6.32497E-03
9	0.912051	6.36186E-03
10	0.902227	6.39880E-03
11	0.892508	6.43588E-03
12	0.882894	6.47319E-03
13	0.873384	6.51086E-03
14	0.863976	6.54906E-03
15	0.854669	6.58806E-03
16	0.845459	6.62826E-03

Table A.1.2 Voltage ratios and synthesized characteristic admittances for array A

Input impedance of the overall antenna array is calculated for different frequencies and the obtained VSWR versus frequency curve is given in Fig. A.1.12. It can be observed from the figure that the required frequency bandwidth is achieved as far as the input impedance is concerned (in finding the bandwidth, VSWR values under 2 are considered).

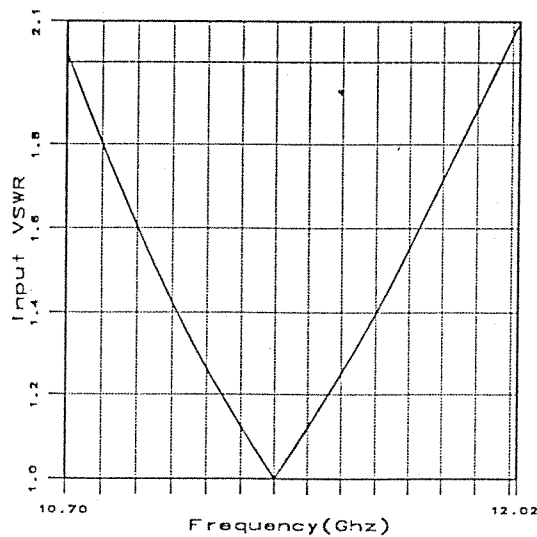


Figure A.1.12 The input VSWR versus frequency of the fourth preliminary design

A.1.2 Theoretical Material

In this section we would like to gather some of the theoretical material that we developed and/or used for the comprehension and the design of the phased array antennas.

Directivity Calculations

In computing the overall directivity of the planar array the formula given in the "Antenna Handbook", written by J.R. James is used [1]. The planar array consists of two orthogonal linear arrays, array A and array B as shown in Fig. A.1.13.

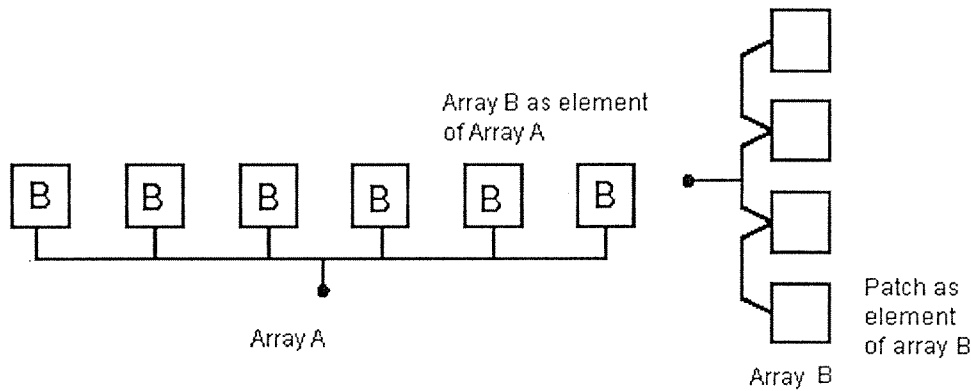


Figure A.1.13 Microstrip patch arrays: Array A and Array B

If D_A and D_B are directivities of these two arrays and D_c is the directivity of the patch element, then the directivity of the overall array according to the book by R.S. James, [1], is given as

$$D = \pi D_A D_B D_c,$$

where

$$\text{Directivity of array A, } D_A = \frac{\left[\sum_{m=1}^{N_A} \alpha_A(m) \right]^2}{\sum_{m=1}^{N_A} \sum_{n=1}^{N_A} \alpha_A(m) \alpha_A(n) \frac{\sin[k_o(d_m - d_n)]}{k_o(d_m - d_n)}}$$

$$\text{Directivity of array B, } D_B = \frac{\left[\sum_{m=1}^{N_B} \alpha_B(m) \right]^2}{\sum_{m=1}^{N_B} \sum_{n=1}^{N_B} \alpha_B(m) \alpha_B(n) \frac{\sin[k_o(d_m - d_n)]}{k_o(s_m - s_n)}}$$

$$d_m = (m-1)d, s_m = (m-1)s$$

α_A, α_B : excitation coefficients of array A and array B, respectively:

$$\alpha_A(n) = \exp\left[\left(\frac{n}{N_A}\right)^2 \ln P_A\right], \alpha_B(n) = \exp\left[\left(\frac{n}{N_B}\right)^2 \ln P_B\right]$$

N_A, N_B : number of elements in array A and B respectively

d: spacing between centers of adjacent two element in array A
s: spacing between centers of adjacent two element in array B

By making use of this formula the overall directivity for $P_A=P=0.25$, $N_A=38$, $N_B=16$, $s=d=0.85\lambda_0$, and $f=11.3$ GHz ($\lambda_0=26.53$ mm) is calculated as 41.75 dB, ($D_A=44.75$, $D_B=16.39$, $D_e = 6.5$, $D = 14,979.25$ (41.75 dB)). On the other hand, the directivity can also be computed approximately by using a modified version of the Kraus formula which is widely used for the analysis of arrays. If θ_E θ_H and are the half power beamwidths (in degrees) in the E-plane and H-plane, respectively, then the directivity of the overall array can be approximated as:

$$D = \frac{32400}{\theta_E \theta_H}$$

This approximate formula is valid as long as the beamwidths are narrow and sidelobe levels are low. In the designed TVRO antenna array, both of these conditions are satisfied so Kraus' formula can be used to calculate the directivity of the array. The field pattern of the array is computed by including the element pattern and the half power beamwidths are found to be 2° in the E-plane and 5° in the H-plane. Consequently, the directivity is computed to be 35.1 dB. The big discrepancy between the two directivity values lead us to question whether there is a mistake in the formula given by the handbook. Pattern multiplication rule is a well known theorem in the array analysis, but this directivity formula makes use of directivity multiplication which is not an admissible approach. In the pattern multiplication, field patterns are multiplied but directivity multiplication requires the multiplication of powers that is not permitted. In order to remove any doubts about the calculation of the directivity, a rigorous approach which makes use of the definition of directivity is used. If U is the radiation intensity (Watts/steradian) and U_0 is radiation intensity of isotropic source, then the directivity is defined as:

$$D = \frac{U_{\max}}{U_0} = \frac{4\pi U_{\max}}{P_{\text{rad}}}$$

where P_{rad} is the total radiated power.

The field pattern has already been computed, so only the integration of the power intensity over the whole space is required. The integration is performed by two different methods. In the first approach, the integration with respect to ϕ is performed analytically and the integration with respect to θ is performed numerically. The ϕ integration results in Bessel functions which can be computed numerically by using some approximations. In the other approach the double integration is performed numerically. In both methods, Gauss' Quadrature procedure is used for numerical integrations. To test the convergence of the integrals, the integration interval is divided into subintervals and the number of Gauss' Quadrature points are increased. As a result, the two different approaches gave the same result which is 35.7 dB. This result is very close to the directivity of an array with isotropic sources, $D=35.4$ dB. This result is not surprising as the array is so directive that the directivity of the element does not contribute to the overall antenna performance. This would not be the case if the array involves grating lobes, fan beams or main beam in any other direction rather than the broadside. As a result, the formula given in the handbook is

basically wrong and not applicable to all types of array configurations and the rigorous calculation of the directivity can be found only by computing the total radiated power.

Linearity Considerations for an Active Phased Array Antenna

Active receive arrays operate in a medium where the frequencies of the signals are closely distributed as in the case of satellite communication. In the framework of COST 245 we deal with passive and active antenna arrays. Linearity is not an important issue for passive arrays because there is no nonlinear element in the structures. However, active antennas and antenna arrays include transistors as the active elements and due to nonlinear structure of these devices, linearity becomes an issue to be considered. Linearity of an active array is of ultimate importance from point of view of intermodulation distortion. Linearity of systems like amplifiers, mixers, have been widely studied by several authors and fast analysis methods are also proposed [2,3], but linearity of an active antenna array is not considered so far.

Such antenna arrays include a number of active elements in their structure and this number increases as the size of the array increases. Active antenna arrays are analysed and designed using microwave circuit simulators [4]. However, a nonlinear analysis for determining linearity of an active array using nonlinear analysis tools of such simulators (e.g harmonic balance) will require a considerable computing time.

Linearity Calculation of an Active Array

We describe a method to calculate the linearity of an active antenna array without using such time consuming simulation tools. Moreover, we present an accurate nonlinear analysis tool which is faster than any previously reported methods [2]. We used this tool for linearity analysis of a 4x8 active antenna array. We show that the linearity of such an array increases as the number of distinct amplifier per antenna element increases, and it is also shown that linearity and noise performance of distributed amplification, as in the case of an active antenna, is superior to amplification with a single amplifier placed at the output of the array.

It is well-known that nonlinear behaviour of the active devices result in intermodulation (IM) products. Nonlinear parameters of the active element and the input and the output impedances connected to the active element at the fundamental and the IM frequencies determine the nonlinear operation.

In the case of an active array, the input signal entering from an antenna element mix with the other frequency components received by the same antenna, at the active device and continue its way to the output together with the generated IM products. All these signals are sum up at the output of the array and yield the distorted received signal. Analysis of the complete active array using a harmonic balance simulation costs a high computation time because of the multiple nonlinear elements in the system.

An active antenna array differs from structures like amplifiers and mixers, being a multiple input, single output system. Therefore, usual nonlinear analysis treatments can not be applied directly [2,3,5].

We treat the active devices as if they are distinct amplifiers operating in a system having the identical connections as in the array. By this way, we come over complicated nonlinear analysis of multiple active devices placed in the same structure. Using our nonlinear analysis tool, the IM products generated by these active devices are calculated considering the nonlinear behaviour and the termination impedances. Then, it is assumed that signals equivalent to these IM products in magnitude are received by antenna elements from outside the antenna. In the next step, active elements are assumed to be linear and the contribution of IM products which are referred to the antenna side are summed up at the antenna output to find the IM product and this cumulative signal is compared with the power of the signal at the fundamental frequency in order to determine the linearity.

Active Antenna Array Structure

A 4x8 active antenna array, which is shown in Fig. A.1.14, is designed and analysed for its linearity. The feed system of the array is designed for a specific feed taper which is required for a given side lobe level. Because of this, other than the symmetry in the feed system, each antenna group which is connected to an active circuit sees a different impedance. Moreover, the impedance matching considerations are taken into account at the fundamental frequency only, but, for IM products the impedance levels at the intermediate frequencies are also of prime importance. Due to these facts the IM products generated by these active circuits will generally be of different phase and amplitude. Therefore nonlinear analysis are carried out for each of them separately.

We have developed a power series based nonlinear analysis of HEMT and MESFET transistors which yields results that are consistent with harmonic balance simulations but at much lower computational cost. This method is capable of calculating IM products for all active devices simultaneously. IM products of the above array is calculated within seconds and written to a data file.

The active array is constructed on the microwave circuit simulator LIBRA, using the transmission line model of the patch antennas and the feed coefficients of the active array, which represent the received power of individual antenna elements through two current sources, are loaded from a data file as described in [4]. In our method, active array is simulated twice by the linear simulation tool of LIBRA. In the first one, the feed coefficients have progressive phase shifts which stands for a received signal at an incident angle. In the next simulation, the data file generated by our nonlinear analysis is used, which stands for the IM products generated by the active elements. The results of these two simulations are processed to obtain the linearity of the active antenna array. This completes the simple and fast nonlinear analysis of active array for its linearity.

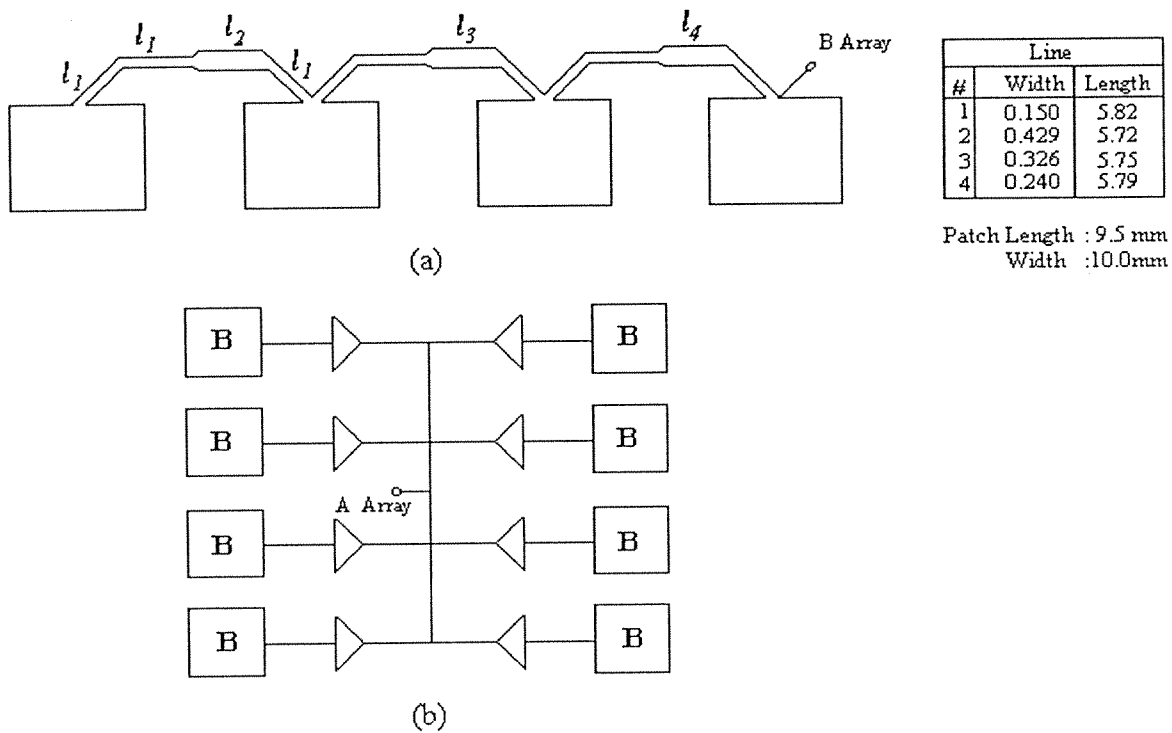


Figure A.1.14 Active antenna array structures: (a) passive sub-array (b) active array

Comment on Linearity of Passive and Active Antenna Arrays

A passive antenna arrays by itself is a highly linear element. However, a low noise amplifier (LNA) should be connected to this passive array for a proper receive operation. The combination of these two structures will be a nonlinear structure due to the nonlinearity of the LNA.

IM products are proportional to the third power of the input signal. In a distributed amplification system like an active antenna array, IM products will be generated for a lower input signal and then, will be added at the output. However, in a passive array and LNA combination, the signal will first be added at the output of the passive array and then, will be amplified and distorted by the LNA, which, obviously, creates more distortion compared to the distributed amplification case under the assumption that active circuits have similar linearity performance in both cases.

This simple comparison shows that active antenna arrays have better linearity compared to passive antenna array systems.

References

- [1] J. R. James and P. S. Hall, "Handbook of Microstrip Antennas", IEE EMT Series 28, vol.2, 1989, p.831.
- [2] J. C. Pedro, J. Perez, 'Accurate Simulation of GaAs MESFET's Intermodulation Distortion Using a New Drain Current Model', IEEE Transactions on MTT, vol. 42, Jan. 1994, pp 25-33.

[3] S. A. Maas, D. Neilson, 'Modeling MESFETs for Intermodulation Analysis of Mixers and Amplifiers', IEEE Transactions on MTT, vol. 38, Dec. 1990, pp 1964-1971.

[4] S. Demir, C. Toker, A.Hizal, "Design of Active Microstrip Array Using a Microwave Circuit Simulator", in 1997 IEEE MTT-S International Topical Symp. on Technologies for Wireless Applications, Vancouver.

[5] A. M. Crosmun, S. A. Maas, 'Minimization of Intermodulation Distortion in GaAs MESFET Small Signal Amplifiers' IEEE Transactions on MTT, vol. 37, Sep. 1989, pp 1411-1417.

Thermal Noise Analysis in Antenna Arrays

Introduction

For satellite receiving antennas, a high value of G/T ratio (the so-called figure of merit of the antenna) is desired. G is the power gain of the antenna system and T characterizes the output noise power of an antenna system in terms of an equivalent temperature [1]. Accordingly, antenna design must also assess the noise performance of the system as well as its gain. The output noise is due to noise sources in space and the sources within the receiving array. Especially for printed antenna arrays that can contain as much as, some few hundred antenna elements, the noise generated within the antenna array can reach quite high levels. In this work we do not consider the space generated noise and present a simple methodology for the analysis of thermal noise generated by receiving arrays, based on Nyquist's formula and basic thermal equilibrium concepts. In other words, the only source of noise is considered to be the thermal noise (Johnson noise) due to lossy elements within the receiving antenna.

Thermal Noise

Thermal noise, which is essentially a *fluctuating* electrical signal, has intimate connection with the losses (i.e., *dissipation*) within the system. This relation was uncovered by the fluctuation-dissipation theorem due to Callen and Welton in 1951 [2]. However, the theoretical basis of thermal noise in electrical circuits was established long time ago by Nyquist taking into account full quantum mechanical effects [3,4]. The expression simplifies for frequencies less than 10 THz and the associated rms noise voltage across a resistor R having a physical temperature T (°K) becomes $v_n = \sqrt{4kTBR}$ where k is Boltzmann's constant and B is an arbitrary bandwidth. For antenna arrays the thermal noise generation is due to interconnecting transmission lines and conductor and dielectric losses within the radiating array elements. In contrast to this, the radiation resistance of the antenna elements do not take part in thermal noise generation and their role is to represent the radiation mechanism. As a matter of fact, the presence of radiation resistances reduces the noise power at the output of the antenna array as the generated thermal noise is *radiated* to outer space through these antenna elements. At this point we assume that the radiated thermal noise from an array element is not picked up by an other member of the array (no mutual coupling), that is to say that part of the noise is completely lost. In summary, from a circuit analysis point of view we consider the radiation resistances to be noiseless (or equivalently at 0 °K). Then for an antenna array that is terminated by a conjugate matched load Z_L (Fig. A.1.15), the thermal noise power delivered to Z_L can be determined with the following equations

$$P_{net} = P_{tot} - \sum_i P_{ni}$$

where P_{net} is the net thermal noise power delivered to load Z_L generated by lossy elements within the receiving array, P_{tot} is the noise power delivered to Z_L as if the radiation

resistances are also noisy and P_{ni} is the noise power contribution of the i 'th radiation resistance (assuming it to be at T degrees) at Z_L . P_{tot} is given by

$$P_{tot} = \frac{4kTB \operatorname{Re}\{Z_{ant}\} \operatorname{Re}\{Z_L\}}{|Z_{ant} + Z_L|^2},$$

and for a conjugate matched load this reduces to the well-known case $P_{tot} = kTB$. Having calculated P_{net} we can characterize this power by an equivalent temperature as $T_{eq} = P_{net} / kB$.

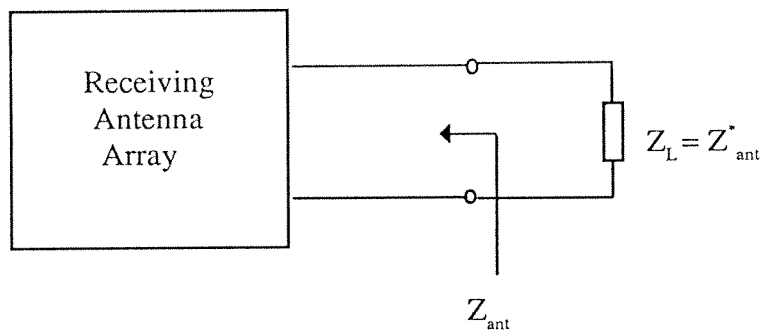


Figure A.1.15 Receiving antenna array and the conjugate matched termination.

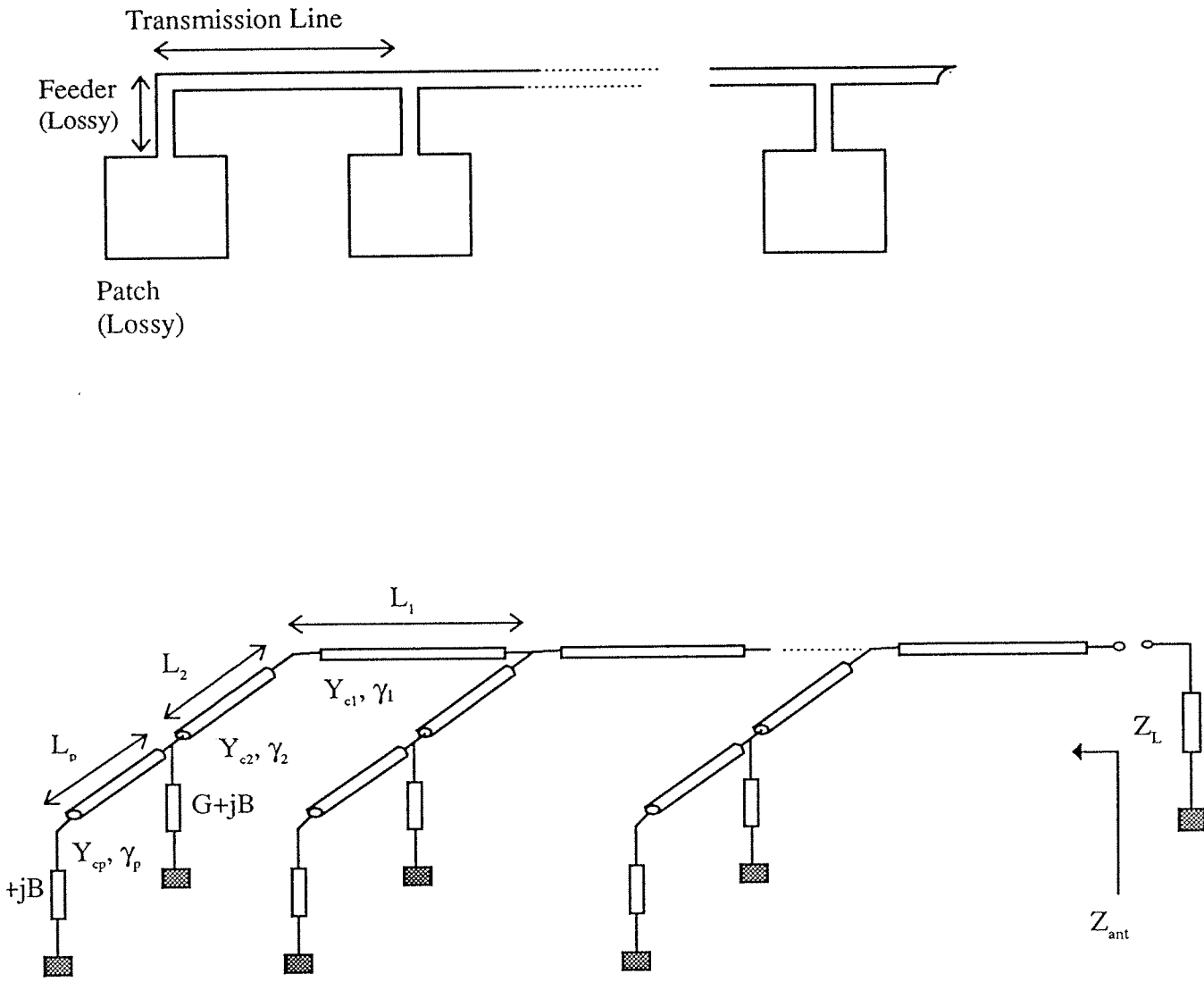


Figure A.1.16 Parallel fed linear microstrip patch array (top) and the transmission-line equivalent model corresponding to this array (bottom).

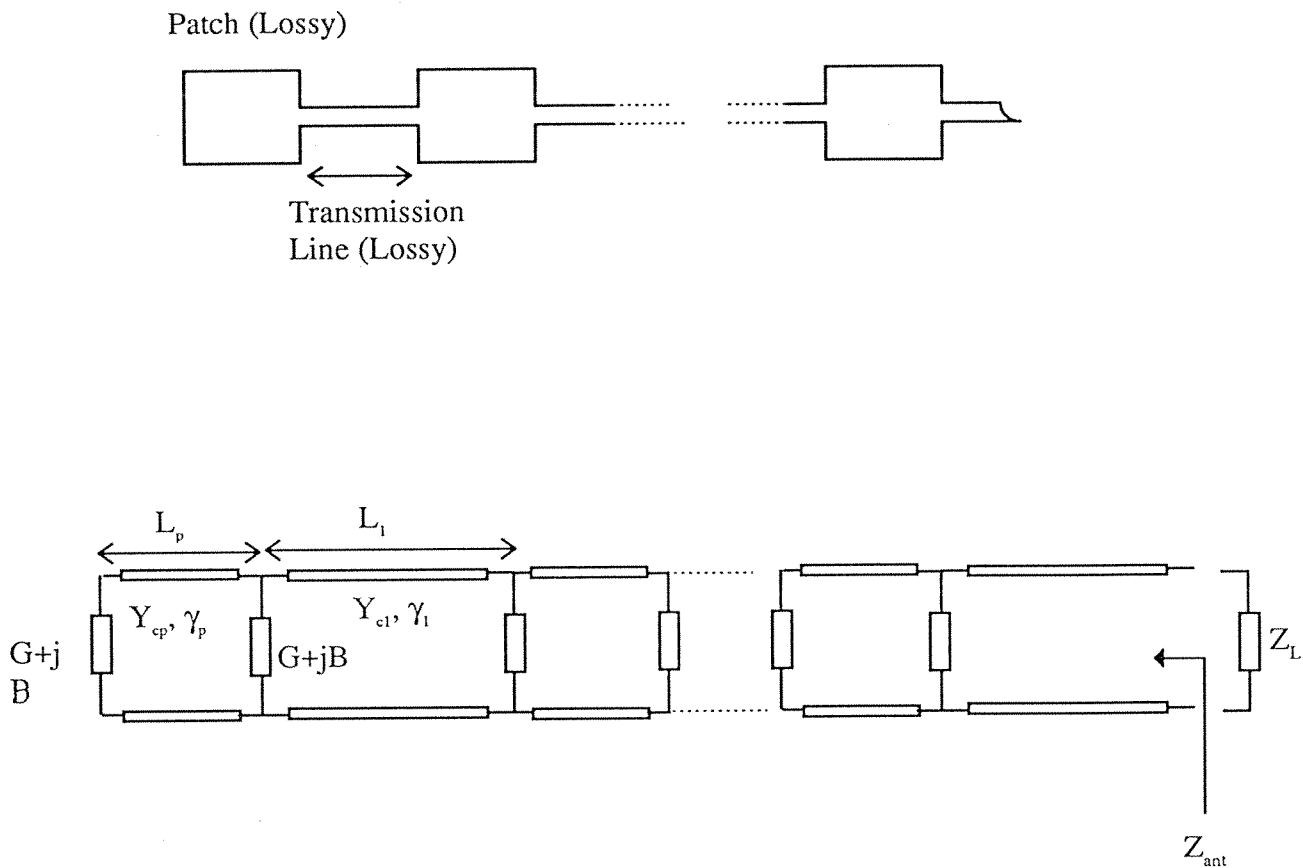


Figure A.1.17 Series fed linear microstrip patch array (top) and the transmission-line equivalent model corresponding to this array (bottom).

Results and Conclusions

The thermal noise output characteristics of linear parallel and series fed microstrip patch arrays are considered in this section. These arrays are analysed by using their equivalent transmission line models [5] shown in Figs. A.1.16 and A.1.17. The variation of equivalent output noise temperature T_{eq} with respect to the number of array elements (N) is illustrated in Fig. A.1.18 for both parallel and series fed arrays. The element values for the equivalent transmission line model is listed in Table A.1.3. For each new value of N , the array is terminated with a conjugate matched load corresponding to the maximum power transfer condition. For a parallel fed array T_{eq} initially increases proportionally with N even though the series fed one virtually does not depend on the number of stages and shows a much smaller value. In Fig. A.1.19, the dependence of T_{eq} on the losses of transmission lines is illustrated for parallel and series fed arrays. The values in Table

3 are used with $N=20$. If every resistive element in the array were noisy T_{eq} would be 290 °K. However, due to dominating contribution of radiation resistances this value is much lower (loss multiplication factor equal to unity case). But as the losses of transmission lines are increased, asymptotically the 290 °K value is reached. From Fig. A.1.19, it is seen that the parallel fed geometry is initially more susceptible to loss variations than the series fed case. As far as thermal noise performance is concerned series fed microstrip arrays seem to be superior to parallel fed linear arrays.

	Characteristic Admittance (mho)	Propagation Constant (mm^{-1})	Length (mm)	Radiation Admittance (mho)
Patch	$Y_{cm} = 0.019804$	$\gamma_n = 4.916 \cdot 10^{-5} + j0.235884$	$L_n = 9.248384$	$G+jB=0.00265 + j0.010162$
Transmission Line	$Y_{cl} = 0.00610$	$\gamma_1 = 8.278 \cdot 10^{-5} + j0.2346$	$L_1 = 26.78179$	Not Applicable
Feeder Line (parallel fed)	$Y_{c2} = 0.00610$	$\gamma_2 = 8.278 \cdot 10^{-5} + j0.2346$	$L_2 = 3.3477$	Not Applicable

Table A.1.3 Element values for transmission-line equivalent model (see Figs. A.1.16 and A.1.17 for the elements).

Finally, the same thermal noise analysis methodology is applied to the *planar* microstrip geometry mentioned in the previous section (A.1.1) shown in Fig. A.1.9. For this geometry the equivalent noise temperature is calculated as $T_{eq}=26.1$ °K.

References

- [1] K. Feher, 'Digital communications', 1983, pp. 29-44
- [2] E. M. Lifshitz and L. P. Pitaevskii, 'Statistical physics', Part 1, (Pergamon Press, 1980), pp. 384-389
- [3] M. Schwartz, 'Information transmission, modulation, and noise' (McGraw-Hill, 1970), pp. 541-555
- [4] R. E. Collin, 'Antennas and radio wave propagation' (McGraw-Hill, 1985), pp. 312-325
- [5] K. C. Gupta, in 'Handbook of microstrip antennas' edited by James, J.R. and Hall, H.A., (Peter Peregrinus Ltd., 1989), pp. 455-460.

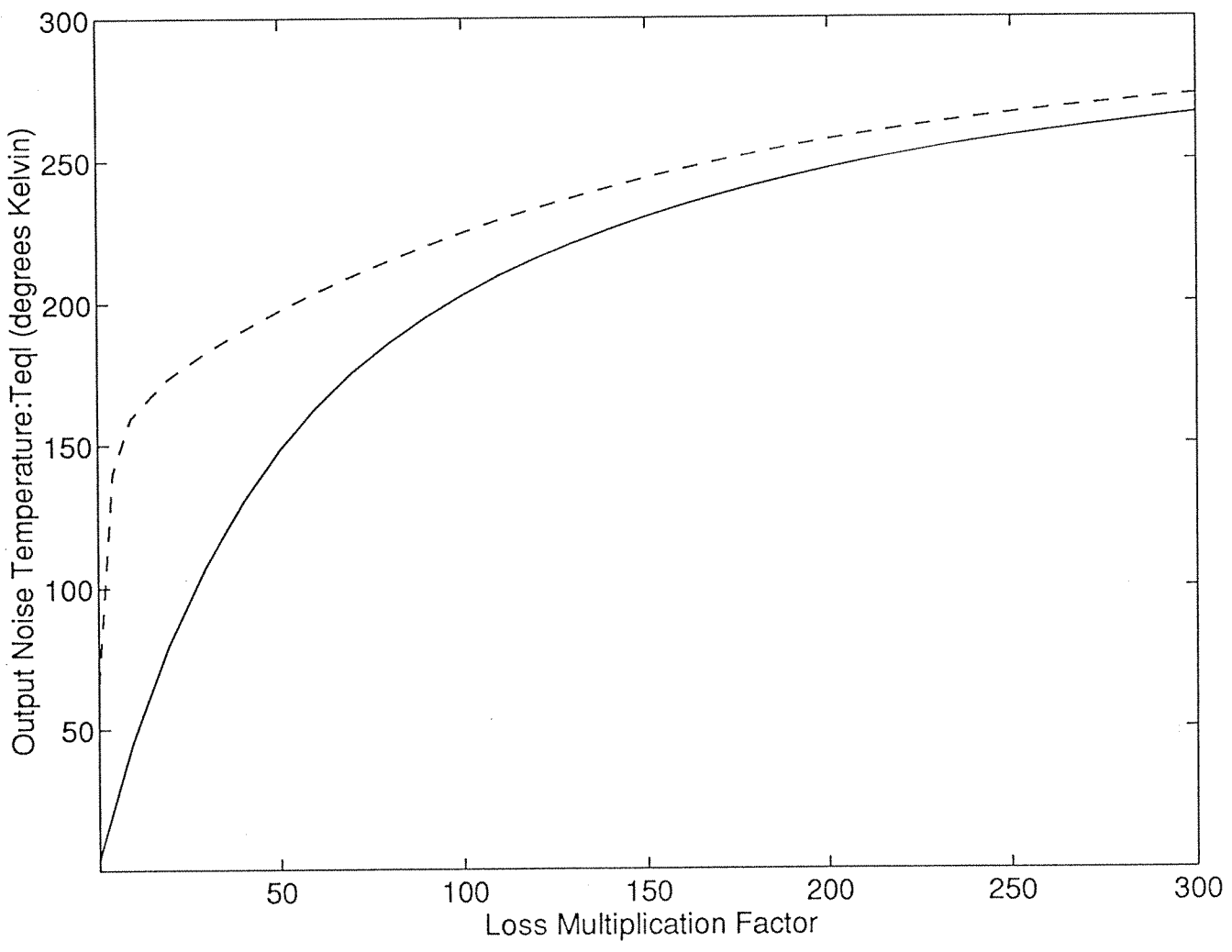


Figure A.1.19 The dependence of output noise temperature on the losses in the transmission lines

A.1.3 Test Fixture (Jig) Design and Patch Antenna Measurements

A microstrip measurement setup is prepared and microstrip lines and patch antennas have been designed for testing purposes. Four different patch antennas which are resonant at 3 and 10 GHz have been manufactured by ASELSAN and measured at METU by using various jigs and HP 8757D Scalar Network Analyzer. RT Duroid 5880 has been used as the substrate of all prototypes, Table A.1.4.

Table A.1.4 Characteristics of RT-DUROID 5880

Dielectric constant, ϵ_r	2.2+0.015
Loss tangent, $\tan \delta$	0.0009
Conductivity, σ	0.556×10^5 S/mm
Cladding, t	0.035 mm

Jig Design

For measurement purposes of microstrip patch antennas, a microstrip to coaxial transition, which would be realized on a jig is necessary. A number of commercial transitions and jigs are available in the market. In order to measure the microstrip patch antennas and antenna arrays of COST 245, two types of transitions and jigs are manufactured in our department.

The first jig is a two-piece structure. Transition from coaxial to microstrip is realized by an SMA connector which is properly fit into the jig and the inner conductor of this connector is further machined to have a smooth tab. The elimination of the sharp corners by smoothing the tab is necessary to reduce the parasitic capacitance which probably will degrade the performance of the jig. This tapered tab provides the transition from coaxial to microstrip line. The two pieces are connected to by means of two screws which are also used as thickness adjustment screws. This thickness adjustment ability enables us to measure antennas which are produced on different thickness substrates.

The second jig is primarily constituted of a coaxial to microstrip SMA connector. The 2052-1618-02 SMA connector for microstrip circuits is a specially designed and produced connector. The inner conductor of the coaxial structure extends as a short strip on the other side. This wide enough strip serves as the launcher to the microstrip structure. A suitable construction which can hold this connector and the microstrip structure together is produced to form the second jig.

Microstrip Line Design

50 ohm microstrip line has been designed and manufactured. Insertion and return loss measurements are shown in Fig. A.1.20 and A.1.21, respectively.

CH2: B -M S - .97 dB
1.0 dB/ REF - :00 dB

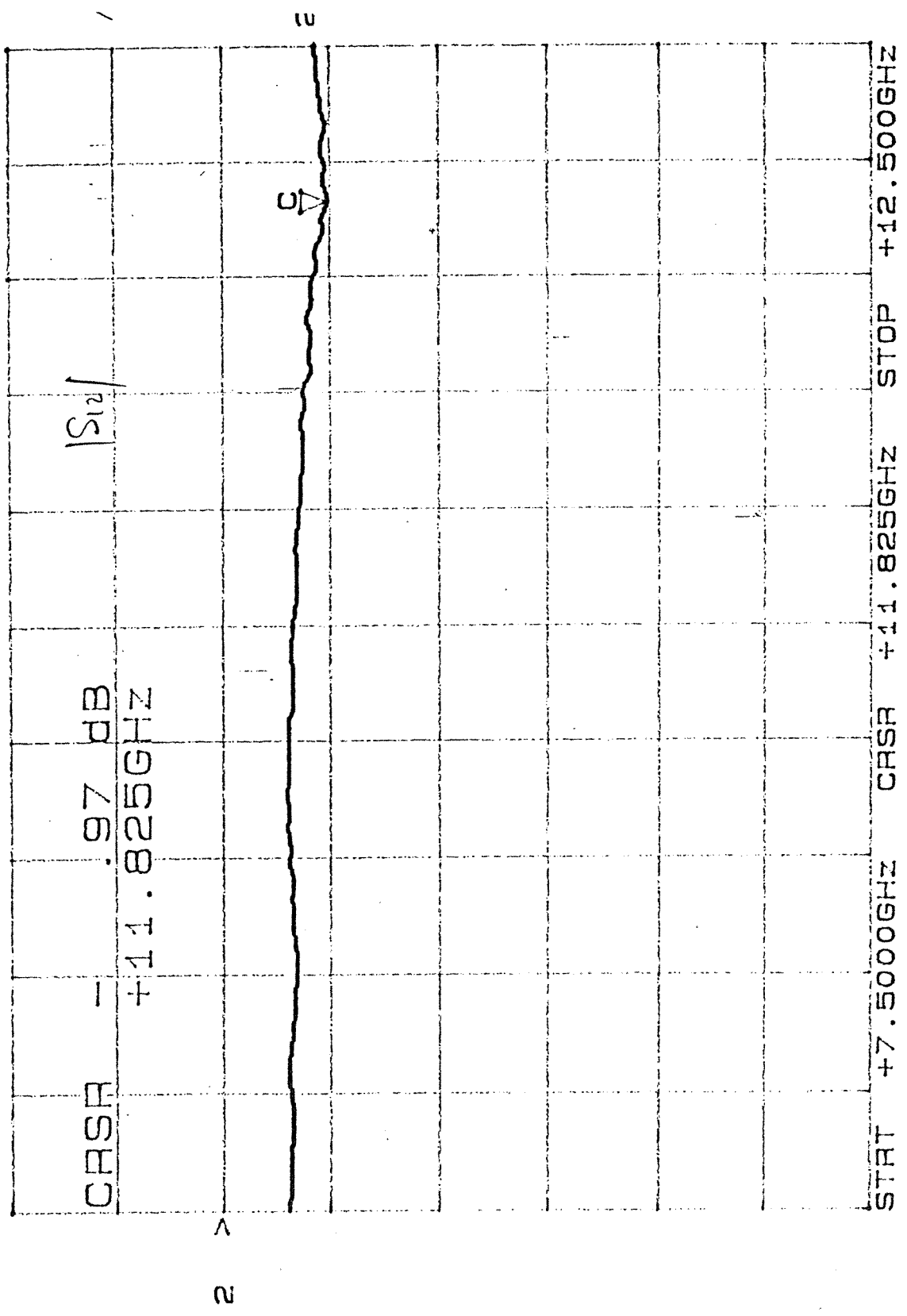
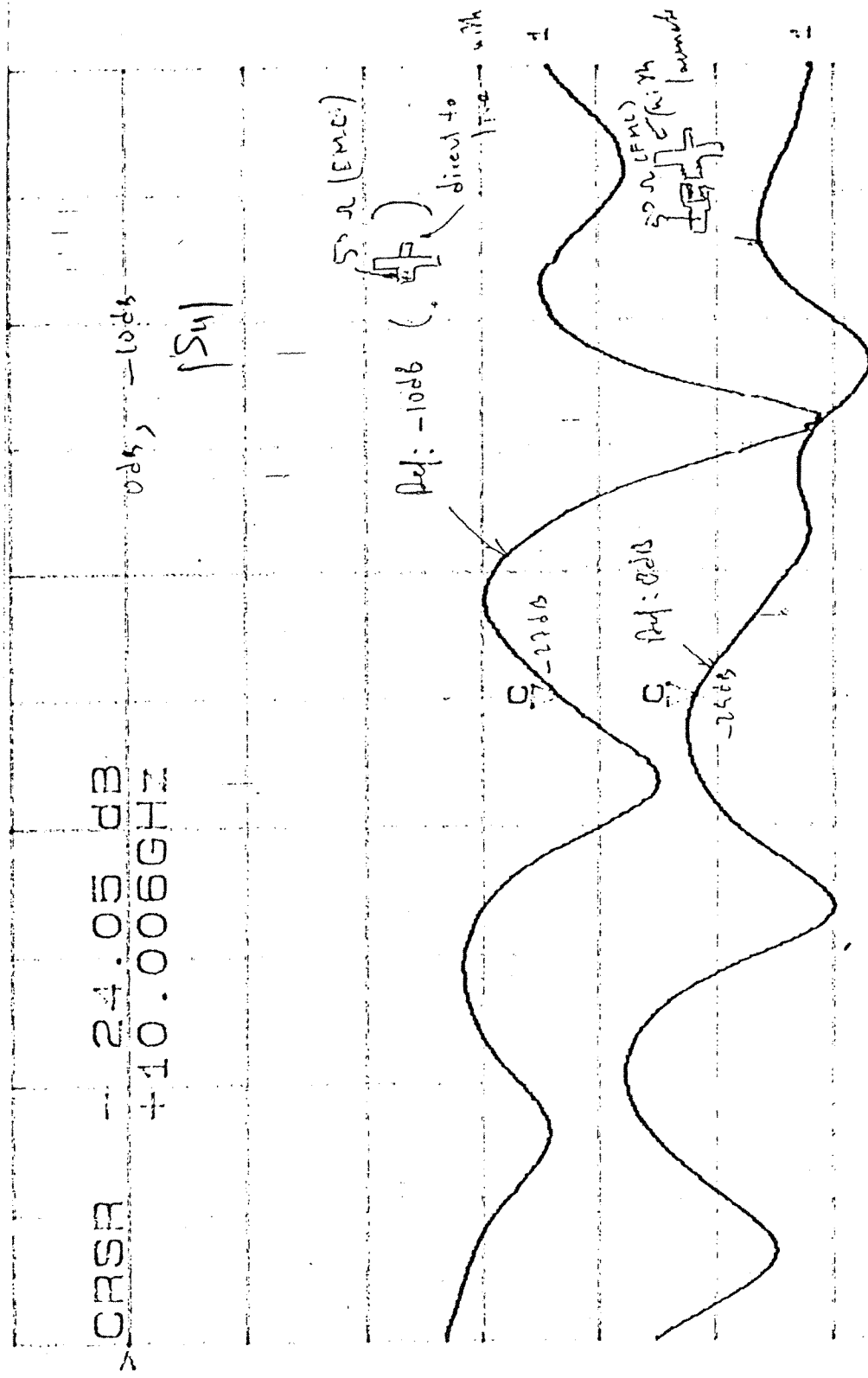


Figure A.1.20 Insertion loss of the microstrip line.

CH1: 1dB, -M S, - 24.05 dB
 5.0 dB, REF, - 24.00 dB



CRSA 24.05 dB
 +10.006 GHz
 STAT 27.5000 GHz CRSA 20.006 GHz STOP 24.5006 GHz

Figure A.1.21 Return loss of the microstrip line.

Patch Antenna Design and Measurements

DESIGN 1: Single rectangular patch antenna with 50 Ω microstrip line has been designed to operate at 3 GHz. Dimensions of the patch and the line are given in Fig. A.1.22.

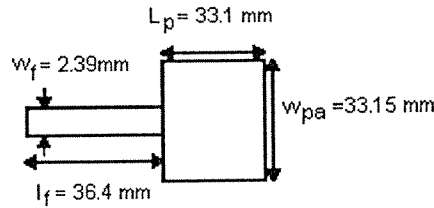


Figure A.1.22 Single patch antenna with 50 Ω microstrip line

Measured return loss curves are shown in Fig. A.1.23 and A.1.24. In Fig. A.1.23, measurement has been performed by using MTF/26 microwave test fixture, while jig #2 has been used in measurement shown in Fig. A.1.24. In both measurements, 50 Ω line was tapered for better transition to the connector. Resonance frequency of patch is measured to be 3.001 GHz. There is a discontinuity capacitance, C_d , between the jig and the microstrip line. Return loss is calculated and presented in Table A.1.5 for different values of C_d , ϵ_r , L_p , and frequency.

Table A.1.5 $|S_{11}|$ values for various C_d , ϵ_r , L_p values

f (GHz)	$L_p=33.10\text{mm}$				$L_p=33.15\text{mm}$
	$C_d=0 \epsilon_r=2.2$	$C_d=0.2 \epsilon_r=2.2$	$C_d=0.2 \epsilon_r=2.185$	$C_d=0.1 \epsilon_r=2.215$	$C_d=0.1 \epsilon_r=2.215$
2.9800		-3.1830	-3.1460	-3.1600	-3.1620
2.9888		-3.1750	-3.1830	-3.1610	-3.1430
3.0000	-3.1590	-3.1040	-3.1720	-3.1030	
3.0200	-3.1200				

DESIGN 2: 3 GHz microstrip patch antenna with matching section has been designed. As shown in Fig. A.1.25, patch is matched to 50 Ω with quarter-wavelength matching line sections.

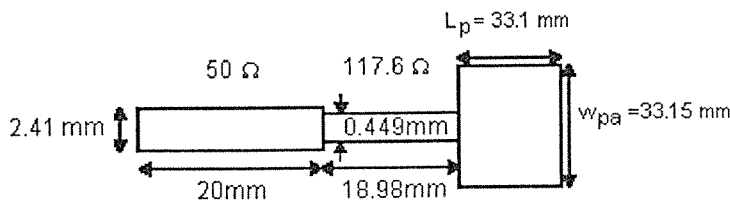
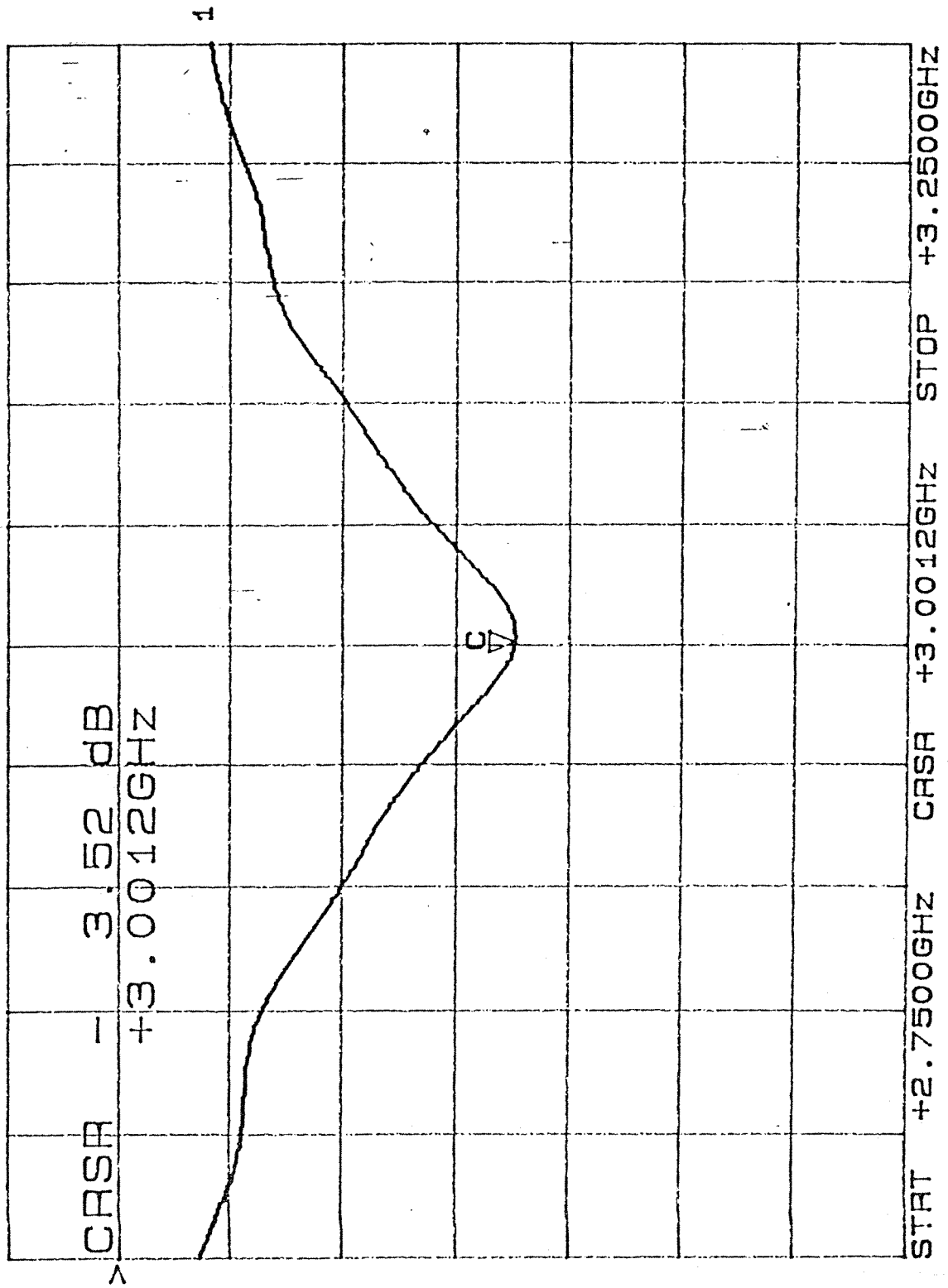


Figure A.1.25 3 GHz patch antenna with matching section

Measurement results of this antenna are shown in Fig. A.1.26-28. In Fig. A.1.26, jig #2 is used in the measurement. The resonance frequency has been measured as 2.966 GHz. In Fig. A.1.27, the end of 50 Ω line has been tapered and measurement has been performed by MTF/26 test fixture. The resonance frequency has been measured as 2.973 GHz, in this case. In Fig. A.1.28, jig #1 with thin strip has been used for measurement. The resonance

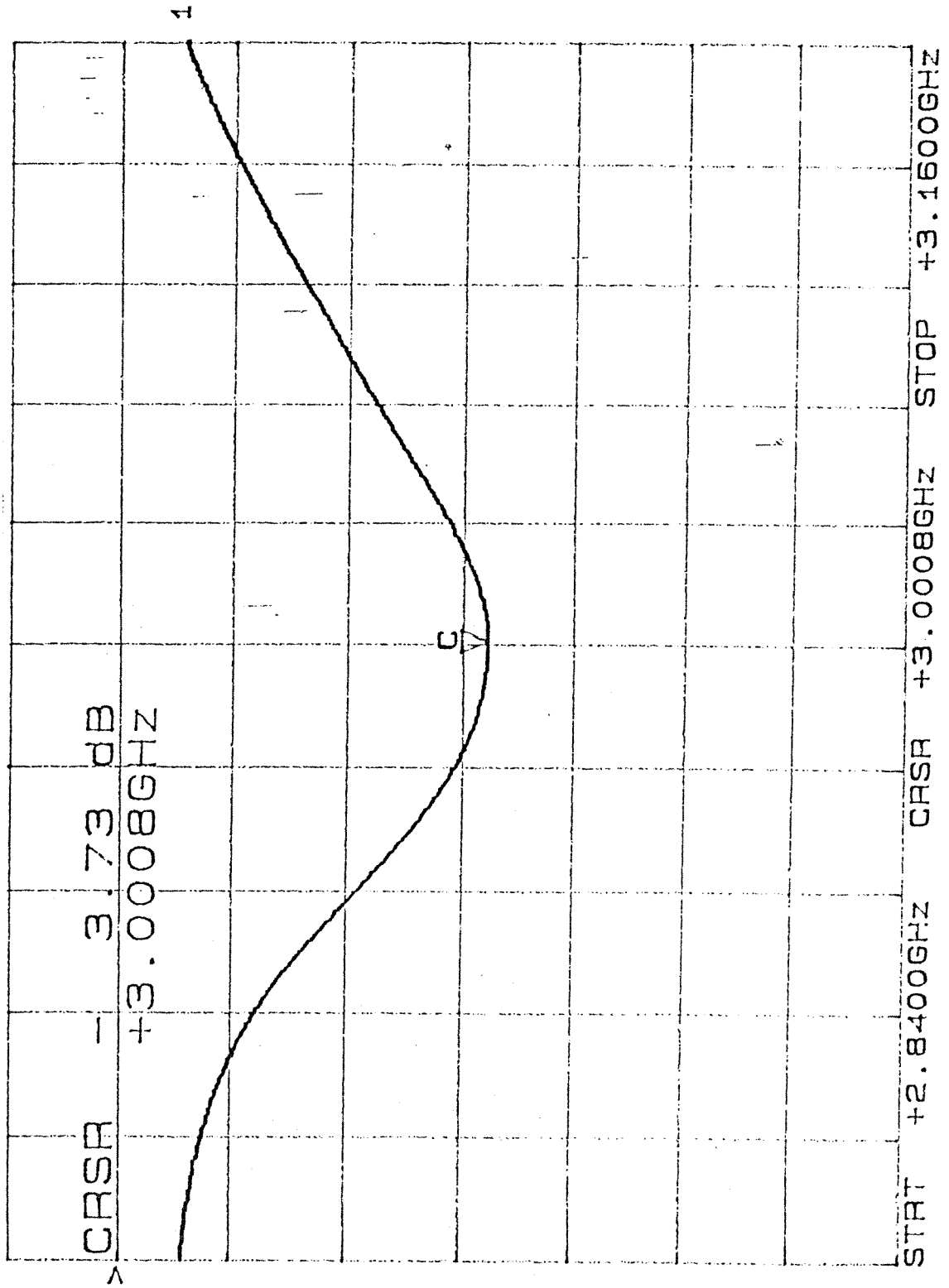
CH1: B -M A = 3.52 dB
1.0 dB/ REF = .00 dB



4

Figure A.1.23 Return loss curve of the patch antenna.

CH1: A -M* A = 3.73 dB
1.0 dB/ REF = .50 dB



1

Figure A.1.24 Return loss curve of the patch antenna.

CH1: A -M - 36.70 dB
5.0 dB/ REF - .00 dB

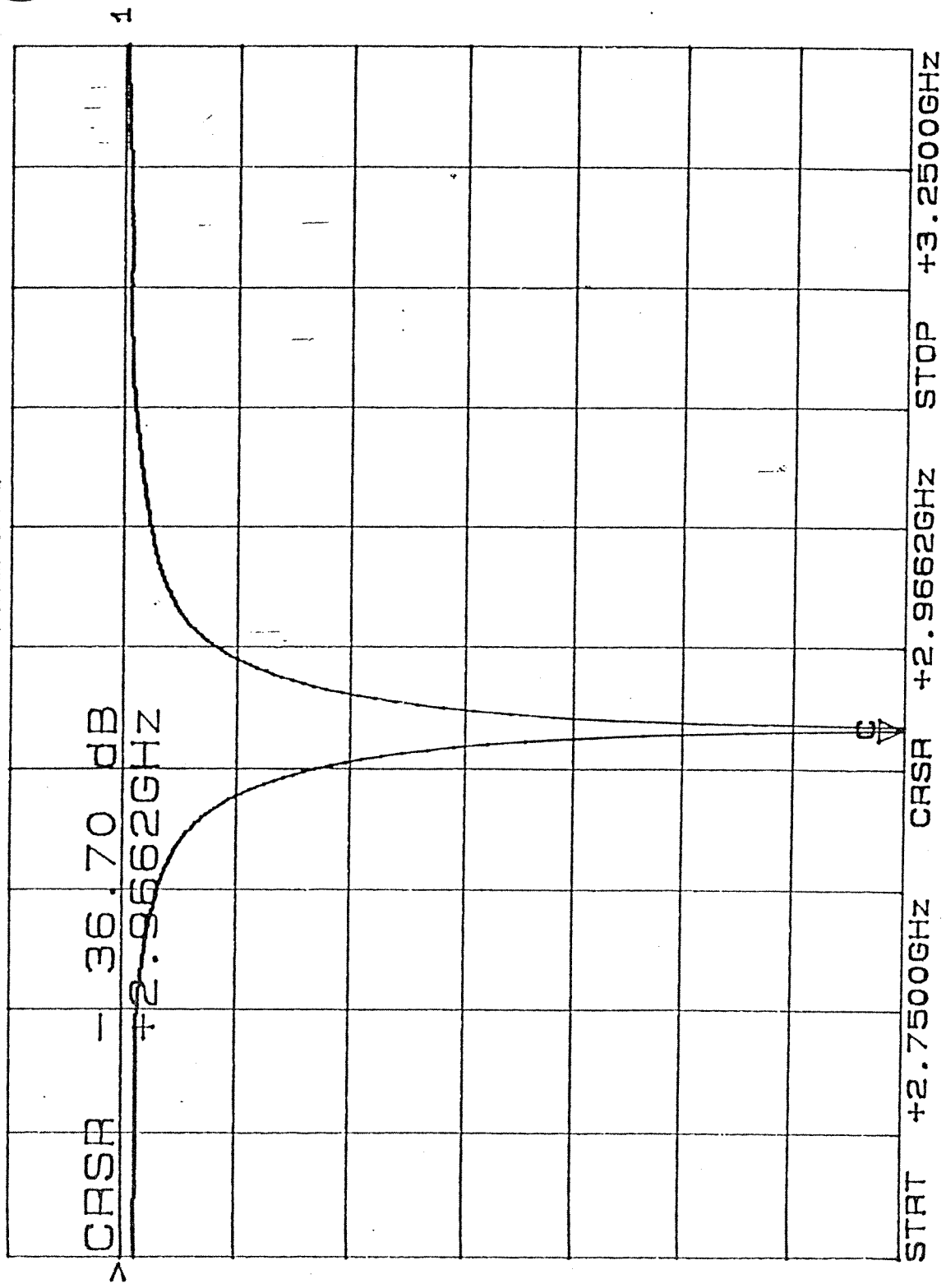
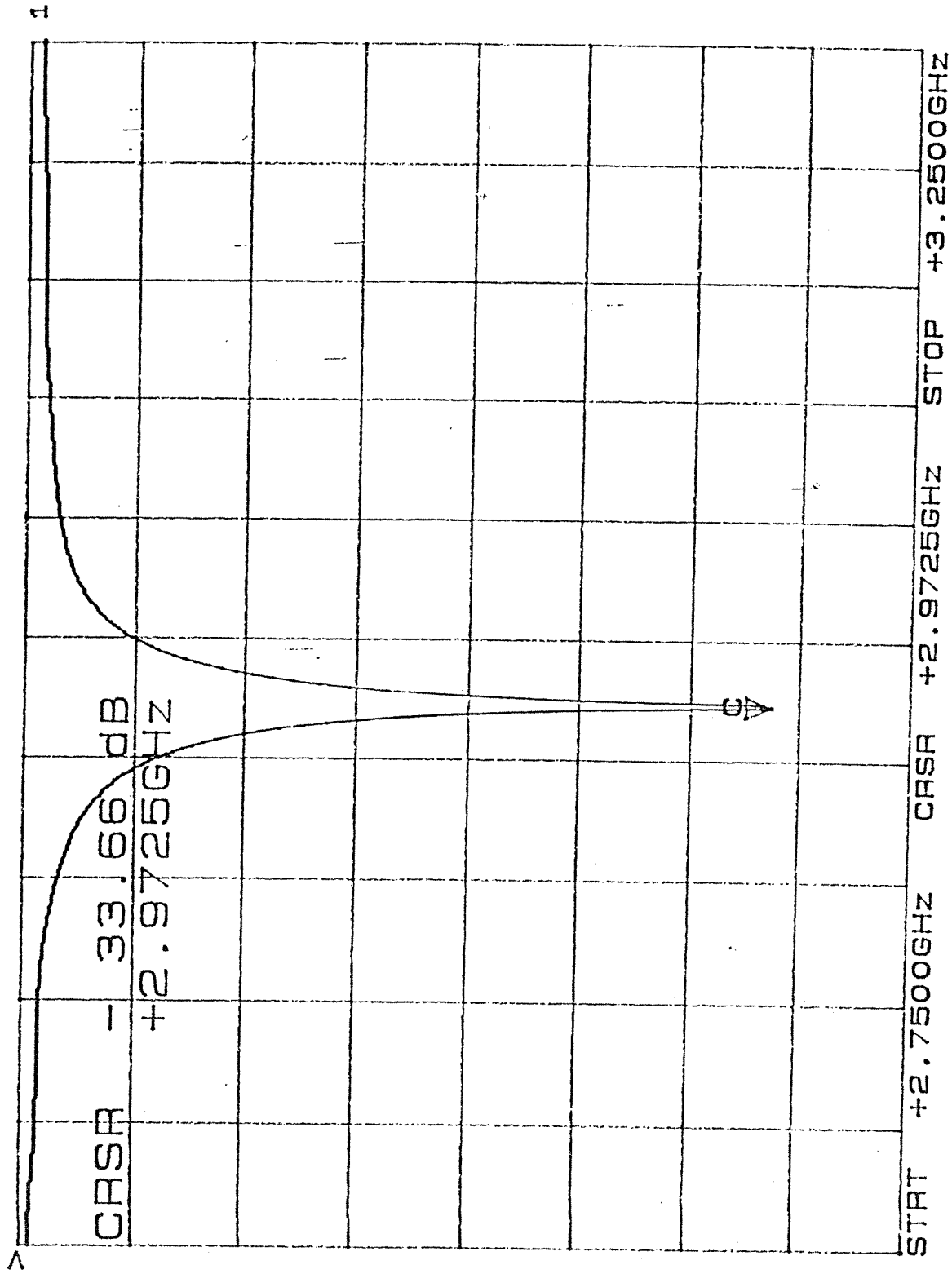


Figure A.1.26 Return loss curve of the patch antenna with jig #2.

5.0 dB/ REF - :00 dB



1

Figure A.1.27 Return loss curve of the patch antenna with MTF 26.

5.0 dB/ REF - .00 dB

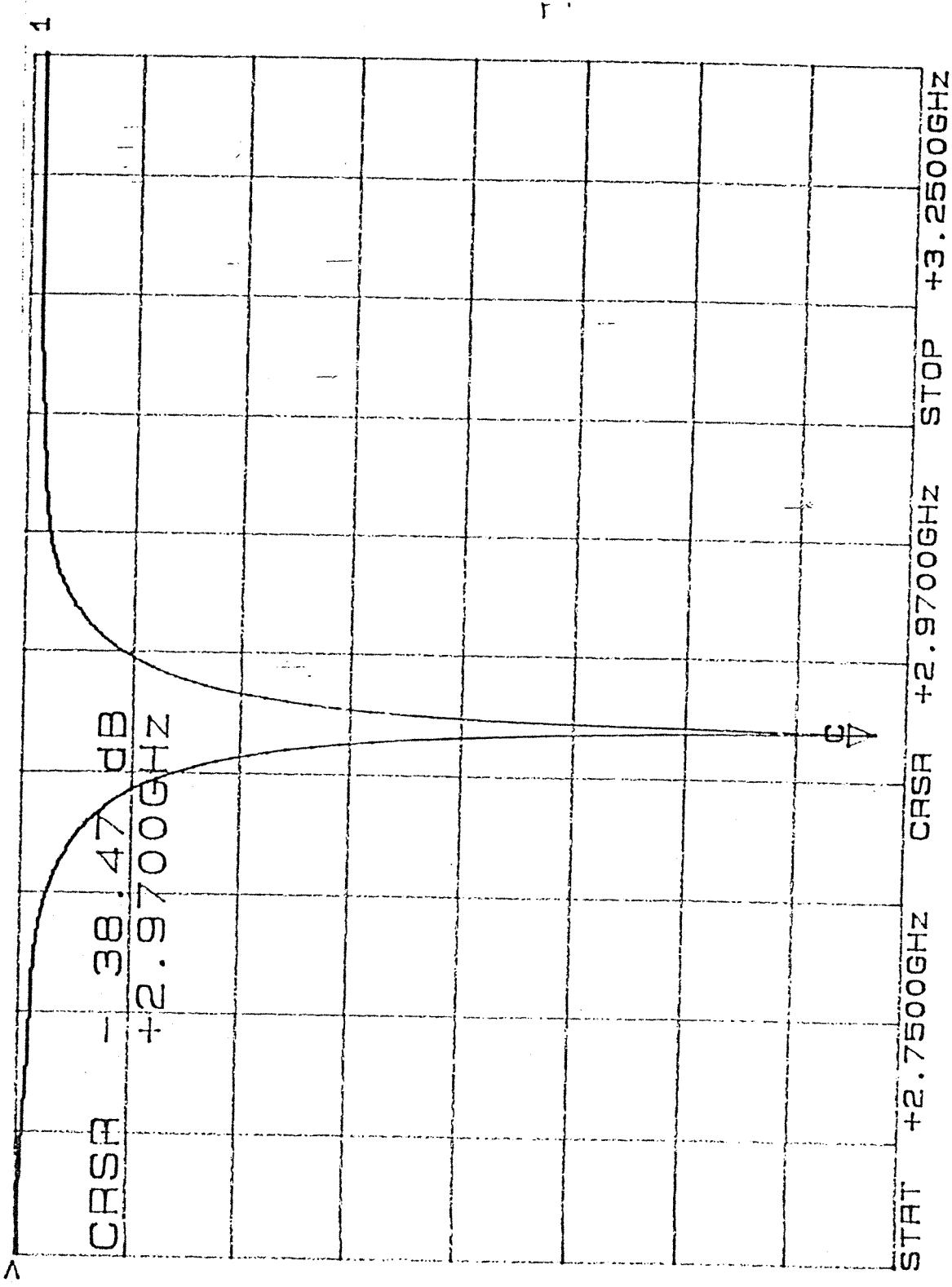


Figure A.1.28 Return loss curve of the patch antenna with jig #1.

frequency is 2.97 GHz. There is a step discontinuity capacitance, C_p , at the transition from quarter-wave transformer to 50 Ω line. This capacitance can be calculated as, [1]

$$C_f = \sqrt{w_1 w_2} (10.1 \log \epsilon_r + 2.33) \frac{w_2}{w_1} - 12.6 \log \epsilon_r - 3.17 \text{ pF/m} \quad (1)$$

w_1 and w_2 are in mm, range of validity $w_2/w_1 < 3.5$, $\epsilon_r < 10$ with 10% accuracy.

Step discontinuity capacitance is calculated by using (1), C_f is 0.025 pF. $|S_{11}|$ calculations have been made and tabulated in Table A.1.6 for different values of C_d , ϵ_r , L_p , and frequency.

Table A.1.6 $|S_{11}|$ values for various C_d , ϵ_r , L_p values

f (GHz)	$L_p=33.175$ mm				$L_p=33.15$ mm	$L_p=33.20$ mm
	$C_d=0.0$ $\epsilon_r=2.2$	$C_d=0.8$ $\epsilon_r=2.2$	$C_d=1.2$ $\epsilon_r=2.2$	$C_d=0.05$ $\epsilon_r=2.2$	$C_d=0.2$ $\epsilon_r=2.215$	$C_d=0.2$ $\epsilon_r=2.215$
2.965			-12.990			
2.970			-14.760		-9.921	-11.270
2.980		-18.000	-11.916		-20.912	-26.970
2.988	-13.335	-13.925	-8.590	-14.280	-18.510	-15.434
3.000	-21.288	-7.776		-19.360		
3.010	-9.182			-9.390		

DESIGN 3: 10 GHz single square patch antenna has been designed and produced. The antenna and the dimensions are shown in Fig. A.1.29.

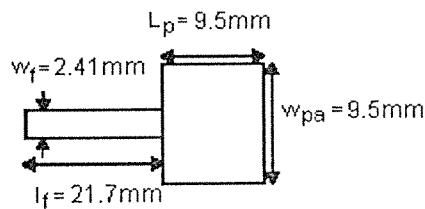


Figure A.1.29 10 GHz microstrip patch antenna

In measurements, tip of the 50 Ω line has been tapered. $|S_{11}|$ has been measured by using MTF/26 and plotted on Fig. A.1.30. The resonance frequency is 10.025 GHz. To observe the effect of variation in length of patch, discontinuity capacitance and ϵ_r on resonance frequency, some calculations have been made and given in Table A.1.7.

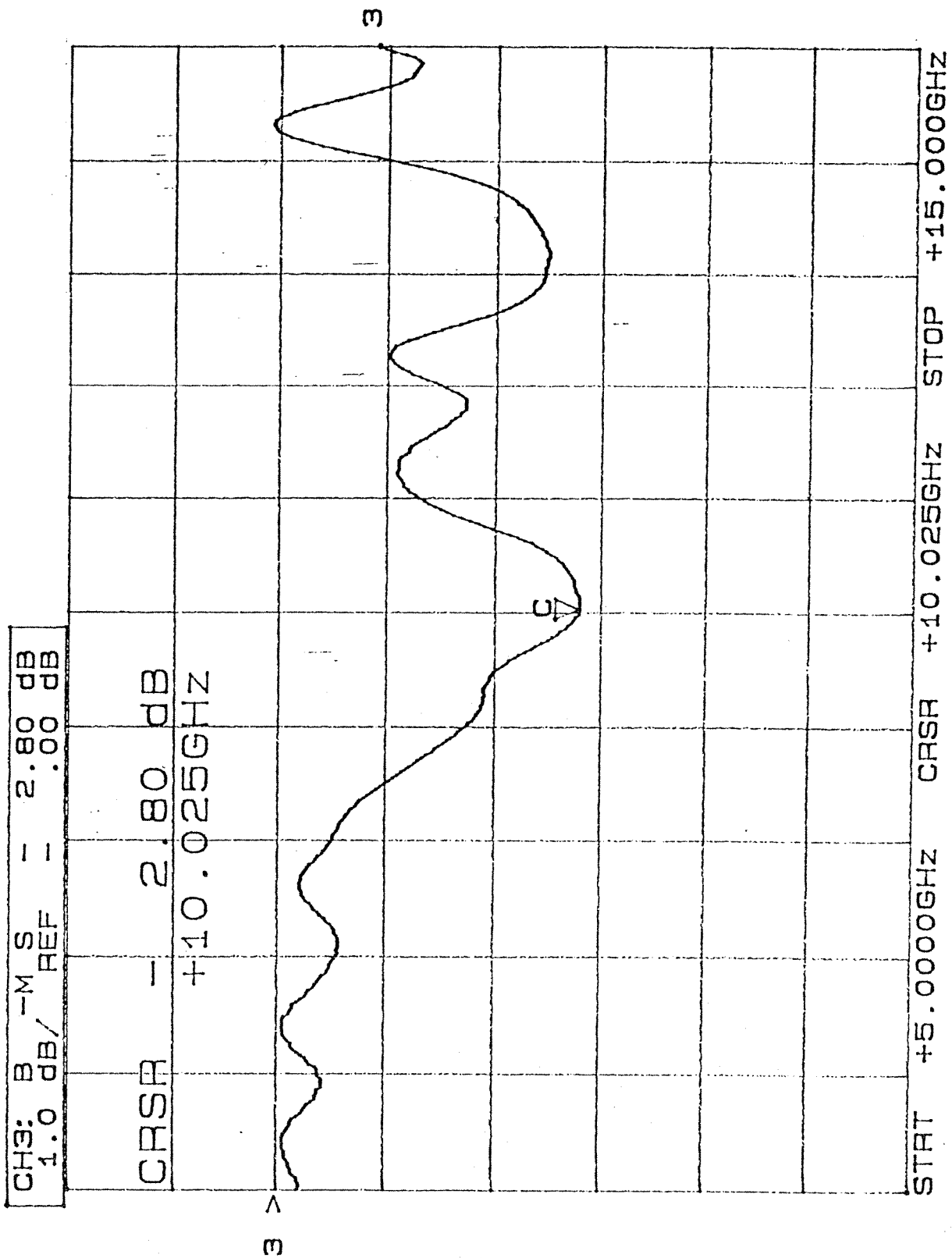


Figure A.1.30 Return loss curve of the patch antenna with MTF 26.

Table A.1.7 $|S_{11}|$ values for various C_d , ϵ_r , L_p values

	$L_n=9.5$ mm			$L_n=9.47$ mm	$L_n=9.47$ mm
f (GHz)	$C_d=0.0$ $\epsilon_r=2.2$	$C_d=0.05$ $\epsilon_r=2.2$	$C_d=0.05$ $\epsilon_r=2.185$	$C_d=0.01$ $\epsilon_r=2.185$	$C_d=0.05$ $\epsilon_r=2.185$
9.800		-2.196	-2.926	-2.923	
9.850		-2.902	-2.920	-2.924	
9.900	-2.760	-2.874	-2.899	-2.910	
9.950	-2.780	-2.835			-2.807
10.000	-2.804	-2.786			-2.812
10.092	-2.815				

DESIGN 4: 10 GHz square patch antenna with matching section has been designed and shown in Fig. A.1.31.

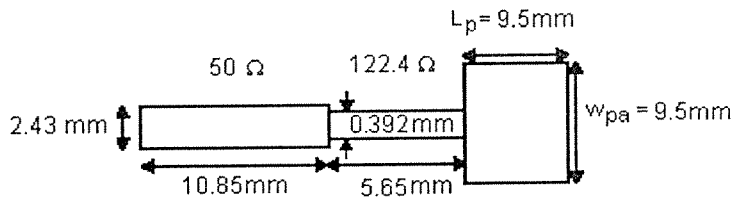


Figure A.1.31 10 GHz Square patch antenna with matching section

Step discontinuity capacitance has been calculated as 0.028 pF, using (1). $|S_{11}|$ measurements by MTF/26 and jig #1 are shown in Fig. A.1.32 and A.1.33 respectively. The resonance frequency of the antenna has been measured as 9.94 GHz by MTF/26 and 9.93 GHz by jig #1. In Table A.1.8, calculated $|S_{11}|$ values for different discontinuity capacitance, ϵ_r values are tabulated.

Table A.1.8 $|S_{11}|$ values for various C_d , ϵ_r , L_p values

f (GHz)	$C_d=0.00$ $\epsilon_r=2.2$	$C_d=0.05$ $\epsilon_r=2.2$	$C_d=0.2$ $\epsilon_r=2.2$	$C_d=0.05$ $\epsilon_r=2.185$	$C_d=0.05$ $\epsilon_r=2.215$
9.980	-26.551	-18.107	-9.402		-27.030
10.000	-42.920	-22.880	-10.620	-16.330	-30.704
10.020	-24.290	-30.690	-11.877	-19.986	-22.246
10.040		-25.600	-12.960	-25.880	
10.060			-13.496	-29.187	
10.100			-12.260		

Reference

[1] T. C. Edwards, 'Foundations for Microstrip Circuit Design', p113, John Wiley & Sons.

CH1: B -M REF - 17.37 dB
5.0 dB/ .00 dB

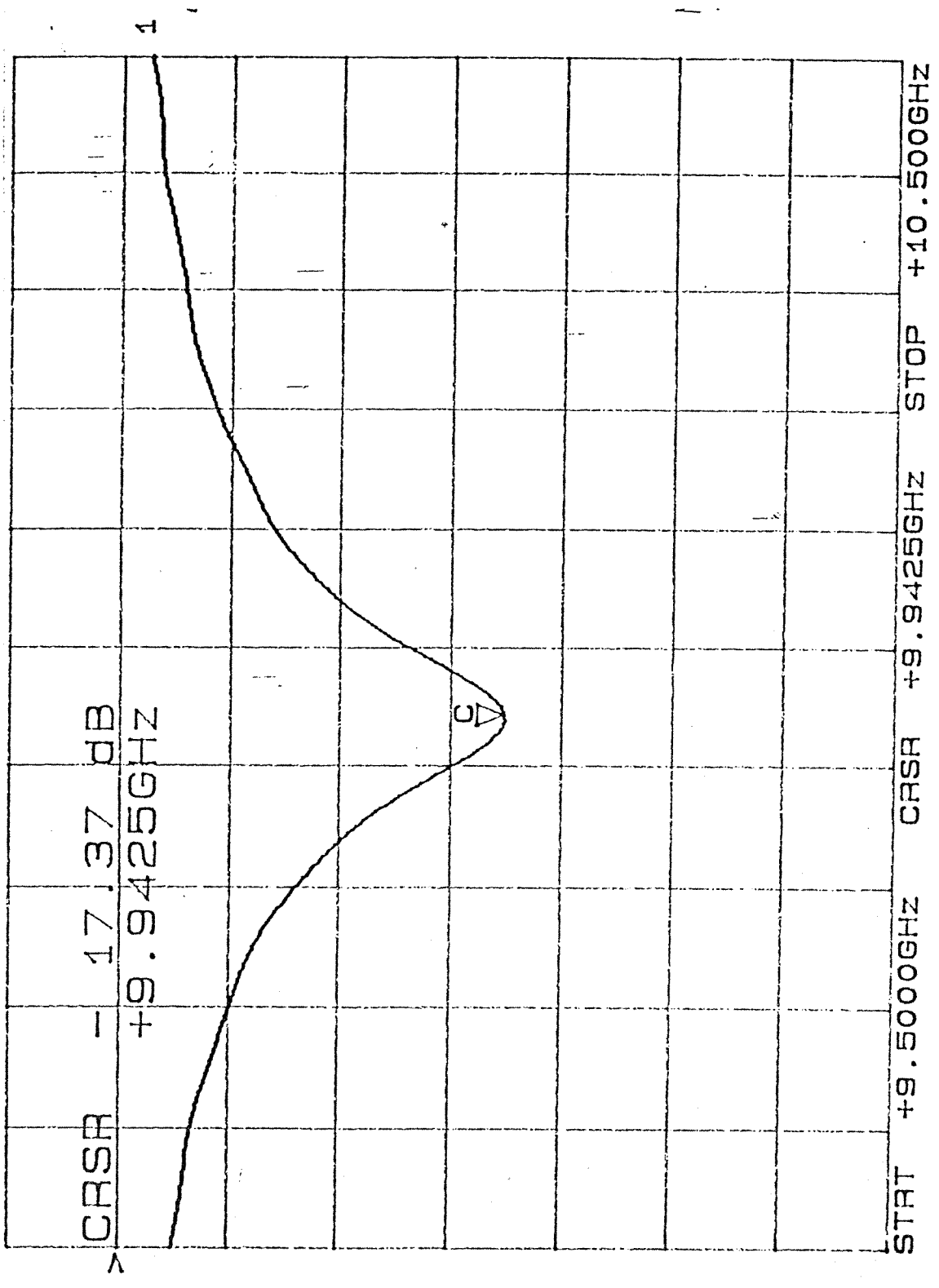


Figure A.1.32 Return loss curve of the patch antenna with MTF 26.

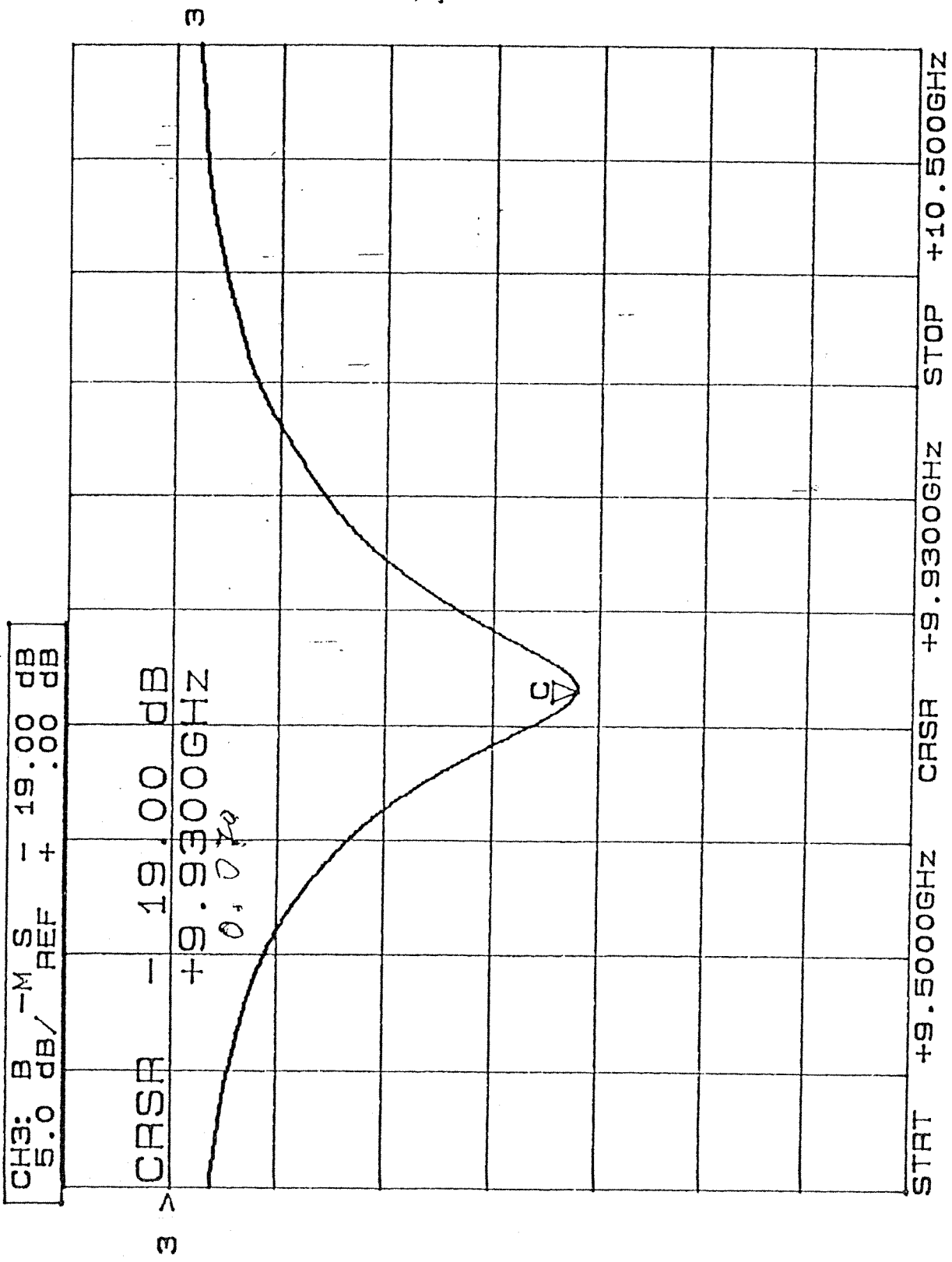


Figure A.1.33 Return loss curve of the patch antenna with jig #1.

A.1.4 Antenna Array Designs

In the following parts, various rectangular microstrip patch antenna array design and measurement studies are presented.

DESIGN 1: 8x4 Microstrip Patch Antenna Array

A 8x4 microstrip patch antenna array has been designed at 10 GHz, Fig. A.1.34 Lengths and widths of the feed lines are given in Table A.1.9. Patches are square with $w_p=L_p=9.488$ mm. Calculations showed that the frequency bandwidth of the input impedance of a single patch and the array are the same, 257 MHz. It is also shown that upto 30 microns variation in widths of lines does not change the resonance frequency.

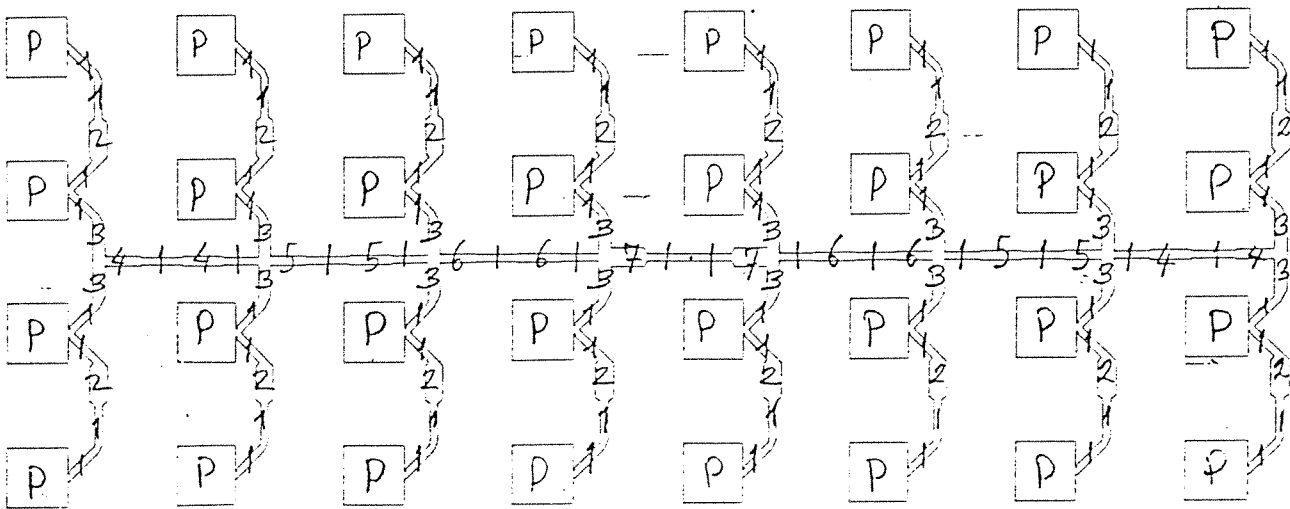


Figure A.1.34 8x4 Microstrip patch array for design 1

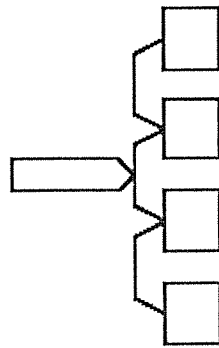


Figure A.1.35 Array B

Array B (Fig. A.1.35) of this planar array has been manufactured and measured. Return loss of array B is measured at ASEL SAN and in METU (jig #2). The resonance frequency

CH1: A -M A = 32.68 dB
5.0 dB/ REF = .00 dB

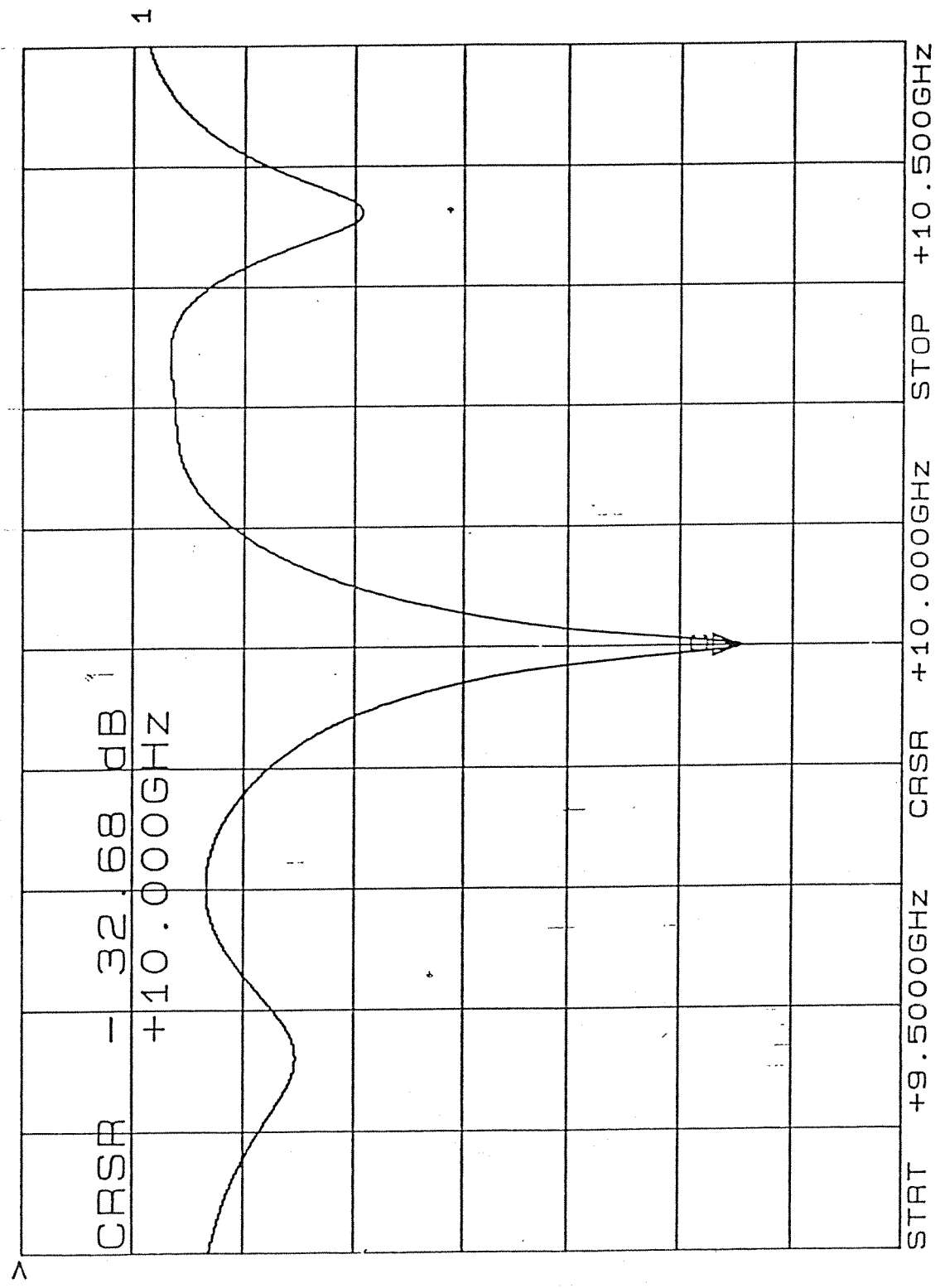


Figure A.1.36 Return loss of the overall array.

E-PLANE PATTERN of 10 GHz 4x8 ARRAY

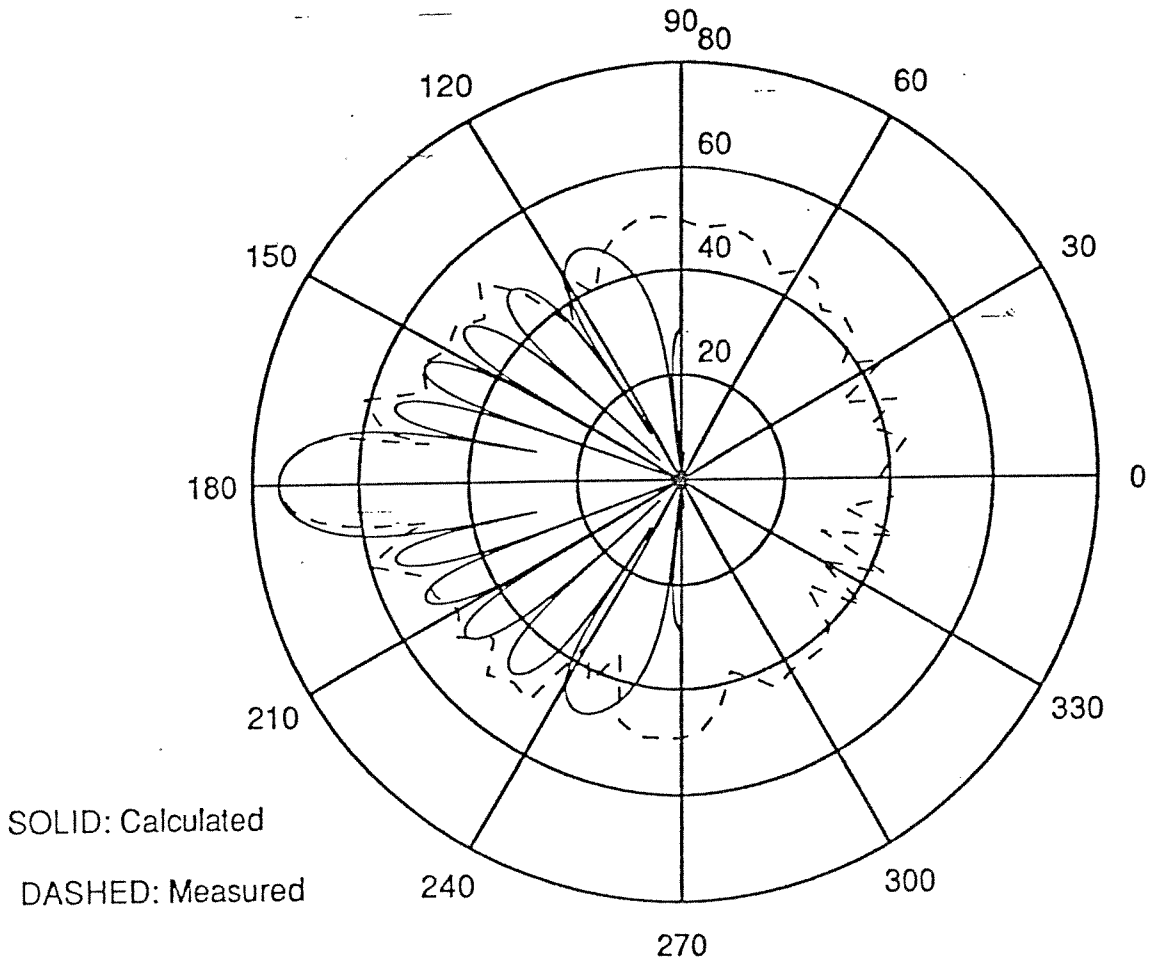


Figure A.1.37 E-plane radiation pattern of the array.

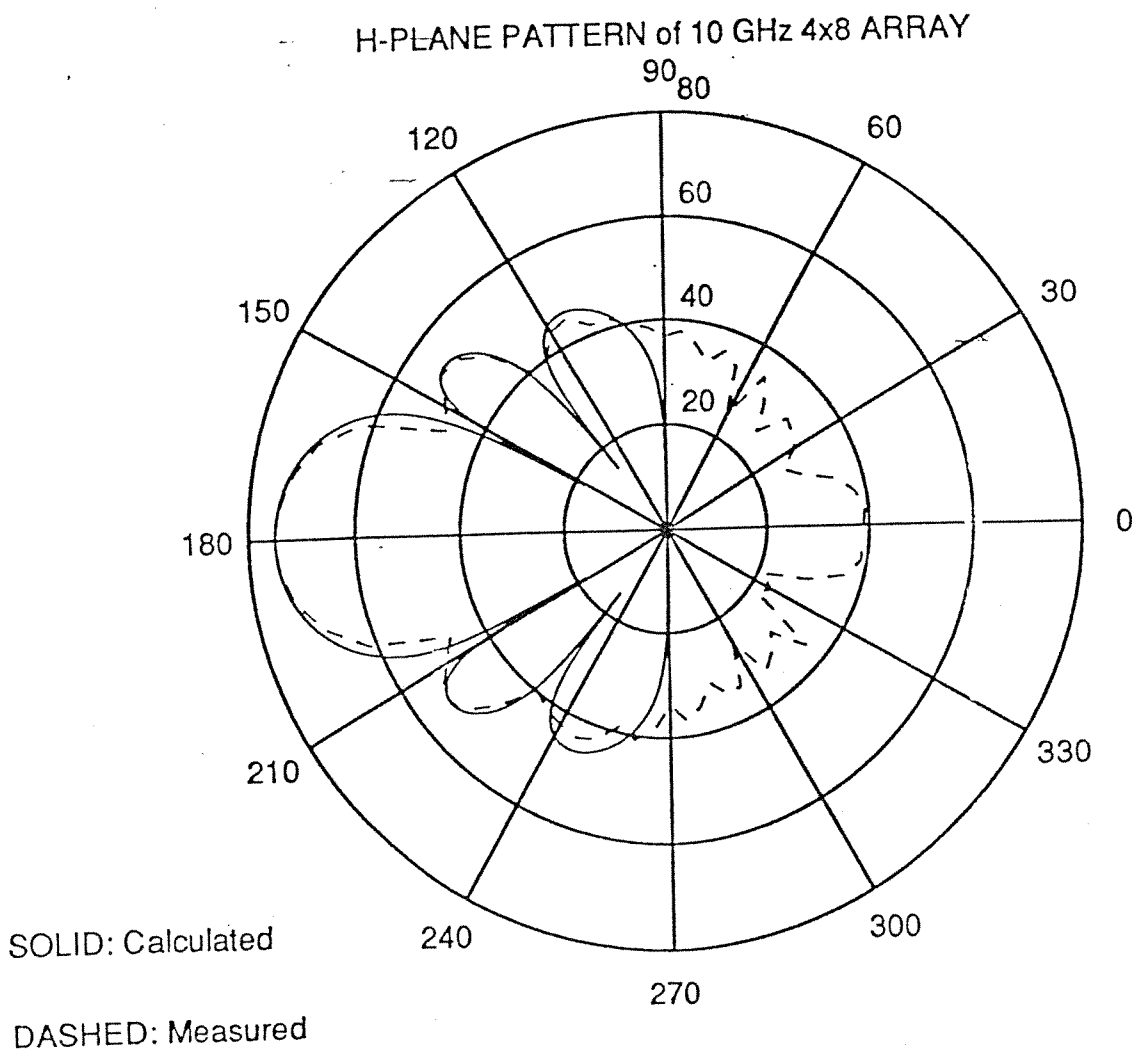


Figure A.1.38 H-plane radiation pattern of the array.

is 10.098 GHz. A small copier patch has been placed on tapered intersection point and the resonance frequency is shifted to 10 GHz. The return loss of the overall array is measured, Fig. A.1.36. It is seen that the resonance frequency is 10 GHz. The E and H-plane radiation patterns are measured and compared with theoretical results, Figs. A.1.37 and A.1.38. Summary of this comparison is given in Table A.1.10 Directivity and efficiency of the array are calculated to be 22.25 dB and 91%, respectively whereas measured gain is 21.5 dB. Array noise temperature due to losses is calculated to be 26°K. Cross polarization level is measured to be -35 dB.

Table A.1.9 Lengths and widths of lines in the array, for t=0.0175 mm

Line #	width (mm)	length (mm)	Line #	width (mm)	length (mm)
1	0.5	5.664	5	0.647	5.635
2	1.504	5.508	6	0.579	5.648
3	0.481	5.668	7	1.239	5.54
4	0.719	5.621			

Table A.1.10 Comparison of results

	Radiation pattern in E-plane		Radiation pattern in H-plane	
	-3 dB beamwidth	Side lobe level	-3 dB beamwidth	Side lobe level
Calculated	22.5°	-21.96 dB at 38.4°	9.5°	-19.75dB at 25.2°
Measured	22.3°	-21.33 dB at 36°	9.3°	-16dB at 15°

DESIGN 2: 11.3 GHz TVRO Antenna

A 32x12 element microstrip patch antenna array which satisfies the COST 245 TVRO requirements is designed at 11.3 GHz; see Fig. A.1.39. Eccofoam PP-4 is used as the substrate, Table A.1.11. Microstrip line parameters and microstrip patch antenna parameters are given in Tables A.1.12 and A.1.13, respectively. Characteristic impedances of the lines, line lengths and widths which satisfy the required phase and amplitude distributions in the antenna elements are given in Tables A.1.14 and A.1.15. In this design, antenna elements are excited according to Gaussian distribution coefficients.

Table A.1.11 Grace Electronic Materials, Eccofoam PP-4 specifications

ϵ_r	1.06	cladding, t	0.075 mm
$\tan \delta$	0.0001	surface roughness, Δ	0.0005 mm
h	1.6 mm	surface conductivity, σ_s	0.556x10 ⁵ s/mm

Table A.1.12 Parameters of microstrip lines

w_s	1 mm	λ_s	26.03624 mm
ϵ_{rs}	1.038312	α_s	0.001119 dB/mm
Z_{0s}	144.3239 Ω	l_s	6.509060 mm

Table A.1.13 Microstrip patch antenna parameters

w_m	1.414214 mm	G_m	-0.00061 mho
w_n, L_n	10.814879 mm	B_n	0.008083 mho
$e_{c,n}$	1.051991	B_m	-0.000994 mho
l_n	25.8666417 mm	G_n	0.004371 mho
D_1	1.254681 mm	h_n	0.994374
G_n	0.002950 mho	$Z_{i,n}$	227.497131 ohm

Microstrip patch antenna element and its equivalent circuit are shown in Fig. A.1.40. Array B is shown in Fig. A.1.41. Impedances, lengths, and widths of the transmission lines used in the input of array B are $Z_{sbc} = 192.769 \Omega$, $w_{sbc} = 0.37075$ mm, $l_{sbc} = 6.5183$ mm, respectively. Impedances, lengths, and widths of the transmission lines used in array B are $Z_{sac} = 88.651 \Omega$, $w_{sac} = 3.0116$ mm, $l_{sac} = 6.4920$ mm, respectively. Array A is given in Fig. A.1.42.

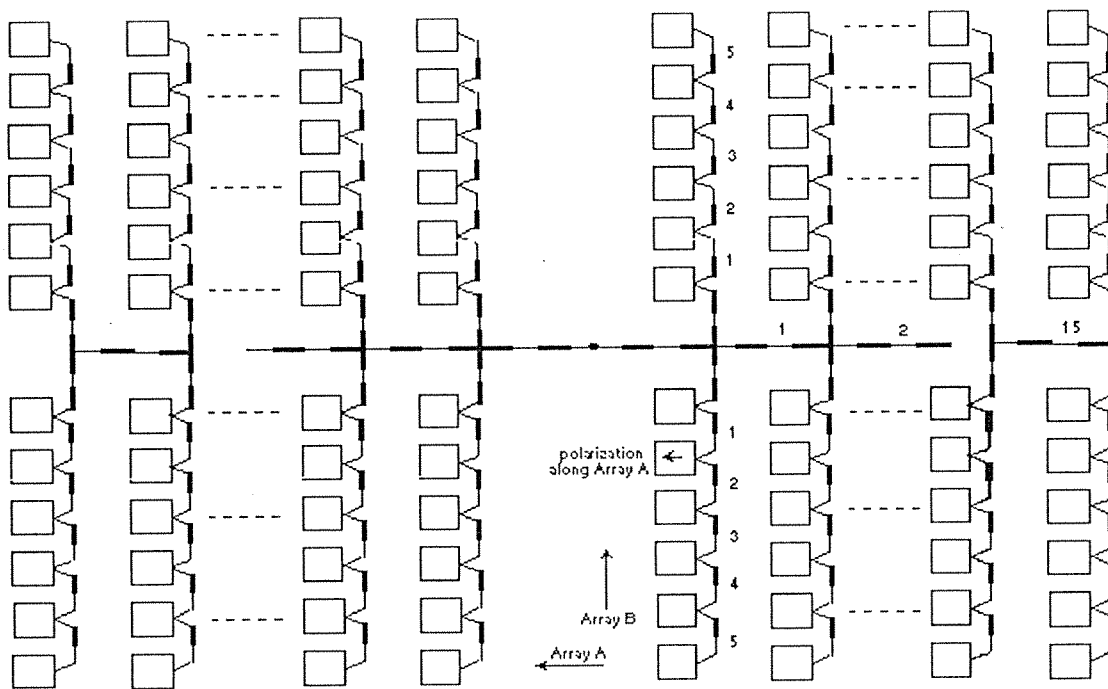


Figure A.1.39 12x32 Array

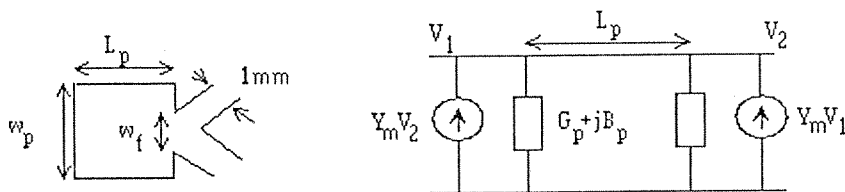


Figure A.1.40 Microstrip patch antenna and equivalent circuit

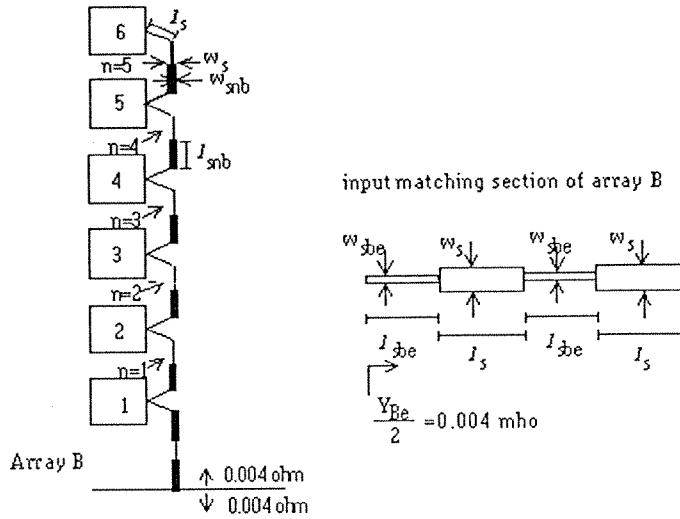


Figure A.1.41 Array B of microstrip patch antenna array

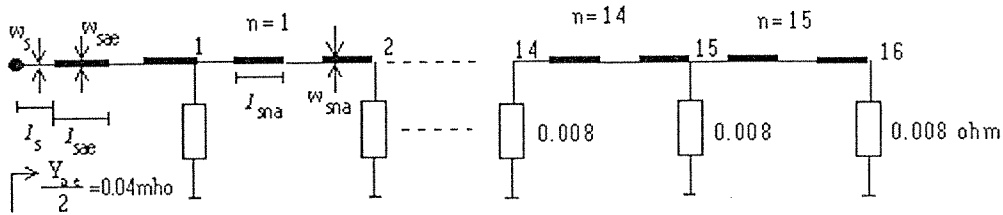


Figure A.1.42 Array A of microstrip patch antenna array

Table A.1.14 Impedances, lengths, and widths of the transmission lines used in array B (see Fig.A.1.35)

n	Z_{snb} (ohm)	w_{snb} (mm)	l_{snb} (mm)
5	94.63515	2.659888	6.4943
4	102.29014	2.277496	6.4970
3	110.54589	1.932812	6.4998
2	119.47627	1.622389	6.5025
1	129.165	1.343555	6.5053

Table A.1.15 Impedances, lengths, and widths of the transmission lines used in array A

n	Z_{sna} (ohm)	w_{sna} (mm)	l_{sna} (mm)	n	Z_{sna} (ohm)	w_{sna} (mm)	l_{sna} (mm)
15	132.9067	1.2493	6.5063	7	139.66	1.095	6.508
14	133.7808	1.228	6.5065	6	140.538	1.0768	6.5082
13	134.469	1.2082	6.5067	5	141.436	1.0581	6.5084
12	135.4638	1.1887	6.5069	4	142.359	1.0392	6.5086
11	136.2934	1.1697	6.5072	3	143.315	1.0199	6.5088
10	137.123	1.1509	6.5074	2	144.314	1.0002	6.5091
9	137.95	1.1323	6.5076	1	145.367	0.9798	6.5093
8	138.8	1.1138	6.5078				

Table A.1.16 Radiation pattern characteristics of array A (E-plane pattern):

-3 dB Beamwidth	2.451156°	Side lobe level	-26.47 dB, at 3.92°
Normalized field at 2.27°	-20 dB	Other side lobe levels	< -26.47 dB
First null	3.23°		

Table A.1.17 Radiation pattern characteristics of array B (H-plane pattern):

-3 dB Beamwidth	6.660424°	First Side lobe level	-31.47 dB at 10.4°
Normalized field at 7.61°	-20dB	Second Side lobe level	-27.5 dB at 15.5°
First null	9°	Other side lobe levels	< -31.47 dB
Second null	12.5°		

Radiation pattern calculations are given in Table A.1.16 and A.1.17. Array directivity, D_{array} , is 33.62577 dB (directivity of the element with low directivity can be neglected in the directivity calculation of highly directive antenna arrays) and overall antenna efficiency, η_A , is 0.869802. Overall noise temperature, T , is 30°K. G/T ratio of the antenna is calculated as 18.25 dB/K and the required minimum G/T is 12.5 dB/K. Hence, our design satisfies this requirement.

DESIGN 3: Active Phased Array Antenna

A 24x32 active microstrip patch antenna array is designed at 9.5 GHz, Fig. A.1.43. Array B is composed of symmetrically placed 24 patch antenna elements. There is one amplifier for a group of 6 elements. Dimensions of the array are 50x40 cm². RT/Duroid 6002 is used as the substrate, Table A.1.18. Microstrip line parameters and microstrip patch antenna parameters are given in Table A.1.19 and Table A.1.20, respectively. Characteristic impedances of the lines, line lengths and widths which satisfy the equi-phase and tapered excitation distributions are given in Tables A.1.21 and A.1.22.

Table A.1.18 Rogers, RT/Duroid 6002 substrate specifications

ϵ_r	2.94	surface roughness, Δ	0.0004 mm
$\tan\delta$	0.0012	surface conductivity, σ_s	0.556x10 ⁵ s/mm
h	1.52 mm	Thermal coefficient	0 (0°C - 100°C)
cladding, t	70 μ m		

Table A.1.19 Parameters of microstrip lines

w_s	0.5 mm	λ_s	21.4152 mm
ϵ_{cs}	2.17144	α_s	0.00288077 dB/mm
Z_s	126.0461 Ω	l_s	5.3538 mm

Table A.1.20 Microstrip patch antenna parameters

w_r	0.5 mm	G_m	0.0030603065 mho
w_n, L_n	8.18884 mm	η_n	0.9764
ϵ_{rn}	2.6699717	Z_{in}	319.059 Ω
Δ_r	0.81072 mm		

Array B is shown in Fig. A.1.44. Inputs of Sections I and II will be fed separately to form a phased array such that each element in the array satisfies the phase shift and amplitude-tapering requirements. There are 4 inputs for array B and then there are $4 \times 32 = 128$ inputs to the array. The array is capable of scanning the beam $\pm 45^\circ$ from the boresight by adjusting the phases of the 128 inputs. In transmit mode the array will be fed by solid state power amplifiers with a maximum power output of one watt to the element $m = \pm 1$, $P_{i,B(1)}(I) = 1 \text{ W}$.

Table A.1.21 Impedances, lengths, and widths of the lines used in Section II of array B.

n	$Z_{snh} (\Omega)$	$w_{snh} (\text{mm})$	$l_{snh} (\text{mm})$	n	$Z_{snh} (\Omega)$	$w_{snh} (\text{mm})$	$l_{snh} (\text{mm})$
12	*	*	*	9	105.400	0.88797	5.27843
11	101.197	0.99568	5.260976	8	107.531	0.83770	5.28695
10	103.294	0.94046	5.269797	7	109.700	0.78935	5.29542

Table A.1.22 Impedances, lengths, and widths of the lines used in Section I of array B.

n	$Z_{snh} (\Omega)$	$w_{snh} (\text{mm})$	$l_{snh} (\text{mm})$	n	$Z_{snh} (\Omega)$	$w_{snh} (\text{mm})$	$l_{snh} (\text{mm})$
6	*	*	*	3	118.460	0.61936	5.32774
5	113.609	0.70874	5.310184	2	120.954	0.57754	5.33648
4	116.016	0.66299	5.318993	1	123.516	0.53726	5.34528

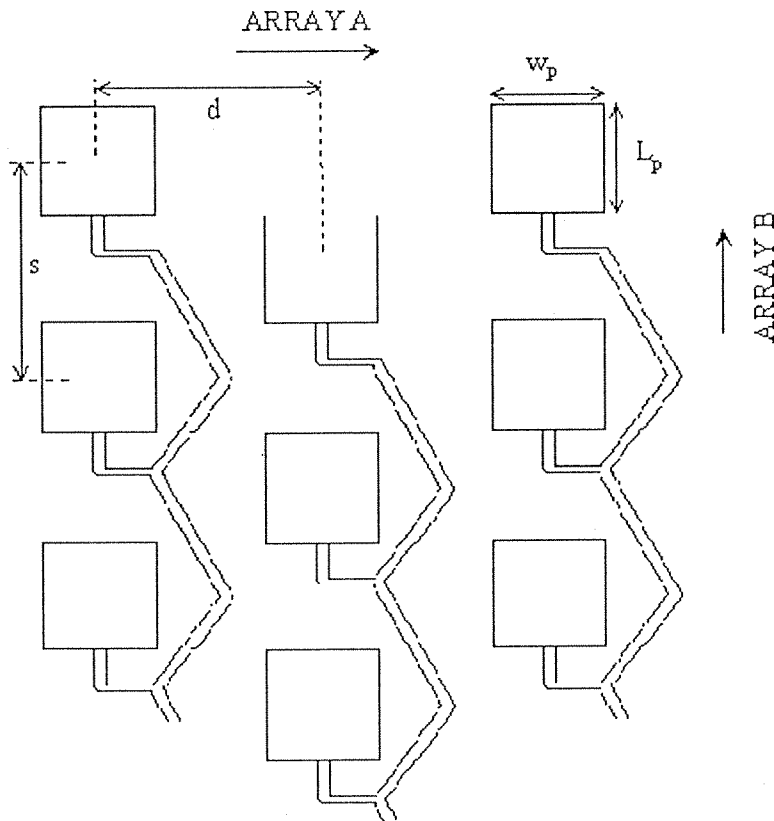


Figure A.1.43 Active array, $s = 18.957 \text{ mm}$, $d = 15.726 \text{ mm}$, $\lambda_0 = 31.56 \text{ mm}$, $w_p = L_p = 8.189 \text{ mm}$

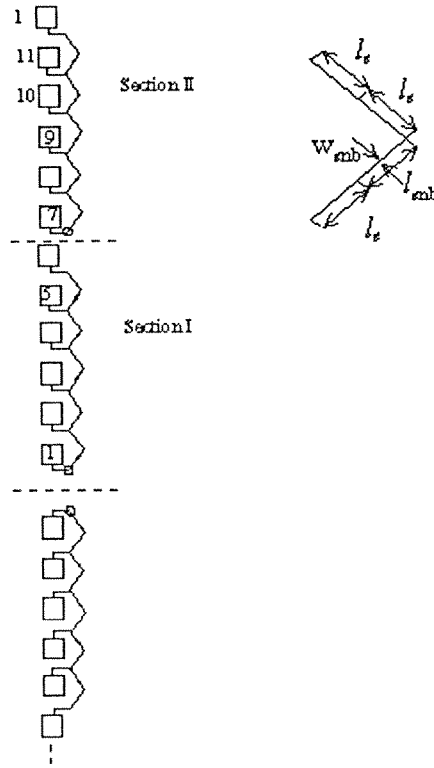


Figure A.1.44 Array B of microstrip patch antenna array

Input admittance seen from element 7 is $Y_{ib}(7)=0.0076974$ mho and the impedance is $Z_{ib}(7)=129.914 \Omega$. Input admittance seen from element 1 is $Y_{ib}(1)=0.011839$ mho and the impedance is $Z_{ib}(1)=84.464 \Omega$. Radiation characteristics of the overall array, together with array A and B are given in Tables A.1.23, A.1.24 and A.1.25, respectively.

Table A.1.23 Radiation characteristics of the antenna array

D_{array}	33.43 dB at 0° scan angle,	P_{input}	40.12 Watt
D_{array}	31.92 dB at 45° scan angle	$P_{radiated}$	37.53 Watt
$\eta_{antenna}$	% 93.549	P_{loss}	2.586 Watt

Table A.1.24 Radiation pattern characteristics of array A (H-plane pattern)

Main beam direction	-3 dB beamwidth	-10 dB beamwidth	Nulls	Side lobe levels
0°	3.9345°	6.787°	$5.1^\circ, 7.6^\circ, 11.2^\circ$	< -25 dB
20°	4.18559°	7.2215°	$8.31^\circ, 12^\circ, 14.5^\circ, 25.5^\circ, 28.3^\circ, 32.6^\circ$	< -25 dB
45°	5.54168°	9.58°	$38.1^\circ, 52.8^\circ$	< -25 dB

Table A.1.25 Radiation pattern characteristics of array B (E-plane pattern)

-3 dB Beamwidth	4.36711°	1 st side lobe level at 6.92°	-27.6 dB
-10 dB Beamwidth	7.5416°	2 nd side lobe level at 10.3°	-27.6 dB
Nulls	$5.69^\circ, 8.46^\circ, 512.5^\circ, 16.3^\circ$	Other side lobe levels	< -31.4 dB

DESIGN 4: Array On Cylindrical Surfaces

Microstrip antennas on cylindrical substrates have found many applications in aircrafts, spacecrafts, missiles, and boosters. We have used our experience and accumulation of know-how in the design of microstrip patch array on cylindrical dielectric substrate. The geometry of a single patch on a cylindrical substrate is shown in Fig. A.1.45.

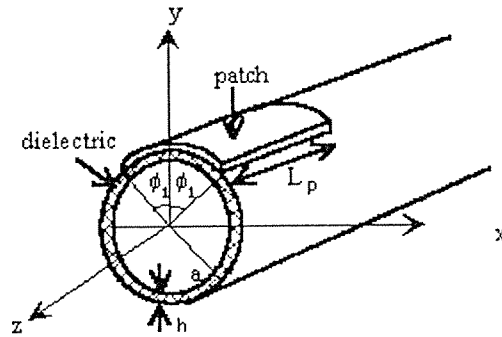


Figure A.1.45 Rectangular microstrip patch antenna on cylindrical substrate

The radius of the cylinder is $a=113.5$ mm and the thickness of the substrate, h , is 1.52 mm. Operating frequency is 2210 MHz ($\lambda=135.6527$ mm). RT/Duroid 6002 is chosen as the substrate, Table A.1.18. Resonance dimensions of a planar microstrip patch antenna of square shape at 2.21 GHz are calculated and tabulated in Table A.1.26.

Table A.1.26 Resonance dimensions of a planar patch antenna of square shape at 2.21 GHz.

w_p, L_p	38.7029252 mm	Δ_l	0.9270432 mm
w_s	1 mm	Z_{in}	331.8529501
l_s	91.522795 mm		

Integral equation formulation using the pertinent Green's function can be used for the exact formulation of the curved patch antenna and MoM gives the current distribution [1]. Alternatively, cavity model can be used for thin substrates ($h \ll a$) [2,3] which gives the resonant frequencies and the electric field under the patch. Then the problem is simplified to the radiation of magnetic currents of the length w_p and separated by $L'=L_p+\Delta_l$ for the TM_{011} mode in the presence of dielectric coated conducting cylinder. Far fields are evaluated using the numerically computed Green's function by method developed in [4].

The resonance frequency of a planar patch antenna and the cylindrically curved patch antenna are approximately equal for $a \gg h$ and $h \ll \lambda_0$, [3]. For the given patch dimensions the radiation patterns are given in Fig. A.1.46 and Fig. A.1.47. Piecewise parabolic functions are fitted to these patterns and the input impedance and directivity of the antenna are calculated. For this design, $f=2.21$ GHz, $a=113.58$ mm, $b-a=1.52$ mm, $w_p=L_p=38.7$ mm, $\epsilon_r=2.94$.

The input impedance of a curved microstrip rectangular patch antenna on a cylindrical body has been considered in [2] for the TM_{01} and TM_{10} modes. Also an expression is given for input impedance for the coaxial fed patch antennas. In the graphs presented in [2,5], it

is seen that the resonance frequency is effected negligibly while the radiation resistance decreases by a factor of 1.1-1.3. We shall estimate the ratio of the input conductance G_p of the curved patch. The ratio of directivities $D_{c,p}/D_{c,c}$ should be the same as the ratio of input conductances, G_c/G_p . The directivity of planar patch antenna, $D_{c,p}$, is 4.793 (6.806 dB). Hence $G_c/G_p=1.0862$ and the input impedance $Z_{i,c}=Z_{i,p}/1.0862$, and the directivity, $D_{c,c}$, of curved patch antenna are 4.413 (6.447 dB) and 305.512Ω respectively. The ratio of $R_{i,p}/R_{i,c}$ is around 1.05-1.2 according to [2,5]. We shall take this ratio as 1.106, so that $Z_{i,c}=331.85/1.10616=300 \Omega$.

The microstrip patch array which wraps around the cylinder with the given radius is designed. The mutual coupling between the patches is calculated as, [6], $|S_{12}| = -25$ dB. Mutual coupling in the E-plane is about -20 dB [6,7].

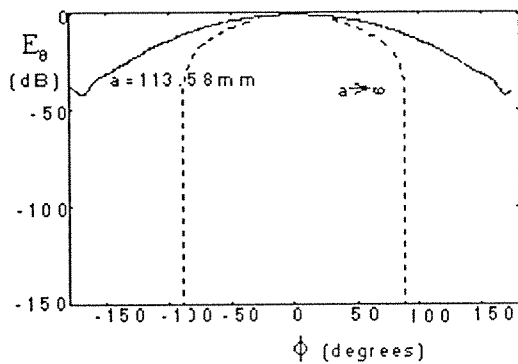


Figure A.1.46 Radiation patterns in $\theta=\pi/2$ plane of patch antenna on a cylindrical substrate

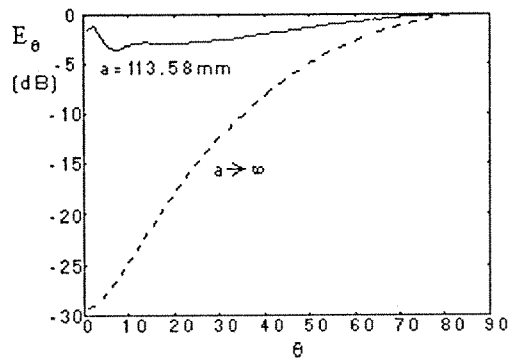


Figure A.1.47 Radiation patterns in $\phi=0$ plane of patch antenna on a cylindrical substrate

References

[1] S. M. Ali, T. M. Habashy, J. F. Kiang, and J. A. Kong, "Resonance in cylindrical-rectangular and wraparound microstrip structures", IEEE Trans. Microwave Theory Tech., vol.37, pp.1773-1783, Nov. 1989.

[2] K. Luk, K. Lee, and J. Dahele, "Analysis of the cylindrical-rectangular patch antenna", IEEE Trans. Antennas Propagat., vol. AP-37, pp.143-147, Feb. 1989.

[3] C. M. Krowne, "Cylindrical-rectangular microstrip antenna", IEEE Trans. Antennas Propagat., vol. AP-31, no.1, pp.194-199, Jan. 1983.

[4] Ö. Aydın Çivi, "Effects of anisotropy of ferrite coating on the radiation characteristics of a cylindrical conductor excited by elementary sources", Ph. D. Thesis, METU, 1996.

[5] J. S. Dahele, R. J. Mitchell, K. M. Lak, and K. F. Lee, "Effect of curvature on characteristics of rectangular patch antenna", Electronics Letter, vol.23, no.14, pp.1258, July 1987.

[6] A. Van de Capella, Microstrip Antenna Handbook, Chap.10, vol.1, (by J.R. James and D.S.Hall)

[7] W. Y. Tam, A. K. Y. Lai, and K. M. Luk, "Mutual coupling between cylindrical rectangular microstrip antennas", IEEE Trans. Antennas Propagat., vol. AP-43, no.8, p.897, August 1995.

A.2 SMART ANTENNAS

With more sophisticated operations required from today's telecommunications and radar systems, techniques for improving the antenna performance are in constant demand. Recently, there is considerable interest in digital beam forming, *smart antennas*. High speed computing developments and advances in hardware technology have made digital beam forming feasible for many applications.

Beamforming methods are used to improve the reception and/or transmission performance of the antenna according to the type of application. For instance, these methods are used to maximize the received signal from the desired source and eliminate unwanted signals; to direct the transmitted signal to the optimum path to reach the target when physical rotation of the antenna is impractical; to scan a wide area in surveillance applications; to shift the main beam to receive data from multiple sources. The methods are based on changing the magnitude and the phase of the signal transmitted/received from each element of an antenna array to collectively change the radiation characteristics of the overall array. Furthermore, maxima or nulls can be created in some directions by changing the array factor both in transmission and reception.

A smart antenna which is capable of direction finding and digital beam forming has been designed and manufactured. Six element linear microstrip patch array with a reference patch antenna has been designed to operate at 7 GHz as the receiving antenna. Antenna has been manufactured by ASELSAN. Designed antenna is shown in Fig. A.2.1. Single patch and its dimensions are shown in Fig. A.2.2. Distance between the patches in linear 6 element array is $d=0.75\lambda_0$. Distance between the reference antenna and the first patch of the array is $2\lambda_0$. RT-Duroid 5880 with thickness 35mm is used as substrate.

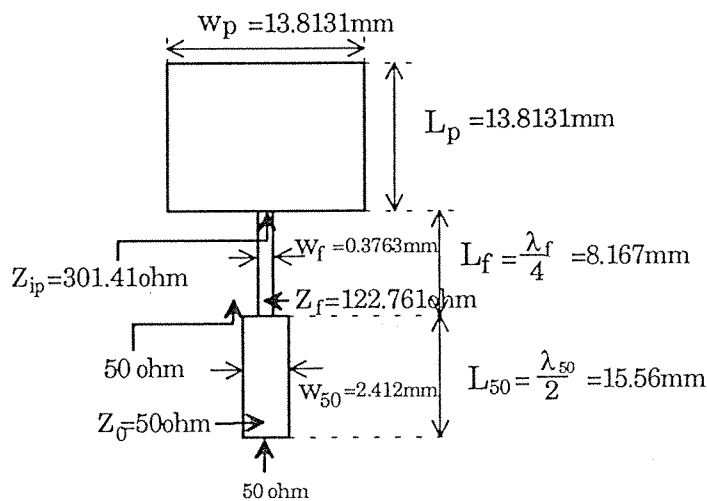
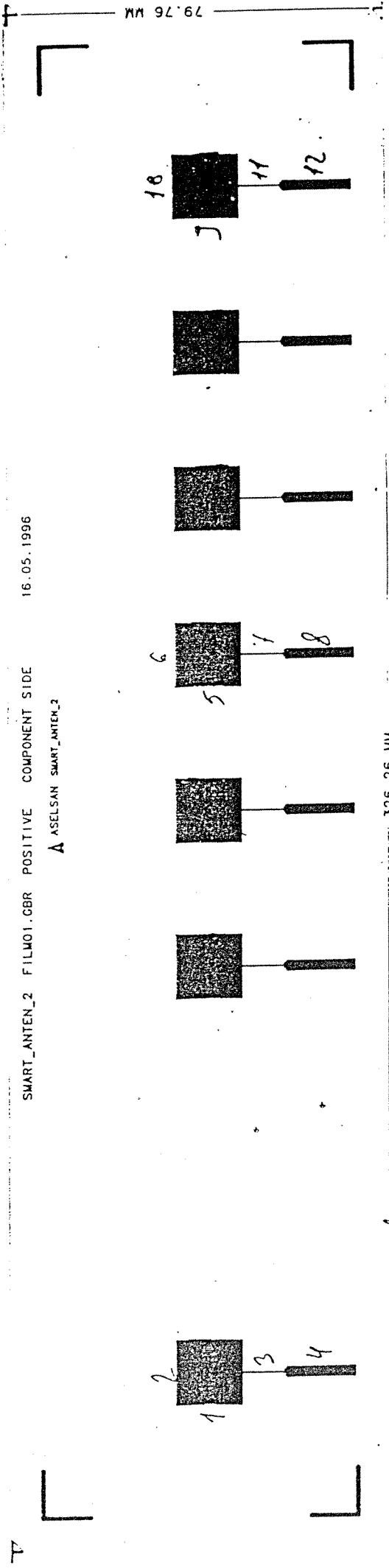


Figure A.2.2 Dimensions of single element of antenna array

In Fig. A.2.3, designed system for direction finding and for the emulation of some beamforming techniques is shown. Signal levels at each antenna terminal are considered separately by means of a switch. Before the received signal data is sent to a digital device, a 90° hybrid and two mixers are used to obtain two uncorrelated signals. These signals are digitally processed to find the direction of the incoming signal.

6.6.1996



	1	2	3	4	5	6	7	8	9	10	11	12
Film (in μm)	13640	13845	413	2442	13655	13845	415	2448	13650	13841	408	2454
Card(in μm)	13643	13860	404	2445	13686	13838	400	2435	13655	13832	398	2445

Figure A.2.1 Layout and dimensions of the smart antenna

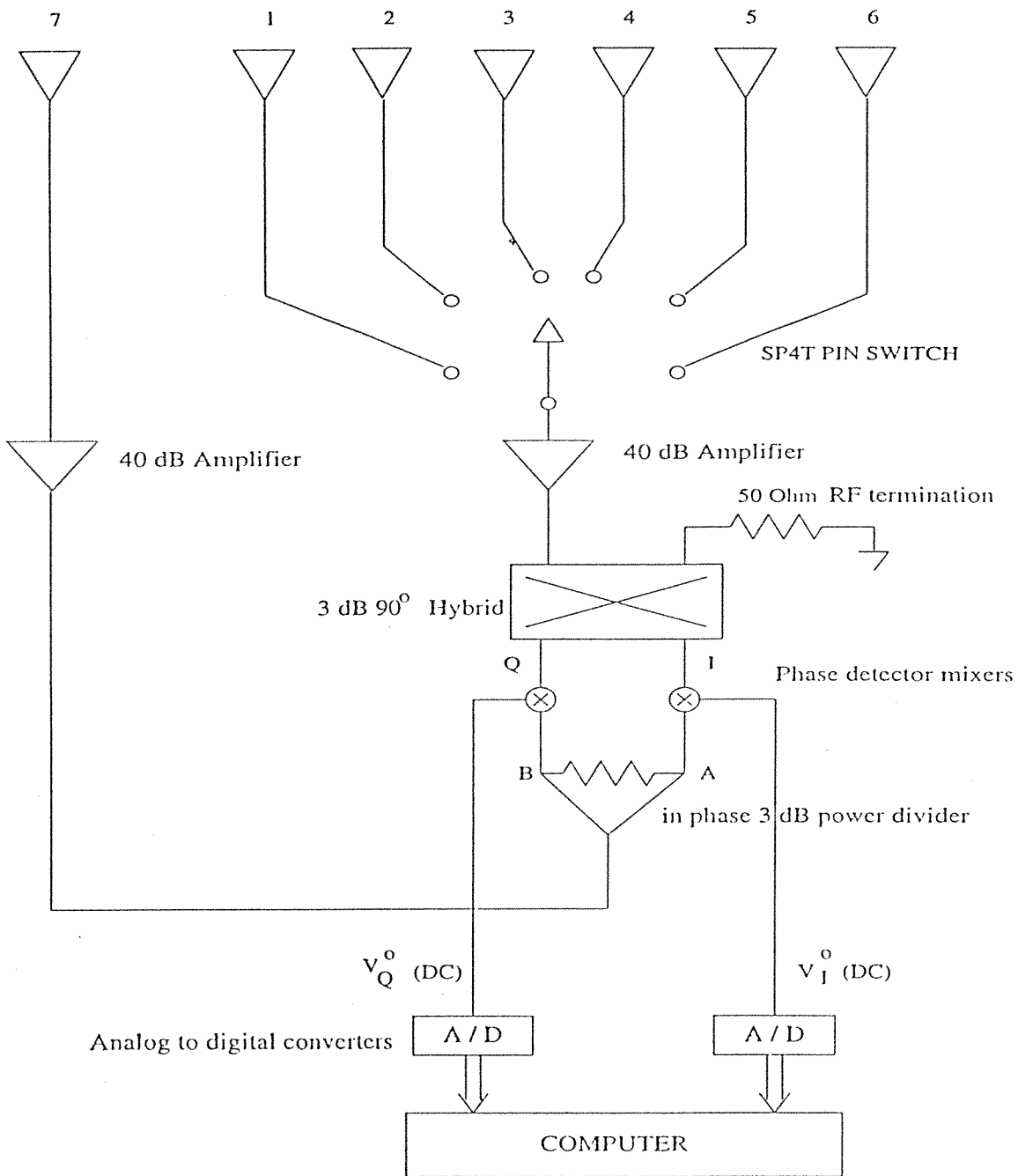


Figure A.2.3a Block diagram of the smart antenna system

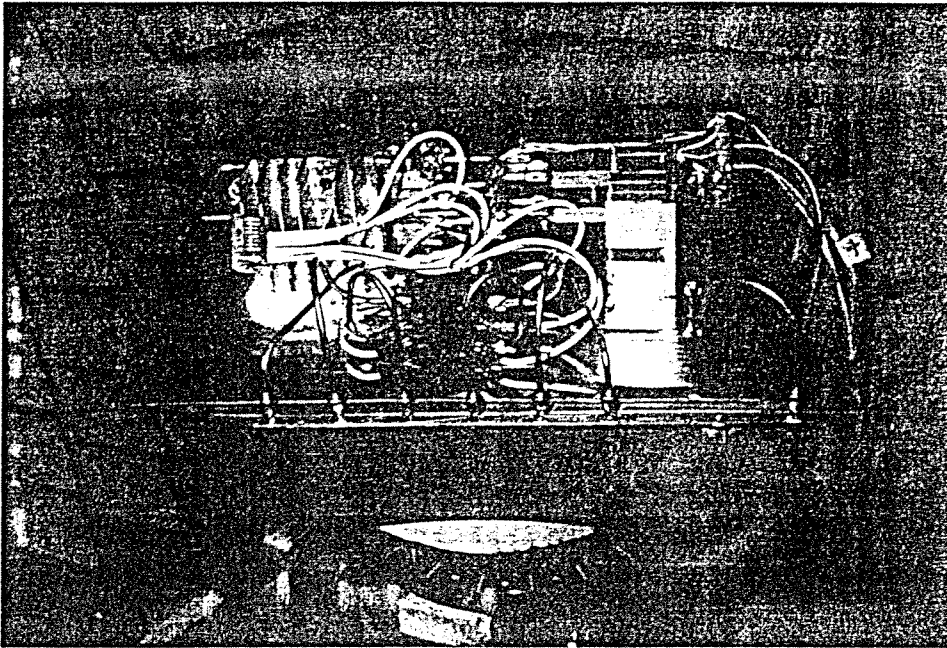


Figure A.2.3b Photograph

Two amplifiers of approximately 35 dB gain, two identical mixers, a 90° hybrid and a Wilkinson power divider are used between antenna elements and digital processing unit. The 90° hybrid supplies the in-phase component of the received signal to one of the mixer and the quadrature component to the other mixer. The mixers yield a DC voltage which is proportional to the phases of the received signals at each element of the array. The signal received from the reference antenna is fed into the inputs of each mixer and the signal received from the other elements is fed into the other inputs of the mixer. The reference signal is used to eliminate the frequency terms and to obtain the phase terms only at the outputs of the mixers. The single pole six throw switch is used rather than using the same set of mixer systems for each of the elements of the antenna array. This switch is to be controlled by the digital circuitry.

Calibration Procedures

In order to model the circuit correctly, a calibration procedure is necessary. Two types of calibration processes are proposed:

1. Method

S-parameters of the parts from each patch to the I and Q ports shown in Fig. A.2.3, are measured in ASELSAN and given in Fig. A.2.6 to Fig. A.2.20. Also, S-parameters S_{A7} and S_{B7} are defined as the S-parameters of the part from reference antenna to ports A and B, shown in Fig. A.2.3, respectively. All the S-parameters are defined with respect to 50 ohm reference.

Then, the voltage at port I, when switch is connected to the i'th element is given by

$$V_{Ii} = \text{Re}\{V_i S_{Ii} e^{j\omega t}\} = |V_i| |S_{Ii}| \cos(\omega t + \phi_i + \psi_{Ii})$$

where

$$V_i = |V_i| e^{j\phi_i}, \quad S_{Ii} = |S_{Ii}| e^{j\psi_{Ii}}$$

V_i is the voltage received by the i'th element, ϕ_i is the random phase of the received signal at the i'th element, ψ_{Ii} is the phase factor introduced by the system on the i'th signal in-phase component.

Similarly, we define

$$V_{Qi} = \text{Re}\{V_i S_{Qi} e^{j\omega t}\} = |V_i| |S_{Qi}| \cos(\omega t + \phi_i + \psi_{Qi})$$

where

$$S_{Qi} = |S_{Qi}| e^{j\psi_{Qi}}$$

The voltages at ports A and B are defined as

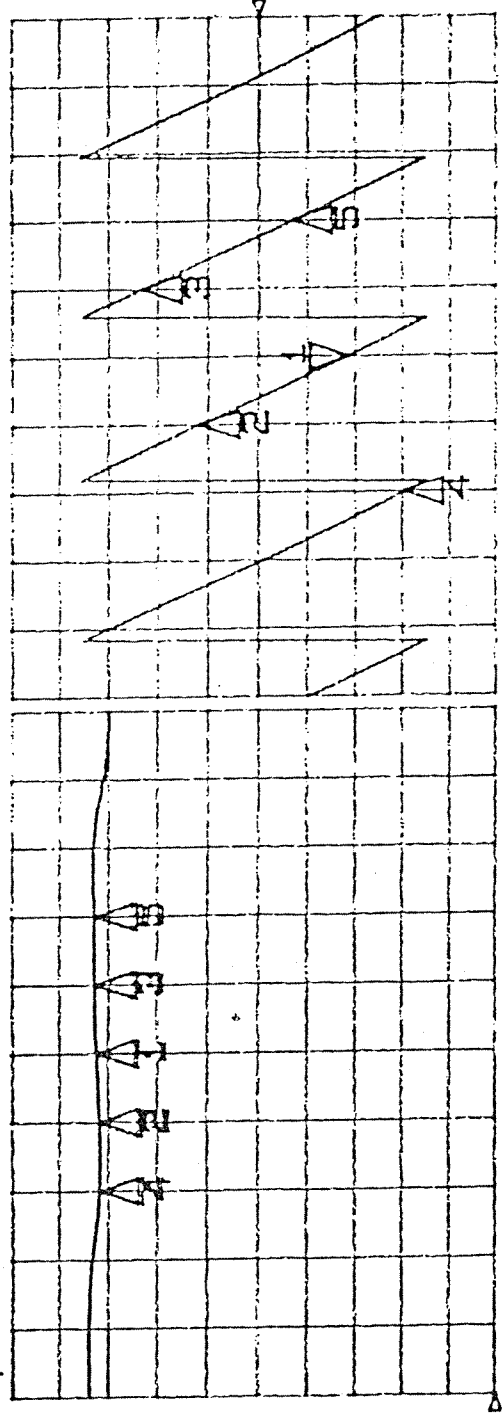
$$V_A = |V_7| |S_{A7}| \cos(\omega t + \phi_7 + \psi_{A7})$$

$$V_B = |V_7| |S_{B7}| \cos(\omega t + \phi_7 + \psi_{B7})$$

The outputs of the mixers for DC component are expressed by

S21 REF 0.0 dB
 REF 0.0 °
 50.0 °
 -93.253 °
 40.282 dB
 hp

CA MARKER 1
 7.0 GHz
 point 101



MARKER 1	7.0 GHz	-93.253 °	40,543dB
MARKER 2	6.9 GHz	57.438 °	40,236 dB
MARKER 3	7.1 GHz	114.32 °	40,709 dB
MARKER 4	5.8 GHz	-154.67 °	40,135 dB
MARKER 5	7.2 GHz	-36.781 °	40,734 dB

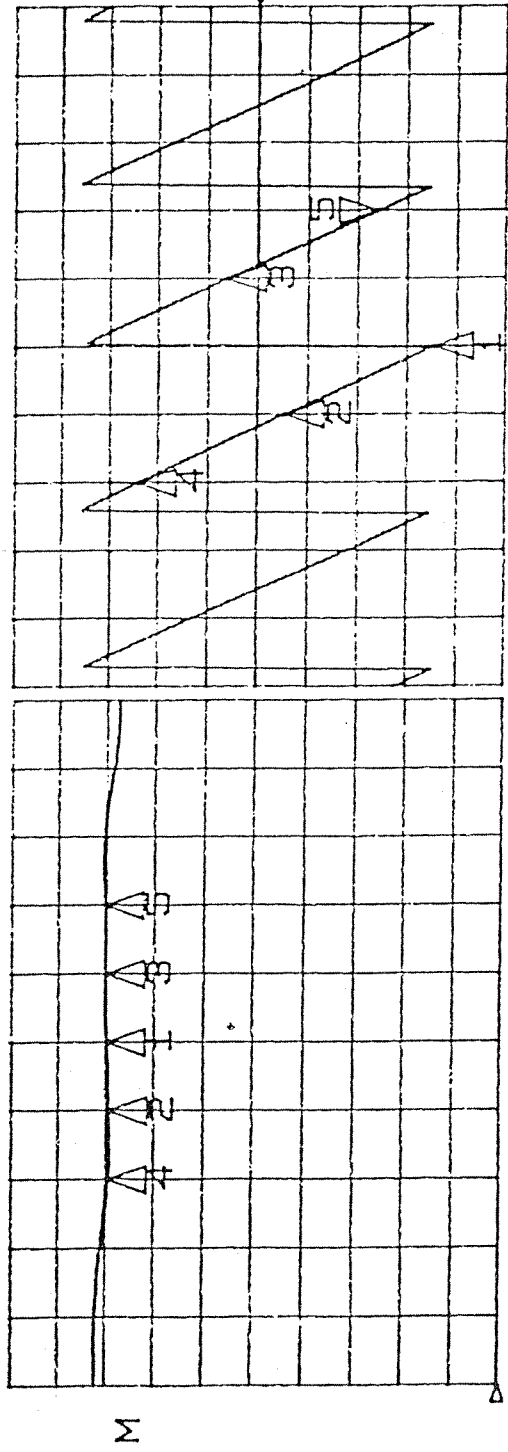
CENTER 7.000000000 GHz
 SPAN 1.000000000 GHz

22 APR 96
 13:15:08

Figure A.2.6 Measured S-parameters: Q1 port

S21 REF 0.0 dB
 S REF 5.0 dB
 S 40.09 dB
 hp
 109 MAG
 S21 REF 0.0 °
 S REF 50.0 %
 S -120.07 °
 phase

C A MARKER 5
 7.2 GHz
 point 141



MARKER 1	7.0 GHz	-177.15 °	39,33dB
MARKER 2	6.9 GHz	-26.524 °	39,102dB
MARKER 3	7.1 GHz	30.816 °	39,459dB
MARKER 4	6.8 GHz	121.18 °	39,063dB
MARKER 5	7.2 GHz	-120.07 °	39,459dB

CENTER 7.000000000 GHz
 SPAN 1.000000000 GHz

22 APR 96
 12:18:12

Figure A.2.7 Measured S-parameters: I1 port

MARKER 1
 7.0 GHz
 -89.531 °
 40,389 dB

MARKER 2
 6.9 GHz
 61.162 °
 40,098 dB

MARKER 3
 7.1 GHz
 118.34 °
 40,516 dB

MARKER 4
 6.8 GHz
 -150.42 °
 40,082 dB

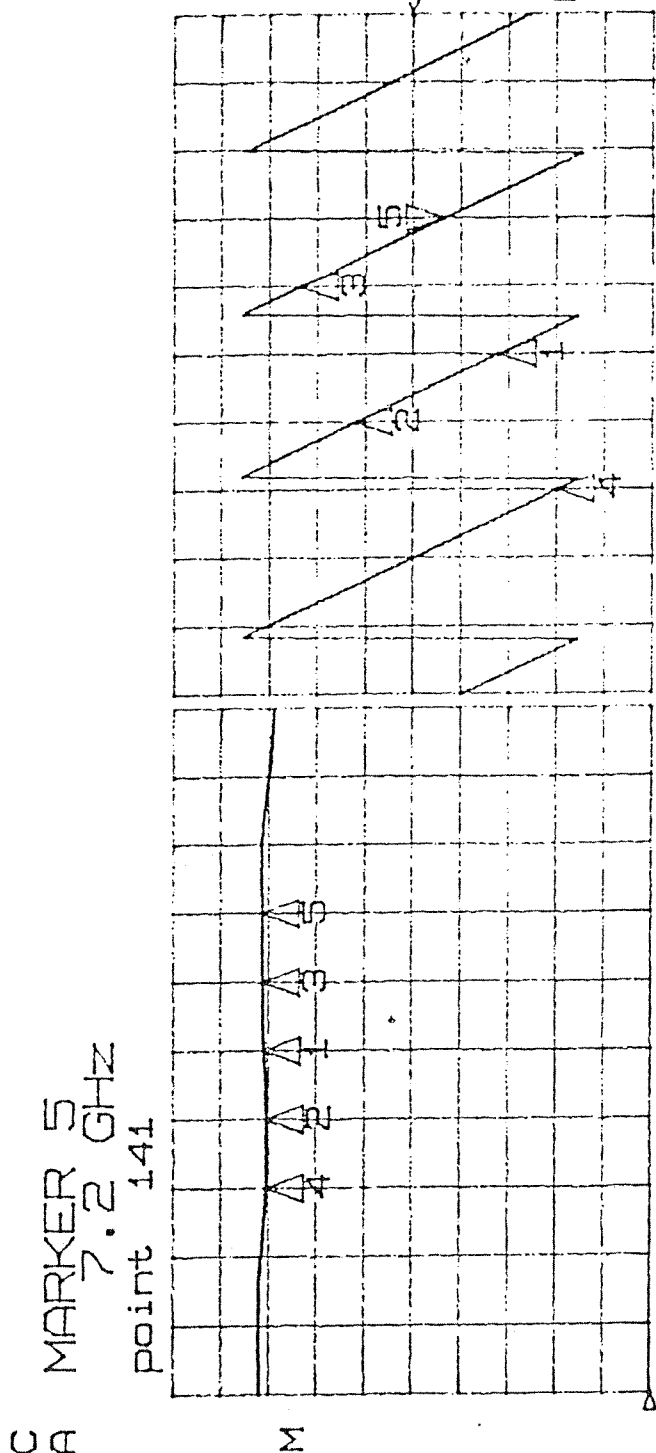
MARKER 5
 7.2 GHz
 -32.375 °
 40,533 dB

S21 REF 0.0 °
 50.0 °
 -32.375 °

log MAG
 phase

S21 REF 0.0 dB
 5.0 dB
 40.701 dB

Δ S
 7p



22 APR 96
 13:19:28

CENTER 7.000000000 GHz
 SPAN 1.000000000 GHz

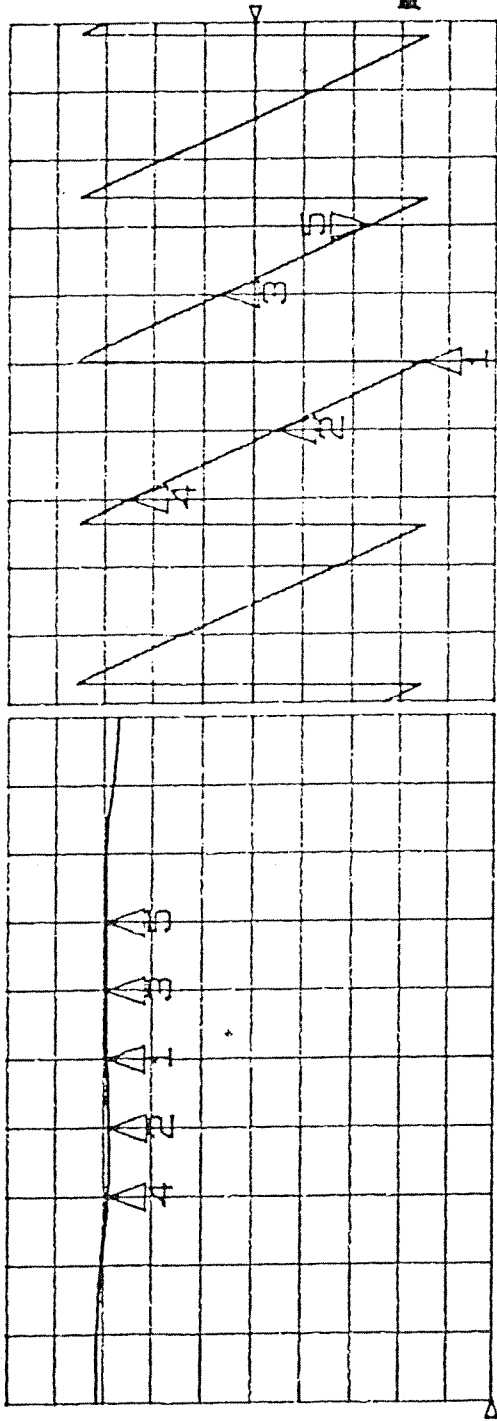
Figure A.2.8 Measured S-parameters: Q2 port

S₂₁ REF 0.0 dB
 S REF 5.0 dB
 S 39.713 dB
 hp

CA MARKER 5
 7.2 GHz
 point 141

109 MAG S₂₁ REF 0.0 °
 5 50.0 °
 ▽ -116.25 °

MARKER 1
 7.0 GHz
 -173.68 °
 39,289 dB
 MARKER 2
 6.9 GHz
 -23.191 °
 39,094 dB
 MARKER 3
 7.1 GHz
 34.303 °
 39,369 dB
 MARKER 4
 6.8 GHz
 124.83 °
 39,178 dB
 MARKER 5
 7.2 GHz
 -116.25 °
 39,381 dB



CENTER 7.000000000 GHz
 SPAN 1.000000000 GHz

22 APR 98
 12:25:46

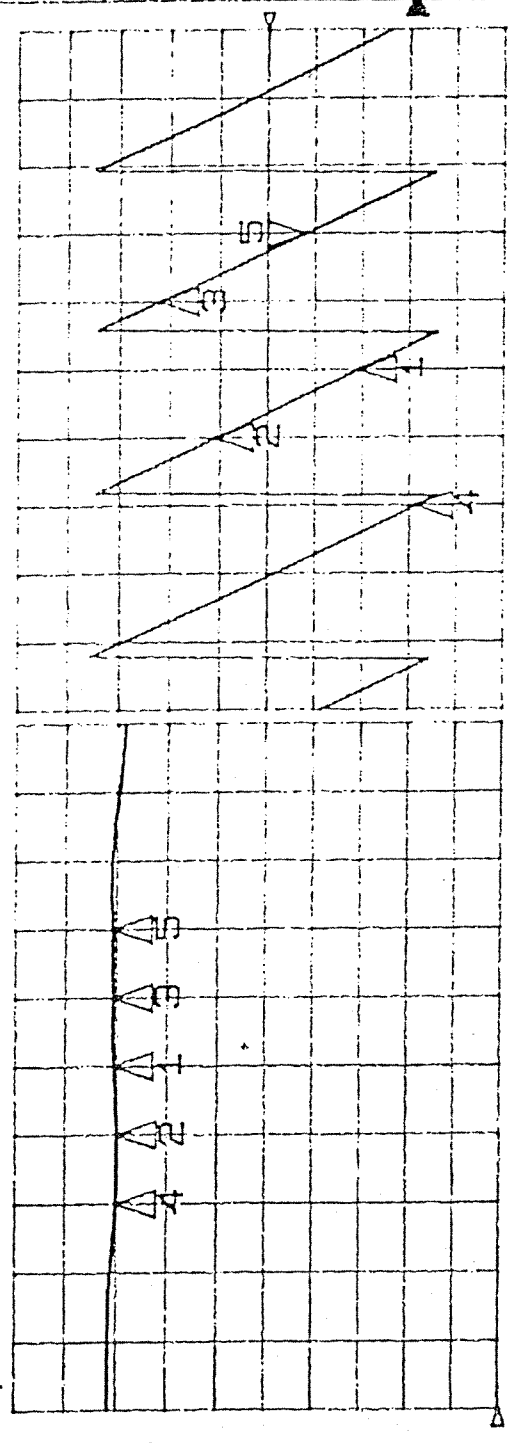
Figure A.2.9 Measured S-parameters: I2 port

MARKER 1	7.0 GHz	-96.238 °	40,271 dB
MARKER 2	6.9 GHz	54.506 °	39,916 dB
MARKER 3	7.1 GHz	111.88 °	40,320 dB
MARKER 4	6.8 GHz	-157.09 °	39,914 dB
MARKER 5	7.2 GHz	-39.096 °	40,410 dB

S21 REF 0.0 °
 S REF 50.0 %
 V -39.096 °
 phase

S21 REF 0.0 dB
 S REF 5.0 dB
 S 40.496 dB
 hp

C A MARKER 5
 7.2 GHz
 point 141



CENTER 7.000000000 GHz
 SPAN 1.000000000 GHz

22 APR 98
 13:24:15

Figure A.2.10 Measured S-parameters: Q3 port

MARKER 1
 7.0 GHz
 -179.8 °
 39,104 dB

MARKER 2
 6.9 GHz
 -29.152 °
 38,918 dB

MARKER 3
 7.1 GHz
 28.481 °
 39,18 dB

MARKER 4
 6.8 GHz
 118.92 °
 39,012 dB

MARKER 5
 7.2 GHz
 -122.29 °
 39,262 dB

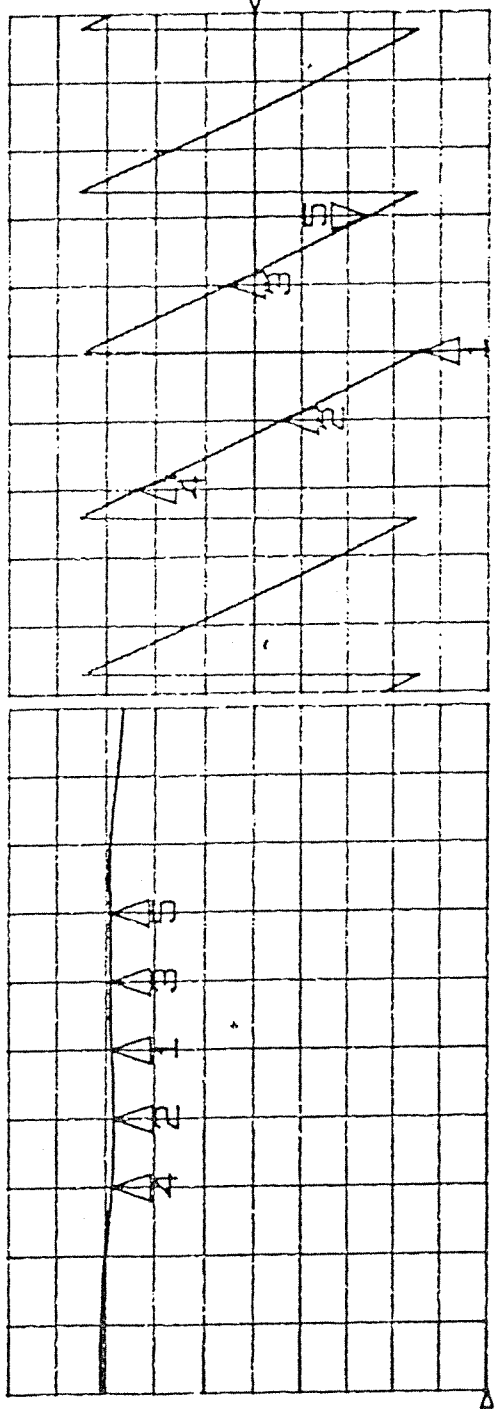
log MAG

S21
 REF 0.0 °
 5 50.0 °
 ▽ -122.29 °

phase

S21
 REF 0.0 dB
 5 5.0 dB
 39.516 dB

C A MARKER 5
 7.2 GHz
 point 141



CENTER 7.000000000 GHz
 SPAN 1.000000000 GHz

22 APR 96
 12:30:03

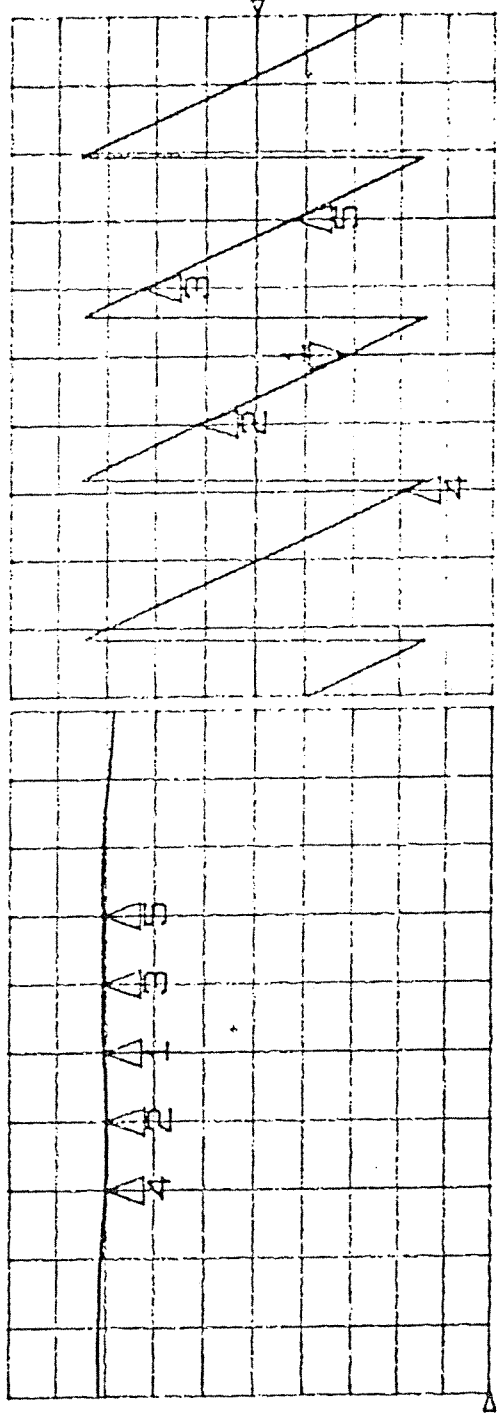
Figure A.2.11 Measured S-parameters: I3 port

MARKER 1	7.0 GHz	-93.656 °	40,162 dB
MARKER 2	6.9 GHz	57.275 °	39,897 dB
MARKER 3	7.1 GHz	114.32 °	40,277 dB
MARKER 4	6.8 GHz	-154.26 °	39,898 dB
MARKER 5	7.2 GHz	-96.455 °	40,336 dB

log MAG
 S21 REF 0.0 °
 1 50.0 %
 V -93.656 °

S21 REF 0.0 dB
 Δ 5.0 dB
 1 40.211 dB
 hp

C A MARKER 1
 7.0 GHz
 point 101



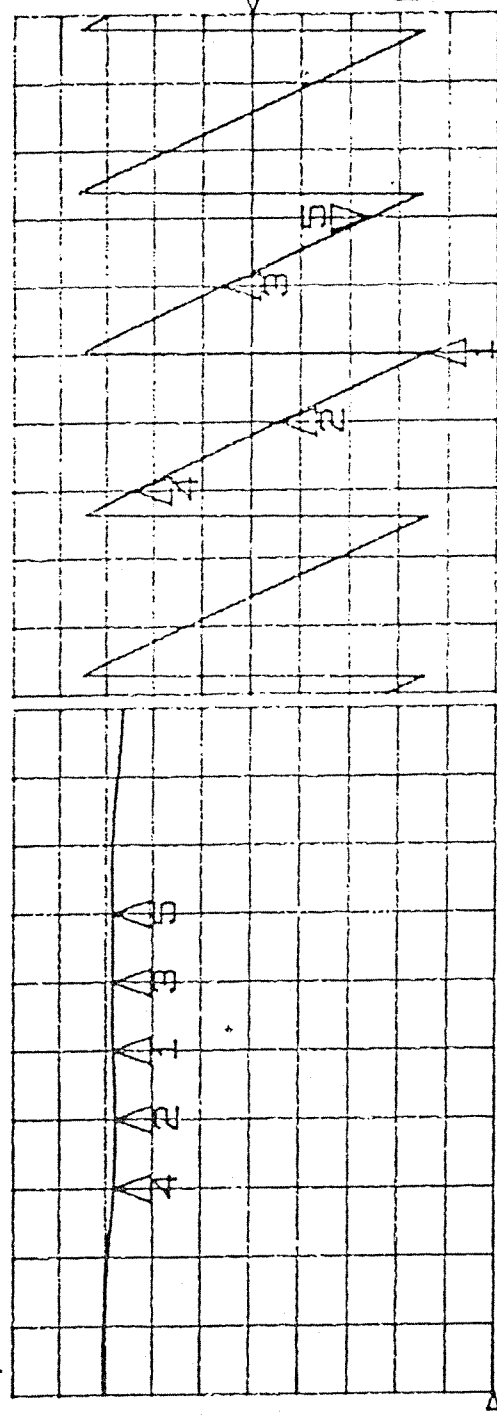
CENTER 7.00000000 GHz
 SPAN 1.00000000 GHz

22 APR 98
 13:28:32

Figure A.2.12 Measured S-parameters: Q4 port

S_{21} REF 0.0 dB
 S_{21} REF 0.0 °
 S 5.0 dB
 V 50.0 %
 S 39.219 dB
 hp -120.23 °

C A MARKER 5
 point 141
 M 7.2 GHz



MARKER 1	7.0 GHz	-177.81 °	39.039 dB
MARKER 2	6.9 GHz	-27.207 °	38.84 dB
MARKER 3	7.1 GHz	30.35 °	39.09 dB
MARKER 4	6.8 GHz	121.05 °	38.955 dB
MARKER 5	7.2 GHz	-120.23 °	39.150 dB

CENTER 7.00000000 GHz
 SPAN 1.00000000 GHz

22 APR 98
 12:34:40

Figure A.2.13 Measured S-parameters: I4 port

MARKER 1
 7.0 GHz
 -120.6 °
 40,107dB

MARKER 2
 6.9 GHz
 30.658 °
 39,859dB

MARKER 3
 7.1 GHz
 86.727 °
 40,113dB

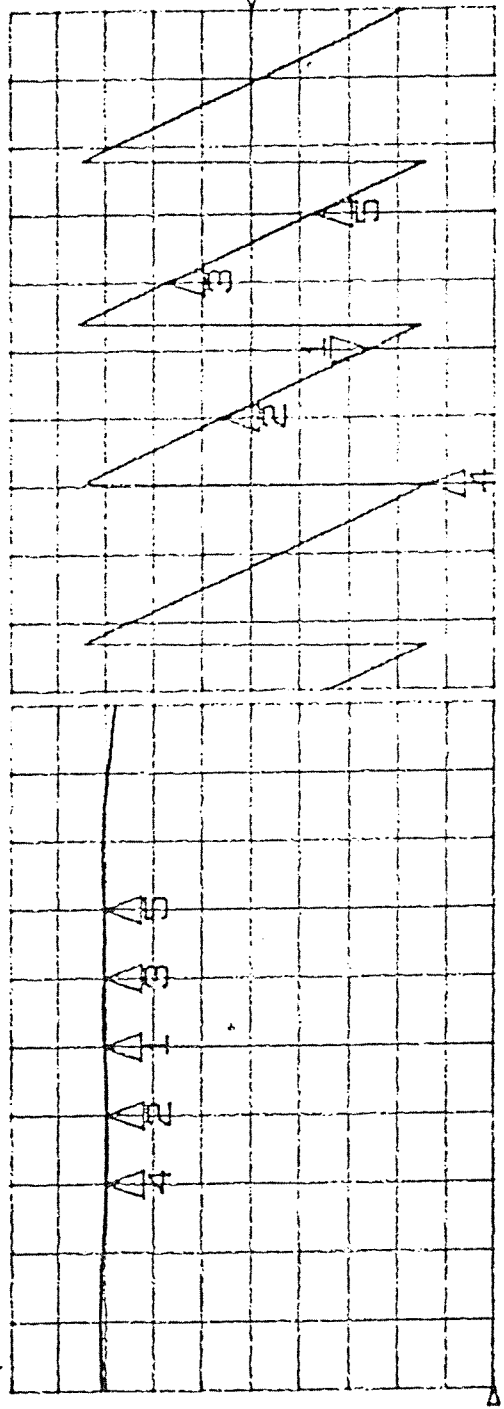
MARKER 4
 6.8 GHz
 -179.42 °
 39,877dB

MARKER 5
 7.2 GHz
 -63.27 °
 40,164dB

LOG MAG
 REF 0.0 °
 50.0 %
 -120.6 °

REF 0.0 dB
 5.0 dB
 40.129 dB

C A MARKER 1
 7.0 GHz
 point 101



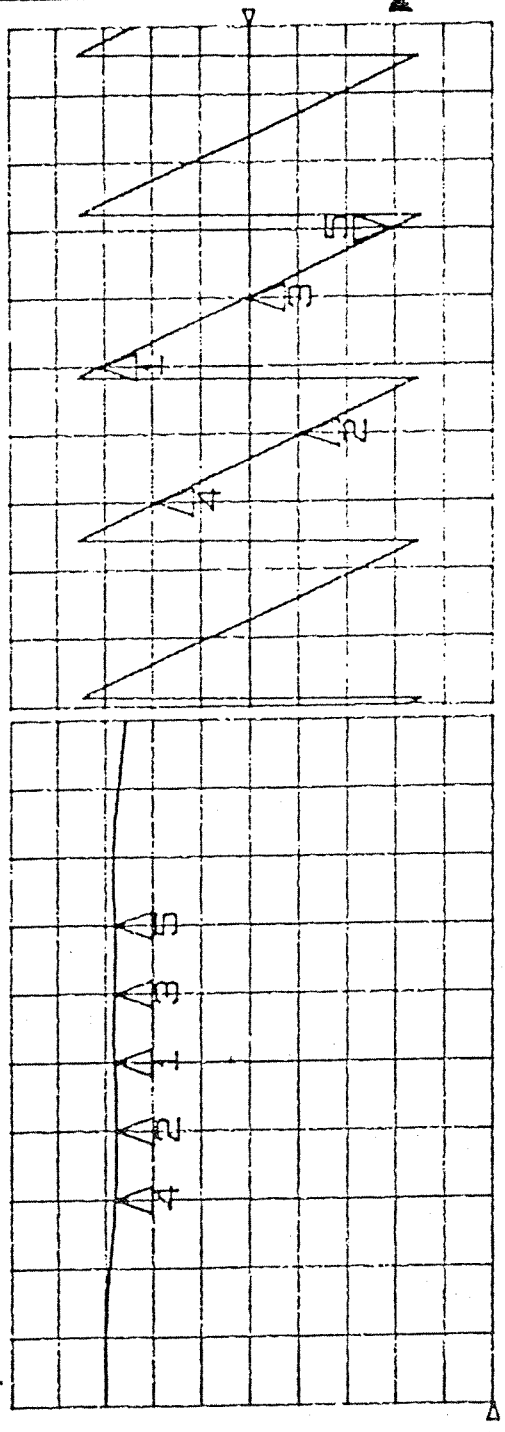
CENTER 7.000000000 GHz
 SPAN 1.000000000 GHz

22 APR 98
 13:33:17

Figure A.2.14 Measured S-parameters: Q5 port

S21 REF 0.0 dB
 Δ 5.0 dB/Δ
 39.008 dB
 hp
 109 MAG
 S21 REF 0.0 °
 50.0 °/Δ
 -146.88 °
 phase

C A MARKER 5
 7.2 GHz
 point 141



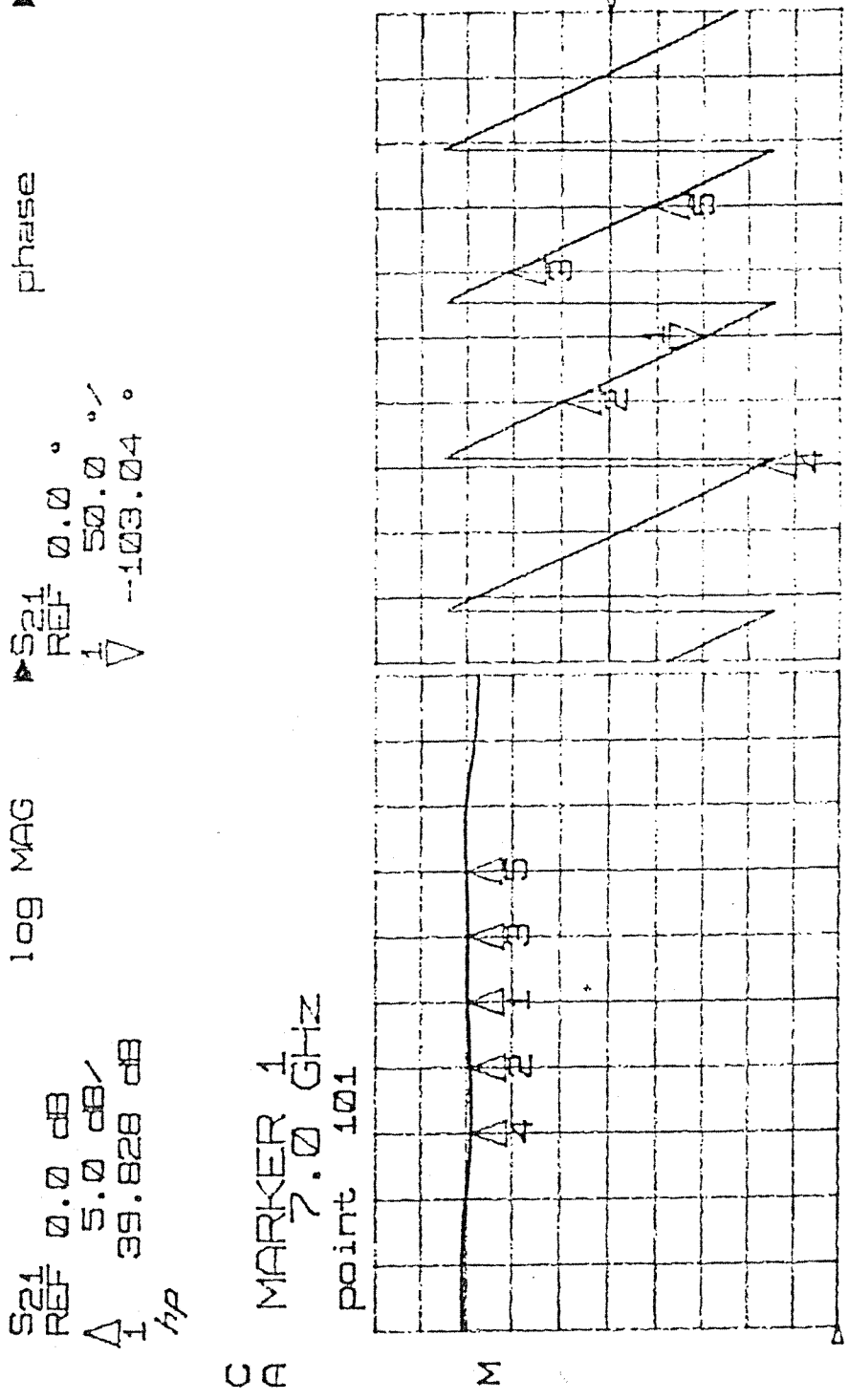
MARKER 1	7.0 GHz	155.42 °	38,965dB
MARKER 2	6.9 GHz	-53.623 °	38,797dB
MARKER 3	7.1 GHz	2.9196 °	38,904dB
MARKER 4	6.8 GHz	96.082 °	38,920dB
MARKER 5	7.2 GHz	-146.88 °	38,955dB

CENTER 7.000000000 GHz
 SPAN 1.000000000 GHz

22 APR 98
 12:39:08

Figure A.2.15 Measured S-parameters: 15 port

S21 REF 0.0 dB
 Δ 5.0 dB
 I 39.828 dB
 hp
 S21 REF 0.0 °
 1 50.0 %
 V -103.04 °
 phase
 MARKER 1
 7.0 GHz
 -103.04 °
 39,797dB
 MARKER 2
 6.9 GHz
 48.73 °
 39,593dB
 MARKER 3
 7.1 GHz
 105.83 °
 39,807dB
 MARKER 4
 6.8 GHz
 -162.8 °
 39,418dB
 MARKER 5
 7.2 GHz
 -44.551 °
 40,074dB



CENTER 7.00000000 GHz
 SPAN 1.00000000 GHz
 22 APR 96
 13:39:05

Figure A.2.16 Measured S-parameters: Q6 port

MARKER 1
 7.0 GHz
 172.82 °
 38,629 dB

MARKER 2
 6.9 GHz
 -35.68 °
 38,49 dB

MARKER 3
 7.1 GHz
 21.792 °
 38,60 dB

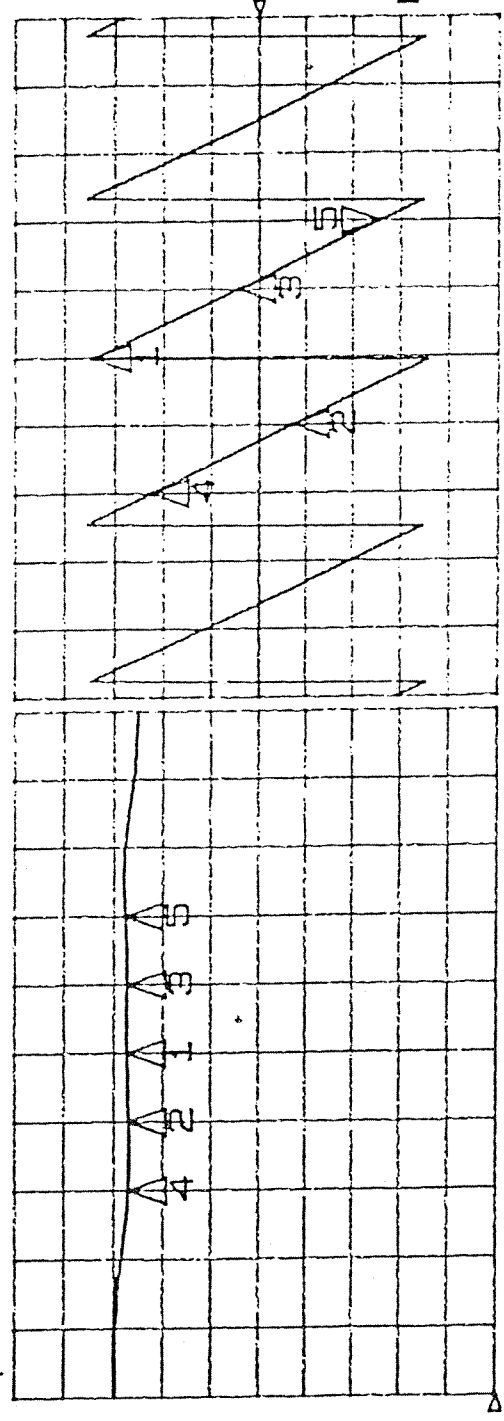
MARKER 4
 6.8 GHz
 112.63 °
 38,455 dB

MARKER 5
 7.2 GHz
 -128.54 °
 38,852 dB

109 MAG
 S21 REF 0.0 °
 5 50.0 %
 V -128.54 °

S21 REF 0.0 dB
 5 5.0 dB
 38.881 dB

C A MARKER 5
 7.2 GHz
 point 141



22 APR 98
 12:43:38

CENTER 7.00000000 GHz
 SPAN 1.00000000 GHz

Figure A.2.17 Measured S-parameters: I6 port

▲ S21 REF 0.0 dB
 S 5.0 dB ✓
 ▼ 42.645 dB
 hp

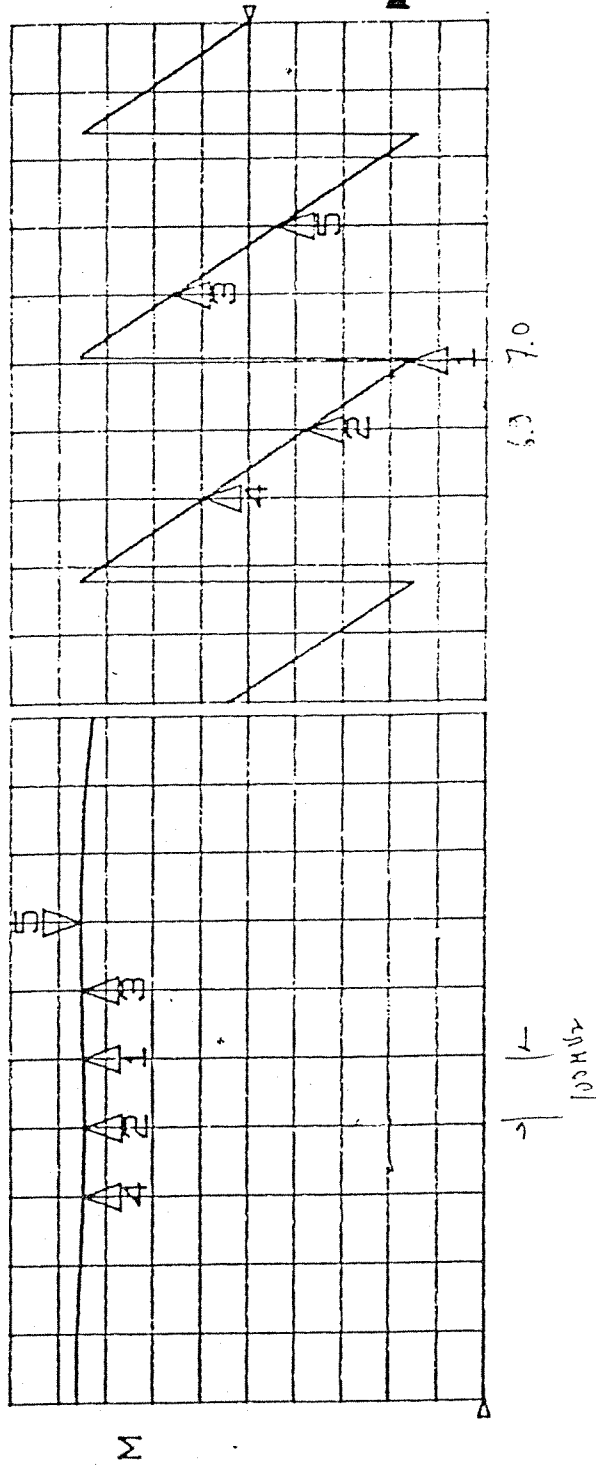
log MAG

S21 REF 0.0 °
 S 50.0 ° ✓
 S -29.772 °

phase

C A PEN NUMBER
 5

MARKER 1	7.0 GHz	42.445 dB	-169,86 deg.
MARKER 2	6.9 GHz	42.275 dB	-61,367 deg.
MARKER 3	7.1 GHz	42.609 dB	80,043 deg.
MARKER 4	6.8 GHz	42.352 dB	46,498 deg.
MARKER 5	7.2 GHz	42.645 dB	-30,307 deg.



CENTER 7.000000000 GHz
 SPAN 1.000000000 GHz

22 APR 98
 10:06:57

Figure A.2.18 Measured S-parameters: A7

MARKER 1	7.0 GHz	42.613 dB	170.18 deg
MARKER 2	6.9 GHz	42.416 dB	-81.06 deg
MARKER 3	7.1 GHz	42.793 dB	59.84 deg
MARKER 4	6.8 GHz	42.496 dB	27.04 deg
MARKER 5	7.2 GHz	42.832 dB	-50.97 deg

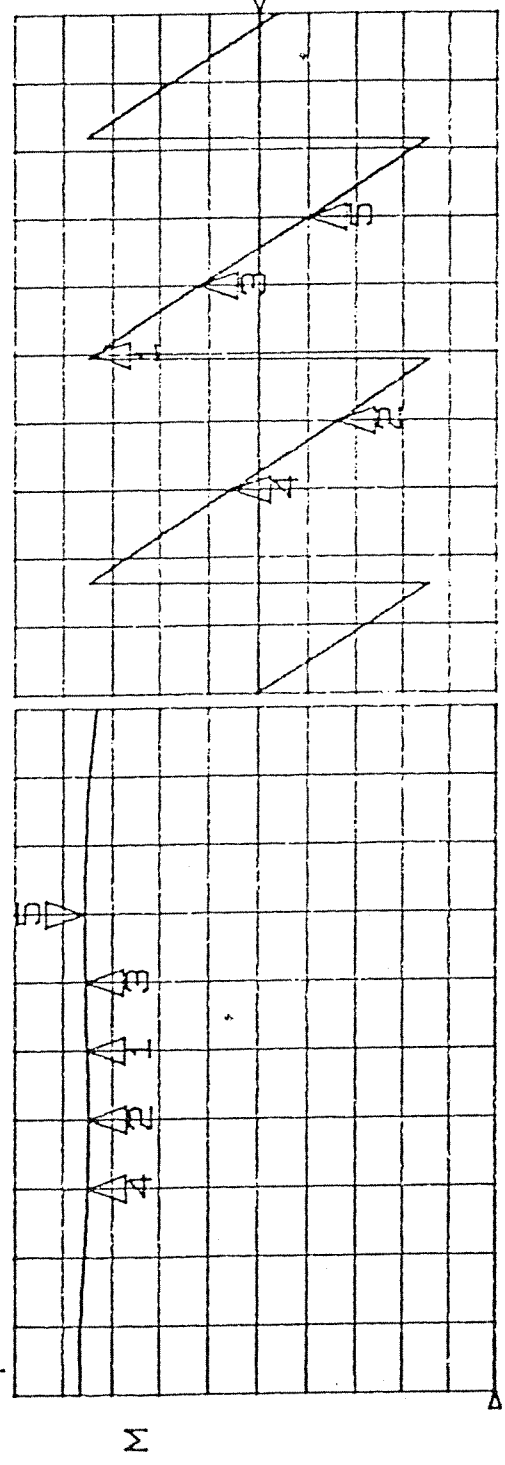
S21 REF 0.0 °
 S 50.0 °
 S -50.395 °

S21 REF 0.0 dB
 S 5.0 dB
 V 42.832 dB
 hp

log MAG

phase

C A MARKER 5
 7.2 GHz
 point 141



CENTER 7.000000000 GHz
 SPAN 1.000000000 GHz

22 APR 98
 10:01:54

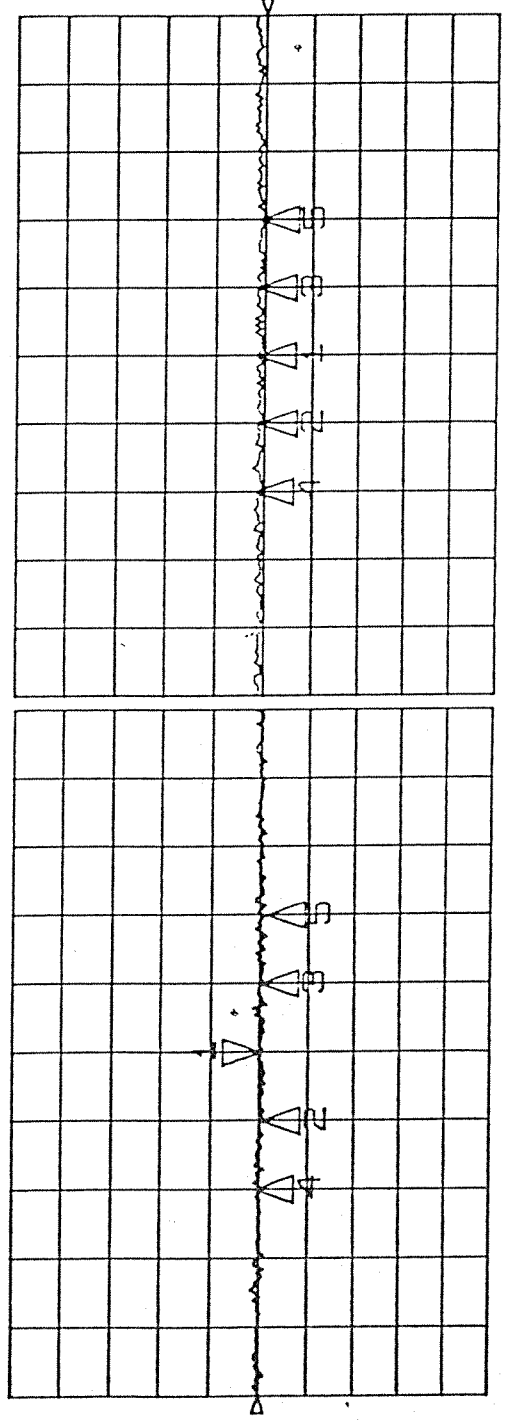
Figure A.2.19 Measured S-parameters: B7

S21 REF 0.0 dB
 1 0.1 dB
 V -0.0025 dB
 hp

log MAG
 S21 REF 0.0 °
 1 1.0 °
 Δ 129.09 m°

phase

C
 A MARKER 1
 7.0 GHz
 point 101



MARKER 1	7.0 GHz	-0.0025 dB
MARKER 2	6.9 GHz	-0.0066 dB
MARKER 3	7.1 GHz	-0.0012 dB
MARKER 4	6.8 GHz	0.0055 dB
MARKER 5	7.2 GHz	-0.0148 dB

CENTER 7.000000000 GHz
 SPAN 1.000000000 GHz

22 APR 98
 08:13:02

Figure A.2.20 Calibration accuracy.

$$V_{Ii}^o = \underbrace{k_I |V_7| |S_{A7}| |V_i| |S_{Ii}|}_{|V_{Ii}^o|} \cos \underbrace{(\phi_i + \psi_{Ii} - \phi_7 - \psi_{A7})}_{\nu_{Ii}}$$

$$V_{Qi}^o = \underbrace{k_Q |V_7| |S_{B7}| |V_i| |S_{Qi}|}_{|V_{Qi}^o|} \cos \underbrace{(\phi_i + \psi_{Qi} - \phi_7 - \psi_{B7})}_{\nu_{Qi}}$$

In our laboratory conditions, the incoming wave is assumed as a spherical wave. Spherical wave model and the receiving array is shown in Fig. A.2.21. The 3rd element of the array is assumed at the origin. Distance from 3rd element to the phase center of the transmitting antenna is h and the angle between y -axis and $R_3 = h$ is θ .

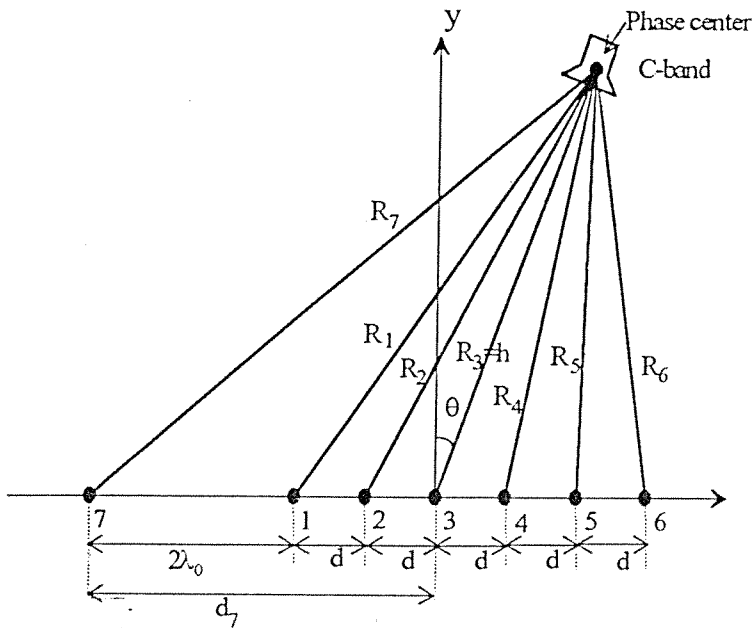


Figure A.2.21 Spherical wave model of the incident wave

Distance from the reference antenna to the phase center of the transmitting antenna is given by

$$R_7 = \left(d_7^2 + h^2 + 2d_7 h \sin \theta \right)^{1/2}$$

Distance of the i 'th element to the phase center is given by

$$R_i = \left[(3-i)^2 d^2 + h^2 + 2(3-i) d h \sin \theta \right]^{1/2}, \quad \forall i.$$

$$\cos \nu_I(i) = \cos (\phi_i - \phi_7 + \psi_I(i) - \psi_{A7})$$

$$\cos \nu_Q(i) = \cos (\phi_i - \phi_7 + \psi_Q(i) - \psi_{B7})$$

Let

$$\gamma_i = \phi_i - \phi_7 = -k_0(R_i - R_7)$$

Since $d_7 \ll h$, then

$$R_7 \approx \left(d_7^2 + h^2\right)^{1/2} + \frac{d_7 h}{\sqrt{d_7^2 + h^2}} \sin \theta.$$

Similarly $|3-i|d \ll h$, then d_7 can be replaced by $|3-i|d$, and R_i becomes

$$R_i = \left[(3-i)^2 d^2 + h^2\right]^{1/2} + \frac{(3-i)dh}{\sqrt{(3-i)^2 d^2 + h^2}} \sin \theta.$$

Then

$$R_i - R_7 \cong P_i + S_i \sin \theta$$

and

$$\gamma_i = -k_0 P_i - k_0 S_i \sin \theta$$

where

$$P_i = \sqrt{(3-i)^2 d^2 + h^2} - \sqrt{d_7^2 + h^2}$$

$$S_i = \frac{(3-i)dh}{\sqrt{(3-i)^2 d^2 + h^2}} - \frac{d_7 h}{\sqrt{d_7^2 + h^2}}$$

Then following manipulations are made to find θ_i

$$\gamma_i(\theta) = -k_0(R_i - R_7)$$

$$N_i(\theta) = \tan \gamma_i(\theta) = \tan [\gamma_i(\theta) - n\pi], \quad n = 0, \pm 1, \pm 2, \dots$$

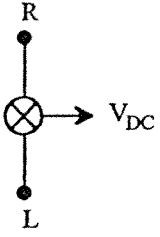
$$\gamma_i(\theta) = \tan^{-1}[N_i(\theta)] + n\pi$$

$$\theta_i = \sin^{-1} \left[\frac{\tan^{-1} N_i(\theta) + n\pi + k_0 P_i}{-k_0 S_i} \right], \quad n = 0, \pm 1, \pm 2, \dots$$

The above equation will be different for each element of the antenna array and hence six different equations will be obtained. Each equation will yield many solutions for θ and only one of them will be correct. Comparing all of the six set of solutions, one should be able to determine the actual solution, since only the actual solution will exist in all of the solution sets. This can be done by a computer program.

Mixer Characterization

To characterize mixers, nonlinear model is used.



$$V_{DC} = k V_L V_R \cos(\phi_L - \phi_R) + \alpha |V_L|^2 + \beta |V_R|^2 \quad ,$$

k , α , β for I and Q components are the unknowns to be determined. Then V_{Ii} and V_{Qi} are expressed by

$$V_{Ii} = k_I V_0^2 |S_{A7}| |S_{Li}| \cos \nu_{Ii} + \alpha_I V_0^2 |S_{A7}|^2 + \beta_I V_0^2 |S_{Li}|^2$$

$$V_{Qi} = k_Q V_0^2 |S_{B7}| |S_{Qi}| \cos \nu_{Qi} + \alpha_Q V_0^2 |S_{B7}|^2 + \beta_Q V_0^2 |S_{Qi}|^2 \quad .$$

We define M_i as the ratio of V_{Ii} and V_{Qi} as

$$M_i = \frac{p \cos \nu_{Ii} + s}{\cos \nu_{Qi} + q}$$

where

$$p = \frac{k_I |S_{A7}| |S_{Li}|}{k_Q |S_{B7}| |S_{Qi}|}, \quad s = \frac{\alpha_I |S_{A7}|^2 + \beta_I |S_{Li}|^2}{k_Q |S_{B7}| |S_{Qi}|}, \quad q = \frac{\alpha_Q |S_{B7}|^2 + \beta_Q |S_{Qi}|^2}{k_Q |S_{B7}| |S_{Qi}|}.$$

Then,

$$M = \frac{p \cos(\gamma + a) + s}{\cos(\gamma + b) + q}$$

After some algebraic manipulations and rearrangements s/p and q/p ratios are found as

$$\frac{s}{p} = \frac{\alpha_I |S_{A7}|}{k_I |S_{Li}|} + \frac{\beta_I |S_{Li}|}{k_I |S_{A7}|} \quad ,$$

$$\frac{q}{p} = \frac{\alpha_Q |S_{B7}|^2}{k_I |S_{A7}| |S_{Li}|} + \frac{\beta_Q |S_{Qi}|^2}{k_I |S_{A7}| |S_{Li}|}.$$

To find θ_i , following steps must be followed beginning from the equation of M :

$$\underbrace{\frac{\frac{M}{p} \cos b - \cos a}{\frac{M}{p} \sin b - \sin a}}_K \cos \gamma = \sin \gamma + \underbrace{\frac{\frac{s}{p} - M \frac{q}{p}}{\frac{M}{p} \sin b - \sin a}}_T$$

$$\tan \gamma = \frac{K \pm T \sqrt{1 + K^2 - T^2}}{1 - T^2}$$

$$W = T \sqrt{1 + K^2 - T^2}$$

$$\tan \gamma = \frac{K \pm W}{1 - T^2}, \quad \gamma = -k_0 P_i - k_0 S_i \sin \theta$$

Both signs are considered in the solution. Hence, solution for θ_i is given by

$$\theta_i = \sin^{-1} \left\{ \frac{1}{-k_0 S_i} \left[\tan^{-1} \left(\frac{K \pm W}{1 - T^2} \right) + n\pi + k_0 P_i \right] \right\}, \quad n = 0, \pm 1, \pm 2, \dots$$

The precision in the calculation of the angle of arrival of the incoming signal is highly dependent on phase variations. Therefore, it is very important that the phase quantities are taken into account correctly.

2. Method

The other proposed calibration procedure is to calibrate the whole system at certain levels of signal strengths. In this procedure, V_{Ii} and V_{Qi} voltages for six antenna elements are measured for incoming signals coming from $0, \pm 1^\circ, \pm 2^\circ, \dots$ at specific signal levels. Then, look-up table is formed from these data. Hence, for unknown incoming signal, the measured V_{Ii} and V_{Qi} values are compared with values in look-up table and the direction of arrival can be found. To make this calibration procedure independent from the strength of the incoming signal, limiting amplifiers can be used in this system.

Beamforming

By using the knowledge of the direction of the incoming signal we can apply a beamforming algorithm and steer either the null or the maximum to the desired direction.

Receiving array pattern in xz plane, including the y-polarized element pattern, can be written as

$$f(\theta) = f_e(\theta) \sum_{n=1}^6 \alpha_n e^{jkd(n-3)\sin \theta}$$

Measured response of the array in I and Q channels are $V_{In}(\theta)$ and $V_{Qn}(\theta)$. We shall combine these voltages as

$$\sum_{n=1}^6 a_n V_{In}(\theta) + j b_n V_{Qn}(\theta) = f_b, \quad -\frac{\pi}{2} \leq \theta \leq \frac{\pi}{2}$$

$f_b(\theta)$ is the synthesized pattern.

Fourier series expansion of $f_b(\theta)$ is given by

$$f_b(\theta) = \sum_{n=-\infty}^{\infty} c_m e^{jm\theta}, \quad c_m = \frac{1}{2\pi} \int_0^{2\pi} f_b(\theta) e^{-jm\theta} d\theta$$

Then

$$c_m = \sum_{n=1}^6 a_n \underbrace{\left[\frac{1}{2\pi} \int_0^{2\pi} V_{In}(\theta) e^{-jm\theta} d\theta \right]}_{I_{mn}} + \sum_{n=1}^6 b_n \underbrace{\left[\frac{j}{2\pi} \int_0^{2\pi} V_{Qn}(\theta) e^{-jm\theta} d\theta \right]}_{Q_{mn}}$$

$$c_m = \sum_{n=1}^6 I_{mn} a_n + \sum_{n=1}^6 Q_{rn}$$

$$\begin{bmatrix} c_1 \\ \vdots \\ c_{12} \end{bmatrix} = \begin{bmatrix} I_{1,1} & \dots & I_{1,6} \\ \vdots & \ddots & \vdots \\ I_{12,1} & \dots & I_{12,6} \end{bmatrix} \begin{bmatrix} a_1 \\ \vdots \\ a_6 \end{bmatrix} + \begin{bmatrix} Q_{1,1} & \dots & Q_{1,6} \\ \vdots & \ddots & \vdots \\ Q_{12,1} & \dots & Q_{12,6} \end{bmatrix} \begin{bmatrix} b_1 \\ \vdots \\ b_6 \end{bmatrix}$$

$$[C] = \underbrace{\begin{bmatrix} I & Q \end{bmatrix}}_{[S]} [x]$$

$[x] = [S]^{-1}[C]$ gives the required coefficient (weights) for the synthesized pattern.

Finding c_m 's

For an equispaced linear array, let $f_b(\theta) = \sum_{n=1}^6 \alpha_n e^{jk_0(n-3)d \sin \theta}$ be the given synthesized pattern.

Then c_m 's can be found by

$$c_m = \frac{1}{2\pi} \sum_{n=1}^6 \alpha_n \int_0^{2\pi} e^{jk_0(n-3)d \sin \theta - jm \theta} d\theta$$

Conclusion

The smart antenna system is in line with the COST 245 activity, as well as with the follow-up COST project, due to its capability of forming adaptive beams by digital electronics and computer software. A prototype is built and tested in the microwave research laboratory of our Department; the early results are promising, however, much more work remains to be done in this prosperous field.

B- MONOLITHIC MICROWAVE INTEGRATED CIRCUIT DESIGNS

Introduction

“Monolithic Microwave Integrated Circuit”, MMIC, can be defined as the implementation of a microwave circuit using a single semi-insulating substrate on which all active and passive circuit elements or components and interconnections are formed by some deposition scheme such as epitaxy, ion implantation, evaporation, diffusion or a combination of these processes and others. The MMIC technology can be considered roughly the microwave equivalent of the low frequency integrated circuit technology which has a direct effect on the development of the low cost, efficient, reliable and compact electronic equipment.

In the last 20 years there has been a tremendous work for the monolithic integration of microwave circuits because of the following inherent advantages:

- Low cost,
- Small size and light weight,
- Design flexibility,
- High reliability,
- Reproducibility,
- Broadband performance.

MMIC's find many applications in various microwave systems. The concept of active microwave antenna array is particularly attractive for radar and satellite applications. Such an array involves the use of active devices combined with each array element, or with each small subarray, for the purpose of microwave power generation, phase shifting or receiving. In a large active antenna array the use of MMIC elements will certainly introduce additional advantages due to their small size, low cost, repeatability and easy integration with the radiating and feed elements.

With the above advantages in mind, various MMIC's have been designed, implemented and tested within the framework of this project. Designs and optimizations of all the circuits are achieved using CAD tools of LIBRA and ACADEMY software packages. The designs are carried out according to GEC-Marconi F20 process rules with an objective of minimizing the chip area. The chips were manufactured through EUROCHIP. The measurements on the manufactured chips were carried out using probe stations and network analysers at Bilkent University Physics Department; Aselsan; GEC Marconi, England and University of Massachusetts at Amherst, USA.

The MMIC chips that are designed in various functional areas are as follows:

- 1- Narrow and Wideband Amplifiers
- 2- Voltage Controlled Oscillator
- 3- Mixer
- 4- Low Noise Amplifier
- 5- Transmit/Receive Switch
- 6- Power Amplifier
- 7- Wideband Voltage Variable Attenuator
- 8- Phase Shifter

In the following sections these circuits will be briefly explained. For more detailed information, the previous progress reports may be resorted.

B1. NARROW AND WIDEBAND AMPLIFIERS

In the design of these amplifiers, the following criteria are considered:

- a) The input and output return losses,
- b) The gain,
- c) The bandwidth.

The choice of the transistors for MMIC applications up to 20 GHz is the MESFET. All the circuit components including MESFET's are the F20 Marconi Plessy Foundry elements. The transistor employed in the amplifiers is a MESFET with 0.5 μ m gate length and 6x50 μ m gate width. The quiescent current is %100 I_{DSS} .

Three amplifier topologies are used: i) one-stage and ii) two-stage 3-8 GHz wideband, iii) 10% bandwidth around 10.5 GHz. For the wide band amplifiers negative feedback is incorporated. The DC biasing circuits are R-C type. To obtain high gain, wide bandwidth and low return loss, optimization methods, which are available in LIBRA, are employed. The circuit diagrams of these amplifiers with the component values obtained after optimization are shown in Fig. B1.1. The narrowband amplifier is designed with the aim of obtaining highest gain from the smallest chip area.

After obtaining the satisfactory results from simulation of schematic circuits, layout of the amplifiers are prepared using ACADEMY. While doing so, maximum care is taken to avoid coupling between the adjacent lines and to occupy the minimum possible chip area. Fig. B1.2 shows the layouts of the three amplifiers placed on the same chip. The overall chip area is about 1.4x1.8mm².

The design objectives of the single-stage amplifier were:

- 6dB gain in 0.1-8 GHz band,
- Minimum -10dB return loss for both input and output ports in 3-8 GHz.
- %100 I_{DSS} for the transistor is 45 mA. However, the manufacturer states that this value could be anywhere between 30-60 mA. The measured value of the current under 5V drain to source voltage was 50 mA.

About ten identical chips were supplied by the foundry. These were labeled as C1, C2,...etc. Measurements were carried out on many of these chips. The results showed that repeatability was excellent. Fig. B1.3 shows the simulation and measurement results for chip number 1 under 5 V drain to source voltage (i.e., C1/5V). As is seen from the figure the agreement between the simulation and measurement results is very good, especially in the band 0.5-6 GHz.

The design objectives of the two-stage amplifier were:

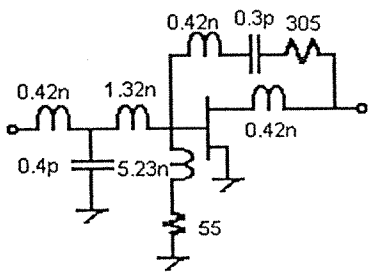
- 14dB gain in 3-8 GHz band,
- Minimum -12dB return loss for both input and output ports in 3-8 GHz.- Total measured current for the two transistors under 5V drain to source voltage was 100mA as expected.

Fig. B1.4 shows The simulation and measurement results of two-stage amplifier. The agreement, again, is very good except for output return loss, S_{22} , at frequencies greater than 6 GHz.

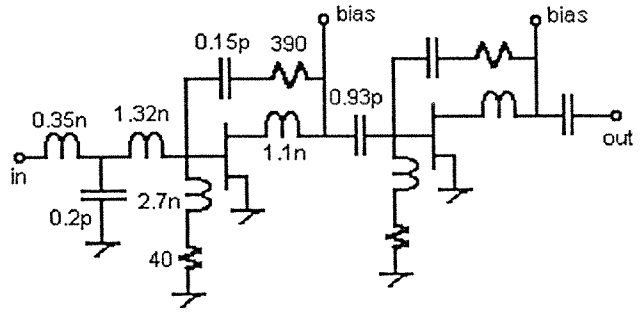
As a final conclusion it can be said that the agreement between the simulation and measurement results is good for both amplifiers. The discrepancy for return losses were attributed to the compact placements of components which might have caused coupling between the adjacent components. These coupling effects are not taken into account during simulation.

REFERENCES

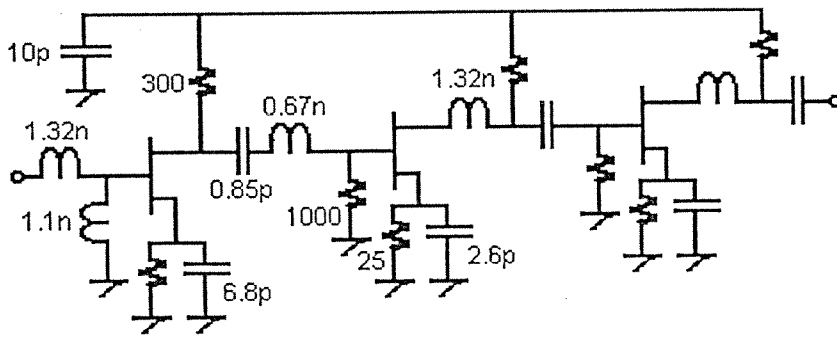
- [1] R. Soares, "GaAs MESFET Circuit Design", Artech House, Boston & London, 1988.
- [2] T.T. Ha, "Solid State Microwave Amplifier Design", Wiley & Son, New York, 1981.
- [3] GaAs IC Foundry Design Process F20/F14 GEC Marconi, 1993.
- [4] K. B. Niclas, "Multioctave Performance of Single Ended Microwave Solid State Amplifiers", IEEE Transactions on Microwave Theory and Techniques, vol. MTT-32, p. 896, 1984.



One-Stage Amplifier



Two-Stage Amplifier



Narrowband Amplifier

Figure B1.1 Circuit Diagrams of the Amplifiers and Component Values

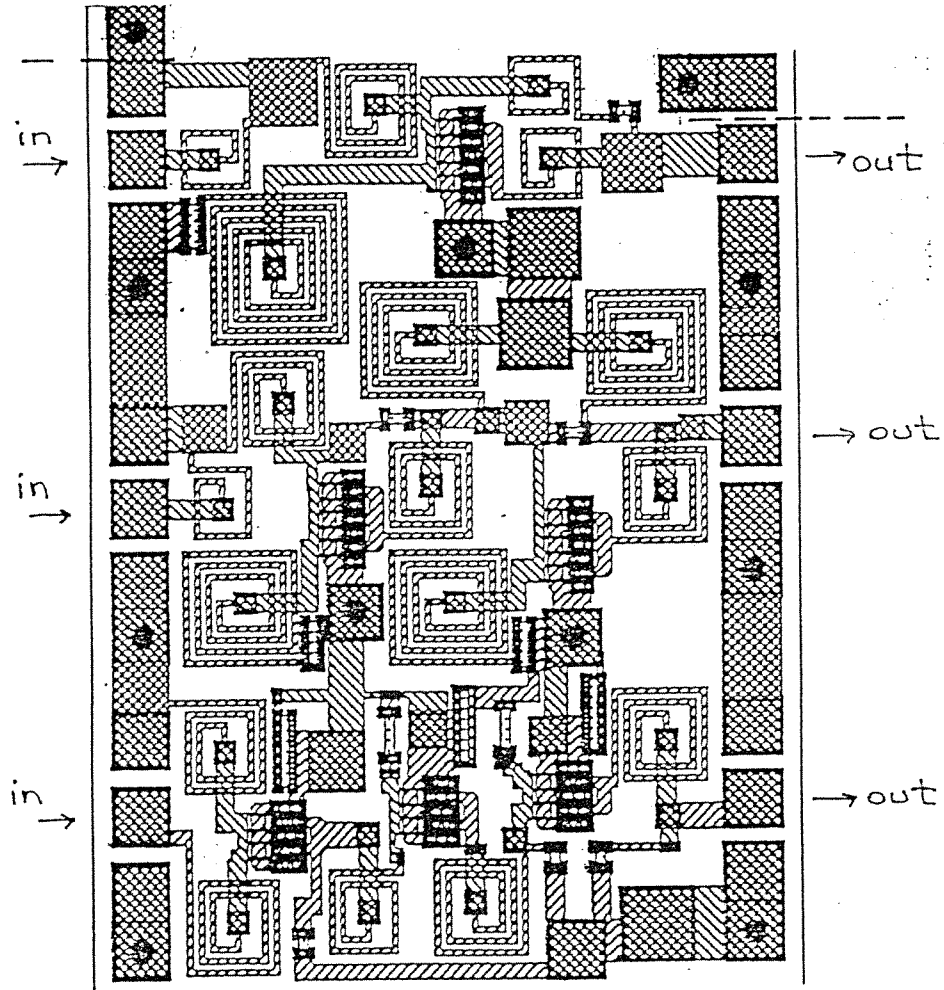


Figure B1.2 MMIC Layout of the Three Amplifiers

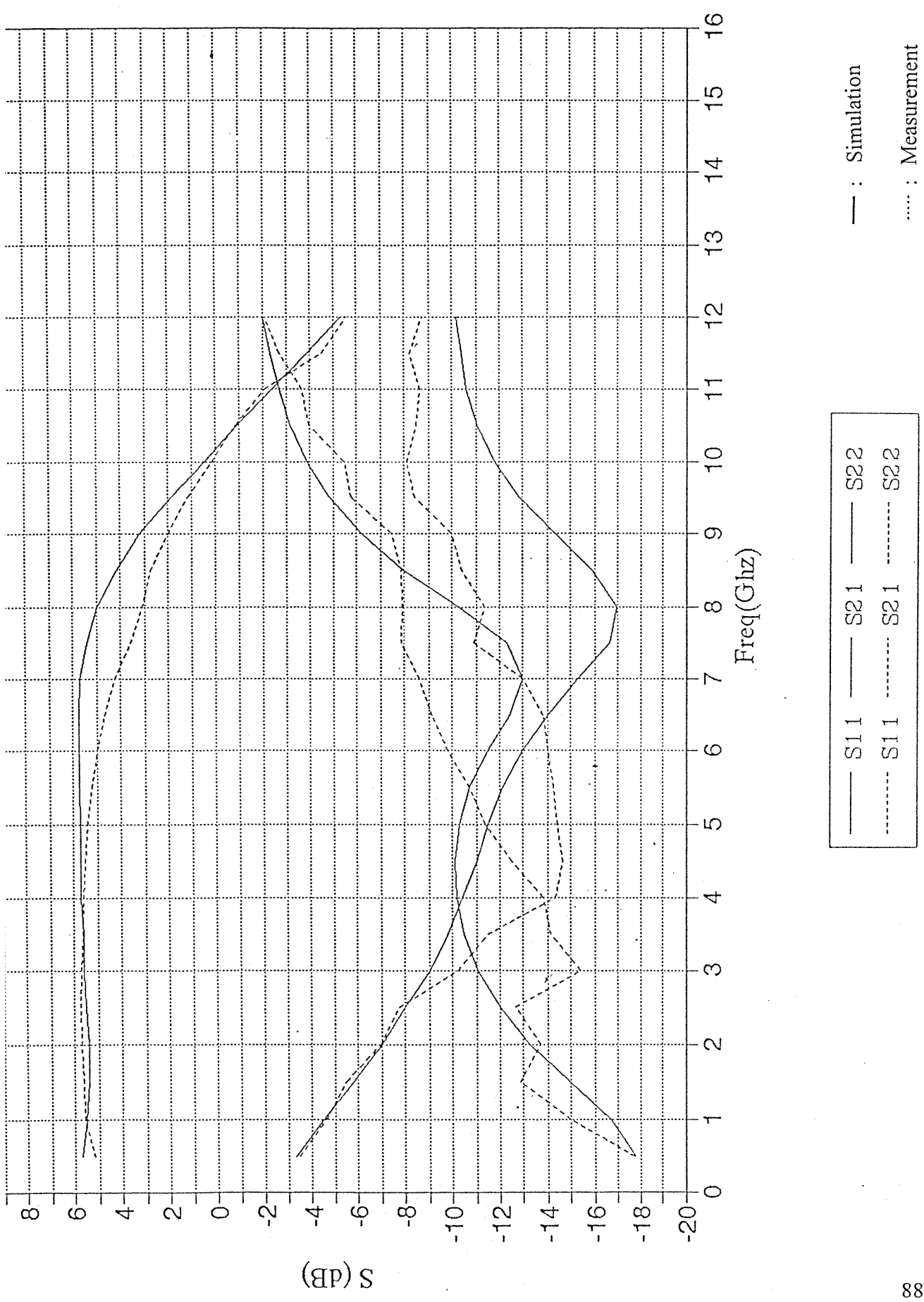


Figure B1.3 Simulation and Measurement Results of the One-Stage Amplifier

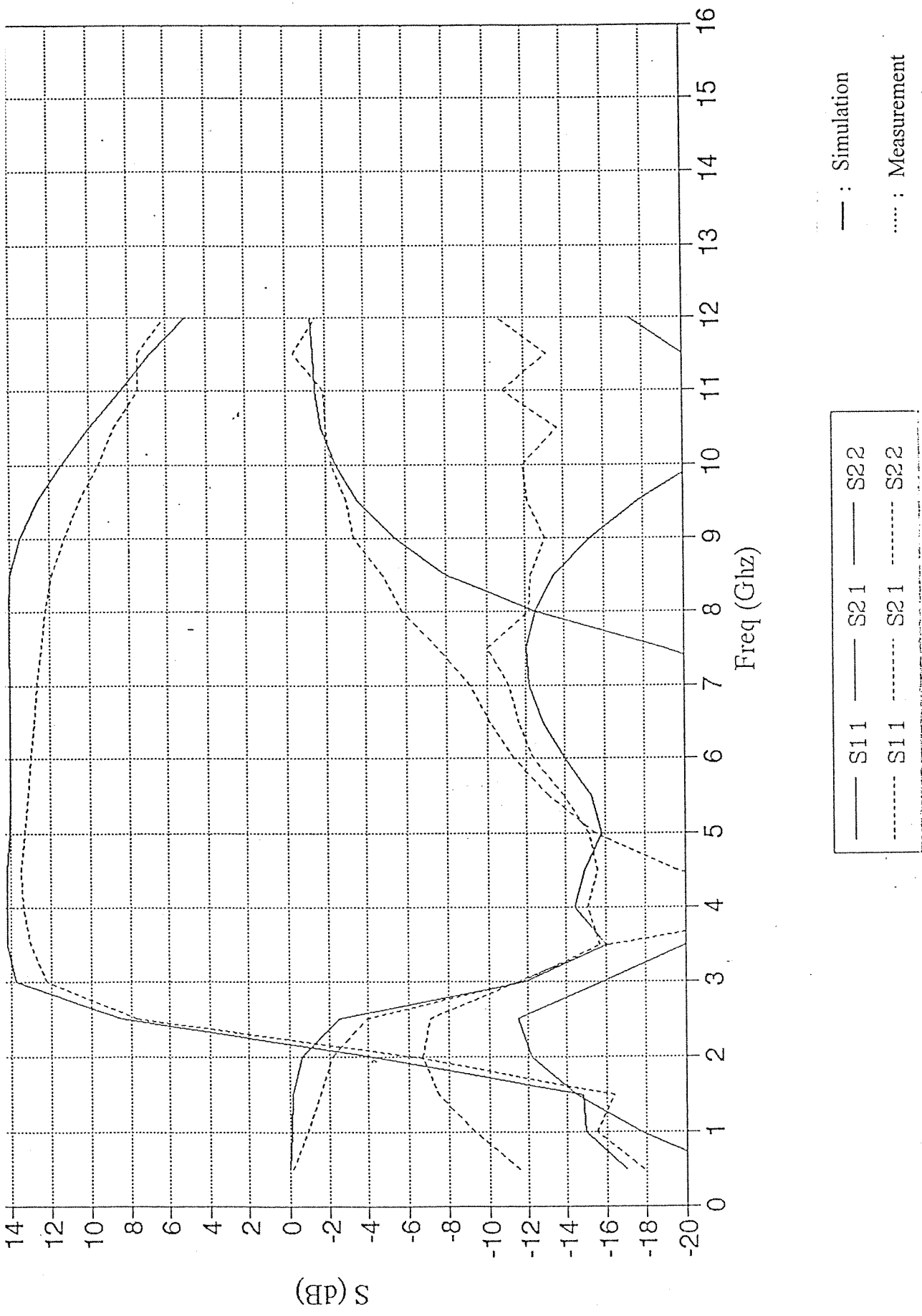


Figure B1.4 Simulation and Measurement Results of the Two-Stage Amplifier

B2. VOLTAGE CONTROLLED OSCILLATOR

A voltage controlled oscillator (VCO) is designed using negative resistance approach [1], and implemented with MMIC technology. In the design stage, the 'harmonic balance analysis' and optimization tools of LIBRA software are used. The circuit schematic and the MMIC layout of the VCO are given in Figs. B2.1 and B2.2, respectively.

In the circuit, a 4 finger MESFET of a total gate width of 300 μm (4x75) is used as the active device. The negative resistance at the gate input of the FET is obtained by means of a capacitive feedback at the source. The variable capacitance (varactor) which is necessary to change the oscillation frequency is also realized by a 4x75 MESFET, since varactor diodes are not available in the GEC Marconi process [2]. For this purpose, the drain and source of the transistor are grounded, and a bias (tuning) voltage is applied at the gate. This creates a variable gate-to-source capacitance. By connecting another capacitance in parallel with this, an equivalent voltage variable capacitor is obtained with a suitable capacitance range. This variable capacitor, together with the inductors connected next to it (see Fig B2.1), forms a resonator, and determines the oscillation frequency of the VCO.

The bias circuit is designed so that the drain current equals $I_{DSS}/2$. The capacitance in the feedback circuit is realized by two polyimide capacitors in parallel to reduce parasitic effects and to use the chip area more efficiently. A band pass filter is also included at the output to suppress the harmonics.

In evaluating the design in LIBRA, the OSCTEST [3] tool is used. This tool allows the user to inject an AC voltage, at the fundamental frequency, into the feedback loop of the oscillator, and determine the oscillation frequency and the output power. Table B2.1 gives the computer simulation results of the VCO. The tuning voltage is varied from 0.5 v down to -10 v, and the corresponding oscillation frequency (both start-up and the steady-state values) and the output power are tabulated.

Measurements are carried out on the fabricated chip, and the results given in Table B2.2 are obtained. A comparison of the two tables reveals that there are some discrepancies between the estimated and measured circuit characteristics:

i) According to the computer simulations, the circuit was expected to oscillate in the frequency range 8.79 to 10.15 Ghz as the tuning voltage is varied from 0.5 to -10 volts. The actual oscillation range turned out to be 9.29 to 11.03 Ghz for tuning voltages between 1 and -8 volts. So there is an upward shift in the oscillation band. The estimated bandwidth was around 14%, whereas the measured bandwidth is 17%.

ii) The output power level was expected to take values between 12.7 and 11 dBm, but the measured power is less (between 8 and 5 dBm for frequencies 9.29 upto 11.01 Ghz,

and even less in the rest of the band). Around 1 dB of this difference is due to the cable losses in the measurement system.

Above discrepancies are thought to be mainly due to the insufficient accuracy of the circuit model which is used for the characterization of the large signal behaviour of the MESFETs.

Figures B2.3 and B2.4 show the variation of the oscillation frequency and the output power, respectively, versus the tuning voltage. Finally, in Fig. B2.5 the spectrum analyzer output at the Hold Maximum Mode is given. In obtaining this characteristic, the tuning voltage is swept from 1v to -10 v in 0.25 v steps.

As a conclusion, it can be said that although there are some differences between the estimated and measured performance, the VCO circuit has satisfactory operation.

REFERENCES

- [1] K. Kurokawa, "Some Basic Characteristics of Broadband Negative Resistance Oscillator Circuits", The Bell System Technical Journal, p.1937, July-August 1969.
- [2] GaAs IC Foundry Design Guide- Process F20/F14, GEC Marconi, 1993.
- [3] EESOF Element Catalog, Version 3.5, November 1982.

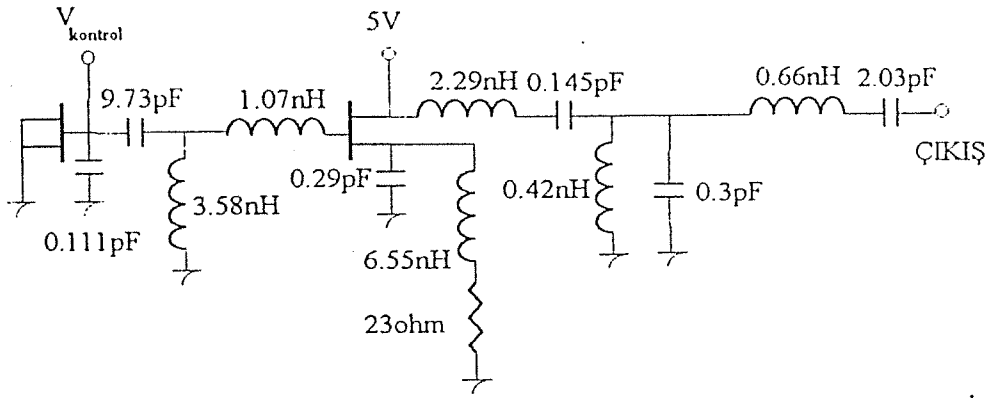


Figure B2.1 Circuit Diagram of the VCO

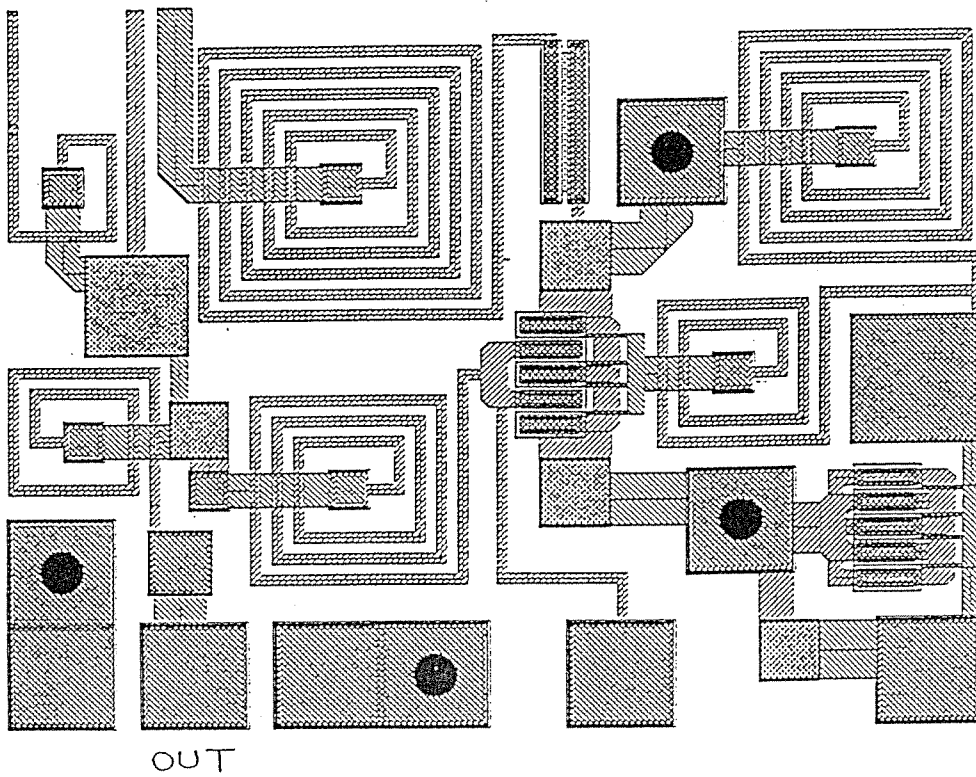


Figure B2.2 MMIC Layout of the VCO

Table B2.1 Simulation Results for the VCO

V_{tune}	$f_{\text{start-up}}$ (GHz)	$f_{\text{oscillation}}$ (GHz)	Output Power (dBm)
0.5	9.46	8.79	12.54
0	9.62	9.27	13.14
-0.5	9.72	9.60	12.70
-1	9.80	9.71	12.45
-1.5	9.83	9.82	12.18
-2	9.88	9.88	12.06
-2.5	9.90	9.92	11.90
-10	10.15	10.15	10.95

Table B2.2 Measurement Results for the VCO

V_{tune} (v)	f_{osc} (GHz)	P_{out} (dBm)	I_{bias} (mA)
1.0	9.295	6.33	32.7
0.5	9.592	7.67	31.3
0.0	10.040	7.67	29.3
-0.5	10.311	8.00	27.7
-1.0	10.488	8.00	26.6
-1.5	10.674	7.50	25.9
-2.0	10.928	5.50	25.9
-3.0	11.010	5.17	25.9
-4.0	11.016	4.83	25.9
-5.0	11.019	4.50	25.9
-6.0	11.022	4.33	25.85
-8.0	11.028	3.67	25.8

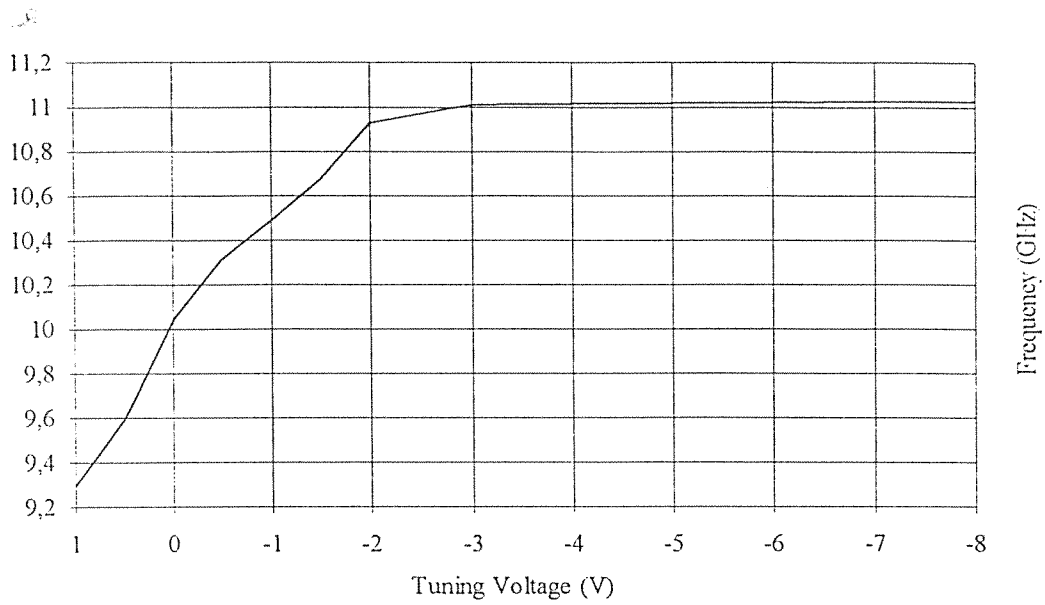


Figure B2.3 Oscillation Frequency versus Tuning Voltage (Measurement)

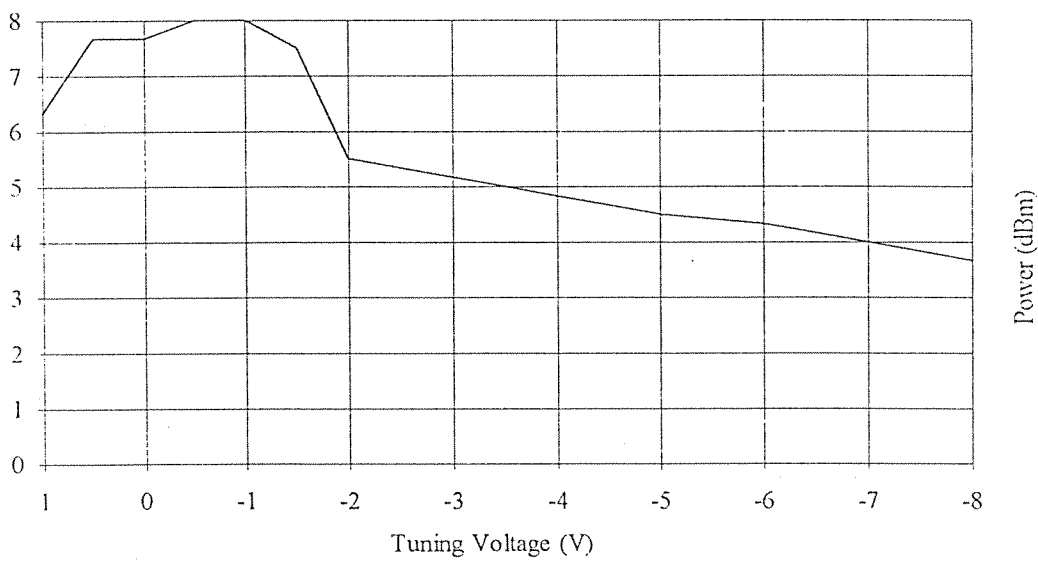


Figure B2.4 Output Power versus Tuning Voltage (Measurement)

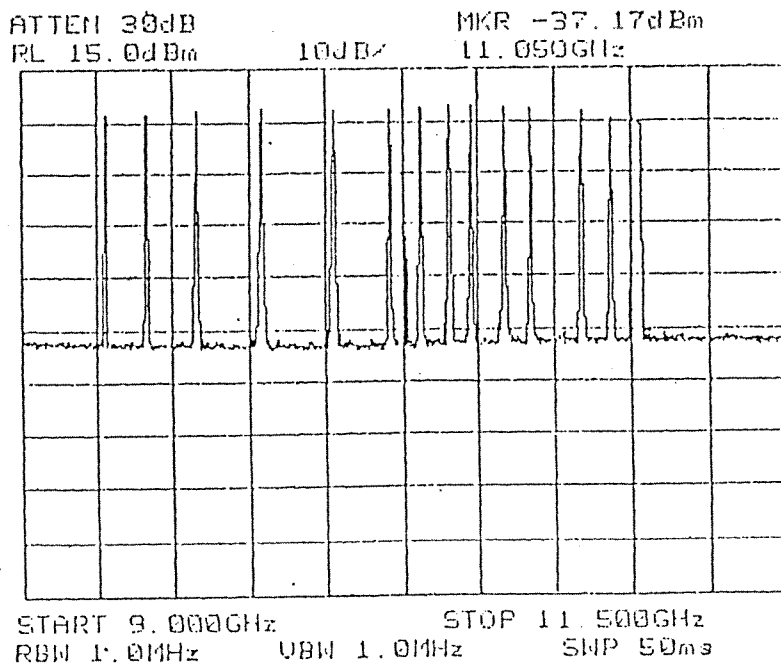


Figure B2.5 Spectrum Analyzer Output at the 'Hold Maximum' Mode

B3. MIXER

Various mixer designs and their simulations are carried out in this project. The nonlinear elements employed are either planar Schottky diodes or FET's. Balance mixer configurations are selected because of their inherent properties of rejection of spurious responses and intermodulation products and good isolation without the need for filters over a broad bandwidth. There are some disadvantages, as well, such as high LO (Local Oscillator) power requirements, higher conversion loss and noise figure. With double balanced mixers it is a common practice to use balun circuits including hybrids, phase shifters and power dividers. However, it is difficult to realize a conventional balun design in monolithic form. The balun and hybrid circuits used in discrete mixers are generally not compatible with MMIC technology. Some passive balun designs are impractical since they occupy large chip area. Therefore, the use of active baluns employing transistors are favored. Most of the MMIC mixers use FET's as nonlinear elements, instead of diodes, because of their high conversion gain, low noise and good intermodulation performance.

The simulation results of various MMIC mixers designed that employ baluns, power dividers and phase shifters will not be given here but can be found in [1]. These designs were not sent for implementation because of their large chip areas, hence, for financial reasons. A simple two-transistor mixer circuit that employs neither baluns, power dividers nor phase shifters, was designed and sent for realization.

The schematic of the designed mixer is shown in Fig. B3.1. Two single gate MESFET's are connected in cascode configuration to simulate a dual-gate FET. From one of the FET gates LO signal and from the other FET gate RF signal are applied. The signal excitations from different gates provide good isolation property especially from LO to RF port as in a mixer using dual-gate FET's. The given LO signal changes the transconductance of the lower FET and achieves the mixing phenomena. LO and RF matching circuits are LC networks between FET gates and LO and RF input ports. At the IF port there is no matching circuit nor an IF amplifier. To suppress LO frequency at the output and improve the LO to IF isolation, a shunt capacitor of value 5 pF is used. Lower FET is biased to operate in its linear region and the upper one works in its saturation mode. A self-biasing scheme is used by incorporating an active load. By connecting gate and source of the FET together, DC wise, creates an active load. From the drain of the upper FET, a DC voltage of 3.5V is applied. With this bias scheme, drain current becomes 21 mA.

Curtice and Ettenberg nonlinear GaAs FET model with cubic dependency is used for the $4 \times 75 \mu\text{m}$ MESFET's in GEC-Marconi F20 process. For the nonlinear simulation of the mixer, Harmonic Balance method in Libra software is used. All the simulations were made at an LO power of 8 dBm. The mixer has an RF bandwidth between 10-11 GHz. At these frequencies RF signal from the RF input port is down converted into the

intermediate frequency signal at 70 MHz. At IF frequency, conversion loss performance is given in Fig. B3.2. Conversion loss has maximum value of 5.95 dB and minimum value of 3.29 dB in the RF band. LO to RF isolation and RF to LO isolations are shown in Fig. B3.3. LO to IF isolation is found to be better than 15 dB over the band. These isolation properties should be evaluated bearing the fact in mind that this is not a balanced mixer. 1 dB compression point is found at -5 dBm RF power. The layout of the final circuit is shown in Fig. B3.4. The total chip area is $1.2 \times 0.8 \text{ mm}^2$.

Measurements were carried out on the two fabricated chips in Hittite Electronics Inc., USA. This was necessary since three-probe probe-station was not available, then, anywhere in Turkey. Due to the non-availability of required instruments, the measurements were carried out at an IF frequency of 10 MHz, instead of the design frequency of 70 MHz. Although the simulations were made for a LO power of 8 dBm, two different LO power levels namely 10 dBm and 15 dBm were used at two bias voltages 3.5 V and 5 V. Fig. B3.5 shows the measured conversion loss characteristics. The legend items for this figure are as follows: CL 1(103.5V) means "conversion loss for chip number 1, at LO power of 10 dBm and bias voltage of 3.5 V". Similarly CL 2(155V) means "conversion loss for chip number 2, at LOA power of 15 db and bias voltage of 5 V". The others follow in this logical sequence. Fig. B3.6 shows LOA to FR isolation. The legend follows the same pattern as to the previous figure except L-R, this time, means isolation from LO to RF. Fig. B3.7 shows isolation LO to IF.

From the measurements of conversion loss characteristics, the RF band seems to be shifted to about 11.5-12 GHz. The discrepancies between the simulated and measured results can be explained as follows: The use of 10 MHz as IF frequency instead of 70 MHz brings the RF and LO frequencies very near to each other. This, in turns, affects the isolation levels. The use of 10 or 15 dBm LO power levels instead of 8 dBm also changes the conversion characteristics. Another factor which is not taken into account during simulations is the effect of bias tee that is used during measurements. Its characteristics is altogether unknown. If one accept the shift in frequency band due to the above reasons, the simulation and measurement results can be considered to be in agreement.

REFERENCES

- [1] S. Baskan, "Design of Microwave Mixers Using MAC Technology", MS Thesis, Department of Electrical and Electronic Engineering, MEET, 1994.
- [2] Y. Imai, M. Tokumitsu and A. Minakawa, "Design and Performance of Low Current GaAs MMIC's for L-Band Front-End Applications", IEEE Trans. on MTT, Vol. 39, Feb. 1991, p.209.
- [3] T. Sugiura, K. Honjo and T. Tsuji, "12 GHz-Band GaAs Dual Gate MESFET Monolithic Mixers", IEEE Trans. on MTT, Vol. 33, Feb. 1985, p. 105.

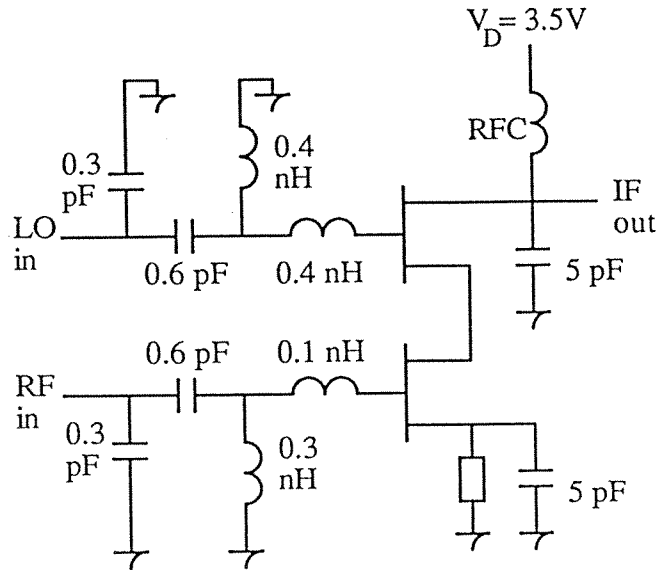


Figure B3.1 Circuit Diagram of the Mixer

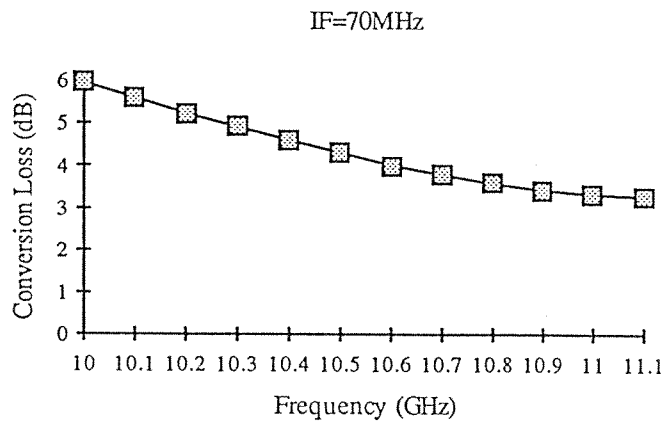


Figure B3.2 Conversion Loss Characteristics

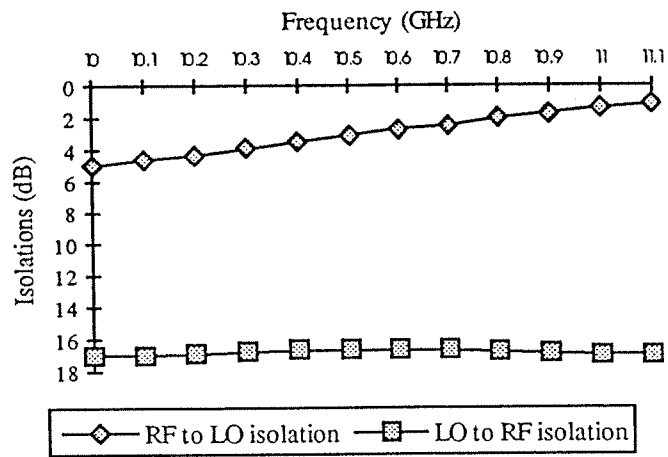


Figure B3.3 Isolation Properties

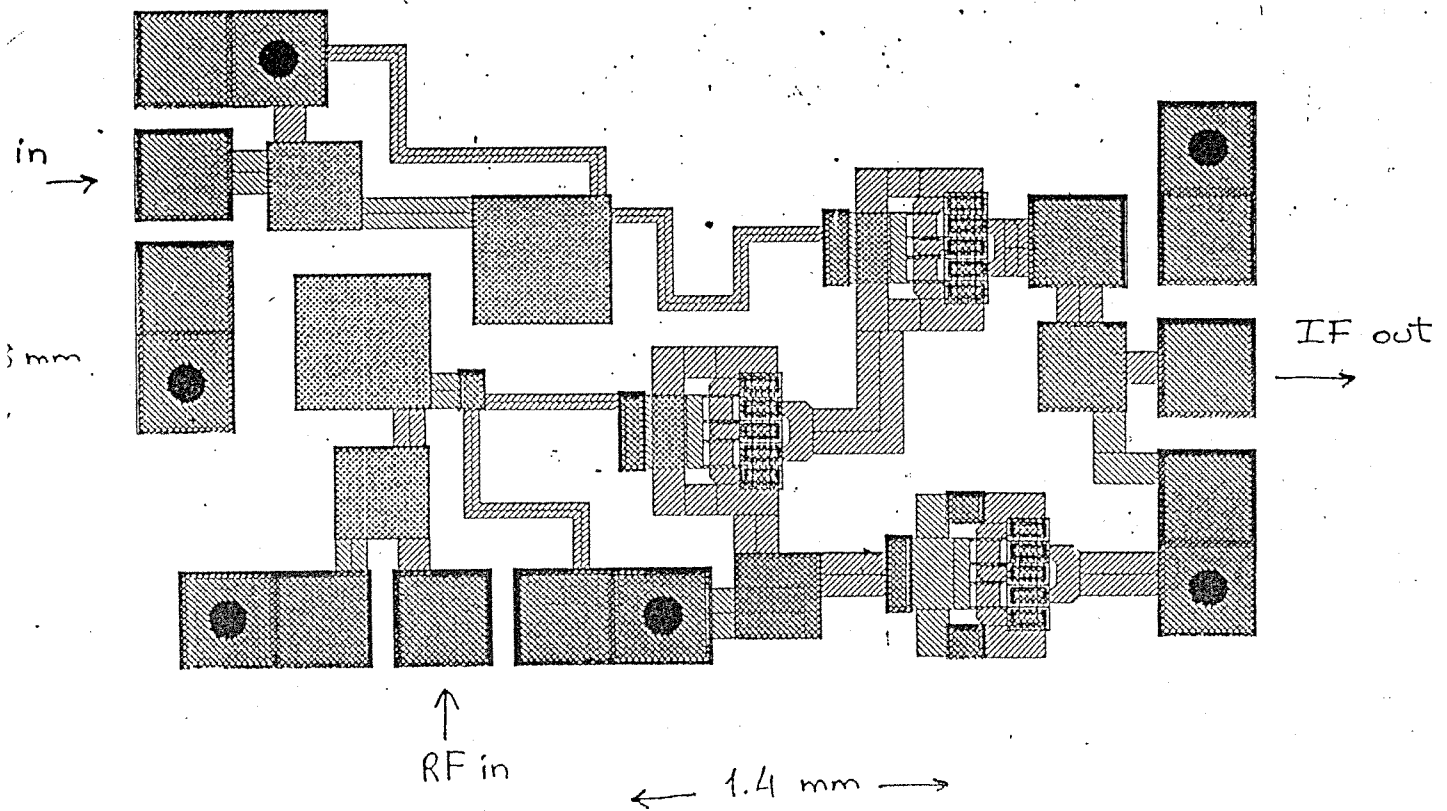


Figure B3.4 Mixer Layout

Conversion Loss (IF=10MHz)

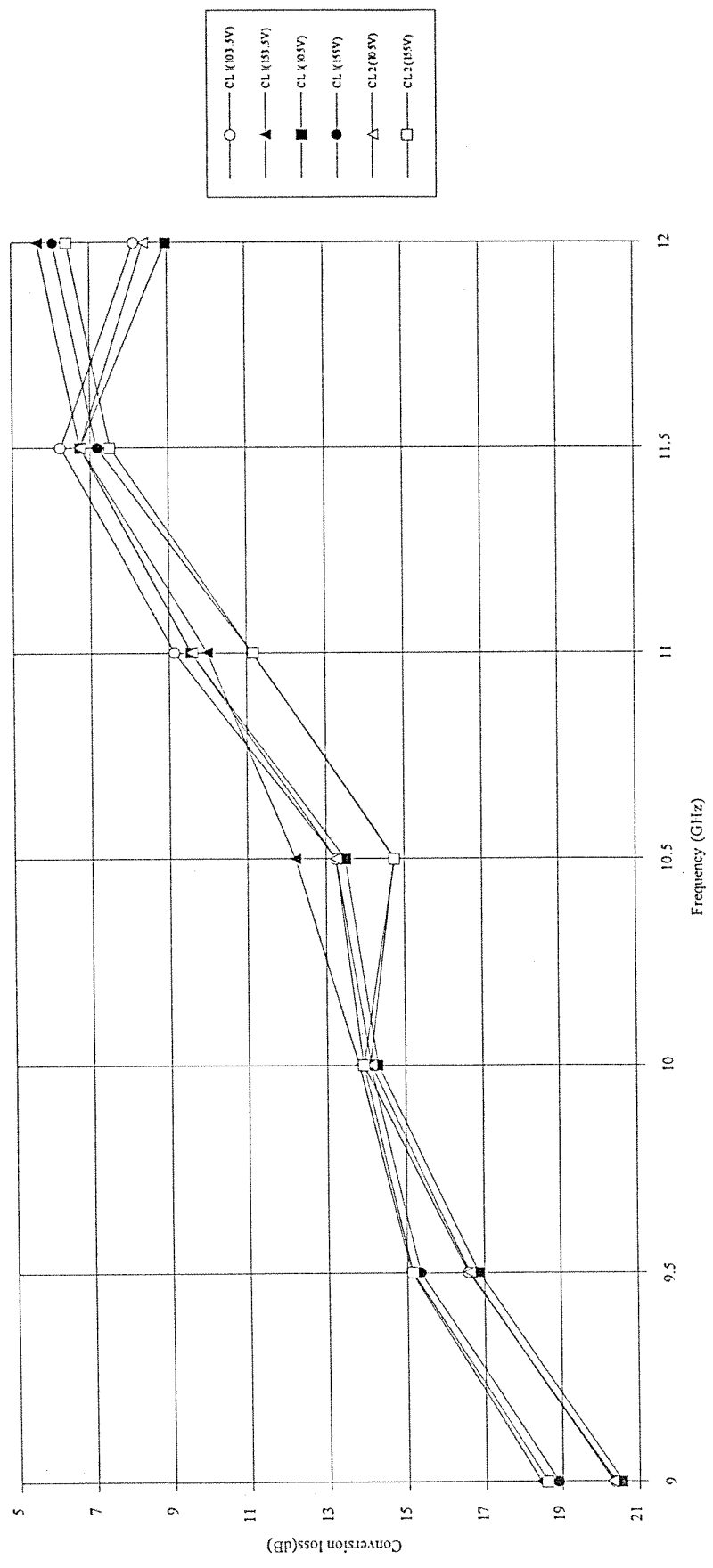


Figure B3.5 Measured Conversion Loss

LO to RF Isolation (IF=10MHz)

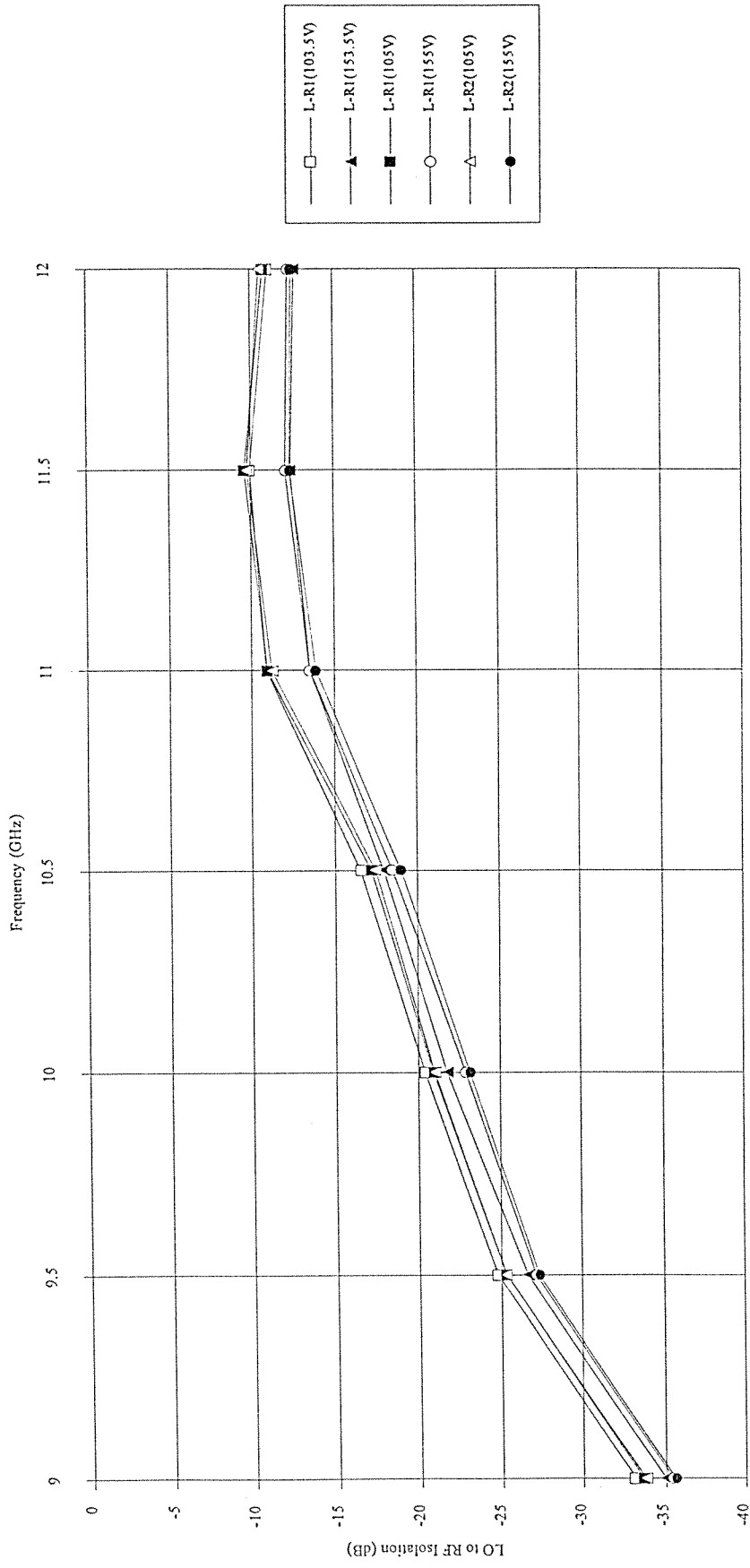


Figure B3.6 Measured LO to RF Isolation

LO to IF Isolation (IF=10MHz)

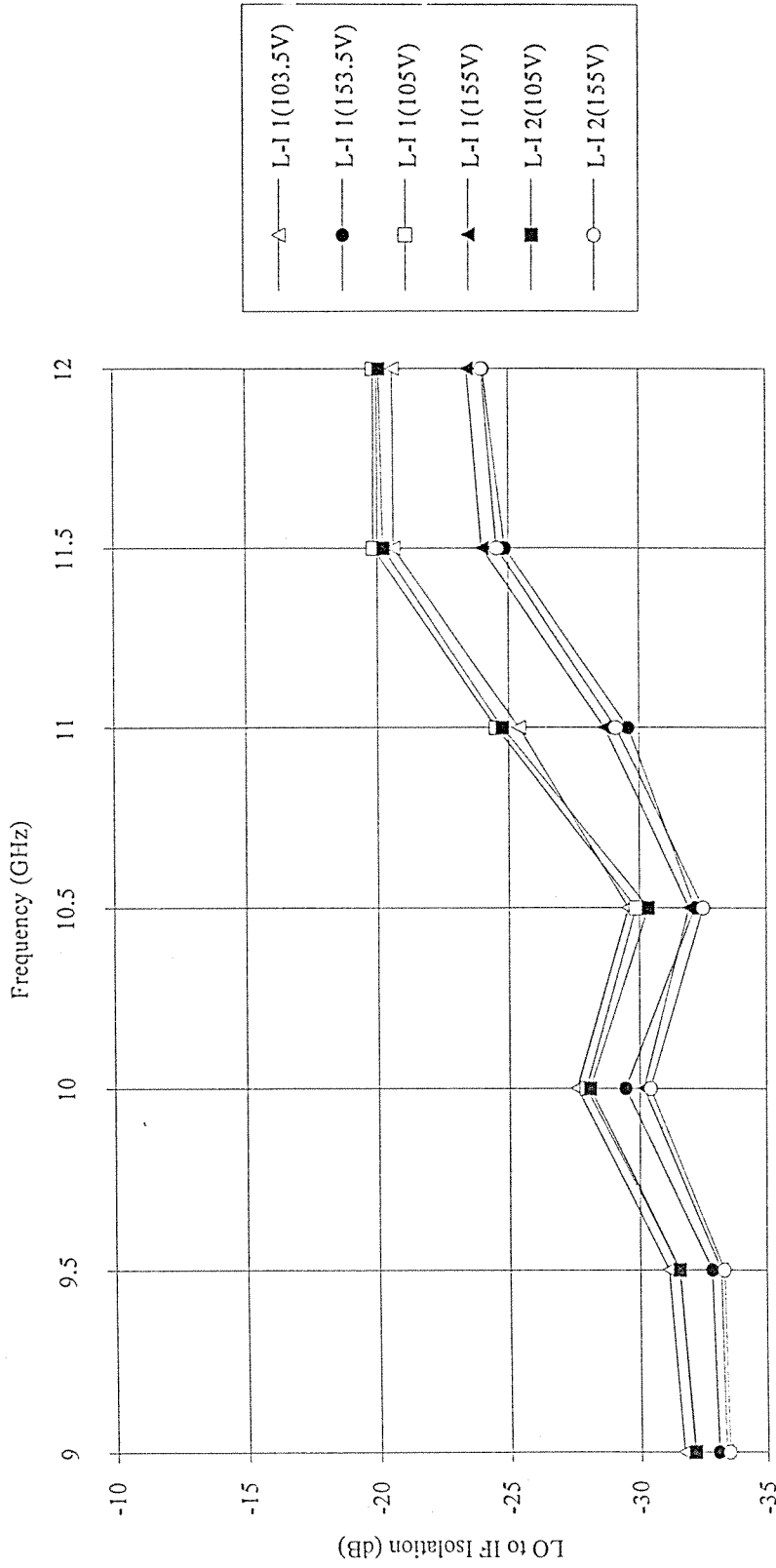


Figure B3.7 Measured LO to IF Isolation

B4. LOW NOISE AMPLIFIER

The MMIC technology is originally addressed for the implementation of microwave circuits around X-band and at higher frequencies by exploiting the excellent high frequency properties of the GaAs material. However, in recent years, there is a tremendous demand on monolithic RF products in the newly emerging wireless communication market. Although these new wireless communication systems use the lower part of the microwave frequencies, the MMIC technology provides efficient, low cost and monolithic solutions. By the motivation of this fact, an LNA is designed in MMIC form according to the specifications of the DECT wireless communication system operating at 1.9 Ghz. Since the cost of a MMIC circuit is inversely proportional with its active chip area, the key objective in this design was to minimize the chip area while achieving satisfactory electrical performance. The design and the optimization of the circuit are achieved using CAD tools LIBRA and ACADEMY.

The design goals were put as follows: An active chip area not exceeding 1 mm², a gain around 13 dB, and a noise figure less than 3 dB while keeping the return losses at the input and the output better than 14 dB. Although the amplifier is designed for a narrowband system, it is desired to have a 400 Mhz bandwidth around 1.9 Ghz (or a 20% bandwidth) with a 1 dB gain margin to compensate for any possible shift in the peak of the gain. Finally, the amplifier should be unconditionally stable at all frequencies.

The amplifier designed (see Fig. B4.1) consists of two stages: The first stage is a common-gate stage used to match the input of the next stage. This active matching technique exploits the low input reflection coefficient property exhibited by the common-gate configuration of the FET. (While the GaAs MESFET shows high gain and low noise in the common-source configuration, it has good input match property in the common-gate configuration. This property is used to achieve high return losses at the input of the amplifiers [1])

The next stage is the main amplifying stage of the LNA, and consists of a common-source FET. Since the second stage also affects the noise (due to the low gain of the first stage) some precautions are taken. In order to bring the optimum noise match impedance to the conjugate input match impedance, a series inductive feedback is used at the source of the FET [2,3]. In order to stabilize the common-source stage, a shunt resistive feedback is also applied. The common-gate FET is stabilized with a resistor connected to its drain. The common-gate simultaneous match output impedance is brought to the conjugate of the simultaneous input impedance of the common-source stage through the use of an inductor. (A piece of a transmission line could also be used here if its length is sufficiently small). The output of the common-source stage is matched through the use of conventional narrowband matching techniques by an L-type high pass section. The introduction of real MMIC elements is then made. The matching inductors are chosen to be of the stacked spiral type. These inductors have the advantage that they offer high

inductance per unit area as compared to the standard spiral inductors, though they are lossy [4]. By this choice a large chip area is saved at the expense of a few dB gain loss.

The MMIC layout of the LNA is shown in Fig.B4.2. The gate of the common-gate is tried to be perfectly grounded to avoid any inductance path which can cause instability problems at higher frequencies. The input and output RF ports are located at the opposite sides of the chip to avoid any positive feedback. Since the operation frequency is low, the packaging density of the elements is kept high. The active chip area of the circuit is about 0.9 mm² (1.18x 0.74 mm). The FETs are biased by using a self bias scheme at 20% I_{dss} , where the FETs have their optimum noise figures. The choke inductors and a bias resistor are connected off chip. The amplifier can be operated from a 6 VDC drawing 36 mA current.

According to the computer simulations, the bandwidth of the LNA is about 600 Mhz with a +/-0.5 dB gain flatness. The expected gain is 14 dB at the middle of the band, and the return losses are better than 14 dB. The noise figure is better than 3 dB with a value of 2.7 dB at the middle of the band. The stability analysis of the overall amplifier reveals that the circuit is stable for all frequencies upto 20 Ghz to which the FETs are defined. Fig.B4.3 shows the simulation results and the measurement results together.

The circuit responses are measured at the Bilkent University by an HP8510C network analyzer. Measurements are done on three LNA chips fabricated on the same wafer, and almost identical responses are obtained. The gain is around 12.5 dB in a frequency band of 1.5 Ghz width about the design frequency. Considering the probe losses, this corresponds to a value which is only 0.5 dB below the expected gain. However, the bandwidth turned out to be greater than the estimated one which was 600 Mhz. The input return loss, S_{11} , follows the simulation results quite closely, and it is in fact better than the expectations. Similar arguments hold for S_{22} as well. S_{12} , which is an indication of the circuit isolation, is measured to be better than 30 dB.

REFERENCES

- [1] Niclas, "Active Matching with Common-Gate MESFETs", IEEE MTT-33, No.6, June 1985, pp. 492-499.
- [2] Engberg, "Simultaneous Input Power Match and Noise Optimization Using Feedback", IV. European Microwave Conf., 1974, pp. 385-389.
- [3] Besser, "Stability Considerations of Low Noise Transistor Amplifiers with Simultaneous Noise and Power Match", IEEE Microwave Symp., 1975, pp. 327-329.
- [4] GEC-Marconi F20 Process Foundry Design Rule Guide, 1991.

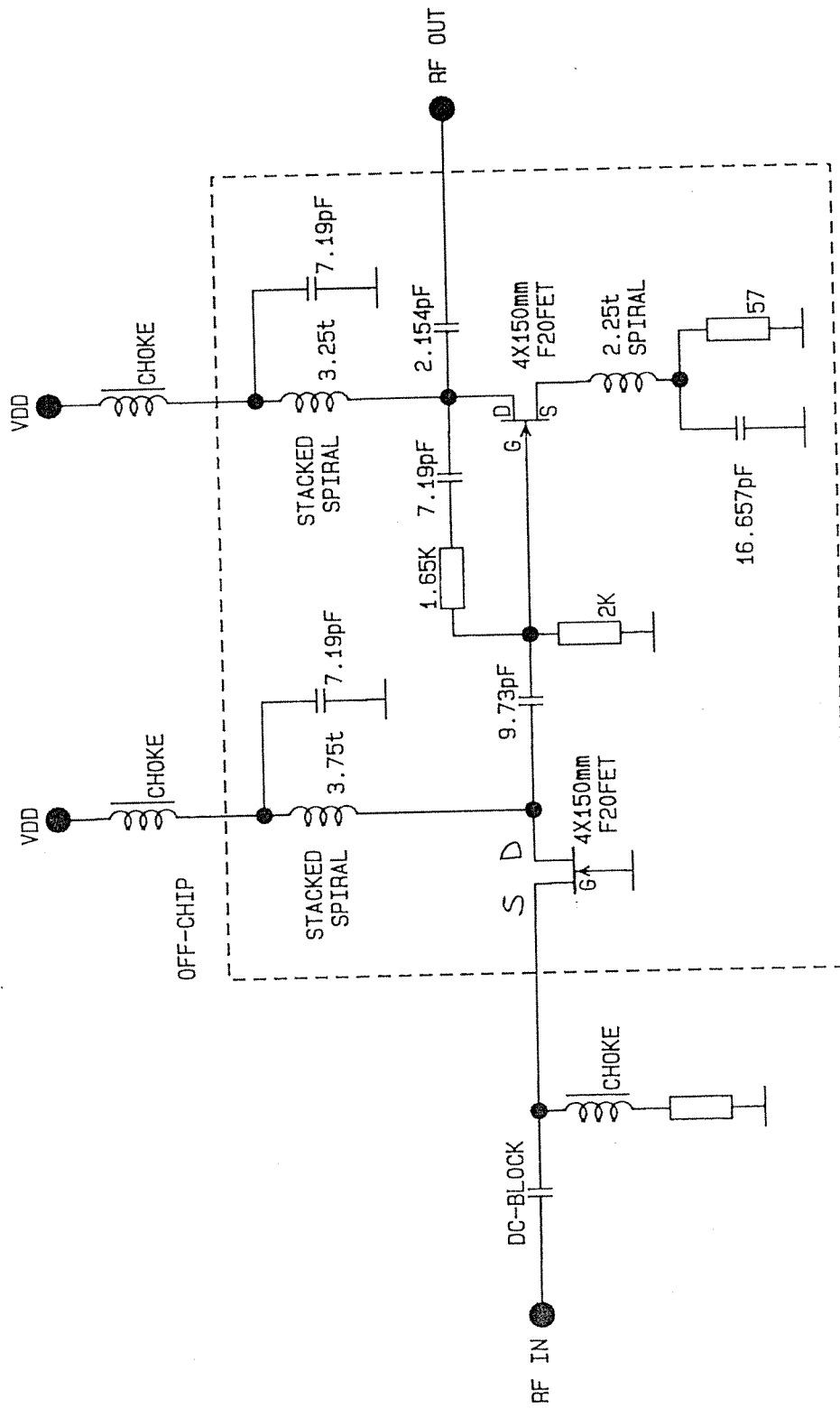


Figure B4.1 Circuit Diagram of the LNA

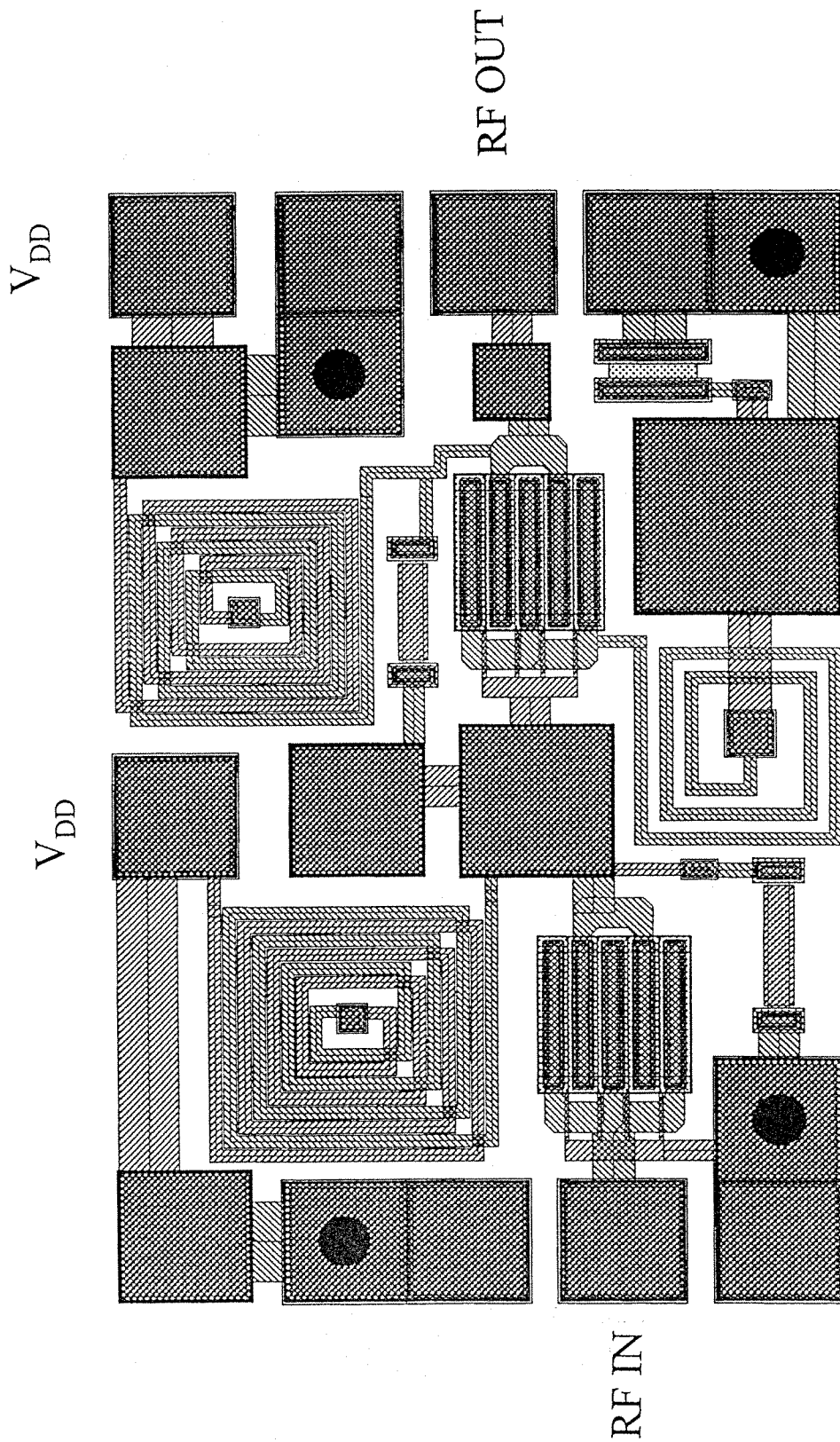
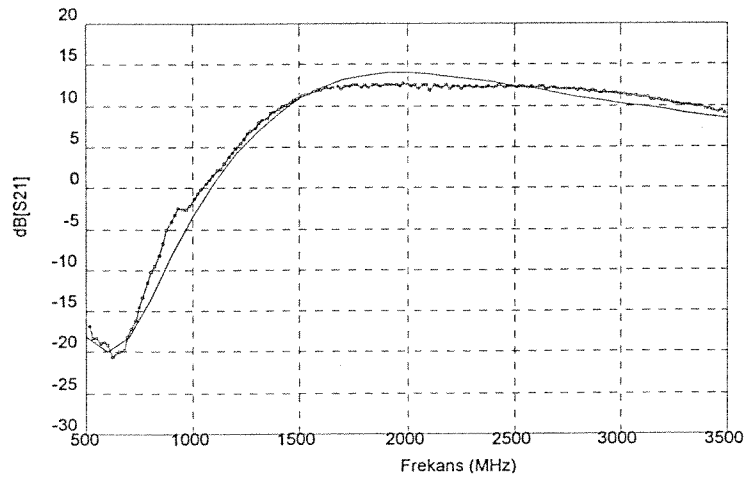
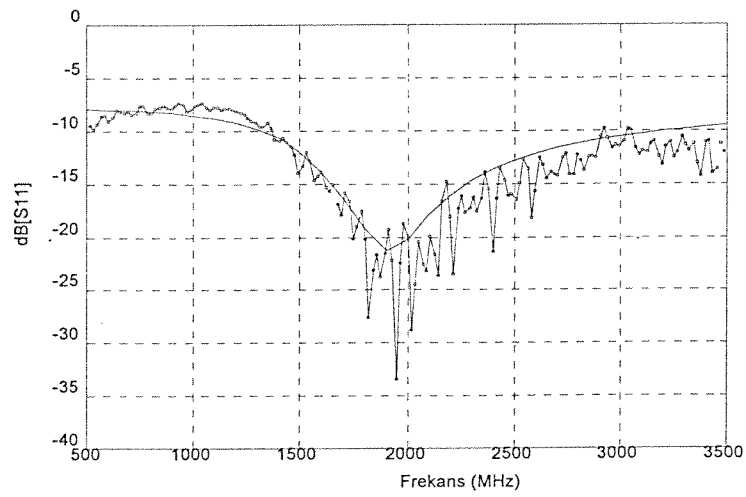


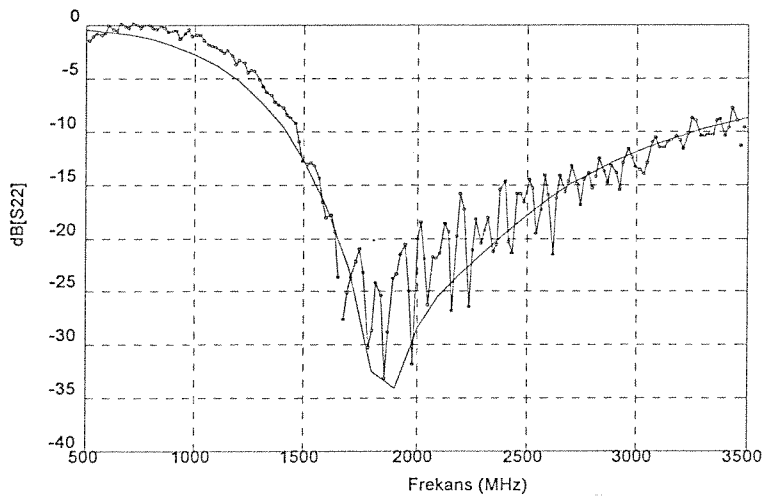
Figure B4.2 MMIC Layout of the LNA



(a)



(b)



(c)

Figure B4.3 Simulation (----) and Measurement (--o--) Results
 (a) Gain (S_{12}) (b) Input Return Loss (S_{11})
 (c) Output Return Loss (S_{22})

B5. TRANSMIT / RECEIVE SWITCH

An asymmetric Transmit / Receive (T/R) switch is designed and implemented in MMIC form for the RF section of a 1.9 Ghz wireless communication system. The key objective in this design was to minimize the chip area while achieving satisfactory electrical performance. The design goals for the switch were put as follows: An insertion loss in the TX-ANT (transmitter-antenna) path less than 0.3 dB, an insertion loss in the ANT-RX (antenna-receiver) path less than 1 dB, a TR-RX isolation better than 20 dB. The switch should handle a power of 400 mW.

In conventional T/R switches for radio applications, discrete solutions using PIN diodes have been popular until recently. However, in monolithic form, the FET as a switch element offers more cost effective solutions. A T/R switch is actually a single pole double throw (SPDT) switch. The SPDT switches, and in general all RF switches made up of FETs, have standard topologies using series and shunt connected FETs like the one shown in Fig. B5.1a. In this symmetric structure, the series FETs are used to effectively break the RF path between the RF common port and the other RF ports. On the other hand, the shunt FETs provide the required isolation between the isolated ports. In radio applications it is desirable to have lower insertion loss in the TX-ANT path than that in the ANT-RX path while preserving the required isolation between the TX and RX in the TX-ANT "ON" mode. For this purpose, the shunt FET in the TX-ANT path can be removed. In this way, the extra insertion loss which would be introduced by the shunt FET is avoided and the chip area is reduced. Another advantage of this structure is that the power handling capacity of the TX-ANT path is no longer limited by the breakdown of the shunt FET. The only disadvantage brought by the removal of the shunt FET is a decrease in the isolation, but this can be tolerable in our case. Fig.B5.1b shows the circuit schematic of the asymmetric T/R switch.

The next stage of the design is to obtain the conducting and non-conducting state equivalent circuits of the FET as a switch element. The equivalent circuits of the switch FET are well established by several workers [1], [2]. In this work we adopt the models proposed by Ayasli. The conducting state model of the FET consists of a simple resistor R_{ON} whose value can be determined from the FET DC I_{ds} - V_{ds} characteristics. The slope of the curve at the ohmic region gives this resistance value. To obtain the non-conducting model elements is more difficult, because some of them are directly related with the physical parameters of the FET such as the doping level, channel thickness etc. which are not always available to circuit designers. However, in the non-conducting model, there is an element which is dominant to the electrical performance, and its value can be accurately predicted using the geometrical information of the FET such as the gate length, drain-source width, etc. This element is the drain to source capacitance, C_{ds} , which describes physically the electrostatic capacitance between the drain and source both via the GaAs substrate and the air. The other elements which have considerable effect on the electrical performance are the gate to source and gate to drain capacitances whose values

are predicted using the standard formulas for FETs [3]. The gate resistances are taken one half of the conducting state resistance as suggested in [1].

Then the gate widths of the three FETs are optimized according to the predetermined design goals, and the MMIC layout is prepared as shown in Fig.B5.2. The active chip area is around 0.5 mm^2 (0.86x0.59 mm).

The designed T/R switch has been fabricated in the GEC Marconi MMIC foundry in England, where they have also carried out several measurements on five chips fabricated on the same wafer. The five switches tested show almost identical responses indicating that the yield would be high on a mass production. The results of these measurements are given in Fig.B5.3 together with the computer simulation results. As can be seen, there is a good agreement between the simulation and measurement results. At 1.9 Ghz, the ANT-RX insertion loss is around 0.6 dB, whereas the TX-ANT insertion loss is around 0.3 dB. The isolation is measured to be 30 dB. Although the switch will be used at 1.9 Ghz, the FET switches can be operated down to DC as the results also indicate.

REFERENCES

- [1] Ayasli, "Microwave Switching with GaAs FETs", Microwave Journal, Vol.25, No.11, 1982, pp.61-74.
- [2] Jain and Gutman, "Modeling and Design of GaAs MESFET Control Devices for Broadband Applications", IEEE MTT-38, No.2, 1990, pp.109-117.
- [3] GEC-Marconi F20 Process Foundry Design Rule Guide F14/F20, 1991.

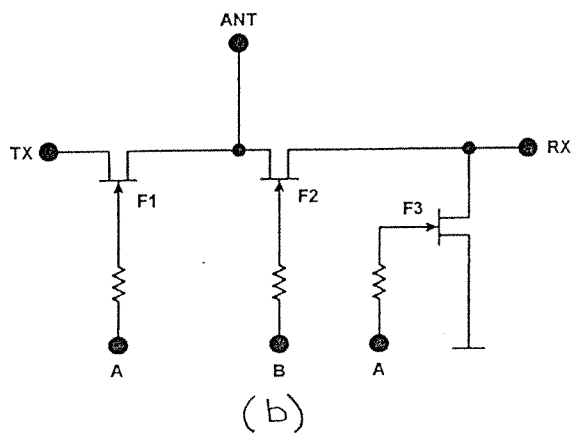
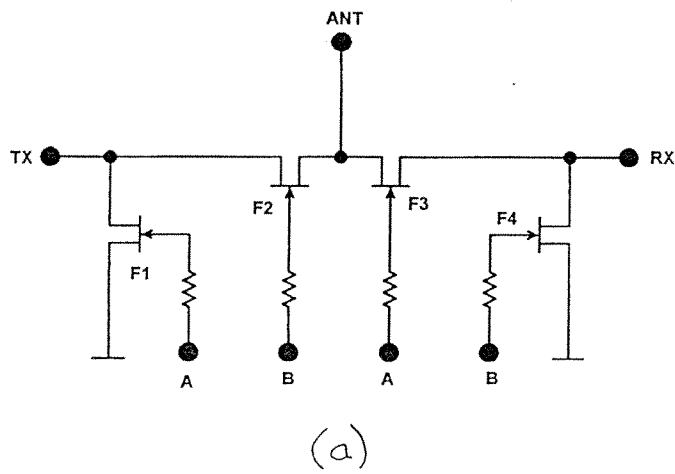


Figure B5.1 a) Circuit Topology of a General Purpose SPDT RF Switch.
 b) Circuit Topology of the Proposed Asymmetric T/R Switch.

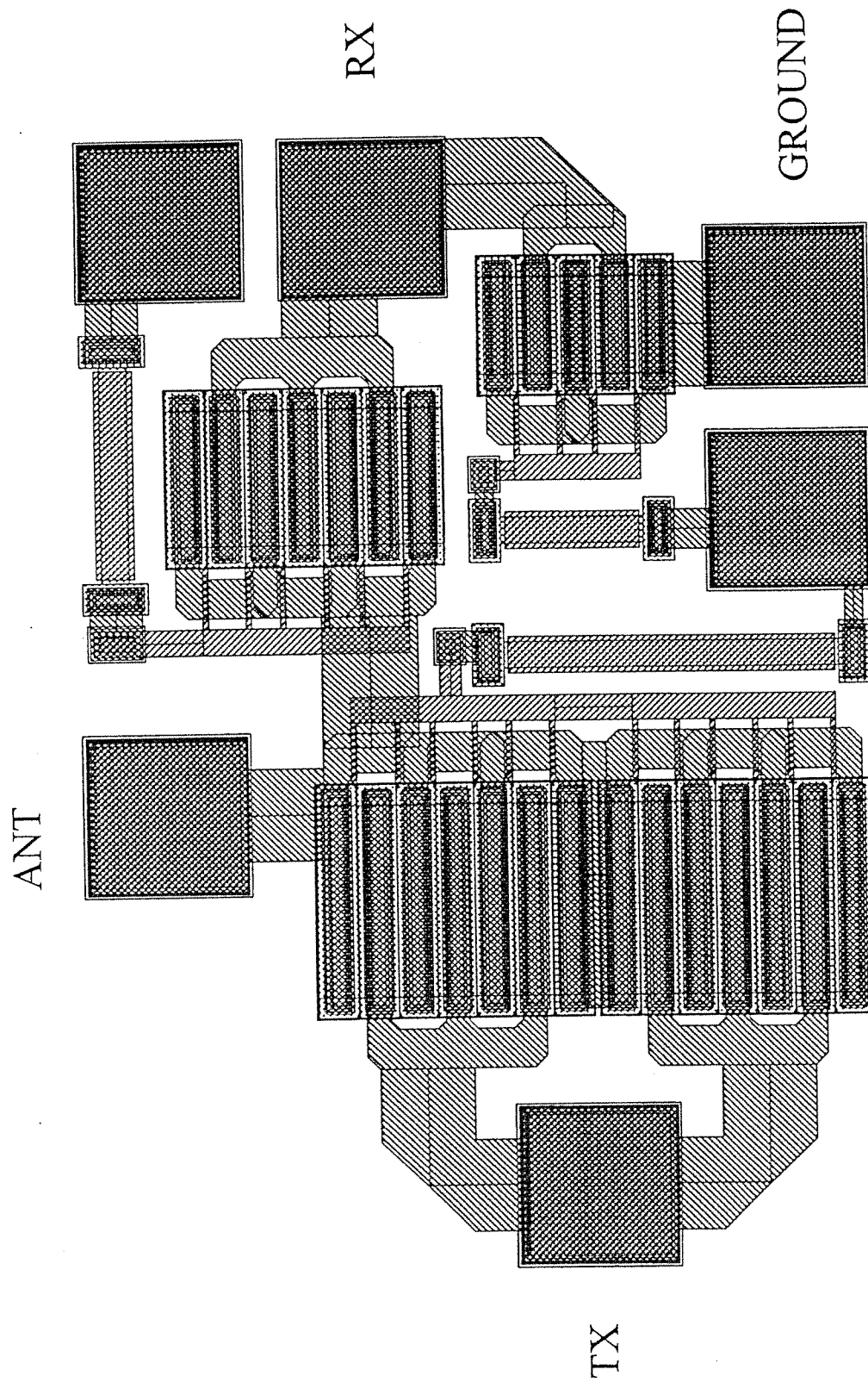


Figure B5.2 MMIC Layout of the T/R Switch.

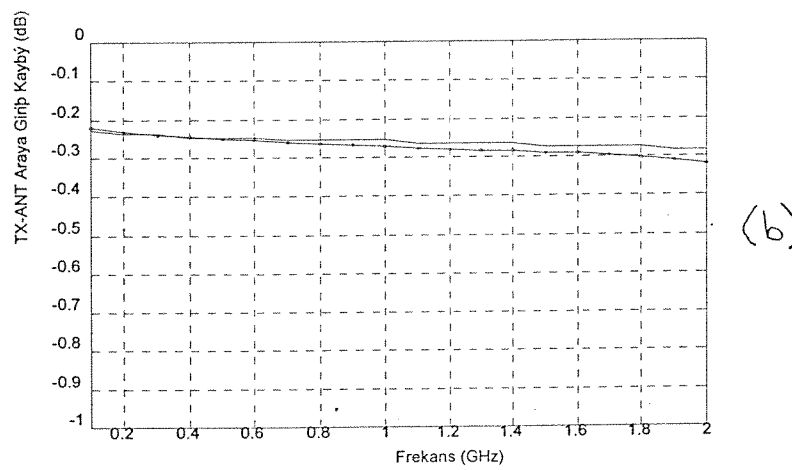
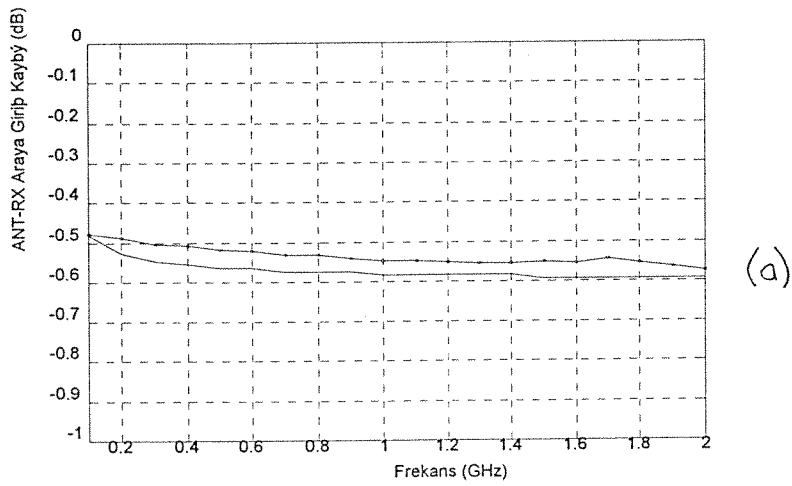


Figure B5.3 Computer Simulation (-----) and Measurement (--o--) Results
 a) ANT-RX Insertion Loss
 b) TX-ANT Insertion Loss

B6. POWER AMPLIFIER

A Power Amplifier is designed using MMIC Technology. The specifications of the design are as follows:

Frequency range: 12.5 GHz - 13.5 GHz
Bandwidth : At least 1 GHz
Output power : 200 mW minimum
Gain : 14 dB minimum
Gain flatness : 0.2 dB
Input and Output return losses < 10 dB
Bias voltage : 5 V.

The circuit topology of the amplifier is shown in Fig. B6.1. Two cascaded stages are used to guarantee the specifications. The types of the GaAs MESFET which are employed in the design is determined according to their drain currents. In GEC-MARCONI F20 foundry process, the current carrying capacity of the metal layer is 5 A/mm. Also the maximum width of the lines of the inductors is 24 μm which corresponds 120 mA maximum. Bearing in mind the circuit topology, the drain current must be less than 120 mA. at $V_{gs}=0$. To fulfill these requirements 4x150 μm FET is selected.

The first stage is designed separately from 50 Ω input to 50 Ω output and 15 dbm output is obtained for 0 dbm input at 13 GHz. To achieve a stable operation throughout the frequency band, RLC feedback is employed at this stage. The feedback is selected such that gain and bandwidth are not affected duly. The best results are obtained with series capacitors having values 5-6 pF. The second stage is also separately designed from 50 Ω input to 50 Ω output and to have at least 200 mW output power. Finally the two stages are combined and optimized. After the final values of the components are determined, the stability check is accomplished. It is shown that the amplifier is stable for all frequencies.

The layout of the amplifier is shown in Fig. B6.2. The chip size is 0.8x1.4 mm. Due to the financial reasons this amplifier is not sent for implementation.

Fig. B6.3 shows the large signal scattering parameters of the simulation results. The gain, bandwidth and output return loss have been achieved with regard to the specifications. However, input return loss is only below 10 dB between 13.7 GHz -16 GHz. Also the simulation results show that 1 dB compression point occurs at 5 dbm input. The corresponding output is 20 dbm or 100mW which is lower than the specified value. It is concluded that FET's having larger gate widths than the ones used would give higher output powers. Still higher output power can be obtained using hybrid divider-combiner techniques, but these require much more chip area than the present one. Simulation results also show that at 100 mW output level, the second harmonic is 40 dB below; and third harmonic is 65 dB below the fundamental.

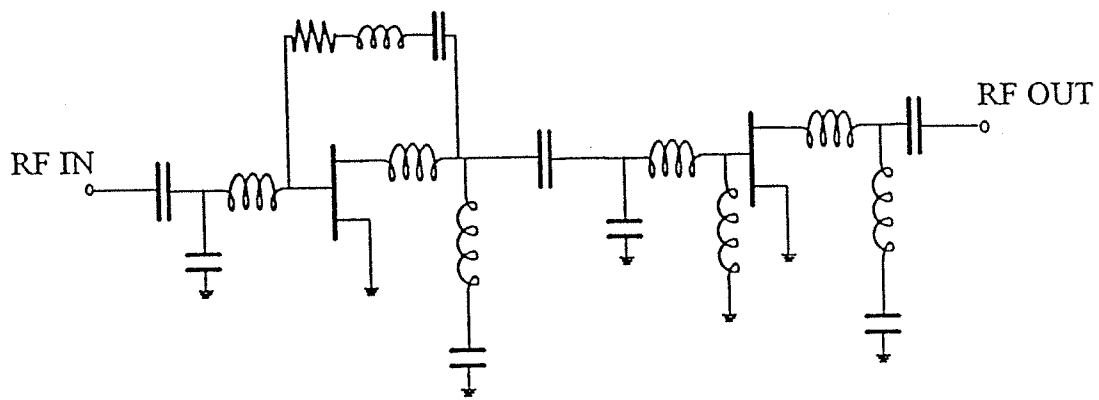


Figure B6.1 Amplifier Circuit Diagram

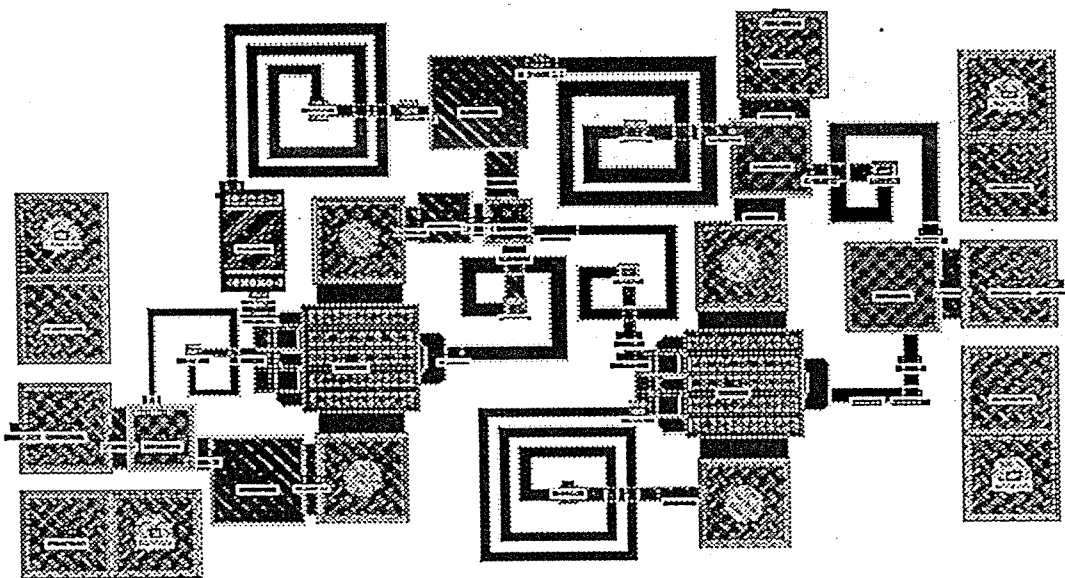


Figure B6.2 Layout of the Amplifier

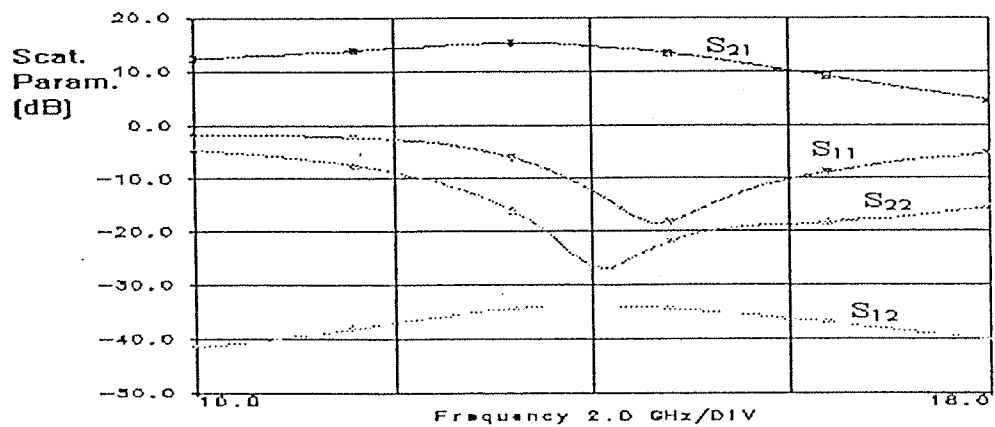


Figure B6.3 Simulation Results of the Amplifier

B7. WIDEBAND VOLTAGE VARIABLE ATTENUATOR

A linear, wideband (1-20 GHz) voltage variable attenuator (VVA) is designed in MMIC form for the high frequency operating communication systems. An attenuator is a network that reduces the input power by a predetermined ratio. To achieve a linear relationship between the attenuation measured in dB and the control voltage, most of the existing attenuator circuits employ external active linearization circuitry which complicates the component and reduces reliability. In this work, linearization is achieved by connecting a number of field effect transistors in a special fashion to form a composite FET whose channel resistance is a prescribed function of its gate-to-source voltage, as suggested in [1].

There are three forms of resistive networks that lend themselves conveniently to realization of microwave attenuators. These are the T, PI, and bridged-T configurations shown in Fig.B7.1. Each configuration can be used to implement a variable attenuator by replacing the fixed value resistors R_1 and R_2 with variable resistors. Variable resistors are three-terminal components where the resistance measured between two terminals is controlled by a signal (a voltage in the case of a VVA) applied to the third terminal. In MMIC technology, variable resistors are realized by using MESFETs. The channel resistance of the MESFET is varied by a control voltage applied between the gate and the source.

In the present design, the bridged-T configuration shown in Fig.B7.1c) is used, and in order to achieve a linear operation, the variable resistors are realized by 'composite' FETs which are formed by the parallel combination of several FETs with a resistive voltage divider as shown in Fig.B7.2. The number of the FETs, and the resistors in the voltage divider are optimized for linear operation of the attenuator in the 1-20 GHz band. A schematic diagram of the complete attenuator is given in Fig.B7.3. Four FETs are used for the series resistor, while two FETs were sufficient to realize the shunt resistor. The circuit is arranged so that the two control voltages V_{c1} and V_{c2} constitute a complementary pair in the form $V_{c2} = -6V_{c1}$. Since it is relatively easy to generate complementary voltages from a single control voltage, this would be desirable in applications where only one control signal is available.

The MMIC layout of the VVA is prepared as shown in Fig.B7.4 using the elements of the GEC Marconi F20 process [2]. All transistors are 4x75 micrometer MESFETs. The active chip area is approximately 1.6 mm².

Since the circuit has not been fabricated yet, only the computer simulation results are available to predict the performance of the attenuator. According to these results (see Figs. B7.5-B7.7), the attenuator has the following characteristics:

i) Through a wide frequency range (1-20 Ghz), a highly linear relationship between the attenuation and the control voltage is obtained.

ii) Attenuator has a dynamic range of 10 dB through the frequency band, with a minimum attenuation value of -2 dB and a maximum attenuation value of -12 dB.

iii) Attenuation flatness at all states of the control voltage is always better than 0.5 dB.

iv) The return loss both at the input and the output is better than 15 dB.

v) At low frequencies, the phase shift through the attenuator remains almost constant for all attenuation values (an overall change of 2.3 degrees at 1 Ghz), whereas at the high frequency end of the band, the phase change shows a large variation with the attenuation level (about 19 degrees at 20 Ghz).

REFERENCES

[1] Barak Maoz, "A Novel, Linear Voltage Variable MMIC Attenuator", IEEE Trans. on MTT, Vol.38, No.11, Nov. 1990, pp.1675-1683.

[2] GaAs IC Foundry Design Guide- Process F20/F14, GEC Marconi, 1993.

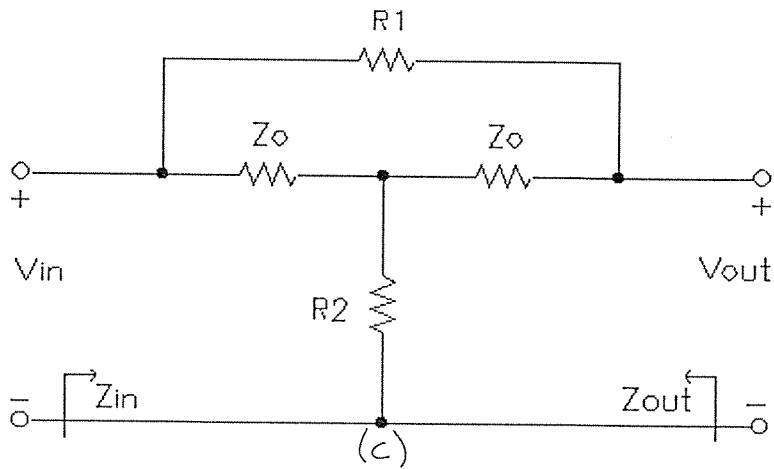
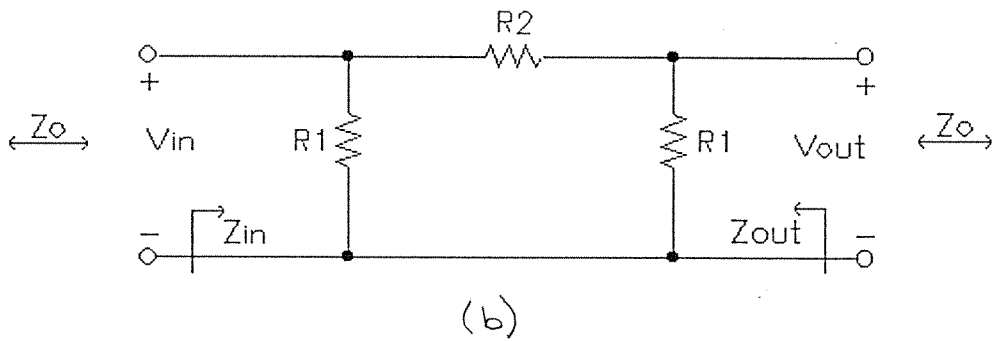
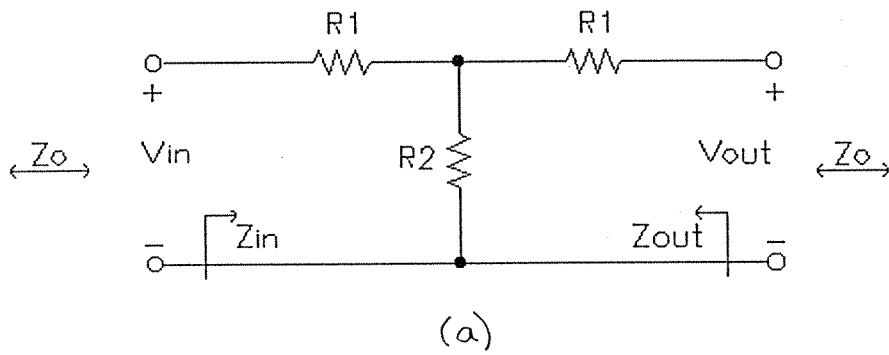


Figure B7.1 Network Configuration for
 a) T-Type Attenuator
 b) PI-Type Attenuator
 c) Bridged T-Type Attenuator

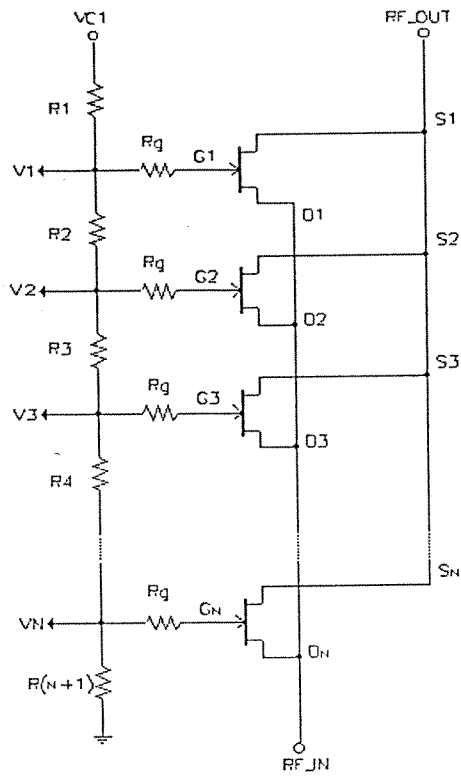


Figure B7.2 Parallel Combination of Several FETs with a Resistive Voltage Divider

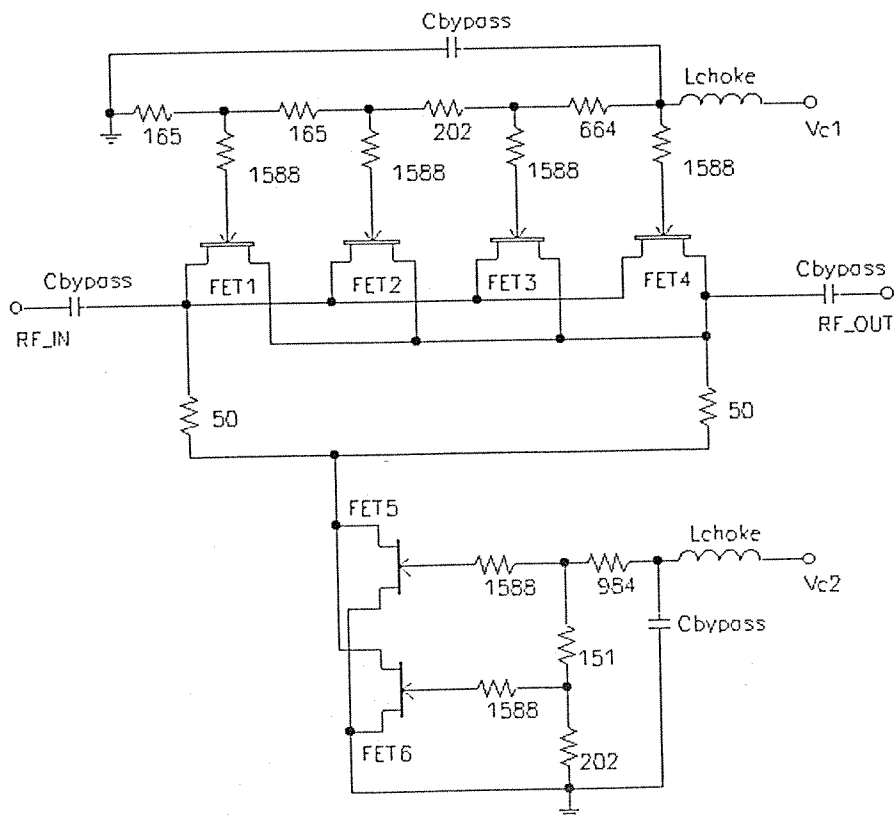


Figure B7.3 Schematic Diagram of the Complete Attenuator

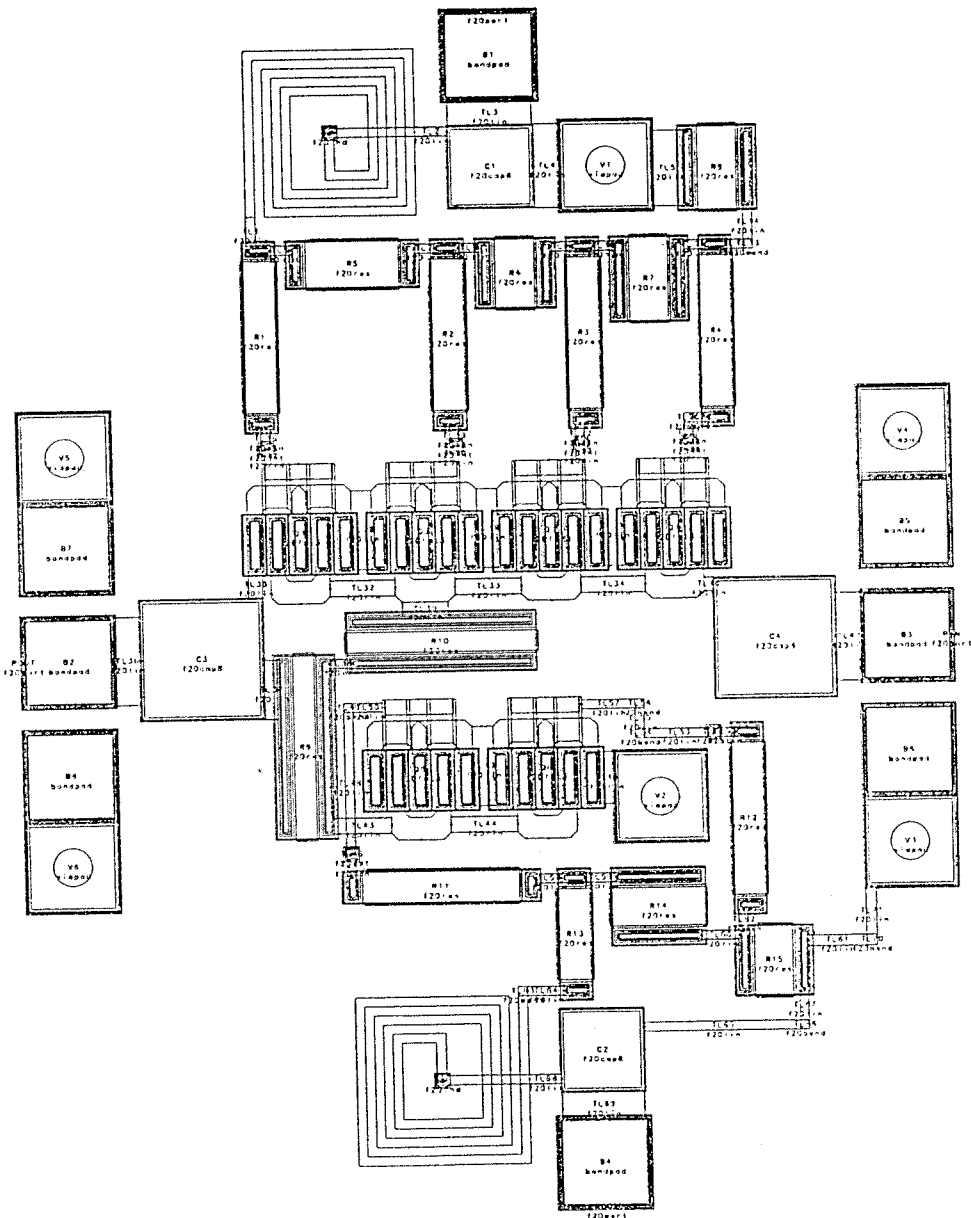


Figure B7.4 MMIC Layout of the Attenuator

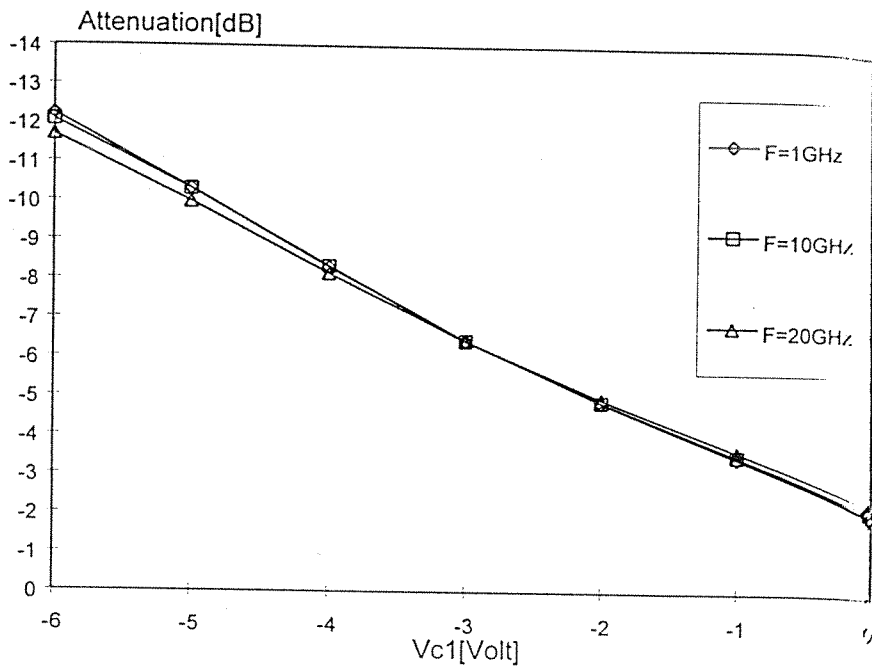


Figure B7.5 Attenuation as a Function of the Control Voltage

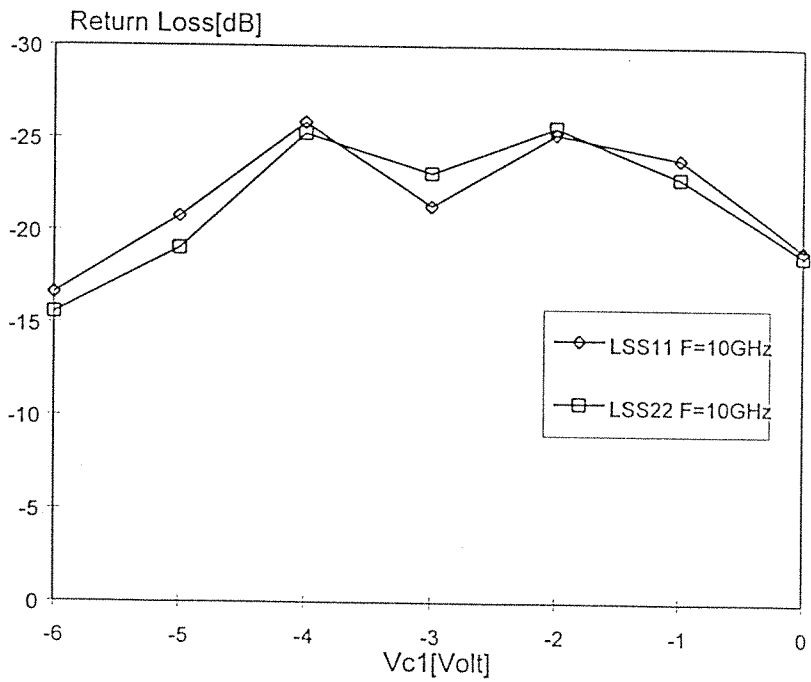


Figure B7.6 Input and Output Return Loss as a Function of the Control Voltage

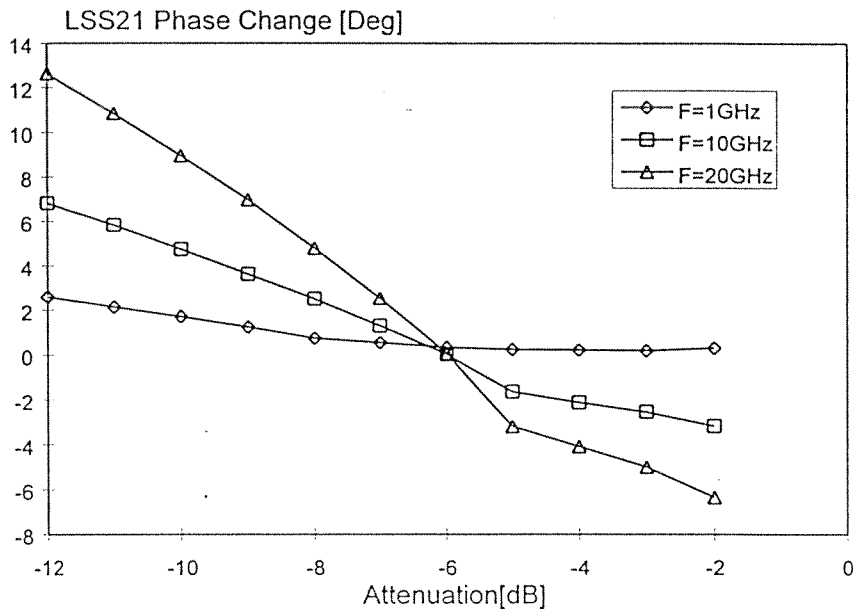


Figure B7.7 Phase Shift through the Attenuator as a Function of Attenuation

B8. PHASE SHIFTER

An extensive study on a variety of phase shifters is made and their principles of operation, tuning mechanisms and circuit topologies are investigated. Phase shifter circuits using switching devices such as “switched line phase shifters”, “loaded line phase shifters” and “high-pass/low-pass phase shifters” are analyzed and their characteristics are noted. Reflective type phase shifters are also examined. A vector modulator topology employing bi-phase modulators, in particular, is simulated and its wide band operation is compared to the performance of other types of phase shifters.

Operation principles of a FET as a switching element in phase shifters are studied in detail. A single pole double throw, SPDT, using GEC-Marconi F20 process MMIC technology is designed and simulated. Also a three phase-bits are designed using GEC-Marconi foundry elements and HP’s Libra 5.0 simulation software. In this design lumped element high-pass/low-pass type phase bits are employed. After the integration of SPDT switches with the high-pass/low-pass sections to form a “three-bit phase shifter”, the simulation results are obtained. Due to the financial reasons, this design is not sent for implementation.

Schematics of a T-type high-pass/low-pass section is shown in Fig. B8.1 together with switches. Block diagram of the three-bit phase shifter is shown in Fig. B8.2 with 90° , 45° and 180° phase bits, but without switches. The three possible combination for cascading scheme are worked out and it is found that, the optimum configuration for good input and output return losses, for less phase error and for less amplitude unbalance, is achieved when 45 degrees phase bit is placed in the middle as shown in Fig. B8.2.

As the first step in the design, ideal normalized reactance and susceptance values are computed for the T-type high-pass/low-pass sections for the given degree of the phase bit and for the reference termination of 50Ω at the center frequency of 10 GHz. These values are compared with the minimum and maximum realizable lumped inductance and capacitance values available in the GEC-Marconi F20 process. Certain microstrip lines are added wherever necessary to obtain the required phase shift. Using the models for the lumped elements of F20 process, appropriate elements are selected to construct the filter sections. Due to the parasitic capacitances, lead inductances, connecting microstrip lines and losses of the lumped elements, more than 1 degree shift in the differential phase from the theoretical values is encountered. Therefore, effects of all the elements on the ultimate results are analyzed and circuit element parameters are optimized towards obtaining the design specifications.

All the 45° , 90° and 180° phase bit circuits are designed and optimized separately first without the switches and then with the switches. Only the 90° phase bit circuit will be

given here in some detail since the others follow similar pattern. Full detail can be found in [1].

Fig. B8.3 shows the layout of the 90^0 phase bit with the SPDT switches. The overall dimensions of the chip are $1770\mu\text{m}$ by $1160\mu\text{m}$. Simulation results of insertion loss, return loss, differential phase shift together with the insertion phases and amplitude difference characteristics in 6-14 GHz band are shown in Figures B8.4, B8.5, B8.6 and B8.7 respectively. After the integration with the SPDT switches, it is observed that return loss of the high-pass section is degraded. In order to reduce the reflections, a 0.15nH inductance is connected in series with the capacitance of the high-pass section. Deviation in the differential phase shift is readjusted by increasing the length of the microstrip line in the low-pass section. The overall insertion loss increases to 5.5 dB (for low-pass path) at 10 GHz. Return loss is better than 11 dB in the overall frequency band for both paths. Frequency band for $\pm 2^0$ phase error is 8 GHz to 12.7 GHz. Since the two paths of the SPDT switch have identical insertion phase characteristics, the differential phase shift remains the same. There exists a maximum amplitude unbalance of 0.8 dB.

After the design of each phase shifter bit, they are cascaded to form a three-bit digital phase shifter. The reference state is specified as high-pass path of 90^0 phase bit, low-pass path of 45^0 phase bit and high-pass path of 180^0 phase bit. Table B8.1 gives the state combinations and the corresponding amplitude difference and differential phase shift at 10 GHz. After examining this table, one sees that an overall phase error of $+6^0$ occurs. Figures B8.8 and Fig. B8.9 show the insertion loss and the input/output return losses of the reference state respectively. Insertion loss at 10 GHz is 15.2 dB, where as input and output return losses are better than 10 dB in the operating band. Fig. B8.10 shows the differential phase shifts of the states from 2 to 8 in the frequency band 6-14 GHz. State 1 which is the reference state, has 0^0 phase shift and hence is not shown.

The excessive insertion loss originates from the individual losses of the SPDT switches. GEC-Marconi F20 process, implant IG has a relatively high resistivity. The other implant offered by GEC-Marconi F20 process, implant IS has half the resistivity of implant IG. The circuit models of implant IS, although not available, should be used in the design procedure. Bandwidth of the phase shifter is 7.8-11.7 GHz (1:1.5). Bandwidth can be widened by using the parasitic reactances of the switches as the elements of the filter sections.

REFERENCE

- [1] M. E. Inal, "Monolithic Microwave Integrated Circuit Phase Shifters", M.S. Thesis, Department of Electrical and Electronic Engineering, Middle East Technical University, April 1997.

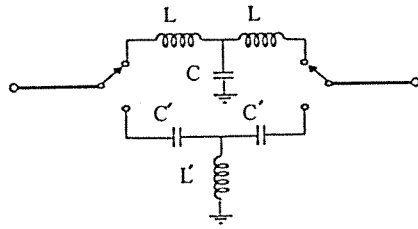


Figure B8.1 Schematics of T-Type Low-Pass/High-Pass Sections and SPDT Switches

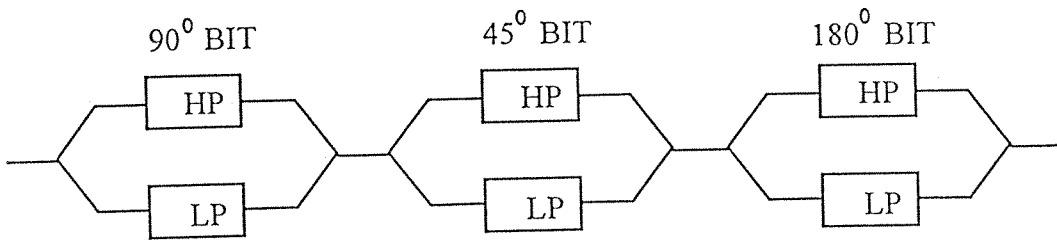


Figure B8.2 Block Diagram of the Three-Bit Phase Shifter

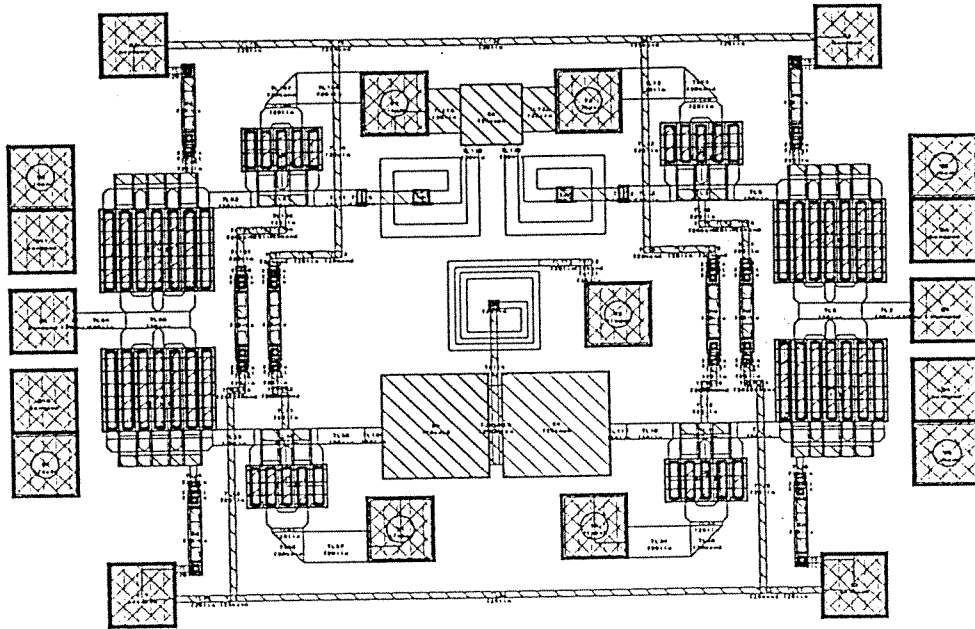


Figure B8.3 Layout of 90° Phase Bit with SPDT Switches

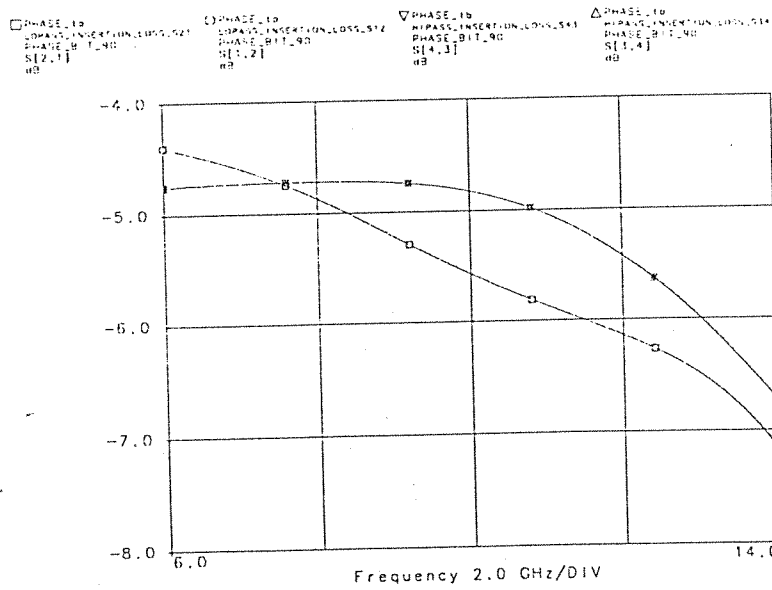


Figure B8.4 Insertion Loss of the 90° Phase Bit when High-Pass and Low-Pass Paths are Selected

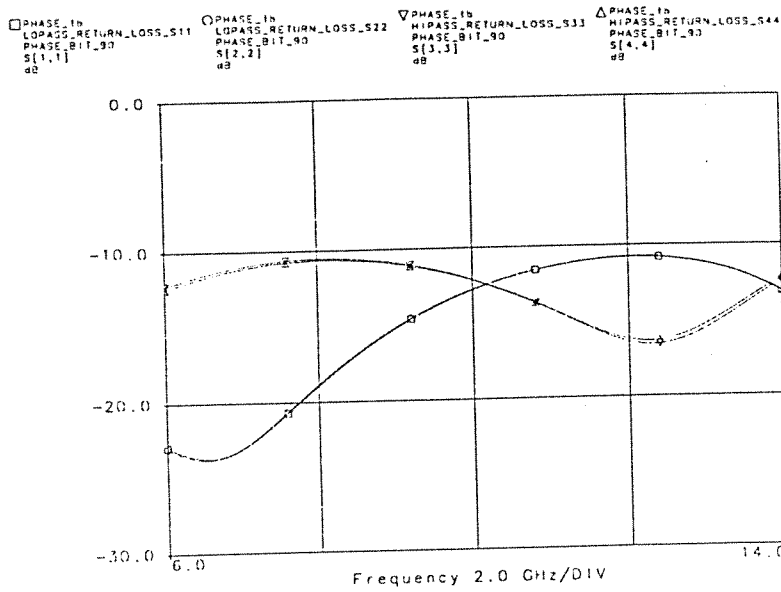


Figure B8.5 Return Loss of the 90° Phase Bit when High-Pass and Low-Pass Paths are Selected

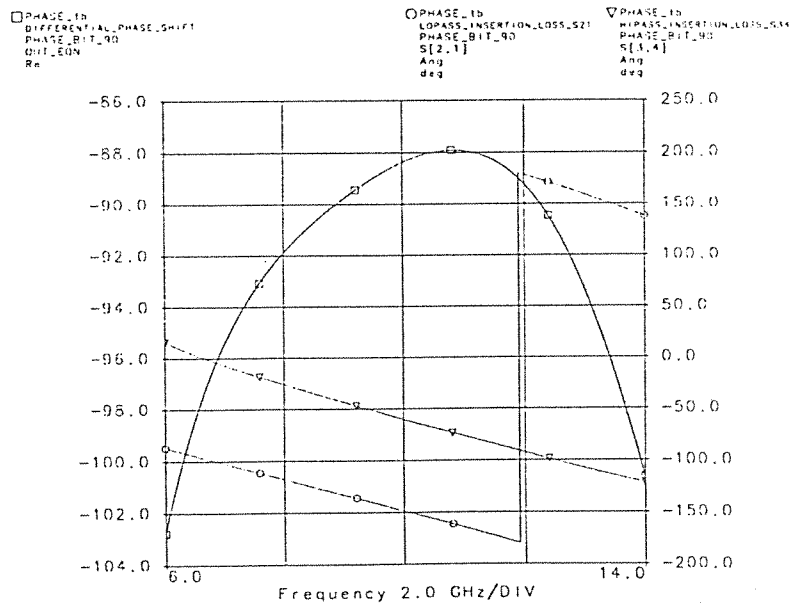


Figure B8.6 Differential Phase Shift and the Insertion Phases of the 90° Phase Bit when High-Pass and Low-Pass Paths are Selected

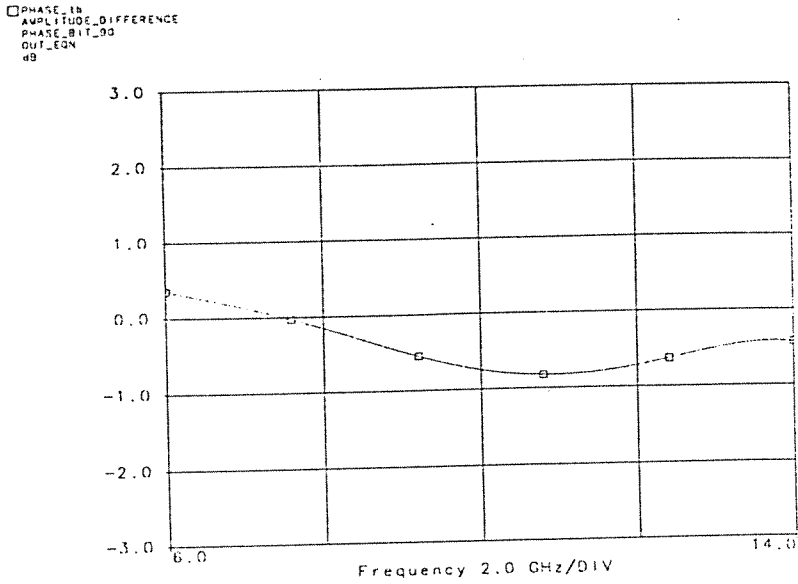


Figure B8.7 Amplitude Difference Between the Two Paths of the 90° Phase Bit when High-Pass and Low-Pass Paths are Selected

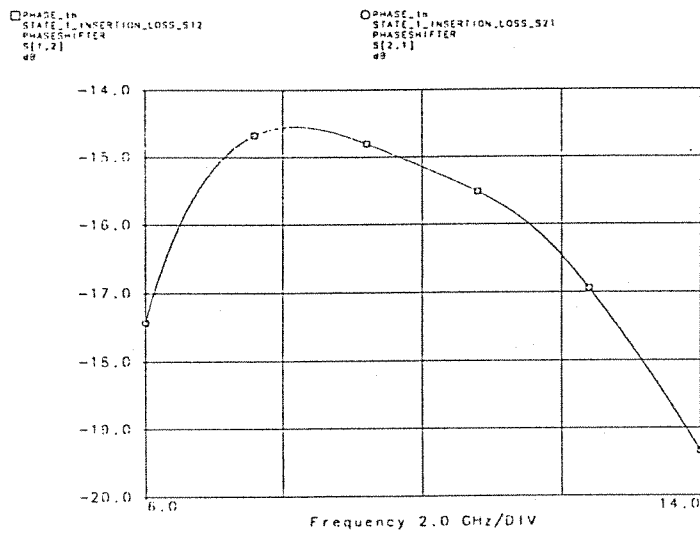


Figure B8.8 Insertion loss of the Reference State (State 1)

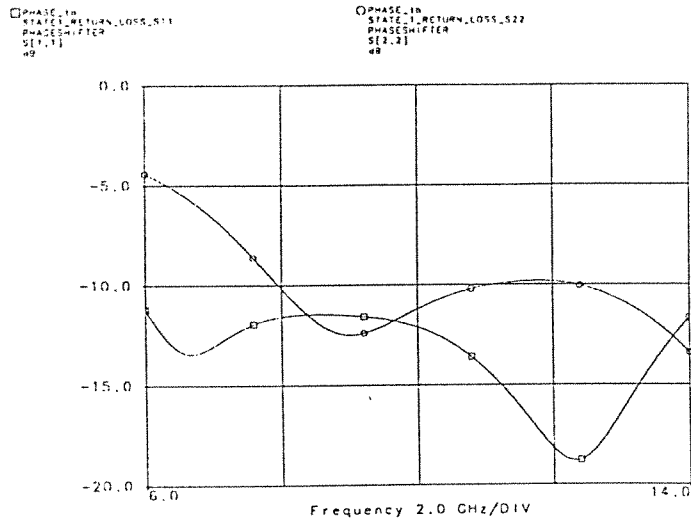


Figure B8.9 Input and Output Return Losses of the Reference State

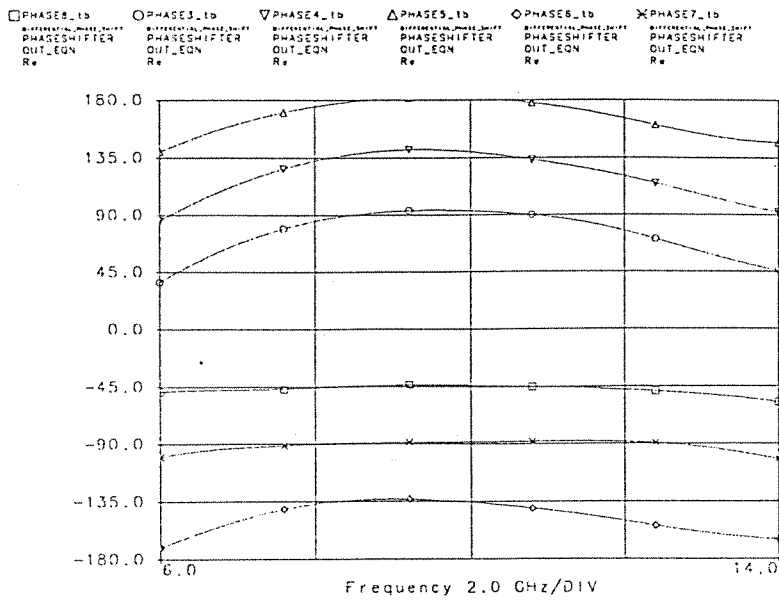


Figure B8.10 Differential Phases of the Seven Phase States

Table B8.1 Amplitude Difference and Phase Error for each State

STATE	90° BIT	45° BIT	180° BIT	ΔIIL (dB)	$\Delta\phi_{\text{theoretical}}$ (°)	$\Delta\phi_{\text{act}}$ (°)	$\Delta\phi_{\text{err}}$ (°)
1	HP	LP	HP	0.0	0	0	0
2	HP	HP	HP	+1.7	45	40	-5
3	LP	LP	LP	-1.3	90	94	+4
4	LP	HP	LP	+0.6	135	141	+6
5	HP	LP	LP	-0.8	180	182	+2
6	HP	HP	LP	+0.8	225	226	+1
7	LP	LP	HP	-0.7	270	272	+2
8	LP	HP	HP	+1.0	315	316	+1

C- GENİŞ BANTLI ANTENLER ve NÜMERİK METOTLARLA İLGİLİ ARAŞTIRMALAR

C1. MİLİMETRİK DALGA BANDINDA İKİ VE ÜÇ KATMANLI (FERİT-DİELEKTRİK) ANTENLERLE ELEKTRONİK DEMET TARAMASI

Üzerine ferit dilim konulmuş tam iletken tabaka içindeki yarık antenin ışınım özellikleri daha önce incelenmiştir [1-2]. Bu yapı ile, ferit dilime uygulanan DC manyetik alanı değiştirerek, milimetrik dalga frekanslarında sürekli bir tarama elde edilebileceği gösterilmiştir. Ayrıca, bu çalışmalarda [1-2], izotropik olmayan maddeler de içeren çok katmanlı düzlemsel sistemler için, belirlenen sınır koşullarını da kapsayan basit bir ağ modeli geliştirilmiştir. Bu yöntem, Şekil-1'de görülen iki katmanlı (ferite-dielektrik) ve üç katmanlı (dielektrik-ferite-dielektrik) yapılara uygulanmış ve çeşitli madde parametrelerinin ve frekansın ışınım örüntüsüne etkisi incelenmiştir [2-3]. Verilen sayısal örneklerde DC manyetik alanın ferit dilime dik olacak şekilde uygulandığı ve ferit dilimin doygunluğa eriştiği varsayılmıştır. Ferit dik olarak manyetize edildiği için ışınım örüntüleri z eksenine göre simetriktir. DC manyetik alan farklı yönlerde uygulanırsa, ışınım örüntüsünün simetrisi bozulur. Bu durumda, problemin çözümünde, geliştirilen ağ modeli kullanılamaz. Kaynak olarak Hertz manyetik dipolü kullanılmıştır. Örneklerdeki dielektriklerin dielektrik sabitleri 2.4, feritinki ise 14'tür. Feritin doygunluk manyetik katsayısı 0.3 T'dir.

Şekil-2'de, ışınım örüntüsü, değişik B_0 (DC manyetik alan) değerleri için çizilmiştir. Görüldüğü gibi, manyetik alan değiştikçe, ışınım demeti de hareket etmektedir. Ayrıca, Şekil-2'de dielektrik kalınlığının değişiminin ışınım örüntüsüne etkisi de gözlenmektedir. Aynı B_0 değerleri için, dielektriğin kalınlığı 2 mm iken, ışınım demeti 30 dereceden 15 dereceye kadar, kalınlık 2.3 mm iken 45 dereceden 35 dereceye kadar, kalınlık 2.7 mm iken ise 55 dereceden 50 dereceye kadar taramaktadır. Dielektriğin kalınlığı, ışınım demetinin şeklini değiştirmemekte yalnızca farklı açılarda tarama yapılmasını sağlamaktadır.

Üç katmanlı (dielektrik-ferit-dielektrik) bir yapıda, ışınım örüntüsünün B_0 ile değişimi Şekil-3'de çizilmiştir. Üstteki dielektriğin kalınlığı "1" dir. Grafikten görüldüğü gibi $B_0=0.24$ T iken tek bir ışınım demeti olmasına karşın, B_0 arttırıldığında demet önce ikiye sonra üçe bölünmüştür. $B_0=0.28$ T iken ise yine iki ışınım demeti vardır.

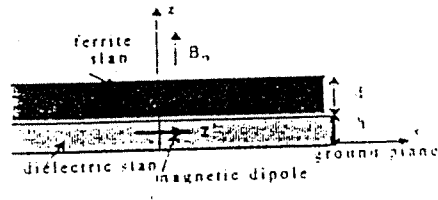
Şekil-4'de iki katmanlı ve üç katmanlı yapılar için, ışın demetinin yönü manyetik alanın fonksiyonu olarak çizilmiştir. Bu ve bundan sonraki örneklerde, üstteki dielektriğin dielektrik sabiti 2'dir. Grafikten de görüldüğü gibi üç katmanlı bir yapı ile daha geniş bir alan taranabilmektedir.

Üç katmanlı yapı için, ışın demeti yönünün frekansla değişimi incelenmiş ve Şekil-5'de gösterilmiştir. Şekilden görüldüğü gibi 25 GHz'de tarama olmamaktadır. Buna karşın 25.5 GHz'de B_0 0.05T ile 0.15 T arasında değişirken 65 derecelik, 26 GHz'de B_0 0.05 T ile 0.2 T arasında değişirken 65 derecelik, 27 GHz'de B_0 0.05 ile 0.31 T arasında değişirken 70 derecelik tarama gerçekleşebilmektedir. Buradan, B_0 'daki küçük değişikliklerin frekans 25.5 GHz veya 26 GHz' olduğunda, 27 GHz durumuna göre, ışın demetinin yönünde daha büyük sapmalar sağladığı sonucunu çıkarabiliriz.

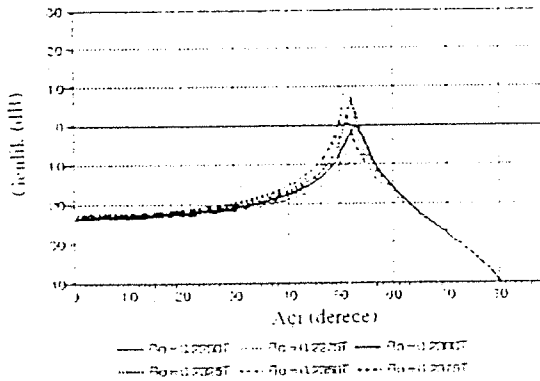
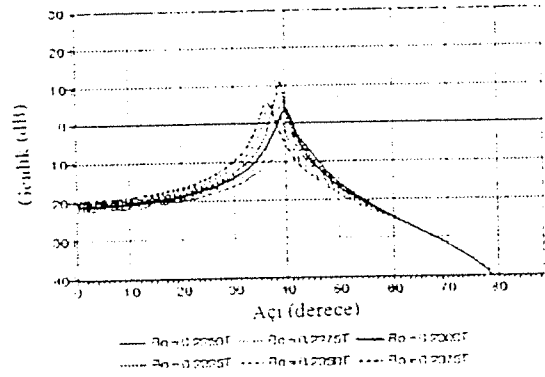
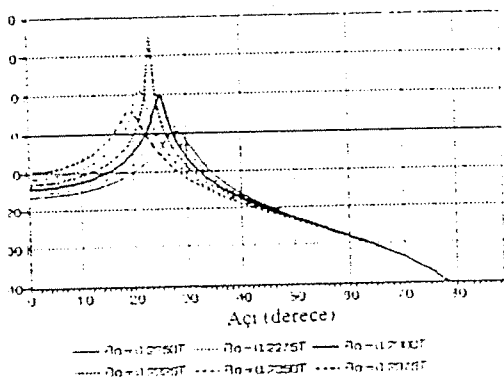
Burada incelenen anten yapısı ile, milimetrik dalga frekanslarında, uygun madde seçimiyle, DC manyetik alanı değiştirerek, ışın demetinin şekli değiştirilebilmekte ve elektronik demet taraması elde edilebilmektedir.

REFERANSLAR:

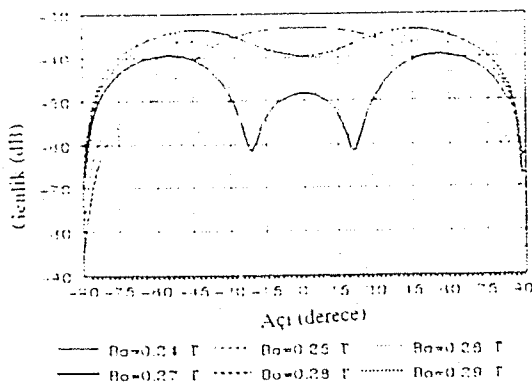
- [1] Ö. Aydın ve A. Hızal, "Electronic beam scanning by a vertically magnetized ferrite slab", COST224 Final Report, Ağustos 1992.
- [2] Ö. Aydın ve A. Hızal, "Dielectric coated vertically magnetized ferrite slab for electronically scanning mm-wave antennas", Elektrik (Turkish Journal of Electrical Engineering and Computer Sciences), s. 206, Ekim 1993.
- [3] Ö. Aydın ve A. Hızal, "Electronic beam scanning in millimeter-wave band with dielectric-ferrite loaded antennas", Antalya'da yapılan MELECON Konferansı bildiriler kitabı, Nisan 1994.



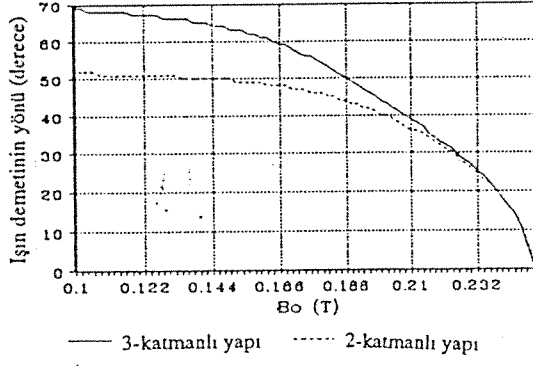
Şekil 1. İki katmanlı yapı



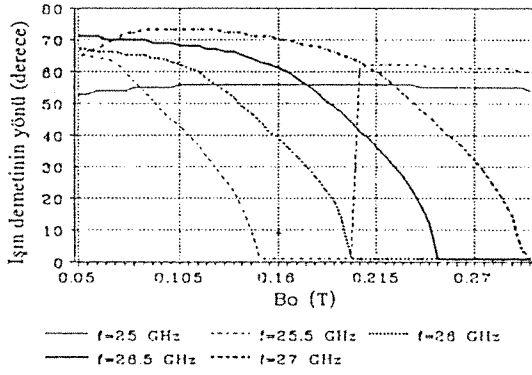
Şekil 2. İki katmanlı yapı için ışıma örüntüleri. $f=26.5$ GHz, $d=6$ mm
a) $h=2$ mm, b) 2.3 mm, c) 2.7 mm



Şekil 3. Üç katmanlı yapı için ışıma örüntüleri. $f=26.5$ GHz, $d=4.1$ mm, $h=3$ mm, $l=1$ mm



Şekil 4. B_0 'ya karşılık ışın demetinin yönü, $f=26.5$ GHz, $d=6$ mm, $h=2$ mm, $l=3$ mm



Şekil 5. Farklı frekanslar için B_0 'ya karşılık ışın demetinin yönü, $d=6$ mm, $h=2$ mm, $l=3$ mm

C2. 2-18 GHz VE 6-18 GHz FREKANS BANTLI VIVALDİ ANTENLER İLE 6-18 GHz FREKANS BANTLI VIVALDİ ANTEN DAİRESEL DİZİSİ TASARIMI

Mikrodalga ve milimetre-dalga teknolojilerindeki en son gelişmeler, küçük, ucuz, kolay üretilebilen, düzlemsel ve almaç ön devreleriyle aynı taban malzemesi üzerinde kolayca birleştirilebilen antenlere gereksinim duymaktadır. Vivaldi anten frekansa göre sürekli kendini tekrar eden, yürüyen dalga tipi antenler sınıfındadır. Teorik olarak sonsuz frekans bandına sahiptir (1:20). Yüksek bir kazancı, düşük yan lob seviyesi ve simetrik end-fire hüzmesi vardır. Düzlemsel, küçük, düşük profilli ve ucuz maliyetli bir antendir. Ekspansiyon olarak açılan yarık hat anten yapısına sahiptir. Yarık hat çift yüzlü ve dengelidir. Antenin girişinde mikroşerit hattın dengeli hatta geçişi sağlayan bir balun bulunmaktadır.

Vivaldi anten yavaş yürüyen dalga antenleri grubundadır. Bu tip yapılar için ışınım sadece düzgün olmayan dağılıma sahip yerlerde, eğriliklerde ve süreksizliklerde oluşur. Yayılmış ya da ayrı olabilen süreksizlikler, anten yüzeyinde hareket eden dalgayı etkiler ve ışımaya sebep olurlar. Vivaldi antende ışınım; yarık genişliği dalga boyunun yarısına eşit olduğunda gerçekleşir. Bu durumda yürüyen dalganın anten üzerindeki faz hızı, uzaydakine eşit olur. Vivaldi antenin geometrik yapısı, frekansa göre kendini tekrarlayan bir yapıdadır. Bu sebeple ışınım özellikleri de teorik olarak frekansdan bağımsızdır. Ancak pratikte antenin fiziksel yapısı belli bir yerden kesildiği için bir alt kesim frekansı bulunmaktadır.

Antenin besleme bölümü bir dengelenmemiş mikroşerit hat, ardından mikroşerit daralan balun, onun ardından da eşit genişlikteki dengeli hat kısımlarından oluşmaktadır. Bütün bu kısımların karakteristik empedansı 50 Ohm dur. Besleme bölümünün ardından ışınımı yapan çift yüzlü yarık hat kısım gelir.

Bu çalışmada ilk olarak 2-18 GHz frekans bandında çalışan tek bir anten tasarlanmış ve RT/duroid® taban malzemesi kullanılarak üretilmiştir. Antenin besleme bölümündeki balun kısmı O.D.T.Ü. de geliştirilen sonlu eleman analiz programı kullanılarak tasarlanmıştır. Antenin giriş yansıma katsayısı (s_{11}), ışınım örüntüsü ve kazancı gibi parametreleri ölçülmüş ve aşağıdaki şekillerde verilmiştir. Daha sonra 6-18 GHz frekans bandında çalışan bir Vivaldi anten tasarlanmış ve aynı taban malzemesi kullanılarak üretilmiştir. Bu tasarımda besleme bölümünün boyu kısaltılmış, antenin elektriksel performansı ölçülmüş ve bu kısaltmadan dolayı bir performans kaybı gözlenmemiştir, ölçüm sonuçları aşağıdaki şekillerde sunulmuştur. Antenin mekanik

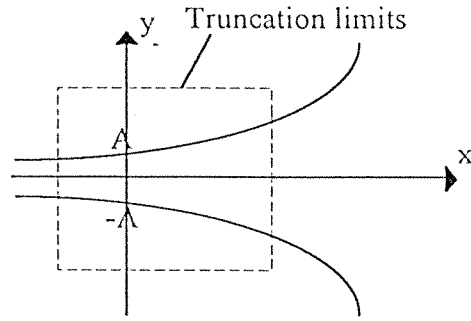
yapısı üzerinde yapılan deneyler sonucunda, ışımayı yapan bölümün boyunun uzatılması durumunda, giriş yansıma katsayısının azalacağı anlaşılmıştır. Bunun üzerine daha uzun bir ışıma bölgesine sahip 6-18 GHz frekans bantlı Vivaldi anten tasarlanmış ve bu antenden 8 adedi aynı taban malzemesi üzerine dairesel bir geometri içinde basılarak bir anten dizisi üretilmiştir. Dizi elemanlarının elektriksel performans özellikleri ölçülmüş ve aşağıda sunulmuştur. Elemanların giriş yansıma katsayısı, tekli 6-18 GHz Vivaldi anteninkine göre daha düşüktür. Ayrıca ışıma yapan bölgenin daha uzun olması sebebiyle kazancı daha yüksek ve komşu dizi elemanların blokaj etkisiyle yan lob ve arka lob seviyeleri de tekli antene göre daha düşüktür.

Tasarlanan ve üretilen antenlerin elektriksel performans özellikleri tatmin edicidir. Dairesel anten dizisi, monopols genlik ya da faz karşılaştırmalı yön bulma sistemlerinde kullanılabilir. Diğer bir uygulama da dizi elemanlarını uygun faz ve genliklerde sürerek, hüzme tarayan anten şeklinde kullanmaktır.

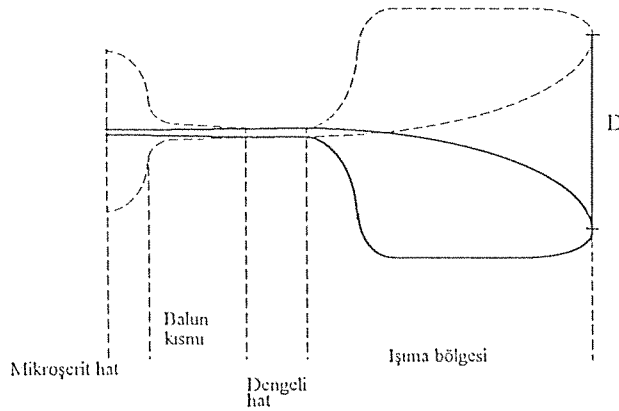
Referanslar:

- [1] Gibson, P.J., " The Vivaldi Aerial ".
9 th European Microwave Conference Proceedings,1979,pp.101-105.
- [2] Gazit, E., " Improved Design of The Vivaldi Antenna".
IEE Proceedings Vol.-135, 1988 pp.89-92.
- [3] Günalp N., Birand T., Hızal A., "Design of Tapered Slot Antennas with Broadband Feeds".
Contribution by the Turkish COST-223 Working Group METU (Turkey):
Cost 223 Final Report.
- [4] Birant T., et al., "Antennas in 1990`s: Active Antenna Array for Future Satellite and Terrestrial Communication".
Project Final Report for TUBITAK within the Frame Work of the COST-223 Project. January 1993 Ankara.

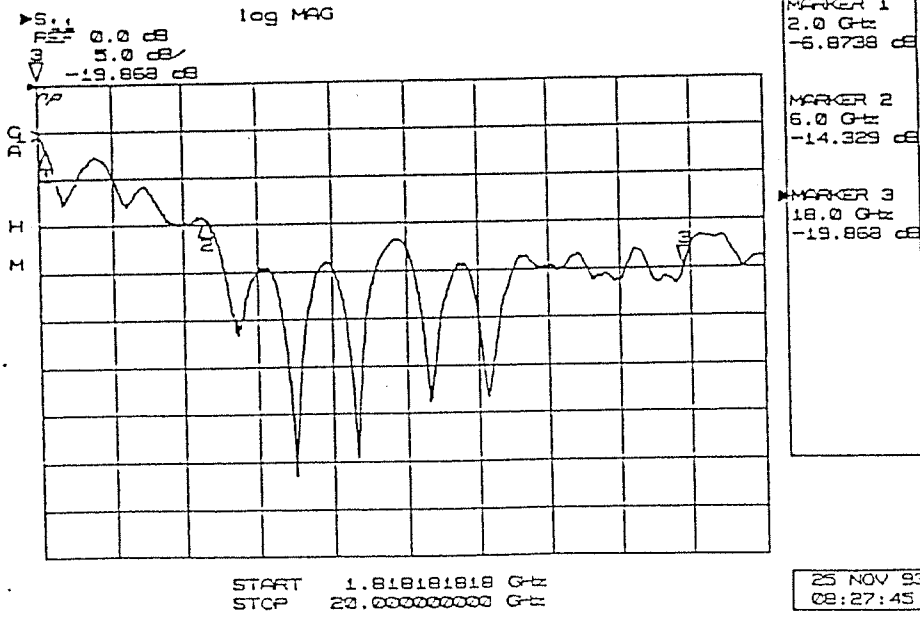
- [5] Gvozdev, V.I., "Use of The Unbalanced Slotted Line in SHF Microcircuits".
Radio Eng. & Electron Phys., Vol.-27, 1982, pp. 42-47.
- [6] Schiek, B., Köhler, J., " An Improved Microstrip-to-Microslot Transition." IEEE Trans. Vol. MTT-24, 1976, pp. 231-233.
- [7] Kuzuoğlu, M., " A New Finite Element Method for Electromagnetic Boundary Value Problems in Combined Exterior and Interior Regions".
Ph. D. Thesis in Elec. and Electron. Eng. METU., 1986.
- [8] Akdeniz, T. " Analysis of Microstrip and Microstrip-like Structures by the Finite Element Method ".
A Master's Thesis in Elec. and Electron. Eng. METU., 1989.



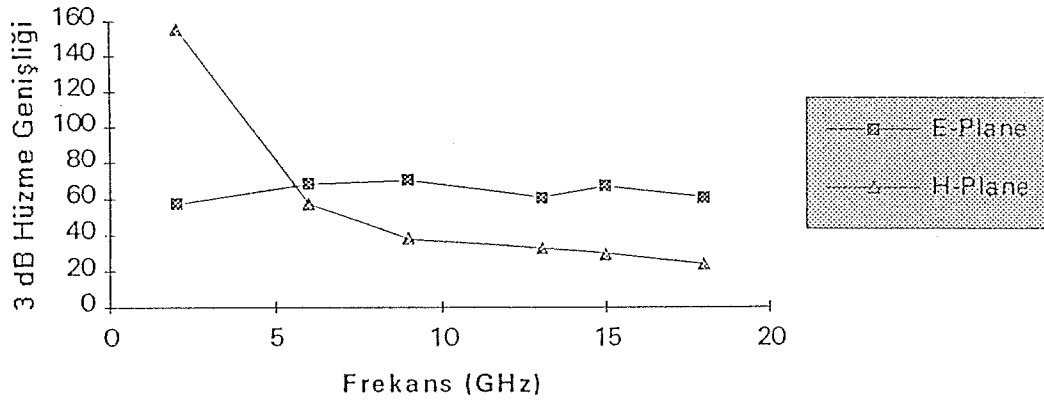
Şekil 1 Vivaldi Antenin Açılım Eğrisi



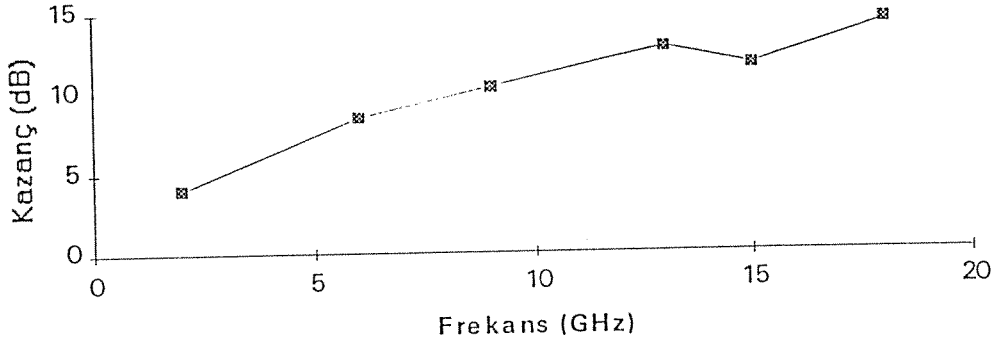
Şekil 2 Vivaldi Anten



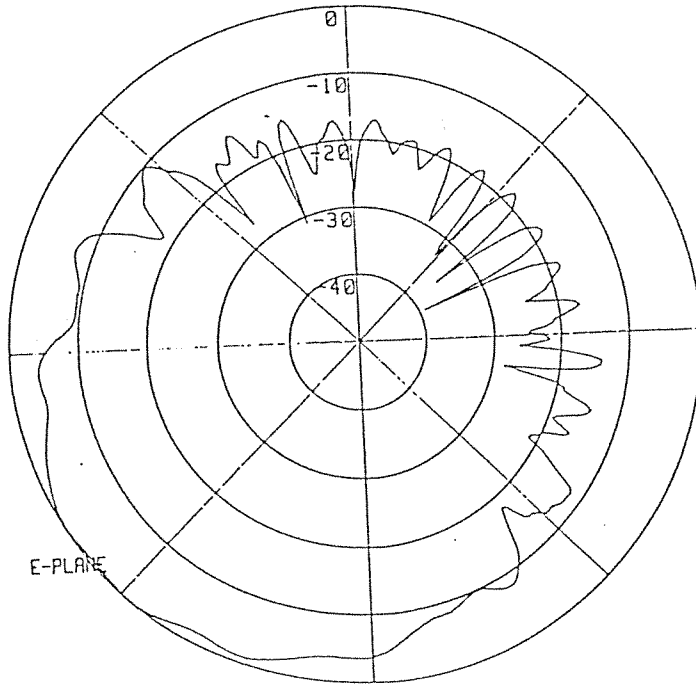
Şekil 3 2-18 GHz Frekans Bantlı Vivaldi Antenin Giriş Yansımaya Katsayısı



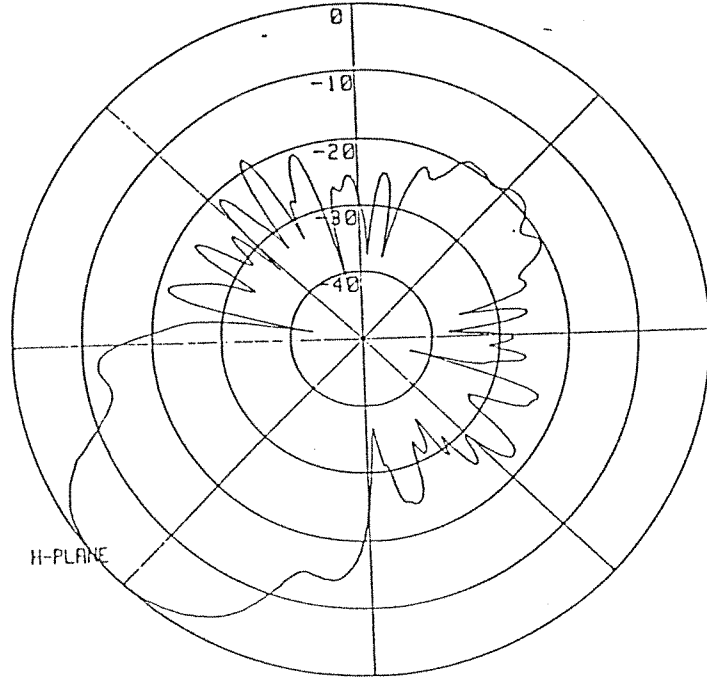
Şekil 4 2-18 GHz Frekans Bantlı Vivaldi Antenin 3 dB Hüzme Genişliği



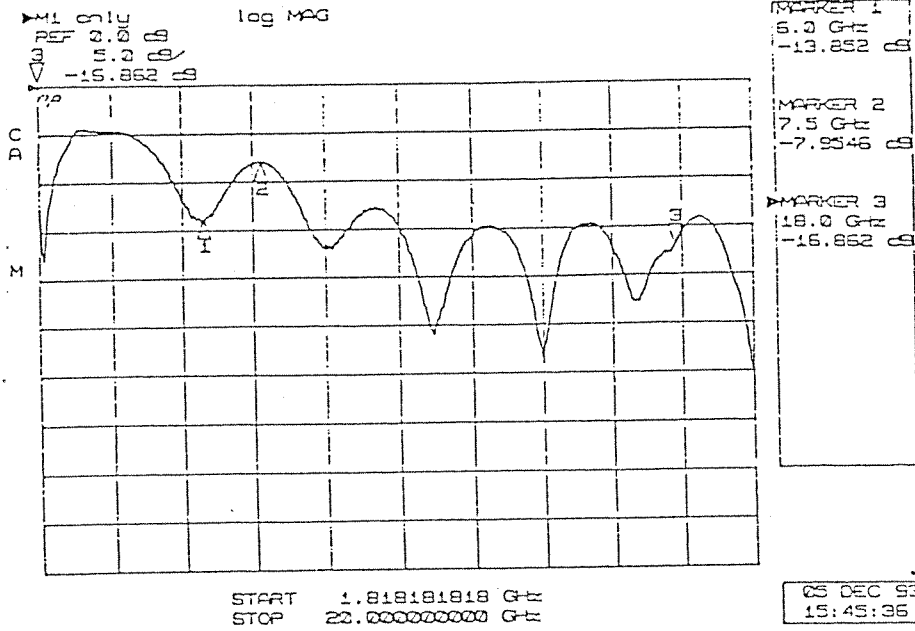
Şekil 5 2-18 GHz Frekans Bantlı Vivaldi Antenin Kazancı



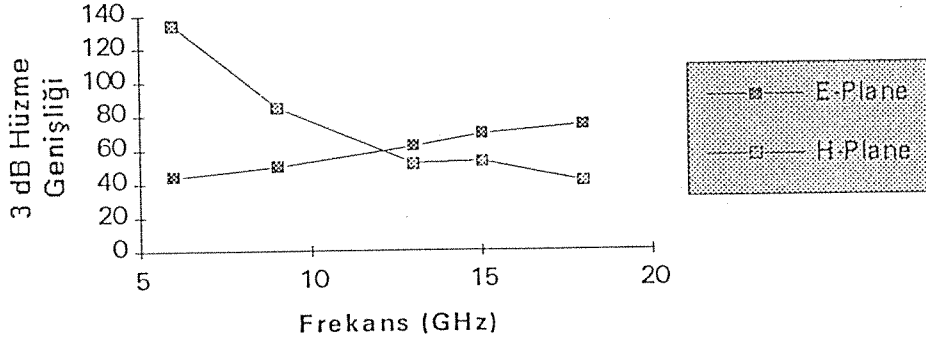
Şekil 6 2-18 GHz Frekans Bantlı Vivaldi Antenin 13 GHz deki Işıma Örüntüsü



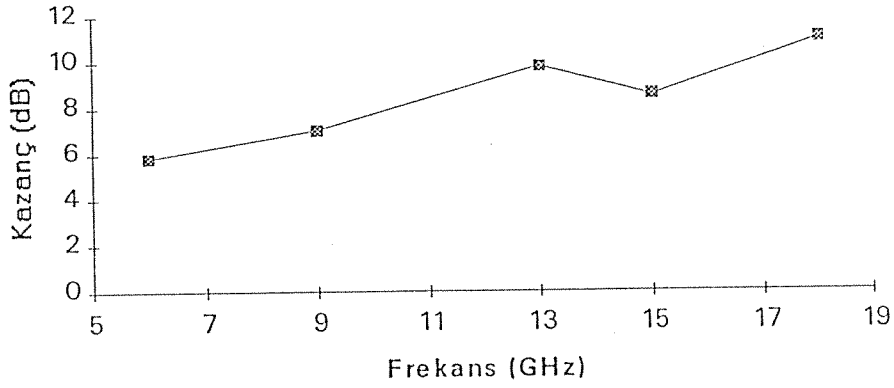
Şekil 7 2-18 GHz Frekans Bantlı Vivaldi Antenin 13 GHz deki Işıma Örüntüsü



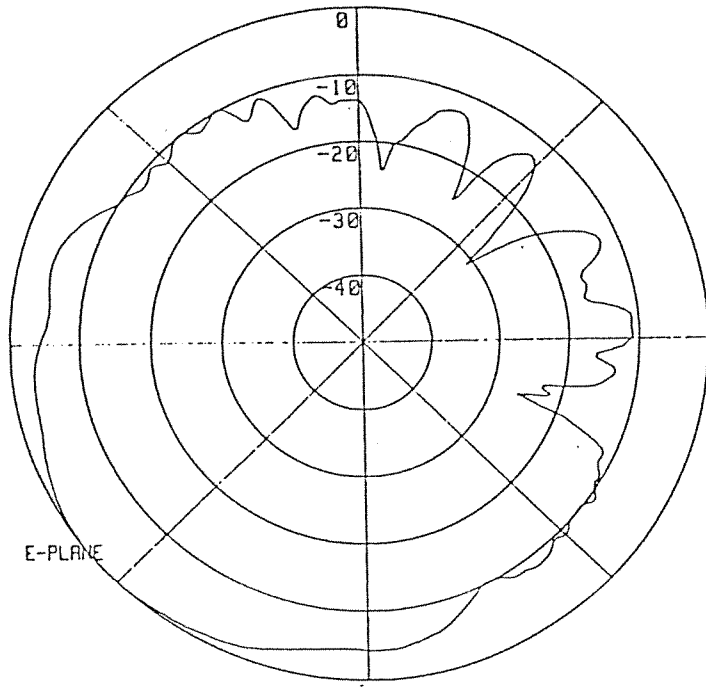
Şekil 8 6-18 GHz Frekans Bantlı Vivaldi Antenin Giriş Yansımaya Katsayısı



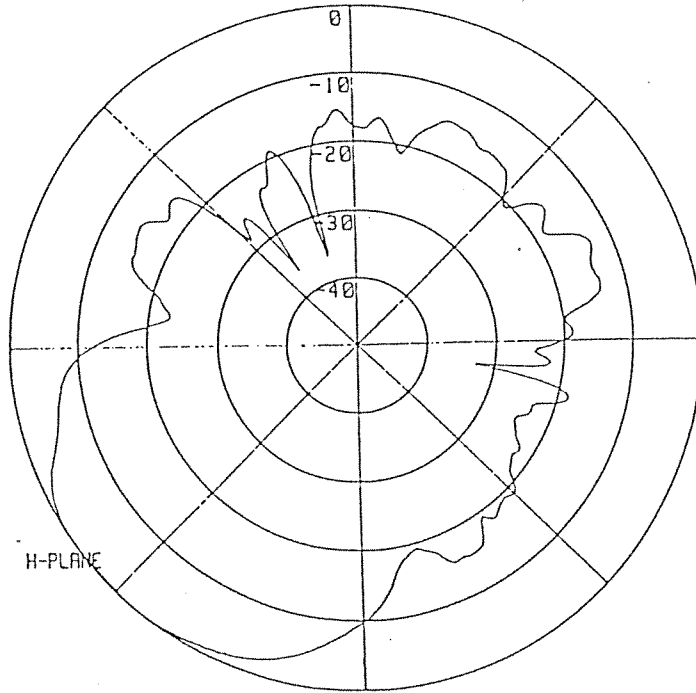
Şekil 9 6-18 GHz Frekans Bantlı Vivaldi Antenin 3 dB Hüzme Genişliği



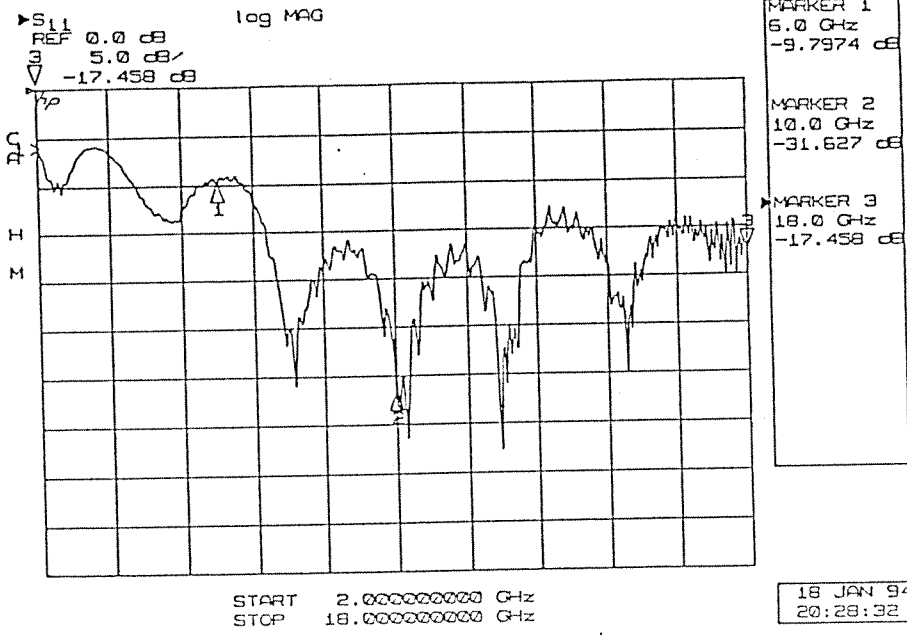
Şekil 10 6-18 GHz Frekans Bantlı Vivaldi Antenin Kazancı



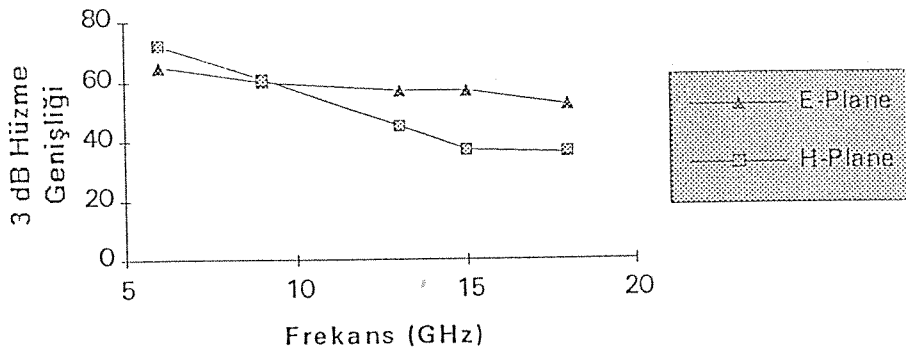
Şekil 11 6-18 GHz Frekans Bantlı Vivaldi Antenin 13 GHz deki Işıma Örüntüsü



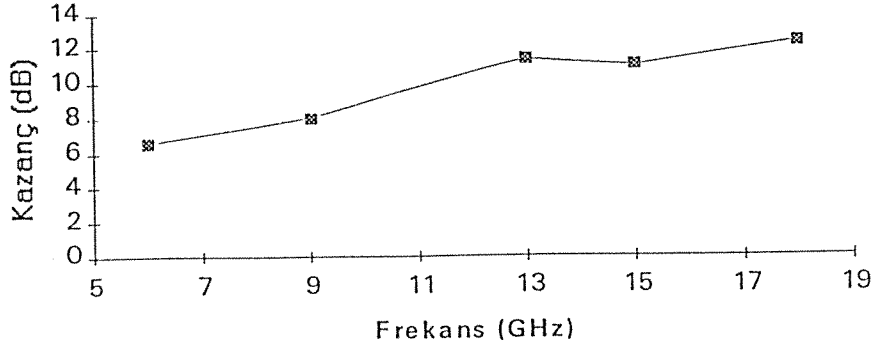
Şekil 12 6-18 GHz Frekans Bantlı Vivaldi Antenin 13 GHz deki Işıma Örüntüsü



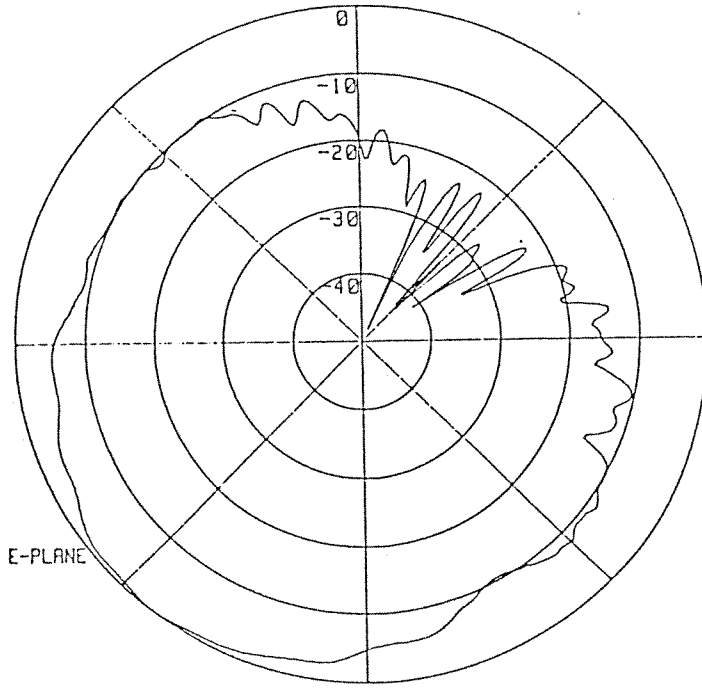
Şekil 13 Bir Dizi Elemanın Giriş Yansıma Katsayısı



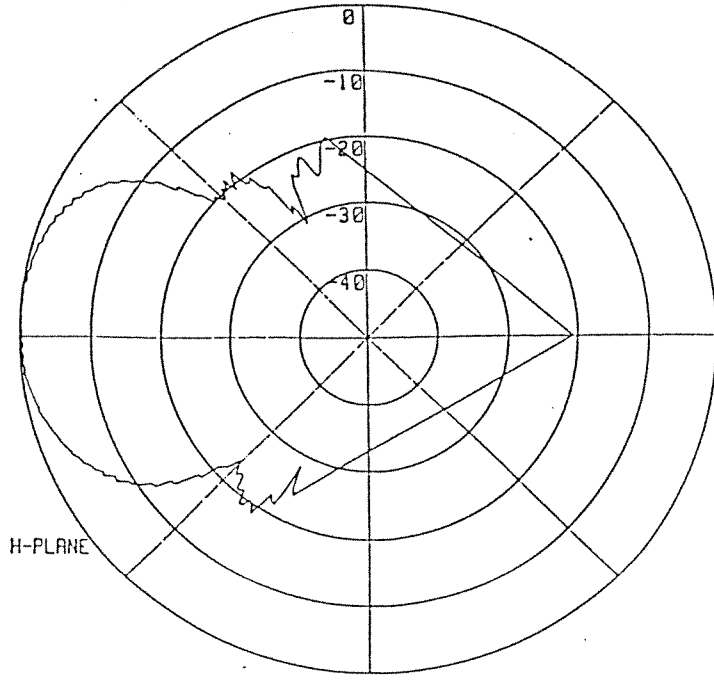
Şekil 14 Bir Dizi Elemanın 3 dB Hüzme Genişliği



Şekil 15 Bir Dizi Elemanının Kazancı



Şekil 16 Bir Dizi Elemanının 13 GHz deki Işıma Örüntüsü



Şekil 17 Bir Dizi Elemanın 13 GHz deki Işıma Örüntüsü

C3. DÜZLEMSEL MİKROŞERİT YAPILARIN İNCELENMESİNDE KULLANILAN MOM METODUNUN NÜMERİK İNTEGRASYONDAN ARINDIRILMASI

GİRİŞ

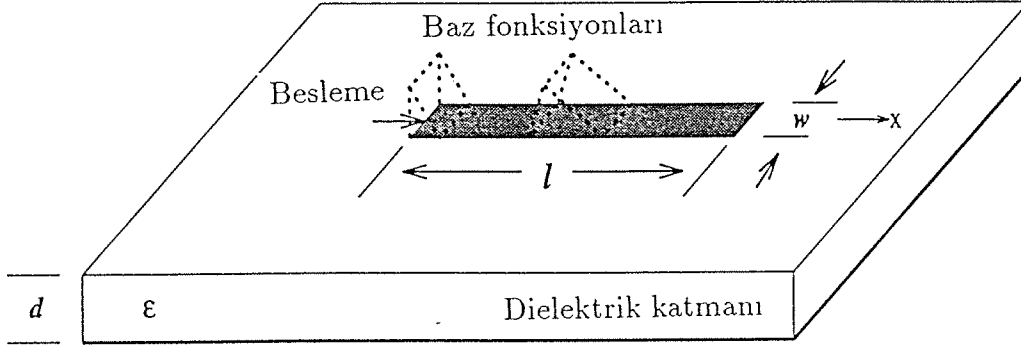
Anten dizilerinin ve monolitik mikrodalga entegre devrelerin (MMIC) tasarımında tüm dalga analizi yapan metodların gelişmesi büyük önem taşımaktadır. Anten dizilerinde ya da mikrodalga devrelerde birbirlerine yakın elemanların etkileşimi, sistemin performansı üzerinde büyük etki yaratmaktadır. Bu nedenle bu tür devrelerin analizinde nümerik bir metod olan Moment Metod (MoM) sık olarak kullanılmaktadır [1],[2]. Bu metod için hem izgesel uzayda hem de gerçek uzayda formülasyonlar mevcuttur. Ancak izgesel uzay formülasyonu çok hızlı salınan ve yavaş yakınsayan fonksiyonların sonsuz limitli ve iki-boyutlu integrallerinin nümerik olarak hesaplanmasını gerektirmektedir. Bu nedenle izgesel uzay uygulamalarında MoM matrisini doldurmak çok uzun zaman almaktadır. Bu metodu hızlandırmak için bazı yöntemler kullanılmasına rağmen, gerçek uzay formülasyonunda elde edilen gelişmelerden sonra izgesel uzay formülasyonu daha az tercih edilir olmuştur.

Gerçek uzay formülasyonundaki sorun ise yavaş yakınsayan izgesel uzay Green Fonksiyonunun Sommerfeld integrali (ya da Hankel Dönüşümü) adı verilen yüksek salınımlı bir integral aracılığı ile gerçek uzay Green Fonksiyonuna dönüştürülmesidir [3]. Bu sorun izgesel uzay Green Fonksiyonunun kompleks üsteller ile yakınlaştırılması ile çözülmüştür [4],[5]. Bu yöntem kullanıldığında gerçek uzay MoM matris elemanlarının hesaplanması, sınırlı bir aralıkta iki-boyutlu integrallerin nümerik olarak alınmasını gerektirmektedir. Bu çalışmada, bahsedilen iki-boyutlu integrallerin integral terimleri (integrand) Taylor Açılımı ile yakınlaştırılarak integraller analitik olarak hesaplanmıştır. Böylelikle gerçek uzay MoM formülasyonu hem nümerik integrasyondan kurtulmakta hem de hesaplama süresinde belirgin azalmalar elde edilmektedir.

Konu ile ilgili formülasyon ikinci bölümünde, mikroşerit bir hat üzerindeki uygulamada elde edilen sonuçlar ve karşılaştırmalar ise üçüncü bölümde sunulmaktadır.

FORMÜLASYON

Bu bölümde sunulan formülasyon, çok katmanlı ortamlardaki [6] üç boyutlu düzlemsel mikroşerit geometrilerine uygulanabilmektedir. Formülasyonun karmaşıklığına girmeden, sunulan metodun ana fikrini verebilmek amacı ile metod Şekil 1'de gösterilen tek katmanlı bir ortamdaki mikroşerit hat için uygulanmıştır.



Şekil 1 : Formülasyonun uygulandığı mikroşerit hat geometrisi

Mikroşerit hat için elde edilen karışık potansiyel integral denklemi, MoM kullanılarak matris denklemine dönüştürüldüğünde matris elemanları aşağıdaki iç çarpım kullanılarak hesaplanır [7]:

$$\langle T_{xm}, G_{xx}^A * B_{xn} \rangle + \frac{1}{\omega^2} \langle T_{xm}, \frac{\partial}{\partial x} \left(G_q * \frac{\partial}{\partial x} B_{xn} \right) \rangle \quad (1)$$

Bu denklemde B_{xm} baz fonksiyonu (basis function), T_{xm} test fonksiyonu, G^A vektör potansiyelin Green fonksiyonu ve G_q skalar potansiyelin Green fonksiyonu için kullanılmıştır.

Türev içermeyen terimde geliştirilen metod türevli terim için de aynı şekilde kullanılabilir. İlk iç çarpımdaki integrasyonun sırası değiştirildiğinde aşağıdaki ifade elde edilmektedir:

$$\langle T_{xm}, G_{xx}^A * B_{xn} \rangle = \int_{D_T} \int dx dy T_{xm}(x, y) \int_{D_B} \int dx' dy' G_{xx}^A(x - x', y - y') B_{xn}(x', y') \int \int du dv G_{xx}^A(u, v) \underbrace{\int \int dx dy T_{xm}(x, y) B_{xn}(x - u, y - v)}_{\text{korelasyon fonksiyonu } (T_{xm} \otimes B_{xn})} \quad (2)$$

Test ve baz fonksiyonları olarak akım yönünde üçgen, akıma dik yönde ise sabit olan çatı (rooftop) fonksiyonları seçildiğinde korelasyon fonksiyonu aşağıdaki şekilde ifade edilmektedir:

$$T_{xm} \otimes B_{xn} = f(u)g(v) \quad (3)$$

bu denklemde

$$\begin{aligned} f(u) &= \gamma_3 u^3 + \gamma_2 u^2 + \gamma_1 u + \gamma_0 \quad (m-n-2)h_x < u < (m-n+2)h_x \\ g(v) &= \frac{1}{h_y^2} \begin{cases} v + h_y & -h_y \leq v \leq 0 \\ -v + h_y & 0 \leq v \leq h_y \end{cases} \end{aligned} \quad (4)$$

Kompleks üsteller ile yakınlaştırma metodu kullanılarak gerçek uzay Green Fonksiyonu aşağıdaki formda elde edilmektedir.

$$G(x, y, z = 0) \cong \sum_{n=1}^N a_n \frac{e^{-jk r_n}}{r_n} \quad (5)$$

bu denklemde $r_n = \sqrt{x^2 + y^2 - \alpha_n^2}$ kompleks uzaklık ve k ise kaynak ortamındaki dalga numarasıdır.

Denklem (4)'de gösterilen korelasyon fonksiyonu ve (5)'de verilen Green fonksiyonu (2)'ye yerleştirildiğinde aşağıdaki integraller elde edilir.

$$\begin{aligned} & \frac{1}{h_y^2} \sum_{n=1}^N a_n \left[\gamma_0 \left(h_y \int \int \frac{e^{-jk_s r_n}}{r_n} dv du - \int \int \frac{e^{-jk_s r_n}}{r_n} v dv du \right) \right. \\ & + \gamma_1 \left(h_y \int \int \frac{e^{-jk_s r_n}}{r_n} u dv du - \int \int \frac{e^{-jk_s r_n}}{r_n} u v dv du \right) \\ & + \gamma_2 \left(h_y \int \int \frac{e^{-jk_s r_n}}{r_n} u^2 dv du - \int \int \frac{e^{-jk_s r_n}}{r_n} u^2 v dv du \right) \\ & \left. + \gamma_3 \left(h_y \int \int \frac{e^{-jk_s r_n}}{r_n} u^3 dv du - \int \int \frac{e^{-jk_s r_n}}{r_n} u^3 v dv du \right) \right] \end{aligned} \quad (6)$$

MoM uygulamalarında bu integraller nümerik olarak hesaplanmakta, bu da matris doldurma süresini çok arttırmaktadır. (6)'da verilen ilk integral terimindeki üstelin Taylor açılımı kullanılarak iki boyutlu integralin analitik olarak alınabileceği gösterilmiştir [8]. Bu bilgi ve bazı integral özellikleri [9] kullanılarak (6)'da verilen tüm integraller analitik olarak hesaplanmıştır.

$e^{-jk r_n}$ teriminin, R_c merkez noktası etrafında açılan m 'inci derecedeki Taylor açılımı için hata aşağıdaki denklem ile sınırlanmıştır.

$$\text{hata} \leq \frac{|k_s(r_n - R_c)|^{m+1}}{(m+1)!}$$

Taylor açılımı nedeniyle gelen hataya bir sınır koyabilmek amacıyla her integral için R_c , o integral aralığının orta noktası olarak seçilmiştir. Integral aralığı x yönünde $4h_x$, y yönünde $2h_y$ olduğu için $|r_n - R_c| \leq \sqrt{(2h_x)^2 + h_y^2}$. Bir dalga boyu için yirmi baz fonksiyonu seçildiğinde beşinci derecedeki Taylor açılımındaki hata 10^{-4} ile sınırlandırılmıştır. Bu hata sınırının sonuçta elde edilen akım dağılımını etkilemediği gözlenerek Taylor açılımındaki terim sayısı daha da arttırılmamıştır.

R_c etrafındaki beşinci dereceden Taylor açılımı kullanılarak $e^{-jk_s r_n}$ aşağıdaki şekilde yakınlaştırılmaktadır.

$$e^{-jk_s r_n} \approx \beta_0 + \beta_1 r_n + \beta_2 r_n^2 + \beta_3 r_n^3 + \beta_4 r_n^4 + \beta_5 r_n^5 \quad (7)$$

(6)'deki $e^{-jk_s r_n}$, (7)'deki Taylor açılımıyla yakınlaştırıldığında aşağıdaki integrallerin analitik olarak hesaplanması gerekmektedir.

$$\int \int r_n^j u^k v^l du dv \quad \text{for } j=-1,0,\dots,4, \quad k=0,\dots,3, \quad l=0,1 \quad (8)$$

Bu integraller kapalı formda elde edilmiştir. Böylelikle MoM nümerik integrallerden tam olarak arındırılmıştır. Önerilen metod test ve baz fonksiyonları polinom benzeri fonksiyonlar olduğu sürece uygulanabilmektedir.

SONUÇLAR

Bir önceki bölümde anlatılan yöntem mikroşerit bir hattın analizi için uygulanmıştır. Ortamın dielektrik sabiti $\epsilon_r = 4$, hattın genişliğinin katman kalınlığına olan oranı 4, katmanın kalınlığı 0.02032 cm , frekans 1 GHz ve hattın uzunluğu 10 cm 'dir. CPU zamanları SUN Sparc 10 iş istasyonu kullanılarak elde edilmiştir.

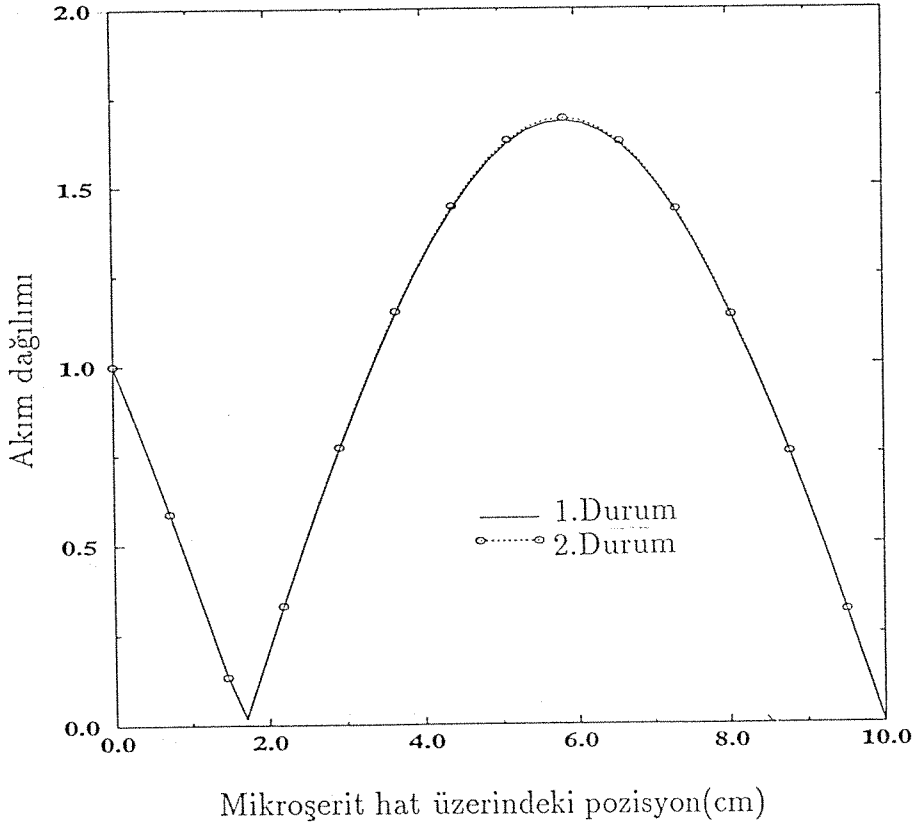
Hat üzerindeki akım dağılımı önce nümerik integrasyon (1. durum), daha sonra da analitik integrasyon yöntemi (2. durum) kullanılarak hesaplanmıştır. Nümerik integrasyon için, mevcut algoritmalar arasında en hızlılarından kabul edilen 16 noktalı Gauss integrasyon algoritması kullanılmıştır. İntegralin yakınsamasını garantilemek için integral aralığı alt aralıklara ayrılmıştır. Değişik sayıdaki baz fonksiyonları için CPU zamanlarının karşılaştırılması Tablo 1'de verilmiştir. 40 baz fonksiyonu kullanılarak ve iki ayrı yöntem ile elde edilen akım dağılımları Şekil 2 'de verilmiştir.

baz fonks. sayısı	CPU zamanı(saniye)(1.Durum)	CPU zamanı(saniye)(2.Durum)
10	13.3	0.36
20	27.0	0.65
30	39.0	0.98
40	52.95	1.33

Tablo 1 : İki ayrı yöntem ile elde edilen CPU zamanları

Tablo 1 incelendiğinde, analitik integrasyonun hesaplama süresinde 40 katlık bir hızlanma sağladığı gözlenmektedir. Nümerik integrasyonun kaldırılması ile MoM nümerik integrasyondan gelen hatalardan ve problemin yapısına uygun nümerik integrasyon algoritması bulmak için harcanan zamandan arındırılmıştır. Matris elemanları kapalı formda ifade edilebildiği için mikroşerit hattın genişliği, uzunluğu gibi parametrelerin akım dağılımı üzerindeki etkileri gerekli değişkenlere göre türev olarak gözlenebilmektedir.

I_x - Amps.



Şekil 2 : Elde edilen akım dağılımları

Bir tam dalga analiz yöntemi olan MoM, bu çalışmada önerilen yöntem ile hızlandırılarak herhangi bir düzlemsel mikroşerit yapısının (anten dizisi ya da MMIC devre) tasarımında uygun bir optimizasyon programı ile verimli olarak çalışabilecek bir metoda dönüştürülmüştür.

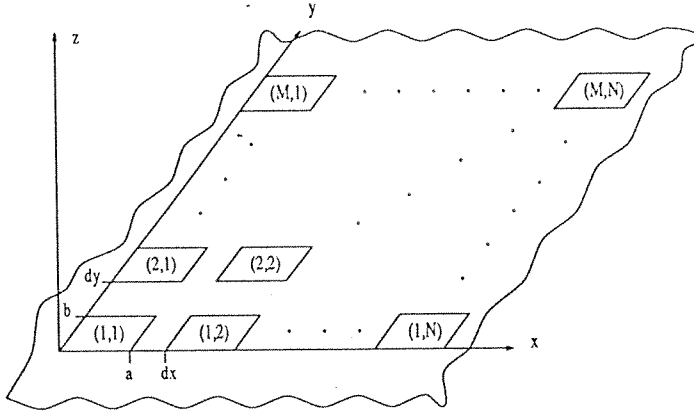
Kaynakça

- [1] R. F. Harrington, *Field Computation by Moment Methods*. New York: MacMillan; Florida; Krieger Publishing, 1983.
- [2] D. M. Pozar, "Input Impedance and Mutual Coupling of Rectangular Microstrip Antennas," *IEEE Trans. Antennas Propagat.*, vol. AP-30, pp. 1191-1196, Nov. 1982.
- [3] A. Sommerfeld, *Partial Differential Equations in Physics*. New York: Academic Press Inc., 1949.
- [4] Y. L. Chow, J. J. Yang, and D. F. Fang and G. E. Howard, "Closed form spatial Green's function for the thick substrate," *IEEE Trans. Microwave Theory Tech.*, vol. MTT-39, pp. 588-592, Mar. 1991.
- [5] M. I. Aksun and R. Mittra, "Derivation of closed-form Green's functions for a general microstrip geometries," *IEEE Trans. Microwave Theory Tech.*, vol. MTT-40, pp. 2055-2062, Nov., 1992.
- [6] G. Dural and M. I. Aksun, "Closed-form Green's functions for general sources and stratified media," submitted for publication.
- [7] J. R. Mosig and F. E. Gardiol, "General Integral Equation Formulation for Microstrip Antennas and Scatterers," *IEE Proc.*, pt. H, no. 7, vol. 132, pp. 424-432, 1985.
- [8] R. F. Harrington, "Matrix methods for field problems," *Proc. IEEE*, vol. 55, pp. 136-149, Feb. 1967.
- [9] K. Mahadevan and H. A. Auda, "Electromagnetic field of a rectangular patch of uniform and linear distributions of current," *IEEE Trans. Antennas Propagat.*, vol. AP-37, pp. 1503-1509, Dec. 1989.

C4. SONLU DİZİ ANTENLERİN İNTEGRAL DENKLEM SİSTEMİ İLE SİSTEMATİK ÇÖZÜMÜ

GİRİŞ

Bu çalışmada mükemmel iletken bir toprak yüzeye açılan dikdörtgen dalga kılavuzlarının oluşturduğu sonlu dizi antenler incelenmiştir. Dalga kılavuzları sadece temel kipi (TE_{10}) destekleyen eşit boyutlardadır. Dalga kılavuzları toprak yüzey üzerine istenildiği gibi (konum kiplenimli dizi elde edebilmek için) yerleştirilebilir. Şekil 1'de, hesaplamaları kolaylaştırmak için sonsuz yüzey üzerine eşit aralıklarla yerleştirilmiş bir dizi anten gösterilmiştir.



Şekil 1: $M \times N$ dizi anten.

Fenn v.d. [1] Şekil.1'de gösterilen dizi anteni moment metod tekniği kullanarak ve temel kipe dik olarak oluşan kipleri ihmal ederek küçük dizi eleman boyutları için çözmüştür. Aynı problemi Sharma v.d. [2] birbirlerinden uzak elemanlardan oluşan dizi antenler için sonuğur (asimtotik) yöntemlerle çözmüştür. Bu çalışmada, sonsuz bir yüzeye açılan dikdörtgen dalga kılavuzunun çözümü (H. Yavuz ve O.M. Büyükdura [3],[4]) dizi antenlere uyarlanmıştır.

Dalga kılavuzlarındaki ve yarı-uzaydaki alanlar uygun 'dyadic Green' işlevleri ve açıklıklar üzerindeki bilinmeyen alan dağılımları cinsinden yazılmış ve bütün açıklıklar üzerinde manyetik alanın yatay bileşeninin sürekliliği kullanılarak bir integral denklem sistemi

elde edilmiştir. Dalga kılavuzu kiplerinin dikgenlik (orthogonality) özelliği kullanılarak açıklıklar üzerindeki bilinmeyen alan dağılımının katsayıları için bir matris eşitliği elde edilmiştir. Bu hesaplamalarda dizi elemanlarının karşılıklı bağlaşımları da gözönüne alınmıştır.

Elde edilen matrisin en önemli özelliği dizi anten elemanlarının beslemesinden bağımsız olmasıdır. Matris, bir dizi anten için bir kere hesaplanıp tersi alındıktan sonra o dizi anten elemanlarının (ışık açıklıkların) alan dağılımlarını ve besleme noktasından görünen admitanslarını değişik besleme birleşimleri için bulunmasında kullanılabilir. Anten elemanları dikdörtgen ızgara biçiminde yerleştirilirse elde edilen matris blok 'Toeplitz' özelliğine sahip olacak ve matrisin hesaplama zamanı, saklama alanı büyük ölçüde azalacaktır.

FORMÜLASYON

Alan eşitlik prensibi kullanılarak Şekil.1'de verilen problem iki bölgeye ayrılmıştır, yani dalga kılavuzlarının ağız açıklıkları mükemmel bir elektriksel iletken ile örtülmüştür. Daha sonra bilinmeyen manyetik akımlar $-\vec{M}_p$ ve \vec{M}_p p'inci eleman ağızının sırasıyla yarı-uzay ve dalga kılavuzu tarafına yerleştirilmiştir; bu seçimle elektrik alanının enine bileşeninin p'inci elemanın ağız açıklığı boyunca devamlılığı sağlanmıştır. Bütün elemanlar istenen tarama açısında ışınım yapması için uygun biçimde evrelendirilmiş temel TE_{10} kipi ile beslenmiştir.

$$\vec{M}_p = \hat{z} \times \vec{E}_p \quad p = 1, 2, \dots, M \times N \quad (1)$$

burada $M \times N$ dizi anten elemanlarının sayısıdır.

Yarı-uzaydaki ve p'inci dalga kılavuzundaki elektrik alanları dizi elemanlarının ağız açıklıklarındaki bilinmeyen manyetik akımlar cinsinden yazılabilirler:

$$\vec{E}^{hs}(\vec{R}) = - \sum_{p=1}^{M \times N} \int_{S_p} [\nabla \times \vec{\Gamma}_2^{hs}(\vec{R}, \vec{R}')] [\hat{z} \times \vec{E}_p(\vec{R}')] ds' \quad (2)$$

$$\vec{E}_p(\vec{R}) = \hat{y} A_p \sin \frac{\pi}{a} x (e^{-jk_{z10}z} - e^{jk_{z10}z}) - \int_{S_p} [\nabla \times \vec{\Gamma}_2^{wg}(\vec{R}, \vec{R}')] \cdot [-\hat{z} \times \vec{E}_p(\vec{R}')] ds' \quad (3)$$

burada

$$k_{z10} = \sqrt{k^2 - \left(\frac{\pi}{a}\right)^2} \quad (4)$$

A_p p'inci dalga kılavuzunun beslemesinin büyüklüğünü ve evresini, s_p p'inci dalga kılavuzunun ağız açıklığını, \vec{R}' s_p üzerindeki bir noktayı, $\overline{\Gamma}_2^{hs}$ yarı-uzay 'dyadic Green' işlevini, $\overline{\Gamma}_2^{wg}$ ağız açıklığı mükemmel bir elektriksel iletken ile örtülmüş yarı-sonsuz dalga kılavuzunun 'dyadic Green' işlevini gösterir. Bu 'dyadic Green' işlevleri aşağıdaki gibi bulunmuştur:

$$\overline{\Gamma}_2^{hs}(\vec{R}, \vec{R}') = -2\left(\overline{I} + \frac{\nabla\nabla}{k^2}\right)G_0(\vec{R}, \vec{R}') \quad (5)$$

$$\overline{\Gamma}_2^{wg}(\vec{R}, \vec{R}') = \sum_{m=0}^{\infty} \sum_{n=0}^{\infty} \frac{2(2 - \delta_0)}{abk_{zmn}k_c^2} [j\vec{M}_{omn}^<(\vec{R})\vec{M}_{omn}^>(\vec{R}') + \vec{N}_{emn}^<(\vec{R})\vec{N}_{emn}^>(\vec{R}')] \quad (6)$$

burada

$$G_0(\vec{R}, \vec{R}') = \frac{e^{jk|\vec{R}-\vec{R}'|}}{4\pi|\vec{R}-\vec{R}'|}, \quad \overline{I} = \hat{x}\hat{x} + \hat{y}\hat{y} + \hat{z}\hat{z} \quad (7)$$

\overline{I} birim 'dyad' ı, G_0 serbest-uzay sayıl Green işlevini, \vec{M} ve \vec{N} ise dikdörtgen dalga kılavuzu geometrisine uygun vektörel Hansen dalga işlevlerini göstermektedir.

Elektrik alanının enine bileşenleri dalga kılavuzlarının ağız açıklıklarında ($z = 0$) bilinmeyen katsayılarla çarpılmış dalga kılavuzu kiplerinin toplamı halinde yazılarak çözüme ulaşılmıştır:

$$\vec{E}_p(\vec{R}')|_{z'=0} = \sum_m \sum_n c_{mn}^p \vec{n}_{omn}(x', y') + d_{mn}^p \vec{m}_{emn}(x, y) \quad (8)$$

burada \vec{m} , \vec{n} dalga kılavuzu kiplerini ve d_{mn} , c_{mn} sırasıyla TE ve TM kiplerinin bilinmeyen katsayılarını göstermektedir. Daha sonra bütün elemanların ağız açıklıkları boyunca manyetik alanın enine bileşeninin sürekliliği uygulanmıştır.

$$\nabla \times \vec{E}^{hs}(\vec{R})|_{R s_p \text{ üzerinde}} = \nabla \times \vec{E}_p^{wg}(\vec{R})|_{R s_p \text{ üzerinde}} \quad p = 1, 2, \dots, M \times N \quad (9)$$

Elde edilen eşitliklerin test işlevleriyle (dalga kılavuzu kipleri) sayıl çarpımları alınıp (Galerkin yöntemi) bütün elemanların ağız açıklığı boyunca manyetik alanın x ve y bileşenlerinin sürekliliği için iki eşitlik sistemi elde edilmiştir. Bu eşitlikler aşağıdaki gibi yazılabilir.

$$\sum_{k=1}^N \left(\sum_m \sum_n X_{mn,li}^{pk} d_{mn}^k + Y_{mn,li}^{pk} c_{mn}^k \right) = T_{li}^p \quad (10)$$

$$\sum_{k=1}^N \left(\sum_m \sum_n Z_{mn,li}^{pk} d_{mn}^k + W_{mn,li}^{pk} c_{mn}^k \right) = 0 \quad (11)$$

burada $p = 1, 2, \dots, M \times N$. Eşitlik (10) ve (11) deki X , Y , Z ve W iki boyutlu integrallerdir ve integral sınırları içinde tekil noktalar vardır. İntegrallerdeki tekilliklerle

şedebilmek için serbest-uzay sayıl Green işlevi G_0 bir düzlem dalgası izgesi (spektrumu) iminde yazılmıştır.

$$G_0(\vec{R}, \vec{R}') = -\frac{j}{8\pi^2} \int_{-\infty}^{\infty} \int_{-\infty}^{\infty} \frac{e^{-j[\beta_x(x-x')+\beta_y(y-y')+\beta_z|z-z'|]}}{\beta_z} d\beta_x d\beta_y \quad (12)$$

rmülasyonun bakışlılık (simetri) özellikleri kullanılarak eşitlik (10) ve (11) dakiğişkenler aşağıdaki gibi 0 dan ∞ a iki boyutlu integraller olarak yazılabilir:

$$\begin{aligned} X_{mn,lp}^{jk} &= -\frac{32}{\pi^2} \int_0^{\infty} \int_0^{\infty} \frac{d\beta_x d\beta_y}{\beta_z} A(\beta_x, \beta_y) B(\beta_x, \beta_y) \beta_y^2 \left(\frac{l\pi}{a}\right) \\ &\quad \left\{ \beta_x^2 \left[\left(\frac{m\pi}{a}\right)^2 + \left(\frac{n\pi}{b}\right)^2 \right] - k^2 \left(\frac{m\pi}{a}\right)^2 \right\} \cos(\beta_x(x_k - x_j)) \cos(\beta_y(y_k - y_j)) \\ &+ k_{zlp} \left(\frac{l\pi}{a}\right) \left(\frac{ab}{4}\right) S_{lp} \delta(l - m, p - n) \delta(k - j) \end{aligned} \quad (13)$$

$$\begin{aligned} Y_{mn,lp}^{jk} &= -\frac{32}{\pi^2} \int_0^{\infty} \int_0^{\infty} \frac{d\beta_x d\beta_y}{\beta_z} A(\beta_x, \beta_y) B(\beta_x, \beta_y) \beta_y^2 \left(\frac{l\pi}{a}\right) \\ &\quad \left[-k^2 \left(\frac{m\pi}{a}\right) \left(\frac{n\pi}{b}\right) \right] \cos(\beta_x(x_k - x_j)) \cos(\beta_y(y_k - y_j)) \\ &+ \frac{k^2}{k_{zlp}} \varepsilon_{lp} \left(\frac{p\pi}{b}\right) \left(\frac{ab}{4}\right) S_{lp} \delta(l - m, p - n) \delta(k - j) \end{aligned} \quad (14)$$

$$\begin{aligned} Z_{mn,lp}^{jk} &= -\frac{4}{\pi^2} \int_0^{\infty} \int_0^{\infty} \frac{d\beta_x d\beta_y}{\beta_z} A(\beta_x, \beta_y) B(\beta_x, \beta_y) \beta_x^2 \left(\frac{p\pi}{b}\right) \\ &\quad \left\{ \beta_y^2 \left[\left(\frac{m\pi}{a}\right)^2 + \left(\frac{n\pi}{b}\right)^2 \right] - k^2 \left(\frac{n\pi}{b}\right)^2 \right\} \cos(\beta_x(x_k - x_j)) \cos(\beta_y(y_k - y_j)) \\ &+ k_{zlp} \left(\frac{p\pi}{b}\right) \left(\frac{ab}{4}\right) U_{lp} \delta(l - m, p - n) \delta(k - j) \end{aligned} \quad (15)$$

$$\begin{aligned} W_{mn,lp}^{jk} &= -\frac{4}{\pi^2} \int_0^{\infty} \int_0^{\infty} \frac{d\beta_x d\beta_y}{\beta_z} A(\beta_x, \beta_y) B(\beta_x, \beta_y) \beta_x^2 \left(\frac{p\pi}{b}\right) \\ &\quad k^2 \left(\frac{m\pi}{a}\right) \left(\frac{n\pi}{b}\right) \cos(\beta_x(x_k - x_j)) \cos(\beta_y(y_k - y_j)) \\ &\quad - \frac{k^2}{k_{zlp}} \varepsilon_{lp} \left(\frac{l\pi}{a}\right) \left(\frac{ab}{4}\right) U_{lp} \delta(l - m, p - n) \delta(k - j) \end{aligned} \quad (16)$$

$$T_{lp}^j = k_{z10} V_j \sqrt{2ab} \delta(l - 1, p) \quad (17)$$

$$A(\beta_x, \beta_y) = e^{j\left(\frac{\beta_x a + m\pi}{2}\right)} \frac{\sin\left(\frac{\beta_x a + m\pi}{2}\right)}{\beta_x^2 - \left(\frac{m\pi}{a}\right)^2} e^{j\left(\frac{\beta_y b + n\pi}{2}\right)} \frac{\sin\left(\frac{\beta_y b + n\pi}{2}\right)}{\beta_y^2 - \left(\frac{n\pi}{b}\right)^2} \quad (18)$$

$$B(\beta_x, \beta_y) = e^{-j\left(\frac{\beta_x a + l\pi}{2}\right)} \frac{\sin\left(\frac{\beta_x a + l\pi}{2}\right)}{\beta_x^2 - \left(\frac{l\pi}{a}\right)^2} e^{-j\left(\frac{\beta_y b + p\pi}{2}\right)} \frac{\sin\left(\frac{\beta_y b + p\pi}{2}\right)}{\beta_y^2 - \left(\frac{p\pi}{b}\right)^2} \quad (19)$$

ları gelişigüzel yerleştirilebilir, yani konum kiplenimli dizi antenler de verilen yöntemle çözülebilir. Bağlaşım matrisi C dizi elemanlarının beslemelerinden bağımsız olduğu için verilen anten geometrisi için bir kez hesaplanıp tersi alınacaktır. Daha sonra herhangi bir besleme için aynı matris dizinin çözümünde kullanılacaktır.

Şekil.1 de verilen dikdörtgen ızgara şeklinde bir dizi için bağlaşım matrisi C block-Toeplitz biçimindedir ve C nin her Toeplitz bloğu yine Toeplitz biçimindedir. C nin bu özellikleri kullanıldığında problemin çözümü için kullanılan bilgisayar zamanı ve saklama alanı azalacaktır.

KAYNAKÇA

- [1] A.J.Fenn, v.d., "Moment Method Analysis of Finite Rectangular Waveguide Phased Arrays", *IEEE Trans. Antennas Propagat.*, vol. AP-30, No. 4, July 1982.
- [2] M. G. Sharma v.d., "Admittance Analysis of Nonuniformly Spaced Phased Arrays of Waveguide Apertures in a Ground Plane", *IEEE Trans. AP*, vol. AP-30, No. 5, pp. 432-437, Mayıs, 1982.
- [3] H.Yavuz, Full-Mode Analysis of Finite Rectangular Phased Arrays, Doktora Tezi (basılacak), Orta Doğu Teknik Üniversitesi Elektrik Elektronik Mühendisliği Bölümü.
- [4] O.M. Büyükdura ve H. Yavuz, "Sonlu bir İletken Yüzey Üzerindeki Anten Dizi Elemanlarının Karşılıklı ve Öz Admitansları", Elektrik Mühendisliği 5. Ulusal Kongresi, Eylül 1993.
- [5] R. Piessens, v.d., *Quadpack a Subroutine Package for Automatic Integration*, Berlin: Springer-Verlag, 1980.

III SONUÇ :

Türkiye, COST 245 projesinde oluşturulan üç çalışma grubunda da projenin genel amaçlarına uygun olarak katkıda bulunmuş, proje faaliyetlerinin eşgüdümünün amaçlandığı yönetim kurulu toplantılarına katılmış, ürettiği bilgileri projenin çeşitli toplantılarında tartışmış ve diğer ülke ekiplerinin çalışmalarını izlemiştir.

COST 245 projesi çerçevesinde üzerinde çalışılması planlanan konular kapsamında ekibimiz çalışmalarını başlıca üç ana bölümde yürütmüştür: A. Faz taramalı anten dizileri, B. Monolitik mikrodalga entegre devreleri (MMIC), C. Geniş bantlı antenler ve nümerik metotlar.

İlk bölümde, uydu yayınlarını televizyon alıcıları ile alabilmeye uygun düzlemsel anten dizisi tasarım ve analizine yönelik çalışmalar yapılmıştır. Tasarlanacak anten dizisinin hem Avrupa hem de Türkiye'den izlenebilen TV yayını verici uydularına uygun olması ön planda tutulmuş ve bu uydulara ilişkin spesifikasyonların belirlenmesi için bir ön çalışma yapılmıştır. Daha sonra mikroşerit yapılarla yapılması öngörülen anten dizilerinin pratik kısıtlamaları incelenmiştir. Ön çalışmalarda iki kutuplu (dual polarization) ve iki hüzmeli anten dizisinin pratik olmadığına görülmesi üzerine, çalışmalar tek kutuplu ve tek hüzmeli alıcı antenler üzerinde yoğunlaştırılmıştır. Bu amaca en uygun anten dizisi yapısının iki seviyeli paralel kol besleme yapısı olduğu görülerek tasarım aşamasına geçilmiştir.

Anten dizisi tasarım çalışmasına paralel olarak anten dizilerinin, yönlülük (directivity), gürültü sıcaklığı gibi performans kriterleri üzerinde analitik çalışmalar sürdürülmüştür. Yüksek kazanç ve düşük gürültü performansına sahip bir anten dizisinin aktif anten dizileri ile gerçekleştirilebileceğinin belirlenmesi üzerine aktif anten dizilerinin gürültü performansının belirlenmesi yanında doğrusallık kriteri de gözönüne alınmış ve aktif anten dizilerine yerleştirilebilecek yükselteçler üzerine analiz, tasarım ve benzetim çalışmaları yapılmıştır.

Tasarım çalışmalarının ardından üretim ve ölçüm çalışmalarına geçilmiş ve mikroşerit yapılarının ölçümlerinin yapılmasına uygun ölçüm düzenekleri geliştirilmiştir. Mikroşerit hatlar ve yama antenler tasarlanarak üretilmiş ve ölçülerek simülasyon sonuçları ile karşılaştırılmıştır. Ölçüm sonuçlarının tasarım değerleri ile uygun olmasının belirlenmesinin ardından anten alt dizileri ve ardından anten dizileri üretilerek ölçümleri yapılmıştır.

Alternatif anten dizi çalışması olarak silindirik yüzeylerde mikroşerit anten dizileri de incelenmiştir.

Akıllı anten özellikleri taşıyan doğrusal bir alıcı anten dizisi tasarımı ve üretimi yapılmıştır. Bu dizi yön bulma ve sayısal hüzme oluşturma yeteneklerine sahip olacak biçimde tasarlanmış ve bu özellikleri ölçümler yoluyla sınanmıştır.

Çalışmaların ikinci bölümü MMIC çalışmalarına ayrılmıştır. Radar ve uydu uygulamalarında, aktif anten kavramı giderek önemini arttırmaktadır. Bu tür antenlerde aktif elemanlar anten dizisi elemanlarıyla birleştirilerek anten performansında belirgin iyileştirmeler elde edilebilmektedir. Büyük ölçekli anten dizilerinde çok sayıda aktif eleman kullanılması gerektiğinden, gerek küçük boyutlar ve hafiflik ve gerekse ucuzluk açısından MMIC uygulamalarına gereksinim duyulmaktadır. Bu avantajları göz önünde bulundurularak, proje kapsamında bir aktif anten dizisinde yer alması sözkonusu devrelerden aşağıda belirtilenler üzerinde çalışmalar yürütülmüştür:

- 1- Dar ve geniş bantlı yükselteçler,
- 2- Voltaj kontrollü osilatör,
- 3- Karıştırıcı,
- 4- Düşük gürültülü yükselteç,
- 5- Alıcı/verici anahtar,
- 6- Güç yükselteci,
- 7- Geniş bantlı voltaj kontrollü zayıflatıcı,
- 8- Faz kaydırıcı.

Tüm devrelerin tasarım ve optimizasyonu, LIBRA ve ACADEMY yazılım paketleri kullanılarak ve GEC-MARCONI firmasının F-20 proses kurallarına göre yapılmıştır. Bu devrelerin tasarımı, üretim aşamasında maliyeti düşürmek için elektriksel performansdan ödün vermeksizin en az yonga alanı kapsayacak şekilde yapılmıştır. Şu ana kadar bunlardan ilk beş maddede belirtilen devreler üretilmiş ve performansları ölçülmüştür. Ölçüm sonuçlarıyla daha önce elde edilen bilgisayar simülasyon sonuçlarının çok iyi uyum içinde oldukları görülmüştür. Bu sonuç, tasarım aşamasında kullanılan aktif ve pasif eleman modellerinin gerçekçi ve yeterince doğru olduğunu göstermektedir. MMIC devreleri üzerinde tasarımdan sonra herhangi bir değişiklik veya düzeltme yapılması mümkün olmadığından, tasarım aşamasında modelleme açısından çok titiz davranılması önemli olmaktadır.

Üretilen MMIC devrelerinin diğer devreler ve anten elemanları ile birlikte kullanılabilmesi için özel bağlantı tekniklerinin (bonding) uygulanması gereklidir. Bu bağlantılar sonucunda devrelerin performansında, az da olsa, bir takım değişikliklerin olması doğaldır.

Çalışmaların üçüncü bölümünde milimetrik dalga bandında iki ve üç ferit-dielektrik katmanlı antenlerle elektronik hüzme taraması konusu incelenmiş ve uygun madde seçimiyle, D.C. manyetik alanı değiştirerek ışın demetinin şeklinin değiştirilebileceği ve elektronik hüzme taraması elde edilebileceği görülmüştür. Geniş bantlı Vivaldi

antennelerle ilgili çalışmalarda ise tasarlanan ve üretilen antenlerin elektriksel performans özellikleri tatmin edicidir. Dairesel Vivaldi anten dizisi, monopols genlik ya da faz karşılaştırılma yön bulma sistemlerinde kullanılabilir. Bu bölümde ayrıca, bir tam dalga nümerik analiz yöntemi olan MoM (Method of Moments) nümerik entegrasyondan arındırılarak hızlandırılmış ve herhangi bir düzlemsel mikroşerit yapısının (anten dizisi veya MMIC devre) tasarımında uygun bir optimizasyon programı ile verimli olarak çalışabilecek bir metoda dönüştürülmüştür. Son olarak mükemmel iletken bir toprak yüzeye açılan dikdörtgen dalga kılavuzlarının oluşturduğu dizi antenler incelenmiş ve bu yapıların bir integral denklem sistemi ile sistematik çözümü yapılmıştır.

Bütün bu çalışmalarla ilgili teknik bilgiler ve varılan sonuçlar, her çalışmanın anlatıldığı bölümde ayrıntılı bir biçimde yer almıştır.

Proje kapsamında ortaya çıkan 16 adet yurt içi ve yurt dışı yayın da ekte sunulmuştur.

İleriye dönük başlıca araştırma önerileri:

Yeni oluşturulmakta olan COST 260 Adaptif Anten Dizileri projesi konularının bir kısmı, COST 245 projesinde ekibimiz tarafından gerçekleştirilen çalışmaların devamı niteliğindedir. Bu yeni projede yine aktif anten sistemleri konu alınmakta, ancak anten dizilerine, sinyal işleme teknikleri kullanmak suretiyle adaptif bir özellik kazandırarak, programlanabilir "akıllı anten dizileri" (smart antenna arrays) elde edilmesi amaçlanmaktadır. Akıllı antenlerin en önemli özelliği adaptif olmasıdır. Bu antenlerde hüzme kontrolü, hüzme formasyonu, çıkış gücü kontrolü, sayısal teknikler ve bilgisayar yardımı ile yapılmaktadır. Bu tür anten dizilerinde, anten elemanları ayrı ayrı kontrol edilebilmektedir. Kullanılan teknoloji, MMIC, VLSI ve mikroşerit anten dizileri ile ilgili teknolojilerdir.

Bu hususlar gözönünde bulundurularak, aşağıda belirtilen konularda çalışmalar yapılması önerilmektedir:

- 1- Mikroşerit antenler ve özellikle de çok katlı ve yarık-kuplajlı (aperture/slot coupled) antenler üzerindeki çalışmaların devam etmesi,
- 2- Antenlerdeki, genlik ve faz kontrolü için MMIC çalışmalarının devam etmesi,
- 3- Adaptif antenlerde hüzme formasyonu için algoritma geliştirilmesi,
- 4- Prototip bir adaptif anten tasarlanarak laboratuvar koşullarında denenmesi.

EK I:
YAYINLAR

YAYINLAR

- 1) Kinayman, G. Dural, M. I. Aksun, "A Numerically Efficient Technique for the Analysis of Slots in Multilayer Media", *IEEE Trans. MTT* de yayımlanmak üzere kabul edildi.
- 2) L. Alatan, M. I. Aksun, K. Mahadevan, M. T. Birand, "Analytical Evaluation of MoM Matrix Elements", *IEEE Trans. MTT*, Vol. 44, No. 4, Nisan 1996, sf. 519-525
- 3) G. Dural, M. I. Aksun, "Closed form Green's Functions for General Sources and Stratified Media", *IEEE Trans. MTT*, Vol. 43, No. 7, Temmuz 1995, sf. 1545-1552.
- 4) M. I. Aksun, G. Dural, "Comparative Evaluation of Absorbing Boundary Conditions Using Green's Functions for Layered Media", *IEEE Trans. AP*, Vol. 44, No. 2, Şubat 1996, sf. 152-156.
- 5) Ş. Demir, C. Toker, A. Hızal, "Design of a Active Microstrip Array Using Microwave Simulator", *IEEE MTT-S Top. Symp. on Tech. for Wireless Appl.*, Vancouver, Kanada, Şubat 1997, sf. 103-106.
- 6) Ş. Demir, C. Toker, A. Hızal, "A Novel Low Noise Active circuit Replacement Criteria for Parallel Fed Large Scale Active Antenna Arrays", *27th European Microwave Conference*, Kudüs, İsrail, Ekim 1997, sf. 56-61.
- 7) L. Alatan, M. I. Aksun, M. T. Birand, "Use of Computationally Efficient Spatial-Domain Method of Moments in CAD of Microstrip Antennas", *COST 245 ESA Workshop on Active Antennas*, ESTEC, Noordwijk, Hollanda, 27-28 Haziran 1996, sf. 13-15.
- 8) A. Hızal, Ş. Demir, L. Alatan, C. Bulutay, H. Yıldız, "Performance of a 10 Ghz, 32 Elements Receiving Planar Microstrip Antenna Array", *COST 245 ESA Workshop on Active Antennas*, ESTEC, Noordwijk, Hollanda, 27-28 Haziran 1996, sf. 205-209.
- 9) L. Alatan, M. I. Aksun, M. T. Birand, "Computationally Efficient Analysis and Design of Printed Structures", *IEEE AP International Symposium*, Baltimore, MD, 1996, sf. 276-279.
- 10) Ö. Aydın, A. Hızal, "Radiation of Dipoles in Multilayered Cylinder with Ferrite Layer", *IEEE AP International Symposium*, Baltimore, MD, 1996, sf. 1836-1939.
- 11) H. Yavuz, M. Büyükdura, "Mutual Coupling Effects of Finite Rectangular Phased Arrays", *IEEE AP international Symposium*, Saettle, WA, 1996, sf. 418-421.
- 12) C. Birdir, N. Günalp, "MMIC Teknolojisi Kullanılarak Tasarınlanmış Voltaj Kontrollü Osilatör", *Elektrik Mühendisliği 6. Ulusal Kongresi*, Bursa, Eylül 1995 sf. 684-687.
- 13) F. Üstüner, N. Günalp, "MMIC Teknolojisiyle Düşük Gürültülü Yükselteç ve Anten Anahtarı Tasarımı", *Elektrik Mühendisliği 7. Ulusal Kongresi*, Ankara, 1997 sf. 244-247.
- 14) Ç. Tokgöz, G. Dural, "Çok Katmanlı Silindirik Yapılardaki Genel Akım Kaynakları için Gerçek Uzayda Kapalı Formda Green Fonksiyonlarının Çıkarılması", *Elektrik Mühendisliği 7. Ulusal Kongresi*, Ankara, 1997 sf. 280-283.
- 15) Ş. Demir, C. Toker, A. Hızal, "Özgün Düşük Gürültülü Aktif Anten Dizisi Analiz ve Tasarım Yöntemi", *Elektrik Mühendisliği 7. Ulusal Kongresi*, Ankara, 1997 sf. 319-322.

A Numerically Efficient Technique for the Analysis of Slots in Multilayer Media

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Abstract— A numerically efficient technique for the analysis of slot geometries in multilayer media is presented using closed-form Green's functions in spatial domain in conjunction with the Method of Moments. The slot is represented by an equivalent magnetic current distribution which is then used to determine the total power crossing through the slot and the input impedance. In order to calculate power and current distribution, spatial-domain closed-form Green's functions are expanded as power series of the radial distance, ρ , which makes the analytical evaluation of the spatial-domain integrals possible saving considerable amount of computation time.

I. INTRODUCTION

Slot geometries have broad spectrum of applications either as transmission lines or radiating elements and have been examined extensively in the literature [1;2;3;4]. The most commonly used numerical technique for analyzing the slot geometries is the Method of Moments (MoM) which can be applied either in spatial domain or

in spectral domain. Although the MoM is preferred over the differential equation methods because it is relatively efficient in terms of the computation time, it is still time consuming because of the slow convergence and the oscillatory nature of the integrals involved. One approach to overcome these difficulties is to employ the closed-form Green's functions in the spatial domain that can speed up the computation of the MoM matrix elements by several orders of magnitude as compared to the numerical evaluation of the Sommerfeld integral [5;6;7;8].

In this paper, the Galerkin's MoM analysis of the slot geometries in multilayer media has been developed by employing the closed-form Green's functions for the vector and scalar potentials of a horizontal magnetic dipole (HMD) in the spatial domain [9]. The formulation is presented for narrow slot geometries excited with coaxial-line feed, however it can be applied to slot geometries of any kind of excitation without any major modification. The equivalent magnetic current distribution of the slot is computed and used for the computation of power crossing the slot and the input impedance. Numerical calculation of the power crossing the slot and equivalent magnetic slot current are computationally very demanding procedure because the numerical evaluation of the integrals involved is very time consuming either in the spatial domain or in the spectral domain. Here, the spatial-domain Green's functions are approximated as power series of radial distance, ρ , and integrals involving the Green's functions are carried out analytically saving considerable amount of computational time both in current and power calculations [10].

II. FORMULATION

An example of a narrow slot placed in a multilayer medium is shown in Fig. 1. It is assumed that the layers extend to infinity in the transverse direction and the slot is excited with a coaxial-line of current I_{in} amperes at the feeding point. It is also assumed that there is no conducting or dielectric losses, therefore the only loss

mechanism is the radiation.

The tangential component of the magnetic field on the slot can be expressed in terms of an equivalent magnetic current density, \vec{J}^m , using the MPIE formulation [11] as follows:

$$H_x = -j\omega G_{xx}^F * J_x^m + \frac{1}{j\omega} \frac{\partial}{\partial x} \left(G_x^{qm} * \nabla \cdot \vec{J}^m \right) \quad (1)$$

where J_x^m is the longitudinal component of the current density \vec{J}^m , G_{xx}^F and G_x^{qm} are the spatial-domain Green's functions for the vector and scalar magnetic potentials for an HMD, respectively. To solve the equivalent magnetic current density J_x^m using the MoM, the current density is expressed as a linear combination of suitable sub-domain basis functions in the following form:

$$J_x^m = \sum_{n=1}^N I_{xn} B_{xn}(x, y) \quad (2)$$

where B_{xn} 's are the basis functions which are chosen in this work to be the rooftops. Since a narrow slot is assumed, the current variation in the \hat{y} direction is considered to be constant. Enforcing the boundary conditions for the tangential fields, the following equation is obtained:

$$\begin{aligned} \langle T_{xm}, J_s \delta(x-d) \rangle &= \left\langle T_{xm}, \left(G_{xx}^F|_{z<0} + G_{xx}^F|_{z>0} \right) * J_{xn}^m \right\rangle \\ &+ \frac{1}{\omega^2} \left\langle T_{xm}, \frac{\partial}{\partial x} \left[\left(G_x^{qm}|_{z<0} + G_x^{qm}|_{z>0} \right) * \frac{\partial J_{xn}^m}{\partial x} \right] \right\rangle \end{aligned} \quad (3)$$

where T_{xm} denotes the testing functions expressed by sub-domain basis functions, $\langle \cdot, \cdot \rangle$ designates the inner product, and $*$ designates the convolution between the basis and the Green's functions. Note that the Green's functions appearing in Eq. (3) are the spatial-domain closed-form Green's functions which can be obtained through the closed-form spectral-domain Green's functions [9] by numerically evaluating the Sommerfeld integral [6;12]. The spatial-domain closed-form Green's functions are expressed in the following form:

$$G_{xx,x}^{F,qm} \cong \sum_{m=1}^N a_m \frac{e^{-jk_i r_m}}{r_m} \quad (4)$$

where $r_m = \sqrt{\rho^2 - b_m^2}$, and $k_i^2 = k_{z_i}^2 + k_\rho^2$. Here, a_m 's and b_m 's are the complex constants in general. Consequently, for the slot geometry given in Fig. 1, the spatial-domain Green's functions encountered in Eq. (3) can be written as follows:

$$G_{xx}^F = \begin{cases} 2 \frac{\epsilon_0}{4\pi} \frac{e^{-jk_0 r}}{r} & : z > 0 & (5a) \\ \sum_{m=1}^M a_m \frac{e^{-jk r_m}}{r_m} & : z < 0 & (5b) \end{cases}$$

$$G_x^{qm} = \begin{cases} 2 \frac{1}{4\pi\mu_0} \frac{e^{-jk_0 r}}{r} & : z > 0 & (6a) \\ \sum_{n=1}^N a_n \frac{e^{-jk r_n}}{r_n} & : z < 0 & (6b) \end{cases}$$

After evaluating the closed-form Green's functions, the remaining job is to evaluate the related integrals. In this work, each exponential term in the above Green's functions is expanded as a power series of ρ which makes the analytical evaluation of the inner products in Eq. (3) possible saving considerable amount of computational time [10]. Also note that since the spatial-domain Green's functions have a surface integrable singularity at the origin, analytical evaluation of these integrals does not need the extraction of singularity.

2.1. Calculation of the Total Power and Input Impedance

Once the equivalent magnetic current density on the slot is obtained, then the power crossing through the slot can be calculated by using the following integral:

$$-P_c = \iint_{slot} \vec{E} \times \vec{H}^* \cdot d\vec{s} \quad (7)$$

where

$$(\vec{E} \times \vec{H}^*)_z = E_x H_y^* - E_y H_x^* \quad (8)$$

$$E_y = J_x^m \quad (9)$$

$$E_x = 0 \quad (10)$$

here H_x and J_x^m are given by Eqs. (1) and (2), respectively, and $(\)^*$ denotes the complex conjugate. It should be noted that since the geometry is physically separated into two half spaces by replacing the slot with a perfect electric conductor, which carries an equivalent magnetic current density instead of slot, the power should be computed for each region separately and then should be combined to get the total power. Hence,

$$P_c^{total} = P_c|_{z>0} + P_c|_{z<0} \quad (11)$$

Note that $P_c|_{z>0}$ and $P_c|_{z<0}$ are evaluated on the slot surface at $z = 0^+$ and $z = 0^-$ but with different sets of Green's functions given in Eqs. (9) and (10), respectively. By substituting Eqs. (1), (9) and (10) into Eq. (7) and taking the complex conjugate of both sides, one can obtain the following expression

$$P_c^*|_{z \lesssim 0} = \iint_{slot} J_x^{m*} \left\{ -j\omega G_{xx}^F * J_x^m + \frac{1}{j\omega} \frac{\partial}{\partial x} \left[G_x^{qm} * \frac{\partial}{\partial x} J_x^m \right] \right\} dx dy \quad (12)$$

and expanding the convolution integrals the following expression is obtained

$$P_c^*|_{z \lesssim 0} = -j\omega \iint_{slot} dx dy J_x^{m*} \iint dx' dy' G_{xx}^F(x-x', y-y') J_x^m + \frac{1}{j\omega} \iint_{slot} dx dy J_x^{m*} \frac{\partial}{\partial x} \iint dx' dy' G_x^{qm}(x-x', y-y') \frac{\partial}{\partial x'} J_x^m \quad (13)$$

Note that Eq. (13) contains quadruple integrals in spatial domain, therefore numerical methods to evaluate Eq. (13) would be very inefficient. On the other hand, it is also possible to carry the convolution in Eq. (12) to the spectral-domain thus eliminating one of the double integrals. In that case, although the spectral-domain Green's functions are in closed form, they are still oscillatory functions and the limits of the integrals extend to infinity yielding computationally expensive numerical integrals. To overcome these difficulties, Eq. (13) can be written in matrix form as

follows:

$$P_c^* \Big|_{z > 0} = \begin{bmatrix} I_{x1} & I_{x2} & \cdots & I_{xn} \end{bmatrix}^* [A_{nn'}] \begin{bmatrix} I_{x1} \\ I_{x2} \\ \vdots \\ I_{xn'} \end{bmatrix} \quad (14)$$

where

$$\begin{aligned} A_{nn'} &= -jw \iint_{slot} dx dy B_{xn}(x, y) \iint dx' dy' G_{xx}^F(x - x', y - y') B_{xn'}(x', y') \\ &- \frac{1}{jw} \iint_{slot} dx dy \frac{\partial}{\partial x} B_{xn}(x, y) \iint dx' dy' G_x^{qm}(x - x', y - y') \frac{\partial}{\partial x'} B_{xn'}(x', y') \end{aligned} \quad (15)$$

Now, one can notice that the matrix entry which appears in Eq. (15) is similar with the MoM impedance matrix entries. Hence, the Green's functions in Eq. (15) can be also approximated by power series of ρ yielding analytical integration possible. Finally, the input impedance seen from the feed point is obtained by

$$Z_{in} = \frac{P_c^{total}}{I_{in}^2} \quad (16)$$

III. RESULTS AND CONCLUSIONS

The first investigated geometry consists of an infinitely large ground plane with narrow rectangular center-fed slot which separates the geometry two infinite half-spaces. This can be achieved by setting $h_2 = h_1 = 0$ in the geometry shown in Fig. 1. The input impedance of the slot is calculated and it is compared with the results presented in literature [2], and as it can be seen in Figs. 2 and 3, there is a good agreement between the results. The difference between the results near resonance could be due to the fact that Kominami et. al. uses a different set of basis functions which forces the edge singularity, and they obtain the results for a lossy dielectric, whereas in our case, the dielectric is assumed to be lossless. As a second example,

a multilayer geometry is selected by setting $h_2 \neq 0$ and $h_1 \neq 0$, and both center-fed and offset-fed configurations are analyzed. The input impedances of the slot for both cases are given in Fig. 4. It should be noted that offset-feeding has not changed the resonance frequency of the structure.

As a conclusion, it can be stated that the use of closed-form spatial-domain Green's functions increases the computational efficiency in the analysis of slot geometries in multilayer media. Although the formulation is presented for narrow slot geometries with coaxial feeding, it can be applied to general slot geometries placed in a multilayer geometry, such as slot-coupled microstrip patch antennas, as well.

ACKNOWLEDGMENT

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REFERENCES

- [1] K. C. Gupta, Ramesh Garg and I. J. Bahl. *Microstrip Lines and Slotlines*. Artech House, Inc., 1979.
- [2] Masanobu Kominami, David M. Pozar and Daniel H. Schaubert "Dipole and Slot Elements and Arrays on Semi-Infinite Substrates," *IEEE Trans. on Antennas and Propagation*, vol. 33, pp. 600-607, June 1985.
- [3] Masoud Kahrizi, Tapan K. Sarkar, and Zoran A. Maricevic "Analysis of a Wide Radiating Slot in the Ground Plane of a Microstrip Line," *IEEE Trans. on Microwave Theory Tech.*, vol. 41, pp. 29-37, Jan. 1993.
- [4] Richard C. Hall, and Juan R. Mosig "The Analysis of Arbitrarily Shaped Aperture-Coupled Patch Antennas Via a Mixed-Potential Integral Equation," *IEEE Trans. on Antennas and Propagation*, vol. 44, pp. 608-614, May 1996.

- [5] Noyan Kinayman and M. I. Aksun "Comparative Study of Acceleration Techniques for Integrals and Series in Electromagnetic Problems," *Radio Science*, vol. 30, pp. 1713-1722, Nov.-Dec. 1995.
- [6] Y. L. Chow, J. J. Yang, D. G. Fang and G. E. Howard "A Closed-Form Spatial Green's Function for the Thick Microstrip Substrate," *IEEE Trans. on Microwave Theory Tech.*, vol. 39, pp. 588-592, Mar. 1991.
- [7] Miguel Marin, Sina Barkeshli and Prabhakar H. Pathak "Efficient Analysis of Planar Microstrip Geometries Using a Closed-Form Asymptotic Representation of the Grounded Dielectric Slab Green's Function," *IEEE Trans. on Microwave Theory Tech.*, vol. MTT-37, pp. 669-679, Apr. 1989.
- [8] Miguel Marin, and Prabhakar H. Pathak "An Asymptotic Closed-Form Representation for the Grounded Double-Layer Surface Green's Function," *IEEE Trans. on Microwave Theory Tech.*, vol. AP-40, pp. 1357-1366, Nov. 1992.
- [9] G. Dural, and M. I. Aksun "Closed-Form Green's Functions For General Sources and Stratified Media," *IEEE Trans. on Microwave Theory Tech.*, vol. 43, pp. 1545-1552, July 1995.
- [10] Lale Alatan, M. I. Aksun, Karthikeyan Mahadevan, and Tuncay Birand "Analytical Evaluation of the MoM Matrix Elements," *IEEE Trans. on Microwave Theory Tech.*, vol. 44, pp. 519-525, Apr. 1996.
- [11] Juan R. Mosig "Arbitrarily Shaped Microstrip Structures and Their Analysis with a Mixed Potential Integral Equation," *IEEE Trans. on Microwave Theory Tech.*, vol. MTT-36, pp. 314-323, Feb. 1988.
- [12] M. I. Aksun "A Robust Approach for the Derivation of Closed-Form Green's Functions," *IEEE Trans. on Microwave Theory Tech.*, vol. 44, pp. 651-658, May 1996.

LIST OF FIGURES

1 A slot structure on a multilayer medium. The region above the slot is free space. 9

2 Input impedance vs. normalized length (l/λ_0) for the slot given in Fig. 1 ($w/l=0.02$ cm, $h_1=h_2=0.0$ cm, $\epsilon_{r3}=2.55$, and $d=5.0$ cm). . . . 10

3 Input impedance vs. normalized length (l/λ_0) for the slot given in Fig. 1 ($w/l=0.02$ cm, $h_1=h_2=0.0$ cm, $\epsilon_{r3}=12.8$, and $d=5.0$ cm). . . . 11

4 Input impedance vs. normalized length (l/λ_0) for the slot given in Fig. 1 ($w/l=0.02$ cm, $h_1=0.2$ cm, $h_2=0.05$ cm, $\epsilon_{r1}=2.55$, $\epsilon_{r2}=12.8$, $\epsilon_{r3}=1.0$). 12

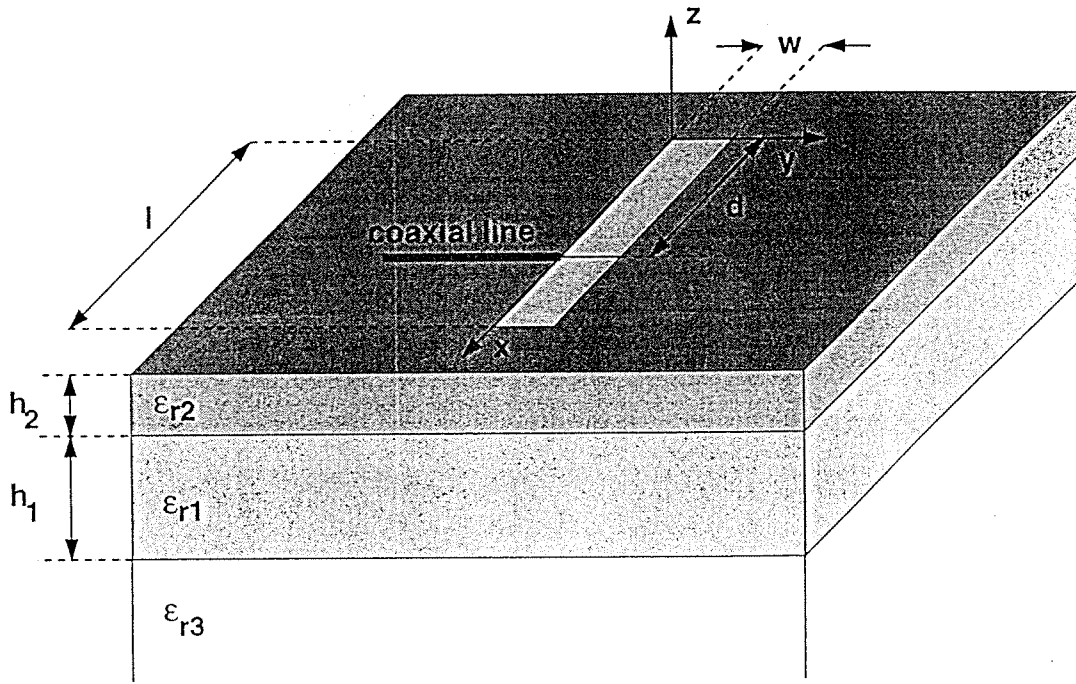


Fig. 1.

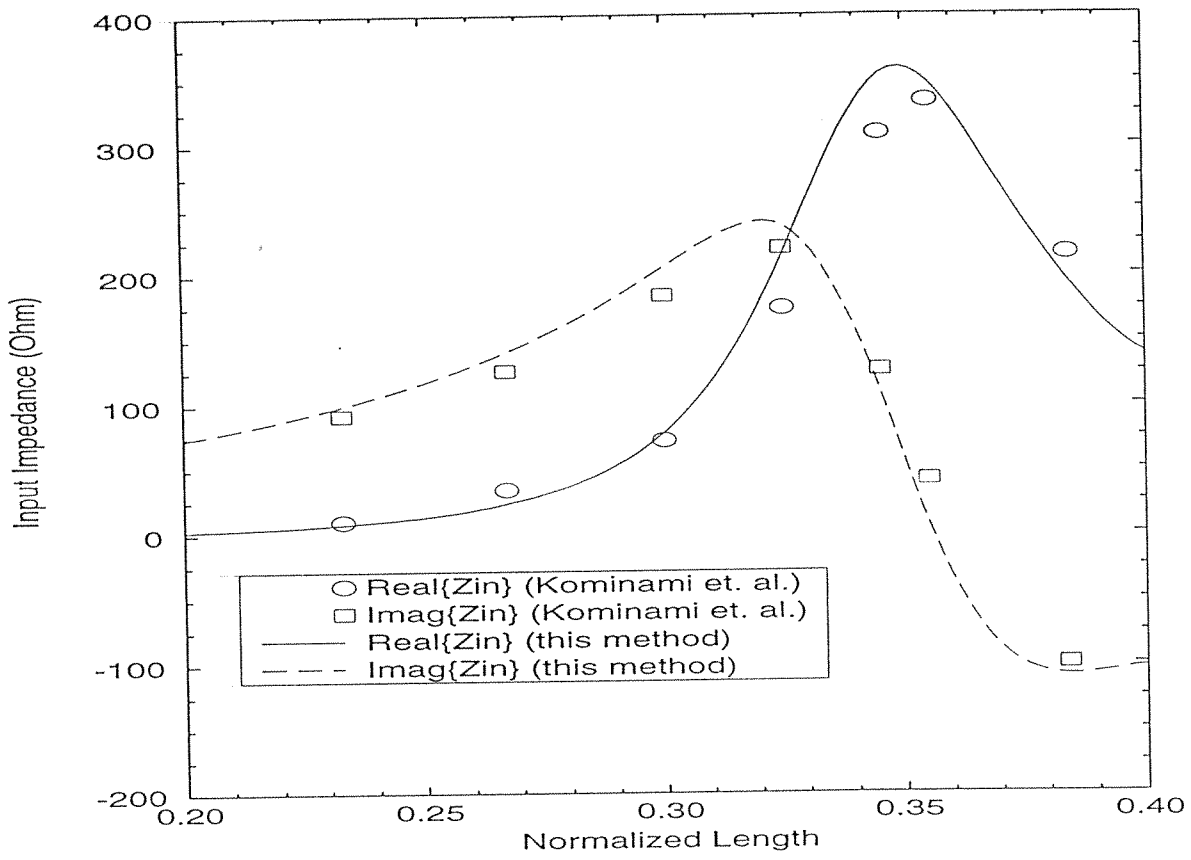


Fig. 2.

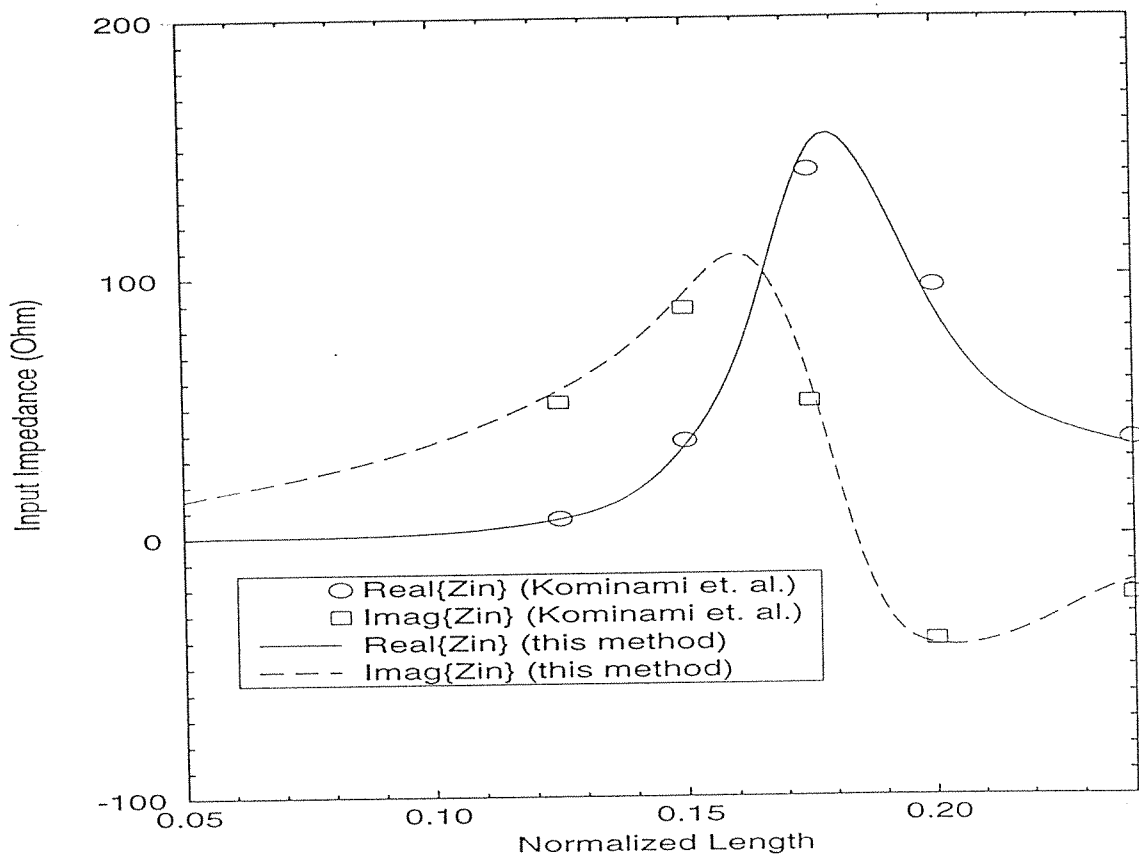


Fig. 3.

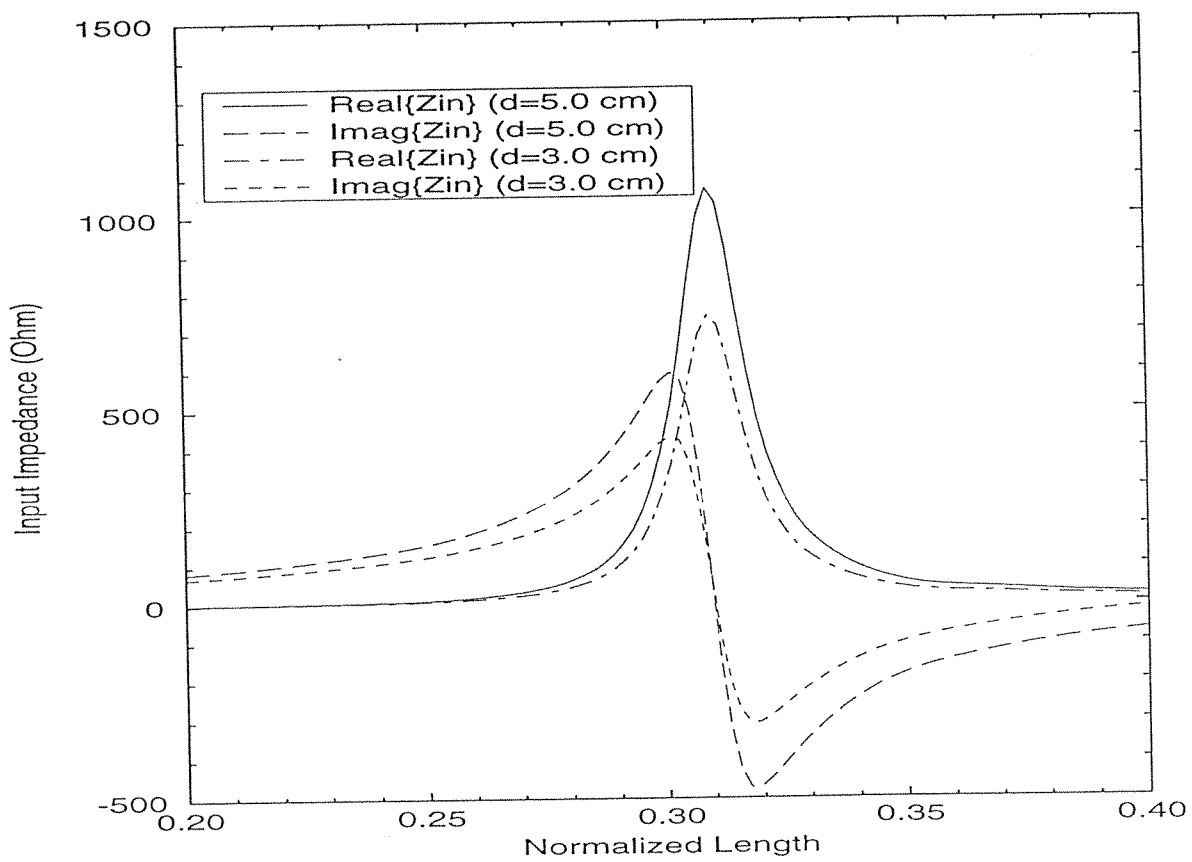


Fig. 4.

Analytical Evaluation of the MoM Matrix Elements

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Karthikeyan Mahadevan, and M. Tuncay Birand, *Member, IEEE*

Abstract—Derivation of the closed-form Green's functions has minimized the computationally expensive evaluation of the Sommerfeld integrals to obtain the Green's functions in the spatial domain. Therefore, using the closed-form Green's functions in conjunction with the method of moments (MoM) has improved the computational efficiency of the technique significantly. Further improvement can be achieved on the calculation of the matrix elements involved in the MoM, usually double integrals for planar geometries, by eliminating the numerical integration. The contribution of this paper is to present the analytical evaluation of the matrix elements when the closed-form Green's functions are used, and to demonstrate the amount of improvement in computation time.

I. INTRODUCTION

ELECTROMAGNETIC modeling plays an important role in the analysis and the design of electronic packages, high-speed digital circuits, and microwave integrated circuits, most of which are fabricated in a planar environment. Therefore, a variety of numerical techniques for accurately modeling and simulating the electrical performances of such circuits have been proposed and studied extensively. These include the method of moments (MoM) [1], the finite element method (FEM) [2], the finite-difference time-domain method (FDTD) [3], and quasi-static methods like conformal mapping [4]. Among these approaches, the MoM in the spatial and the spectral domains are the most commonly used numerical techniques in the rigorous analysis of printed geometries in multilayer planar media. As these structures are generally used in the design of monolithic microwave integrated circuits (MMIC) and printed antennas, improving the numerical efficiency of the MoM has been a major research topic in computational electromagnetics. In the analysis of electrically small geometries (spanning a few wavelengths in two dimensions), the efficiency can be improved by reducing the computation time used to evaluate the matrix elements, since the significant part of the overall solution time is the calculation of the matrix elements, also called matrix-fill time.

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In the spectral domain formulation, the MoM matrix elements involve two-dimensional (2-D) integrals of complex, oscillatory, and slow-converging functions over an infinite domain [5]. Therefore, the numerical evaluation of these elements is quite time consuming, rendering the technique computationally inefficient. Although acceleration techniques and approximations can improve the computational efficiency of the spectral-domain MoM, they are more likely to impose some restrictions.

On the other hand, the application of the spatial-domain MoM to the mixed-potential integral equation (MPIE) requires the necessary Green's functions in the spatial domain [6]. The spatial-domain Green's functions can be obtained from their spectral domain counterparts, which can be derived analytically for planar multilayer media, via Hankel transformation, also called Sommerfeld integral [7], [8]. Because the kernel of the transformation is the Bessel function of the first kind and because the function to be transformed is the spectral-domain Green's function, the integrand is an oscillatory and slow-converging function. Therefore, the calculation of the spatial-domain Green's function, i.e., numerical implementation of the Hankel transformation, is the computational bottleneck of the spatial-domain MoM.

An approach has recently been proposed to accelerate the calculation of the spatial-domain Green's functions [9]. In its original form, the spectral-domain Green's function to be transformed is approximated by complex exponentials via the original Prony method, and the Hankel transformation can be performed analytically with the use of the Sommerfeld identity. Although the original approach was restricted for a single, thick substrate and for an horizontal electric dipole source, it was improved first to cover geometries with a substrate and a superstrate of arbitrary thicknesses [10], then to cover for multilayer geometries with arbitrary thicknesses and for arbitrary source types, horizontal electric dipole (HED), vertical electric dipole (VED), horizontal magnetic dipole (HMD), and vertical magnetic dipole (VMD) [11]. A deficiency of this approach is its being not robust, that is, one needs to examine the function to be approximated prior to the application of an exponential approximation method in order to decide on the approximation parameters, like the range of the approximation and the number of samples in this range. With a recent improvement on the approximation scheme, the calculation of the spatial-domain Green's functions has become robust and extremely efficient [12]. The use of the closed-form Green's functions in conjunction with the MoM results in 2-D integrals over finite domains, and consequently the computational efficiency of the spatial-domain MoM has

improved significantly, about two order of magnitudes, compared to the spectral domain approach. In this paper, we demonstrate that the use of the complex exponentials in place of the spatial-domain Green's functions facilitates analytical evaluation of the double integrals. Therefore, a substantial improvement in the matrix-fill time is achieved. Since the use of the closed-form Green's functions is essential for the formulation proposed in this paper, we review closed-form Green's functions in Section II. Section III gives evaluation of the double integrals and necessary integral identities. Section IV describes application of the formulation to microstrip geometry and computational efficiency. Section V presents the conclusion.

II. CLOSED-FORM GREEN'S FUNCTIONS

It is well known that the spectral-domain Green's functions for the vector and scalar potentials are represented analytically in a multilayer medium, [11], [14]. Hence, the spatial-domain Green's functions are simply the Hankel transform of the spectral-domain Green's functions as defined

$$G = \frac{1}{4\pi} \int_{SIP} dk_\rho k_\rho H_o^{(2)}(k_\rho \rho) \tilde{G}(k_\rho) \quad (1)$$

where $k_\rho^2 = k_x^2 + k_y^2$, ρ is the variable in cylindrical coordinate system, G and \tilde{G} are the Green's functions in the spatial and spectral domains, respectively, $H_o^{(2)}$ is the Hankel function of second kind and SIP is the Sommerfeld integration path. Note that this integral, also called the Sommerfeld integral, can be evaluated analytically for the spectral-domain Green's functions \tilde{G} . Chow *et al.* [9] recognized that if the spectral-domain Green's function \tilde{G} is approximated by exponentials, the Sommerfeld integral (1) can be evaluated analytically using the well-known Sommerfeld identity

$$\frac{e^{-jk_s r}}{r} = -\frac{j}{2} \int_{SIP} dk_\rho k_\rho H_o^{(2)}(k_\rho \rho) \frac{e^{-jk_z |z|}}{k_z} \quad (2)$$

The approximation of the spectral-domain Green's functions by complex exponentials is the heart of this technique, and as described in [12] the two-level approximation scheme in conjunction with the generalized pencil of function (GPOF) method, [15], results in a robust and computationally efficient approach, whose details are given in [12]. Following the two-level approach, the spectral-domain Green's function can be written as

$$\tilde{G} \cong \frac{1}{j2k_{z_s}} \left[\sum_{n=1}^{N_1} a_{1n} e^{-\alpha_{1n} k_{z_s}} + \sum_{n=1}^{N_2} a_{2n} e^{-\alpha_{2n} k_{z_s}} \right] \quad (3)$$

where a_{1n} , α_{1n} and a_{2n} , α_{2n} are the coefficients and exponents obtained from the application of the GPOF method in the first and second parts of the two-level approximation, respectively, and the subscript "s" denotes the layer number of the source location. Once this representation of the spectral-domain Green's function is substituted into (1) and the Sommerfeld identity (2) is employed, the spatial-domain Green's function can be cast into a form of

$$G \cong \sum_{n=1}^{N_1} a_{1n} \frac{e^{-jk_s r_{1n}}}{r_{1n}} + \sum_{n=1}^{N_2} a_{2n} \frac{e^{-jk_s r_{2n}}}{r_{2n}} \quad (4)$$

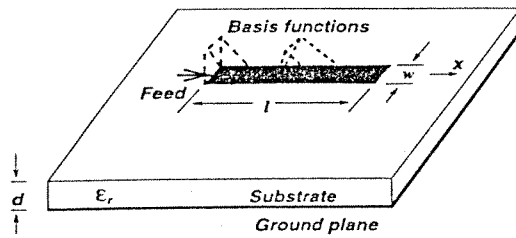


Fig. 1. A typical microstrip geometry. $\epsilon_r = 4.0$, $d = 0.02032$ cm, $f = 1.0$ GHz.

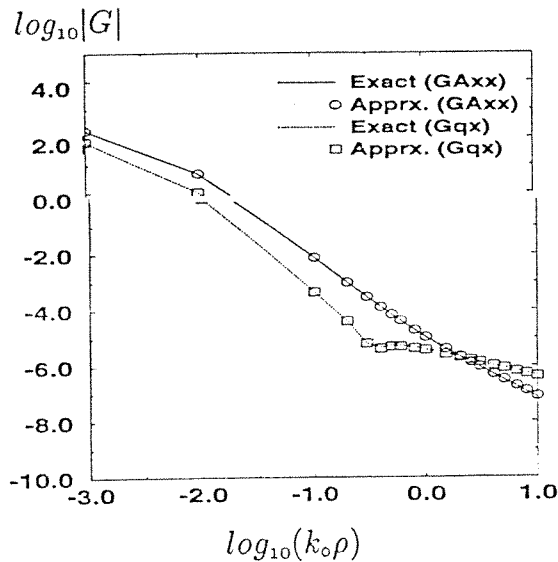


Fig. 2. The magnitude of the normalized Green's functions $4\pi G_{xx}^A / \mu_0$, $4\pi \epsilon_0 G_q$. $\epsilon_r = 4.0$, $d = 0.02032$ cm, $f = 1.0$ GHz.

where $r_{1n} = \sqrt{x^2 + y^2 - \alpha_{1n}^2}$ and $r_{2n} = \sqrt{x^2 + y^2 - \alpha_{2n}^2}$ are the complex distances and k_s is the wave number in the source medium.

As an example, consider the following parameters for the geometry of a substrate backed by a ground plane as in Fig. 1 which shows the dielectric constant of the substrate $\epsilon_r = 4$; the thickness of the substrate $d = 0.02032$ cm; and the frequency of operation $f = 1.0$ GHz. The Green's functions of the vector and scalar potentials due to a HED at the air-substrate interface are obtained in closed forms via two-level approximation scheme, and the coefficients a_{1n} , a_{2n} and the exponents α_{1n} , α_{2n} are given in Table I along with the normalized Green's functions for vector and scalar potentials, $4\pi G_{xx}^A / \mu_0$ and $4\pi \epsilon_0 G_q$, respectively, in Fig. 2.

III. FORMULATION

This formulation is applicable to general microstrip geometries in a multilayer medium where it is assumed that the layers extend to infinity in the transverse directions. However, to avoid complexity and to emphasize the main idea of the proposed method, the formulation is presented, without loss of generality, for a microstrip line on a substrate for which only the longitudinal current is assumed to exist.

The mixed-potential integral equation for the microstrip line can be transformed into the matrix equation with the use of

TABLE I
COEFFICIENTS AND EXPONENTS FOR THE CLOSED-FORM GREEN'S FUNCTIONS

$4\pi G_{xx}^A/\mu_0 = \sum_{n=1}^{N_1=4} a_n e^{-jk_x r_n}/r_n$	
a_n	α_n
-1.0000+j0.0000	0.000+j0.0406
0.495e-6-j0.123e-5	-0.0512+j0.0505
0.498e-6+j0.123e-5	0.0511+j0.0506
1.0+j0.0	0.0+j0.0

$4\pi\epsilon_0 G_q = \sum_{n=1}^{N_2=8} a_n e^{-jk_x r_n}/r_n$	
a_n	α_n
-0.590623+j0.0	0.0-j0.103e-3
0.0196+j0.0374	0.0390+j0.0598
-0.4485+j0.0	0.0+j0.0345
0.0196-j0.0374	-0.0390+j0.0598
-0.260e-10+j0.771e-11	-53.33+j439.67
0.279e-5-j0.245e-6	-0.3396+j0.9239
0.204e-6+j0.328e-6	1.0270-j0.2907
1.0+j0.0	0.0+j0.0

the well-known MoM procedure, and a typical matrix element given below to help demonstrate the use of the formulation

$$\langle T_{xm}, G_{xx}^A * B_{xn} \rangle + \frac{1}{\omega^2} \left\langle T_{xm}, \frac{\partial}{\partial x} \left(G_q * \frac{\partial}{\partial x} B_{xn} \right) \right\rangle \quad (5)$$

here $\langle \cdot, \cdot \rangle$ and $*$ denote inner product and convolution, respectively, and T_{xm}, B_{xn} are the testing and basis functions, respectively. The first inner product of (5) is written explicitly as

$$\begin{aligned} & \langle T_{xm}, G_{xx}^A * B_{xn} \rangle \\ &= \iint_{D_T} dx dy T_{xm}(x, y) \\ & \cdot \iint_{D_B} dx' dy' G_{xx}^A(x-x', y-y') B_{xn}(x', y') \quad (6) \end{aligned}$$

where D_T and D_B denote the domains of the testing and basis functions, respectively, and the closed-form Green's function G_{xx}^A is expressed as in (4). By changing the order of integration, the inner product takes the form of

$$\iint du dv G_{xx}^A(u, v) \iint dx dy T_{xm}(x, y) \cdot B_{xn}(x-u, y-v) \quad (7)$$

where the inner double integral is a correlation function represented as $T_{xm} \otimes B_{xn}$. As is well known, the choice of the basis and testing functions are of great importance for the accuracy of the results and for the convergence of the matrix elements involved in the MoM [16]. Since the formulation presented here requires the correlation function to be polynomial function, the choice of testing and basis functions is restricted to polynomial like functions. Therefore, we choose the rooftop functions, which are triangular functions in the longitudinal direction and uniform in the transverse direction, as the basis and testing functions. Half rooftop

functions are also used to model the current density at the load and source terminals [13].

For the above choice of the basis and testing functions, the correlation function becomes

$$T_{xm} \otimes B_{xn} = f(u)g(v) \quad (8)$$

where

$$\begin{aligned} f(u) &= \gamma_3 u^3 + \gamma_2 u^2 + \gamma_1 u + \gamma_0 \\ & \quad (m-n-2)h_x < u < (m-n+2)h_x \\ g(v) &= \frac{1}{h_y^2} \begin{cases} v+h_y & -h_y \leq v \leq 0 \\ -v+h_y & 0 \leq v \leq h_y \end{cases} \quad (9) \end{aligned}$$

and $\gamma_0, \gamma_1, \gamma_2, \gamma_3$ are constants determined by m, n , and h_x (the half-span of the basis functions in x -direction); and the length of the unit cell in y -direction, h_y , is chosen to be equal to the width of the microstrip line for the specific geometry considered herein. It should be noted that the formulation given here is also valid for a 2-D patch since the order of the polynomials in (9) is the highest that can be encountered in the analysis. By substituting the correlation function (8) and the Green's function (4) into (7), the inner-product term can be written as

$$\begin{aligned} & \frac{1}{h_y^2} \sum_{n=1}^N a_n \left[\gamma_0 \left(h_y \iint \frac{e^{-jk_x r_n}}{r_n} dv du \right. \right. \\ & \quad \left. \left. - \iint \frac{e^{-jk_x r_n}}{r_n} v dv du \right) \right. \\ & \quad \left. + \gamma_1 \left(h_y \iint \frac{e^{-jk_x r_n}}{r_n} u dv du \right. \right. \\ & \quad \left. \left. - \iint \frac{e^{-jk_x r_n}}{r_n} uv dv du \right) \right. \\ & \quad \left. + \gamma_2 \left(h_y \iint \frac{e^{-jk_x r_n}}{r_n} u^2 dv du \right. \right. \\ & \quad \left. \left. - \iint \frac{e^{-jk_x r_n}}{r_n} u^2 v dv du \right) \right. \\ & \quad \left. + \gamma_3 \left(h_y \iint \frac{e^{-jk_x r_n}}{r_n} u^3 dv du \right. \right. \\ & \quad \left. \left. - \iint \frac{e^{-jk_x r_n}}{r_n} u^3 v dv du \right) \right] \quad (10) \end{aligned}$$

where r_n is either r_{1n} or r_{2n} as defined in (4).

Because the integrals in (10) occur in the calculation of matrix elements, and because they cannot be evaluated analytically, their numerical evaluations constitute almost the entire fill time of the MoM matrix. Although the use of the closed-form Green's functions in conjunction with the MoM improves the matrix fill time significantly [13], it could be further improved if the integrals involved (10) can be evaluated analytically. It has been shown that the Taylor's series expansion of the exponential term in the integrand of the first integral in (10) results in an analytically integrable function over a surface [17]. Using this fact, and some of the integral identities given in [18], we can evaluate the integrals in (10) analytically. The case of the Taylor's series expansion requires examining its convergence for all r_n values

h the same number of terms; therefore, the expansion performed around different center points R_c for different ions corresponding to different basis and testing functions. The m th order Taylor series expansion of $f(z)$ around involves an error term of

$$\text{error} = \left| \frac{f^{m+1}(c)}{(m+1)!} (z - z_0)^{m+1} \right|$$

where c is a point in the region of convergence. As the m th derivative of $e^{-jk_s r_n}$ is bounded by k_s^m , the error introduced using the m th order expansion is

$$\text{error} \leq \frac{|k_s(r_n - R_c)|^{m+1}}{(m+1)!}$$

can be observed that the distance to the center point directly determines the error. Hence, to minimize the error, the locations of the center points are chosen to be the midpoint of each integration region for which the integration intervals are $2h_y$ and $4h_x$ for v and u integrations, respectively. Consequently, $r_n - R_c \leq \sqrt{(2h_x)^2 + h_y^2}$. For the choice of 20 basis functions for each wavelength, $r_n - R_c$ is bounded 0.11λ and the error is obtained in the following form

$$\text{error} \leq \frac{(2\pi \times 0.11)^{m+1}}{(m+1)!} = \frac{(0.7)^{m+1}}{(m+1)!} \quad (11)$$

from which it is easily shown that an error bounded by 10^{-4} can be obtained with the use of at least five terms of the Taylor series. The results presented in Section IV demonstrate that an amount of error of 10^{-4} or smaller does not affect the end result as the current distributions obtained by using analytical and numeric integrations are in good agreement. Hence, it is not worthwhile to increase the number of terms any further.

Using the fifth-order Taylor series expansion around c , $e^{-jk_s r_n}$ can be approximated as

$$e^{-jk_s r_n} \approx e^{-jk_s R_c} (\beta_0 + \beta_1 r_n + \beta_2 r_n^2 + \beta_3 r_n^3 + \beta_4 r_n^4 + \beta_5 r_n^5) \quad (12)$$

here

$$\begin{aligned} \beta_0 &= \left(1 + jk_s R_c - \frac{k_s^2 R_c^2}{2} - j \frac{k_s^3 R_c^3}{6} + \frac{k_s^4 R_c^4}{24} + j \frac{k_s^5 R_c^5}{120} \right) \\ \beta_1 &= \left(-jk_s + k_s^2 R_c + j \frac{k_s^3 R_c^2}{2} - \frac{k_s^4 R_c^3}{6} - j \frac{k_s^5 R_c^4}{24} \right) \\ \beta_2 &= \left(-\frac{k_s^2}{2} - j \frac{k_s^3 R_c}{2} + \frac{k_s^4 R_c^2}{4} + j \frac{k_s^5 R_c^3}{12} \right) \\ \beta_3 &= \left(j \frac{k_s^3}{6} - \frac{k_s^4 R_c}{6} - j \frac{k_s^5 R_c^2}{12} \right) \\ \beta_4 &= \left(\frac{k_s^4}{24} + j \frac{k_s^5 R_c}{24} \right) \\ \beta_5 &= -j \frac{k_s^5}{120} \end{aligned}$$

Replacing the exponential term $e^{-jk_s r_n}$ in (10) by its Taylor series expansion given in (12) results in the integrals of the

type

$$\iint r_n^j u^k v^l du dv \quad \text{for } j = -1, 0, \dots, 4, \quad k = 0, \dots, 3, \\ l = 0, 1. \quad (13)$$

These integrals are analytically integrable and their results are given in the Appendix. Note that the same procedure presented above can be applied to the second inner-product term of (5) in which G_q has the same functional form as G_{xx}^A given in (4).

IV. RESULTS AND DISCUSSIONS

In this part of the study, the formulation described above is applied to a microstrip line to evaluate computational efficiency. The dielectric constant of the medium is $\epsilon_r = 4.0$, the ratio of line width w to substrate thickness d is 4.0. The thickness of the substrate is 0.02032 cm (= 8.0 mils.), the frequency is 1 GHz, and the length of the line is 10 cm. Computational efficiency of the proposed method is assessed in terms of the CPU (central processing unit) time obtained from a SUNsparc-10 workstation.

The current distribution on the microstrip line is obtained by numerically integrating the double integrals (7) (Case 1) involved in the MoM matrix elements, and then by using the analytic integration formulation presented in Section III (Case 2). The current distributions obtained via the use of the numerical integration (Case 1) have been verified by comparing it with the results obtained via the transmission line method described in [13]; therefore, Case 1 serves here as a reference for the accuracy of the current distribution as well. In the numerical integration, 16-point Gauss quadrature integration algorithm, which is considered to be one of the fastest numerical integration algorithms, is employed for the double integrals for which the range of the integration is divided into subregions to guarantee the convergence of the numerical integration. For both cases, the CPU times are obtained for different numbers of basis functions and are listed in Table II. The current distributions obtained via numerical and analytical evaluations of the integrals for 40 basis functions are shown in Fig. 3. It can be observed from Table II that the elimination of the numerical integrals reduces the computation time approximately by a factor of 40. Besides the improvement in computational efficiency, the formulation based on the analytical integration also provides a number of other advantages. First, as the MoM becomes a technique free from any numerical integrations, the numerical errors due to integration and the time used to find an appropriate numerical integration algorithm are eliminated. Second, as the matrix entries are expressed in closed-forms, the effect of changes in geometrical parameters, such as length and width of the microstrip line, onto the output parameters like, current distribution, input impedance or spurious radiation, can be studied analytically by taking a derivative with respect to the desired parameter. Finally, if a method uses numerical integrations, it is necessary to extract the singularity at the source point, while in the analytic integration formulation this problem is completely eliminated because the singularities involved are integrable over a surface. It should be noted that

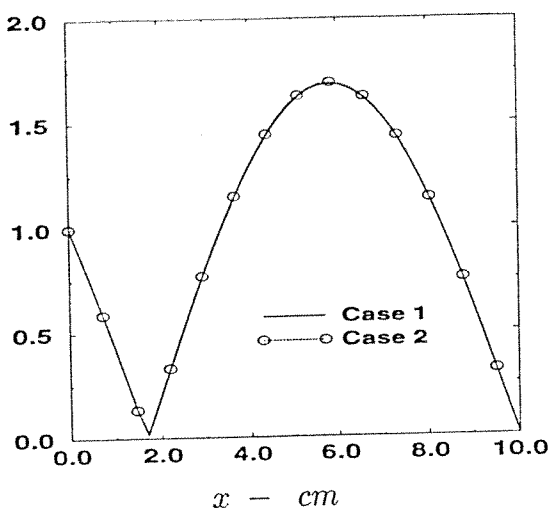
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Fig. 3. Current distributions obtained by using 40 basis functions. $a = 4.0$, $d = 0.02032$ cm, $f = 1.0$ GHz, $w = 0.08128$ cm, $l = 10$ cm.

TABLE II
CPU TIMES FOR DIFFERENT NUMBER OF BASIS FUNCTIONS

number of basis func.	CPU time in sec. (Case 1)	CPU time in sec. (Case 2)
10	13.3	0.36
20	27.0	0.65
30	39.0	0.98
40	52.95	1.33

he application of the proposed approach here has no restriction on the size of the geometry, provided the closed-form Green's functions are valid for the distance as far as the maximum distance of the geometry.

V. CONCLUSION

When the spatial-domain MoM is used in conjunction with the closed-form Green's functions for the solution of the mixed-potential integral equation, the MoM matrix elements involve 2-D integrals whose numerical evaluations increase the matrix fill-time. In order to improve the numerical efficiency of the method, the integrand is approximated by its Taylor series and each term of the expansion is integrated analytically. By eliminating the numerical integration from the MoM, the matrix fill-time is decreased drastically, which is a significant improvement in the matrix-fill time of the MoM. This acceleration in the matrix fill time makes the MoM a fast full-wave analysis technique which can be utilized in an optimization algorithm for the solution of a design problem. Besides, the proposed method offers other advantages such as expressing the matrix entries in closed-forms, which opens up the possibility of investigating the effect of some parameters on the end result by examining the matrix entries analytically.

APPENDIX

THE ANALYTIC EVALUATION OF THE INTEGRALS GIVEN IN (13)

$$R = \sqrt{u^2 + v^2 + c^2}$$

where c is any of the complex exponents. Some special integrals are defined in order to simplify the formulation

$$J_0 = \int R du = \frac{1}{2}(Ru + (v^2 + c^2) \cdot \log(u + R))$$

$$J_1 = \int uR du = \frac{R^3}{3}$$

$$J_2 = \int u^2 R du = \frac{u(v^2 + c^2 + 2u^2)R}{8} - \frac{(v^2 + c^2)^2}{8} \cdot \log(u + R)$$

$$J_3 = \int u^3 R du = \frac{R^5}{5} - (v^2 + c^2) \frac{R^3}{3}$$

$$J_4 = \int u^4 R du = \left(-\frac{3}{2}(v^2 + c^2)^2 + (v^2 + c^2)u^2 + 4u^4 \right) \left(\frac{uR}{24} \right) + \frac{1}{16}(v^2 + c^2)^3 \log(u + R)$$

$$J_5 = \int u^5 R du = \frac{R^7}{7} - \frac{2}{5}R^5(v^2 + c^2) + \frac{R^3}{3}(v^2 + c^2)^2$$

$$J_6 = \int u^6 R du = \frac{7u}{8} J_5 - \frac{(v^2 + c^2)}{40} J_4 + \frac{(v^2 + c^2)^2}{30} J_2 - \frac{(v^2 + c^2)^3}{15} J_0$$

$$J_7 = \int u^7 R du = \frac{R^9}{9} - 3(v^2 + c^2) \frac{R^7}{7} + 3(v^2 + c^2)^2 \frac{R^5}{5} - (v^2 + c^2)^3 \frac{R^3}{3}$$

$$K_0 = \int \frac{1}{R} du = \log(u + R)$$

$$K_1 = \int \frac{u}{R} du = R$$

$$K_n = \int \frac{u^n}{R} du = J_{n-2} - (v^2 + c^2) \cdot K_{n-2}$$

$$I_0 = \int \frac{1}{(u^2 + c^2)R} du = \frac{1}{vc} \arctan \left(\frac{uv}{cR} \right)$$

$$I_1 = \int \frac{u}{(u^2 + c^2)R} du$$

$$= \frac{\log(R - v) - \log(R + v)}{2v}$$

$$I_n = \int \frac{u^n}{(u^2 + c^2)R} du$$

$$= K_{n-2} - c^2 I_{n-2}$$

$$L_0 = \int \frac{1}{(u^2 + c^2)} du$$

$$= \frac{1}{c} \arctan\left(\frac{u}{c}\right)$$

$$L_1 = \int \frac{u}{(u^2 + c^2)} du = \frac{\log(u^2 + c^2)}{2}$$

$$L_n = \int \frac{u^n}{(u^2 + c^2)} du = \frac{u^{n-1}}{n-1} - c^2 L_{n-2}$$

$$M_n = \iint \frac{u^n}{R} dv du$$

$$= (u^{n+1} \log(v + R) - L_{n+2} + v J_{n+2}) / (n + 1)$$

$$\iint u^n R dv du = \frac{1}{2} (v J_n + M_{n+2} + c^2 M_n)$$

$$\iint u^n R^2 dv du = \frac{u^{n+1}}{n+1} \left(\frac{v^3}{3} + v c^2 \right) + \frac{u^{n+3}}{n+3} v$$

$$\iint u^n R^3 dv du = \frac{5}{8} v J_{n+2} + \frac{v}{4} \left(\frac{5c^2}{2} + v^2 \right) J_n$$

$$+ \frac{3}{8} (M_{n+4} + 2c^2 M_{n+2} + c^4 M_n)$$

$$\iint u^n R^4 dv du = \frac{u^{n+1}}{n+1} \left(c^4 v + \frac{v^5}{5} + \frac{2c^2 v^3}{3} \right)$$

$$+ \frac{2u^{n+3}}{n+3} \left(\frac{v^3}{3} + c^2 v \right) + \frac{v u^{n+5}}{n+5}$$

$$\iint \frac{u^n v}{R} dv du = J_n$$

$$\iint u^n v R dv du = \frac{J_{n+2}}{3} + \frac{(v^2 + c^2) J_n}{3}$$

$$\iint u^n v R^2 dv du = \frac{u^{n+3} v^2}{2(n+3)} + \frac{v^2}{2} \left(c^2 + \frac{v^2}{2} \right) \frac{u^{n+1}}{n+1}$$

$$\iint u^n v R^3 dv du = \frac{J_{n+4}}{5} + \frac{2(v^2 + c^2)}{5} J_{n+2}$$

$$+ \frac{(v^2 + c^2)^2}{5} J_n$$

$$\iint u^n v R^4 dv du = \frac{u^{n+5} v^2}{2(n+5)} + \frac{u^{n+3}}{n+3} \left(c^2 v^2 + \frac{v^4}{2} \right)$$

$$+ \frac{u^{n+1}}{n+1} \left(\frac{c^4 v^2}{2} + \frac{v^6}{6} + \frac{c^2 v^4}{2} \right)$$

REFERENCES

- [1] R. F. Harrington, *Field Computation by Moment Methods*. New York: MacMillan; FL: Krieger, 1983.
- [2] J. Jin, *The Finite Element Method in Electromagnetics*. New York: Wiley, 1993.
- [3] K. Kunz and R. Luebber, *The Finite Difference Time Domain Method for Electromagnetics*. Boca Raton, FL: CRC, 1993.
- [4] R. Schinzinger and P. Laura, *Conformal Mapping: Methods and Applications*. New York: Elsevier, 1991.
- [5] D. M. Pozar, "Input impedance and mutual coupling of rectangular microstrip antennas," *IEEE Trans. Antennas Propagat.*, vol. AP-30, pp. 1191-1196, Nov. 1982.
- [6] J. R. Mosig and F. E. Gardiol, "General integral equation formulation for microstrip antennas and scatterers," *IEE Proc.*, pt. H, vol. 132, no. 7, pp. 424-432, 1985.
- [7] A. Sommerfeld, *Partial Differential Equations in Physics*. New York: Academic, 1949.
- [8] W. C. Chew, *Waves and Fields in Inhomogeneous Media*. New York: Van Nostrand, 1990.
- [9] Y. L. Chow, J. J. Yang, D. F. Fang and G. E. Howard, "Closed form spatial Green's function for the thick substrate," *IEEE Trans. Microwave Theory Tech.*, vol. 39, pp. 588-592, Mar. 1991.
- [10] M. I. Aksun and R. Mittra, "Derivation of closed-form Green's functions for a general microstrip geometries," *IEEE Trans. Microwave Theory Tech.*, vol. 40, pp. 2055-2062, Nov. 1992.
- [11] G. Dural and M. I. Aksun, "Closed-form Green's functions for general sources and stratified media," *IEEE Trans. Microwave Theory Tech.*, vol. 43, no. 7, pp. 1545-1552, Jul. 1995.
- [12] M. I. Aksun, "A robust approach for the derivation of the closed-form Green's functions," *IEEE Trans. Microwave Theory Tech.*, in press.
- [13] M. I. Aksun and R. Mittra, "Estimation of spurious radiation from microstrip etches using closed-form Green's functions," *IEEE Trans. Microwave Theory Tech.*, vol. 40, pp. 2063-2069, Nov. 1992.
- [14] N. K. Das and D. M. Pozar, "A spectral-domain Green's function for multilayer dielectric substrates with application to multilayer transmission lines," *IEEE Trans. Microwave Theory Tech.*, vol. MTT-35, pp. 326-335, Mar. 1987.
- [15] Y. Hua and T. K. Sarkar, "Generalized pencil-of-function method for extracting poles of an EM system from its transient response," *IEEE Trans. Antennas Propagat.*, vol. 37, pp. 229-234, Feb. 1989.
- [16] M. I. Aksun and R. Mittra, "Choices of expansion and testing functions for the method of moments applied to a class of electromagnetic problems," *IEEE Trans. Microwave Theory Tech.*, vol. 41, pp. 503-509, Mar. 1993.
- [17] R. F. Harrington, "Matrix methods for field problems," *Proc. IEEE*, vol. 55, pp. 136-149, Feb. 1967.
- [18] K. Mahadevan and H. A. Auda, "Electromagnetic field of a rectangular patch of uniform and linear distributions of current," *IEEE Trans. Antennas Propagat.*, vol. 37, pp. 1503-1509, Dec. 1989.




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Closed-Form Green's Functions for General Sources and Stratified Media

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Abstract—The closed-form Green's functions of the vector and scalar potentials in the spatial domain are presented for the cases of horizontal electric, magnetic, and vertical electric, magnetic dipoles embedded in general, multilayer, planar media. In the spectral domain Green's functions in an arbitrary layer are derived analytically from the Green's functions in the source layer by using a recursive algorithm. Then, the spatial domain Green's functions are obtained by adding the contributions of the direct terms, surface waves, and complex images approximated by the Generalized Pencil of Functions Method (GPOF). In the derivations, the main emphasis is to put these closed-form representations in a suitable form for the solution of the mixed potential integral equation (MPIE) by the method of moments in general three-dimensional geometry. The contributions of this paper are: 1) providing the complete set of closed-form Green's functions in spectral and spatial domains for general stratified media; 2) using the GPOF method, which is more robust and noise sensitive, in the derivation of the closed-form spatial domain Green's functions; and 3) casting the closed-form Green's functions in a form to provide efficient applications of the method of moments.

I. INTRODUCTION

Due to the increased use of multilayer microstrip geometries in the application of microstrip antennas [1]–[6] and monolithic microwave integrated circuits [7]–[11], the layered geometries have recently attracted widespread attention. Therefore, a considerable amount of interest has been focused on the development of a rigorous and yet computationally efficient computer-aided design tools for microstrip geometries in a layered medium.

The rigorous analysis of layered microstrip structures requires the computation of the Green's functions for multilayer media, which are traditionally represented by the Sommerfeld integrals in the spatial domain, and by closed-form expressions in the spectral domain. When these traditional expressions for the Green's functions are employed in the method of moments (MoM), the numerical evaluation of the MoM matrix elements becomes very time consuming in either domain, because the integrals involved are oscillatory and slow decaying functions [12]. To alleviate this problem, the spatial domain Green's functions for the vector and scalar potentials, represented by the Sommerfeld integrals, are approximated by closed-form

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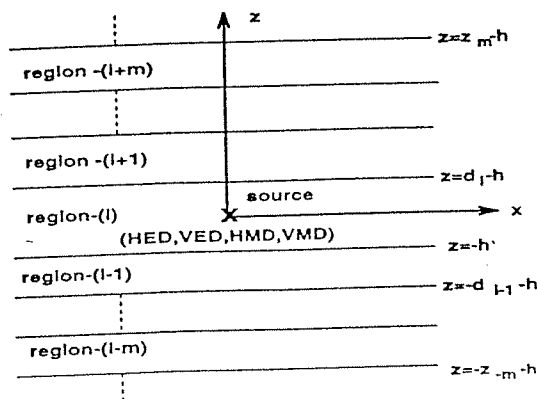


Fig. 1. Sources embedded in a multilayer medium.

expressions and used in the solution of the mixed potential integral equation (MPIE) by the MoM. This approach of approximating the spectral domain Green's functions was first proposed in [13] for a horizontal electric dipole (HED) over a thick substrate backed by a ground plane and extended to a geometry with a substrate and a superstrate with arbitrary thicknesses [14], using the original and least-square Prony's methods [16], respectively. It was demonstrated that the use of the closed-form Green's functions in the analysis of a microstrip geometry via the MoM improves the computational efficiency significantly [15].

In this paper, the closed-form Green's functions of the vector and scalar potentials of a Horizontal Electric Dipole (HED), Horizontal Magnetic Dipole (HMD), Vertical Electric Dipole (VED), and a Vertical Magnetic Dipole (VMD) located in an arbitrary layer of a planar-layered medium are presented. The layers are considered to have different dielectric and magnetic properties (ϵ_r, μ_r) or are made of perfect electric or magnetic conductors (PEC, PMC), as shown in Fig. 1. The Green's functions are first obtained in the spectral domain, which can be represented in closed-form, in the source layer and these expressions are extended to an arbitrary layer using an iterative algorithm [8] for TE and TM components individually. Then, the spatial domain closed-form Green's functions are obtained by adding the contributions of the direct terms and surface waves to the complex images approximated by the Generalized Pencil of Functions (GPOF) method [17], which is less noise sensitive and more efficient than the Prony's methods. Since the spectral domain Green's functions, excluding the direct term and the surface wave components, are approximated by the GPOF method, their dependence on z must be kept in

form to avoid the repeated use of GPOF approximation increase the computational efficiency in cases of vertical sources. Since the Green's functions for the vector and potentials are not uniquely defined in stratified media [9], the closed-form representations of an alternative formulation of the Green's functions are also provided, which can be used in cases where the vertical and horizontal sources are present at the same point [20].

Derivation of the closed-form Green's functions are given in Section II and the numerical considerations associated with their evaluation are discussed. In Section III, some numerical examples of the closed-form Green's functions are presented for two different multilayer geometries and the alternative Green's functions are compared with the exact functions obtained by the numerical evaluation of the bounding Sommerfeld integrals.

II. FORMULATION

A general planar-layered medium is shown in Fig. 1. The source (HED, HMD, VED or VMD) is embedded in region i . The observation point can be located in an arbitrary layer. A layer can have different electric and magnetic properties (ϵ_i) and thickness (d_i). The perfect electric or magnetic conducting planes and half space are also considered as layers in the formulation. The procedure for deriving the closed-form Green's functions can be summarized as the following

Derivation of the Green's functions in the spectral domain.

- Green's functions are derived in the source layer.
- Green's functions in the observation layer are obtained using an iterative algorithm applied to each TE and TM component of the Green's functions in the source layer.

Derivation of the spatial domain, closed-form Green's functions.

- Spectral Domain Green's functions, after having the surface wave poles and the direct terms extracted, are approximated in terms of complex exponentials obtained from the GPOF method.
- Closed-form Green's functions are obtained analytically using the Sommerfeld identity for each complex exponential.

The derivation of the Green's functions for the vector and scalar potentials in the spectral domain follows the similar procedure given in [8], where the Green's functions for the electric and magnetic fields are obtained. Thus, the derived Green's functions, without giving the details of the derivation, are given in Section II-A with all the necessary definitions for the reflection coefficients and amplitudes for the sake of completeness and for later references.

All of the Green's functions presented here are for the vector and scalar potentials that are indeed not uniquely defined in stratified media [18], [19]. Therefore, different sets of Green's functions for the vector and scalar potentials can be chosen to satisfy the same boundary conditions. The following form

of the Green's function is commonly used and referred as the traditional form for the vector potentials

$$\vec{G}_{A,F} = (\hat{x}\hat{x} + \hat{y}\hat{y})G_{xx} + \hat{z}\hat{x}G_{zx} + \hat{z}\hat{y}G_{zy} + \hat{z}\hat{z}G_{zz} \quad (1)$$

and for the scalar potentials, $G_{x,y}^{q_e,m}$ and $G_z^{q_e,m}$ [20]. Note that in this representation, the scalar potentials of the point charges associated with the horizontal and vertical dipoles are not identical. This results in some difficulties in the solution of the mixed potential integral equation for a geometry where both the horizontal and vertical sources (HED and VED or HMD and VMD) are present at the same point, as in the case of a microstrip etch fed by a vertical probe. To overcome this difficulty, an alternative formulation is proposed in [19] and adopted in this paper to the procedure described above. The alternative representations of the Green's functions are given in the Appendix.

A. Green's Functions in the Spectral Domain

To derive the spectral domain Green's function for the source layer (layer i), the z dependence of the fields in the source region is written as the sum of the direct term and up- and down-going waves due to the reflections from the boundaries at $z = -h$ and $z = d_i - h$, respectively. The coefficients of the up- and down-going waves can be obtained in terms of the generalized reflection coefficients by applying the appropriate boundary conditions. The spectral domain Green's functions (traditional form) in the source layer are obtained for the sources of HED, HMD, VED, and VMD as

$$\text{HED} \quad \tilde{G}_{xx}^A = \frac{\mu_i}{2jk_{z_i}} [e^{-jk_{z_i}|z|} + A_h^e e^{jk_{z_i}z} + C_h^e e^{-jk_{z_i}z}] \quad (2)$$

$$\tilde{G}_{zx}^A = \frac{-\mu_i}{2jk_{z_i}} \left[\frac{k_x k_{z_i}}{k_\rho^2} (A_h^e + B_h^e) e^{jk_{z_i}z} + \frac{k_x k_{z_i}}{k_\rho^2} (D_h^e - C_h^e) e^{-jk_{z_i}z} \right] \quad (3)$$

$$\tilde{G}_x^{q_e} = \frac{1}{j2\epsilon_i k_{z_i}} \left[e^{-jk_{z_i}|z|} + \frac{k_{z_i}^2 B_h^e + k_i^2 A_h^e}{k_\rho^2} e^{jk_{z_i}z} + \frac{k_i^2 C_h^e - k_{z_i}^2 D_h^e}{k_\rho^2} e^{-jk_{z_i}z} \right] \quad (4)$$

$$\text{HMD} \quad \tilde{G}_{xx}^F = \frac{\epsilon_i}{2jk_{z_i}} [e^{-jk_{z_i}|z|} + A_h^m e^{jk_{z_i}z} + C_h^m e^{-jk_{z_i}z}] \quad (5)$$

$$\tilde{G}_{zx}^F = \frac{-\epsilon_i}{2jk_{z_i}} \left[\frac{k_x k_{z_i}}{k_\rho^2} (A_h^m + B_h^m) e^{jk_{z_i}z} + \frac{k_x k_{z_i}}{k_\rho^2} (D_h^m - C_h^m) e^{-jk_{z_i}z} \right] \quad (6)$$

$$\tilde{G}_x^{q_m} = \frac{1}{j2\mu_i k_{z_i}} \left[e^{-jk_{z_i}|z|} + \frac{k_{z_i}^2 B_h^m + k_i^2 A_h^m}{k_\rho^2} e^{jk_{z_i}z} + \frac{k_i^2 C_h^m - k_{z_i}^2 D_h^m}{k_\rho^2} e^{-jk_{z_i}z} \right] \quad (7)$$

$$\text{VED} \quad \tilde{G}_{zz}^A = \frac{\mu_i}{j2k_{z_i}} [e^{-jk_{z_i}|z|} + A_v^e e^{-jk_{z_i}z} + B_v^e e^{jk_{z_i}z}] \quad (8)$$

$$\tilde{G}_z^{q_e} = \frac{1}{j2k_{z_i}\epsilon_i} [e^{-jk_{z_i}|z|} + C_v^e e^{-jk_{z_i}z} + D_v^e e^{jk_{z_i}z}] \quad (9)$$

MD:

$$\tilde{G}_{zz}^F = \frac{\epsilon_i}{j2k_{z_i}} [e^{-jk_{z_i}|z|} + A_v^m e^{-jk_{z_i}z} + B_v^m e^{jk_{z_i}z}] \quad (10)$$

$$\tilde{G}_z^{q_m} = \frac{1}{j2k_{z_i}\mu_i} [e^{-jk_{z_i}|z|} + C_v^m e^{-jk_{z_i}z} + D_v^m e^{jk_{z_i}z}] \quad (11)$$

where $\tilde{G}_{ij}^{A,F}$ denotes the spectral domain Green's functions for the vector potentials in direction- i due to a unit j -directed current element, $\tilde{G}_i^{q_e, q_m}$ represents the Green's function of the scalar potential in the spectral domain due to a unit i -directed electric or magnetic current element, $k_i^2 = k_\rho^2 + k_{z_i}^2$, the superscripts A and F represent the magnetic and the electric vector potentials, respectively, q_e and q_m represent electric and magnetic scalar potentials, respectively. The coefficients, $A_v^m, B_v^m, C_v^e, D_v^e, C_v^m, D_v^m$ are functions of the generalized reflection coefficients $\tilde{R}_{TE, TM}$ [8], and are given by

$$A_h^{e,m} = e^{-jk_{z_i}(d_i-h)} \tilde{R}_{TE, TM}^{i,i+1} [e^{-jk_{z_i}(d_i-h)} + \tilde{R}_{TE, TM}^{i,i-1} e^{-jk_{z_i}(d_i+h)}] M_i^{TE, TM} \quad (12)$$

$$B_h^{e,m} = e^{-jk_{z_i}(d_i-h)} \tilde{R}_{TM, TE}^{i,i+1} [e^{-jk_{z_i}(d_i-h)} - \tilde{R}_{TM, TE}^{i,i-1} e^{-jk_{z_i}(d_i+h)}] M_i^{TM, TE} \quad (13)$$

$$C_h^{e,m} = e^{-jk_{z_i}h} \tilde{R}_{TE, TM}^{i,i-1} [e^{-jk_{z_i}h} + \tilde{R}_{TE, TM}^{i,i+1} e^{-jk_{z_i}(2d_i-h)}] M_i^{TE, TM} \quad (14)$$

$$D_h^{e,m} = e^{-jk_{z_i}h} \tilde{R}_{TM, TE}^{i,i-1} [-e^{-jk_{z_i}h} + \tilde{R}_{TM, TE}^{i,i+1} e^{-jk_{z_i}(2d_i-h)}] M_i^{TM, TE} \quad (15)$$

$$A_v^{e,m} = e^{-jk_{z_i}h} \tilde{R}_{TM, TE}^{i,i-1} [e^{-jk_{z_i}h} + \tilde{R}_{TM, TE}^{i,i+1} e^{-jk_{z_i}(2d_i-h)}] M_i^{TM, TE} \quad (16)$$

$$B_v^{e,m} = e^{-jk_{z_i}(d_i-h)} \tilde{R}_{TM, TE}^{i,i+1} [e^{-jk_{z_i}(d_i-h)} + \tilde{R}_{TM, TE}^{i,i-1} e^{-jk_{z_i}(d_i+h)}] M_i^{TM, TE} \quad (17)$$

$$C_v^{e,m} = e^{-jk_{z_i}h} \tilde{R}_{TM, TE}^{i,i-1} [-e^{-jk_{z_i}h} + \tilde{R}_{TM, TE}^{i,i+1} e^{-jk_{z_i}(2d_i-h)}] M_i^{TM, TE} \quad (18)$$

$$D_v^{e,m} = e^{-jk_{z_i}(d_i-h)} \tilde{R}_{TM, TE}^{i,i+1} [-e^{-jk_{z_i}(d_i-h)} + \tilde{R}_{TM, TE}^{i,i-1} e^{-jk_{z_i}(d_i+h)}] M_i^{TM, TE} \quad (19)$$

here

$$M_i^{TE, TM} = [1 - \tilde{R}_{TE, TM}^{i,i+1} \tilde{R}_{TE, TM}^{i,i-1} e^{-jk_{z_i}2d_i}]^{-1} \quad (20)$$

$$\tilde{R}_{TE, TM}^{j+1, j} = \frac{R_{TE, TM}^{j+1, j} + \tilde{R}_{TE, TM}^{j, j-1} e^{-jk_{z_j}2d_j}}{1 - R_{j, j+1} \tilde{R}_{TE, TM}^{j, j-1} e^{-jk_{z_j}2d_j}} \quad (21)$$

and R and \tilde{R} are the Fresnel and generalized reflection coefficients [8] for which the subscripts TE and TM represent the polarization of the wave, and the superscripts $(i, i-1)$ or $(i, i+1)$ show the layer numbers. The subscripts h and v used in the coefficients (12)–(17) represent the orientation of the source, horizontal and vertical, respectively, while the superscripts e and m denote the type of the source, electric and magnetic, respectively. It should be noted that the horizontal Green's functions for the y -oriented dipoles can be obtained

simply by setting $\tilde{G}_{yy}^{A,F} = \tilde{G}_{xx}^{A,F}, \tilde{G}_{zy}^{A,F}/k_y = \tilde{G}_{zx}^{A,F}/k_x$, and $\tilde{G}_y^{q_e, q_m} = \tilde{G}_x^{q_e, q_m}$.

The amplitudes of the up- and down-going waves in a layer different from the source layer are related to those in the adjacent layers by

$$A_j^- = A_{j+1}^- \frac{T_{j+1, j} e^{-j(k_{z_{j+1}} - k_{z_j})(h+z_{-m+1})}}{1 - R_{j, j+1} \tilde{R}_{j, j-1} e^{-jk_{z_j}2d_j}} \quad (22)$$

where A_j^- and A_{j+1}^- are the amplitudes of the down-going waves in layers j and $j+1$, respectively, $(j = i - m)$, T is the transmission coefficient, and z_m is the distance between the lower boundary of the source layer i and the lower boundary of layer j (see Fig. 1). Similarly, the amplitudes of the up-going waves in layer $j = i + m$ can be written as

$$A_j^+ = A_{j-1}^+ \frac{T_{j-1, j} e^{-j(k_{z_{j-1}} - k_{z_j})(z_{m-1} + d_i - h)}}{1 - R_{j, j-1} \tilde{R}_{j, j+1} e^{-jk_{z_j}2d_j}} \quad (23)$$

Therefore, starting from the source layer, the field expressions for any layer can be obtained iteratively [8].

B. Closed-form Green's Functions in the Spatial Domain

The spatial domain Green's functions are represented by the Sommerfeld integral [21] as

$$G^{A, F, q_e, q_m} = \frac{1}{4\pi} \int_{SIP} dk_\rho k_\rho H_o^{(2)}(k_\rho \rho) \tilde{G}^{A, F, q_e, q_m}(k_\rho) \quad (24)$$

where G and \tilde{G} are the Green's functions in the spatial and spectral domains, respectively, $H_o^{(2)}$ is the Hankel function of the second kind, and SIP is the Sommerfeld integration path. The Sommerfeld integral given in (24) cannot be integrated analytically, except for a few special cases. On the other hand, if the spectral domain representation of the Green's function, \tilde{G} , in the integrand can be approximated in terms of complex exponentials, then the analytical evaluation of the integral (24) becomes possible via the Sommerfeld identity. Since the contributions of the direct terms, $e^{-jk_{z_i}|z|}/k_{z_i}$, and the surface waves can be calculated analytically, they are excluded from the expressions to be approximated, [13], [14].

In approximating the spectral domain Green's functions, the GPOF method, which is based on solving a generalized eigenvalue problem, is used [17]. The spectral domain Green's functions, \tilde{G} , are uniformly sampled along an integration path, $k_z = k[-jt + (1 - t/T_o)]$ deformed from SIP [13] and approximated by complex exponentials as

$$\tilde{G} \cong \sum_{m=1}^N a_m e^{-b_m k_{z_i}} \quad (25)$$

where N is the number of exponentials used in the approximation. Then, the Sommerfeld identity

$$\frac{e^{-jk_r}}{r} = -\frac{j}{2} \int_{SIP} dk_\rho k_\rho H_o^{(2)}(k_\rho \rho) \frac{e^{-jk_z|z|}}{k_z} \quad (26)$$

is employed to obtain the Green's functions in the following form, referred as the closed-form

$$G \cong \sum_{m=1}^N a_m \frac{e^{-jk_i r_m}}{r_m} + \text{direct term} + \text{surface waves} \quad (27)$$

$r_m = \sqrt{\rho^2 - b_m^2}$ represents a complex distance. Since surface wave contributions for thin-layered structures are negligible for such geometries; meanwhile, the extraction of surface wave poles could improve the approximation of geometries with thick layers. Note that the approximation of spectral domain Green's functions (2)–(11) must be modified for the terms in the square brackets, i.e., the terms are apart from $1/k_{z_i}$, after extracting the direct term surface wave poles, to be able to use the Sommerfeld identity. In addition, k_x and k_y parameters in $\tilde{G}_{xx}^{A,F}$ and $\tilde{G}_{yy}^{A,F}$, respectively, are excluded in the approximation and their contributions are added in the spatial domain (after having added the spatial domain representations of $\tilde{G}_{xx}^{A,F}/k_x$ and $\tilde{G}_{yy}^{A,F}/k_y$) by differentiating analytically with respect to x and y , respectively.

Closed-Form Green's Functions for MoM Applications

So far, a general procedure to obtain the closed-form Green's functions for the vector and scalar potentials has been obtained, but nothing has been done yet to make these closed-form expressions numerically efficient when they are used in conjunction with the method of moments. As mentioned before, the terms in the square brackets in (2)–(11) are to be applied uniformly along k_{z_i} and approximated by complex exponentials. To do so, one needs to fix the vertical coordinate variable z ; that is, the approximation technique GPOF has to be applied for each z value involved in the analysis. In cases of horizontal conductors only, this wouldn't cause computational inefficiency because the conductors must be located at constant z -planes, resulting in the following MoM matrix element:

$$T_{xm}, G_{xx}^A * B_{zn} + \frac{1}{\omega^2} \left\langle T_{xm}, \frac{\partial}{\partial x} \left[G_x^{q_c} * \frac{\partial B_{zn}}{\partial x} \right] \right\rangle \quad (28)$$

where T_{xm} and B_{zn} are testing and basis functions, respectively. G_{xx}^A and $G_x^{q_c}$ used in this formulation are approximated by GPOF for constant z 's corresponding to the planes of the conductors in the geometry. However, in geometries with both vertical and horizontal conductors with z and x -directed current components, respectively, typical MoM matrix elements have the terms of

$$\begin{aligned} &\langle T_{zm}, G_{zz}^A * B_{zn} \rangle, \quad \left\langle T_{zm}, \frac{\partial}{\partial z} \left[G_z^{q_c} * \frac{\partial B_{zn}}{\partial z} \right] \right\rangle \\ &\langle T_{zm}, G_{zz}^A * B_{zn} \rangle, \quad \left\langle T_{zm}, \frac{\partial}{\partial z} \left[G_z^{q_c} * \frac{\partial B_{zn}}{\partial z} \right] \right\rangle \end{aligned} \quad (29)$$

where $G_{xx}^A, G_{zz}^A, G_x^{q_c}$ and $G_z^{q_c}$ need to be approximated at every observation point z and/or source point z' values (assuming the origin is at the bottom of the source layer for the application of the MoM, the coordinates used in the derivation of the Green's functions here can be transformed by $z \leftarrow z - h, h \leftarrow z'$) in the integration due to the testing and expansion processes along a vertical conductor. This would defeat the purpose of using the closed-form Green's functions in a MoM application. To circumvent the problem associated with the testing process, which corresponds to integration along z , the

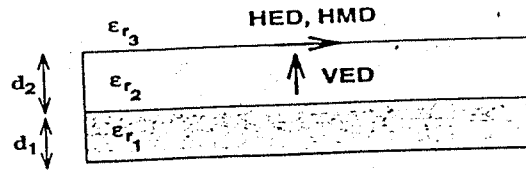


Fig. 2. Geometry of a 4-layer structure. Layer-0: PEC, Layer-3: half space, $\epsilon_{r1} = 10, d_1 = 0.075$ cm, $\epsilon_{r2} = 2, d_2 = 0.15$ cm, $\epsilon_{r3} = 1, h = d_2$ for HED and HMD, $h = d_2/2$ for VED, $z = 0.0$ cm.

GPOF method can be applied to the complex coefficients of $e^{\pm jk_{z_i} z}$ in all the Green's functions except $\tilde{G}_{xx}^{A,F}$. Hence, the z -dependence in the closed-form Green's functions becomes explicit and the testing procedure along the z -direction can be performed analytically for some testing functions like uniform and roof-top functions, which further improves the computational efficiency of using the closed-form Green's functions in conjunction with the method of moments. Another technique, proposed here, to overcome the above mentioned difficulties is to interchange the order of integration (29), provided that the basis and testing functions are so chosen that the involved integrals are uniformly convergent [12], and carrying out integration over z analytically for spectral domain representation of the Green's function multiplied with the testing function. Next, the approximation method, GPOF, is applied to the resulting spectral domain function. For the inner product terms involving both the z and z' integrations, these integrals can be performed analytically by using the procedure described above and subsequently applying the GPOF algorithm. Note that the spectral representations of the Green's functions are exponential functions of z and z' , and this permits us to carry out z and z' integrations analytically.

III. NUMERICAL RESULTS AND DISCUSSIONS

The closed-form Green's functions presented in Section II can be used for planar-layered geometries having an arbitrary number of layers with arbitrary layer parameters and general sources. In this section, a multilayer geometry is investigated for different types of sources and the Green's functions obtained using the closed-forms (approximate) are compared with the exact Green's functions, calculated by evaluating the corresponding Sommerfeld integrals numerically.

The geometry investigated in this paper consists of a substrate and a superstrate with three different dipoles (HED, HMD, and VED) and modeled as a 4-layer structure with the following parameters—layer-0: PEC, layer-3: half-space, $\epsilon_{r1} = 10, \epsilon_{r2} = 2, \epsilon_{r3} = 1, d_1 = 0.075$ cm, $d_2 = 0.15$ cm, as shown in Fig. 2. The horizontal dipoles (HED and HMD) are located at the air-dielectric interface ($h = d_2$) and the vertical dipole is located in the middle of the top layer ($h = d_2/2$). In all three cases, the observation points are chosen at the source plane ($z = z' = 0.0$ cm), which is the worst case as far as the convergence of the Green's functions are concerned. Figs. 3–9 show the magnitude of $G_{xx}^A, \int G_{xx}^A dx, G_x^{q_c}, G_{xx}^F, G_x^{q_c}, G_{zz}^A$ and $G_z^{q_m}$ with respect to the distance $k_0 \rho$, which are obtained using both the closed-form representations and numerically evaluating the

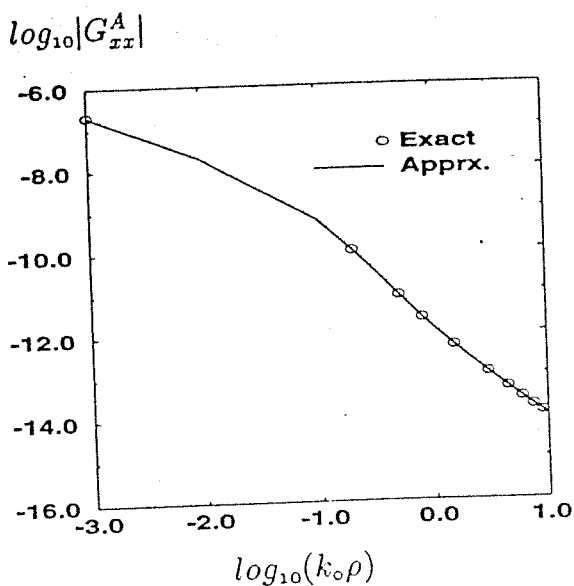


Fig. 3. Magnitude of the Green's function for the vector potential, G_{xx}^A , for an HED. Layer-0: PEC, Layer-3: half space, $\epsilon_{r1} = 10, d_1 = 0.075$ cm, $\epsilon_{r2} = 2, d_2 = 0.15$ cm, $\epsilon_{r3} = 1, h = d_2, z = 0.0$ cm, $f = 1$ GHz.

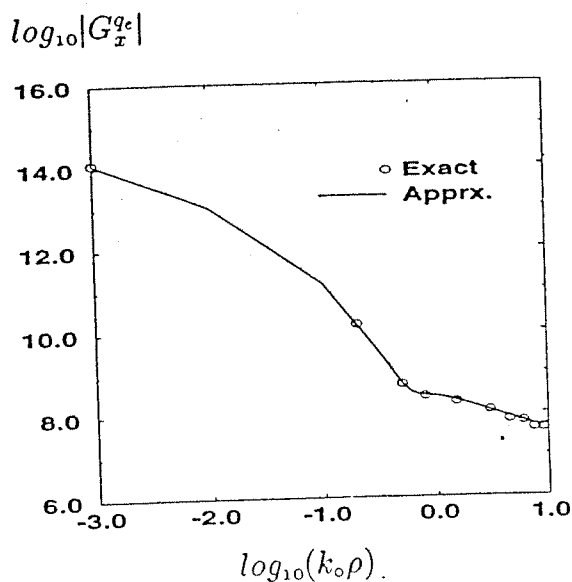


Fig. 5. Magnitude of the Green's function for the scalar potential, G_x^{qe} , for an HED. Layer-0: PEC, Layer-3: half space, $\epsilon_{r1} = 10, d_1 = 0.075$ cm, $\epsilon_{r2} = 2, d_2 = 0.15$ cm, $\epsilon_{r3} = 1, h = d_2, z = 0.0$ cm, $f = 1$ GHz.

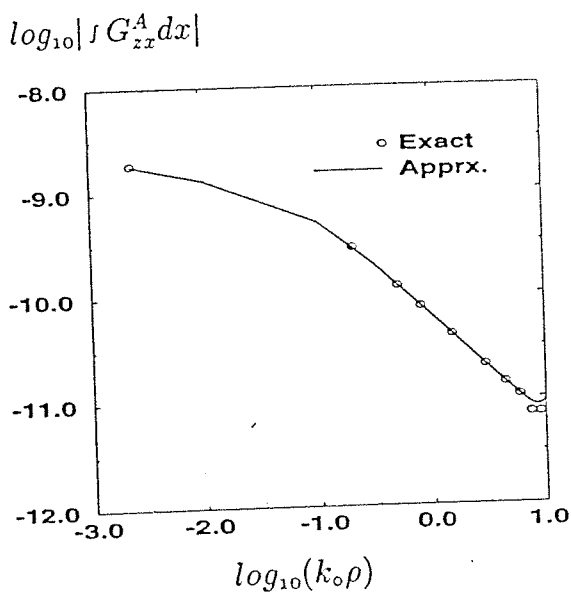


Fig. 4. Magnitude of the Green's function for the vector potential, $\int G_{zz}^A dx$, for an HED. Layer-0: PEC, Layer-3: half space, $\epsilon_{r1} = 10, d_1 = 0.075$ cm, $\epsilon_{r2} = 2, d_2 = 0.15$ cm, $\epsilon_{r3} = 1, h = d_2, z = 0.0$ cm, $f = 1$ GHz.

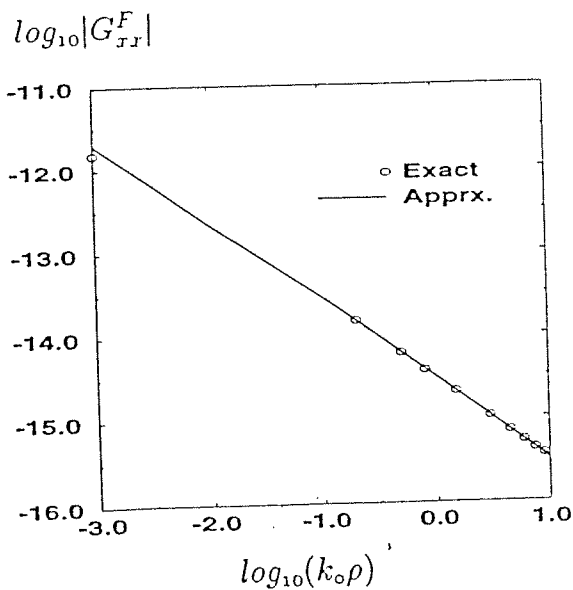
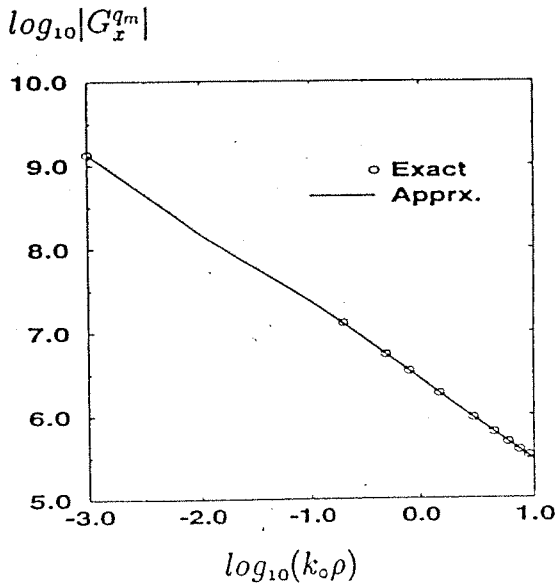


Fig. 6. Magnitude of the Green's function for the vector potential, G_{xx}^F , for an HMD. Layer-0: PEC, Layer-3: half space, $\epsilon_{r1} = 10, d_1 = 0.075$ cm, $\epsilon_{r2} = 2, d_2 = 0.15$ cm, $\epsilon_{r3} = 1, h = d_2, z = 0.0$ cm, $f = 1$ GHz.

corresponding Sommerfeld integrals at a frequency of 1 GHz. In Fig. 4 $|\int G_{zz}^A dx|$ is given, instead of $|G_{zz}^A|$, because the approximation is performed on \tilde{G}_{zz}^A/k_x . Fig. 10 shows the approximate and the exact Green's functions, G_{zz}^A , calculated using the alternative form.

In approximating the spectral domain Green's functions using the GPOF, the choice of the number of samples used to represent a Green's function in the spectral domain, the maximum sampled value of k_z , and the number of exponentials used to approximate the spectral domain Green's functions

depend on the parameters of the multilayer geometry, the type and the orientation of the dipole, and the Green's function to be approximated. For example, it is observed that fewer sampling points, a fewer number of exponentials, and a smaller value of T_0 are required for G_{xx}^A than those required for G_x^{qe} . This is because the vector potential contributes to the far field in the spatial domain; the major contributions to the spectral domain come from the region close to the origin. On the other hand, the scalar potential, which contributes to the near field dominantly, extends to larger values of k_ρ in the spectral domain. As one of the contributions of this paper, the



7. Magnitude of the Green's function for the scalar potential, G_x^{qm} , in HMD. Layer-0: PEC, Layer-3: half space, $\epsilon_{r1} = 10, d_1 = 0.075$ cm, $\epsilon_{r2} = 2, d_2 = 0.15$ cm, $\epsilon_{r3} = 1, h = d_2, z = 0.0$ cm, $f = 1$ GHz.

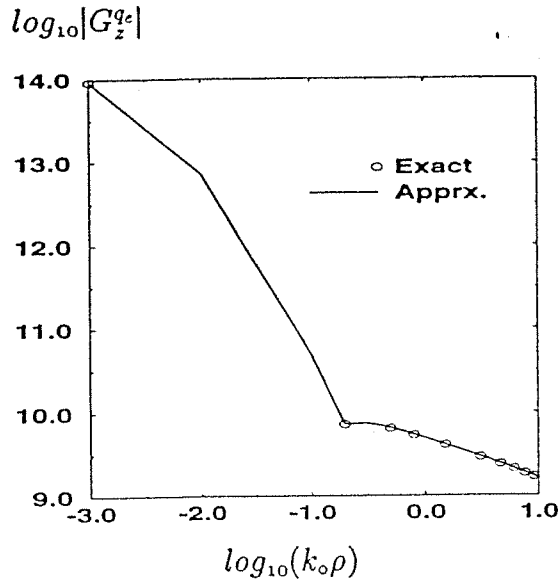
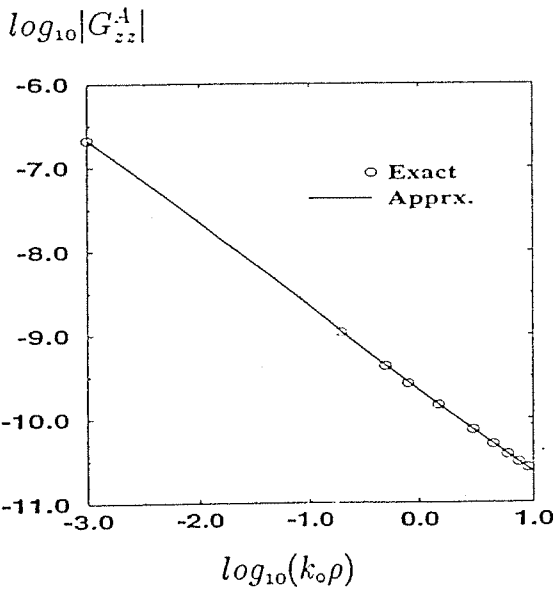


Fig. 9. Magnitude of the Green's function for the scalar potential, G_z^{qe} , for a VED, traditional representation. Layer-0: PEC, Layer-3: half space, $\epsilon_{r1} = 10, d_1 = 0.075$ cm, $\epsilon_{r2} = 2, d_2 = 0.15$ cm, $\epsilon_{r3} = 1, h = d_2/2, z = 0.0$ cm, $f = 1$ GHz.



8. Magnitude of the Green's function for the vector potential, G_{zz}^A , for a VED, traditional representation. Layer-0: PEC, Layer-3: half space, $\epsilon_{r1} = 10, d_1 = 0.075$ cm, $\epsilon_{r2} = 2, d_2 = 0.15$ cm, $\epsilon_{r3} = 1, h = d_2/2, z = 0.0$ cm, $f = 1$ GHz.

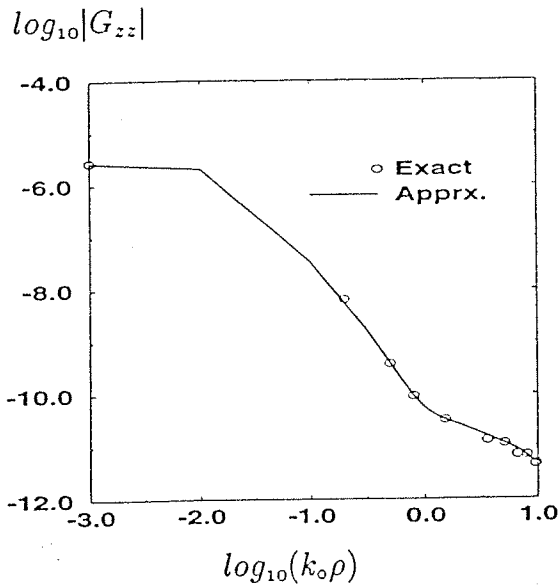


Fig. 10. Magnitude of the Green's function for the vector potential, G_{zz}^A , for a VED, alternative representation. Layer-0: PEC, Layer-3: half space, $\epsilon_{r1} = 10, d_1 = 0.075$ cm, $\epsilon_{r2} = 2, d_2 = 0.15$ cm, $\epsilon_{r3} = 1, h = d_2/2, z = 0.0$ cm, $f = 1$ GHz.

Approximation of the spectral domain Green's functions by complex exponentials is performed by using the GPOF [17]. This technique is more robust and less noise sensitive [22] than the original and the least-square Prony's methods. The robustness of the technique comes from the fact that it utilizes singular value decomposition technique as an intermediate step to extract the complex exponentials, through which the number of exponentials used in the approximation can be chosen as the number of the most significant singular values either automatically or interactively. Consequently, the number

of exponentials chosen for each Green's function in the examples given in this paper is different. For example, in the approximation of G_{xx}^A of Fig. 3, the number of exponentials, the number of samples, and the maximum sampled value T_0 are chosen as 4 (including the direct term), 201, and 100, respectively, while the same parameters are chosen as 10 (including the direct term with no surface wave extraction), 401, and 100 for G_x^{qm} of Fig. 5. It should be noted that the numbers given above are strongly dependent on the parameters of the geometry and the source.

IV. CONCLUSION

In this work, a complete set of closed-form, spatial domain Green's functions are provided in stratified media for general sources. The closed-form Green's functions are obtained using the GPOF method, which is more robust and less noise sensitive than the original Prony's and the least-square Prony's methods. In addition, the Green's functions are cast into a form to increase the numerical efficiency in the MoM applications. Numerical examples of the closed-form Green's functions are given for a multilayer medium. The approximate Green's functions are compared with the exact ones and very good agreement is observed.

APPENDIX

ALTERNATIVE FORM OF GREEN'S FUNCTION

Since the vector and scalar potentials are not uniquely defined in stratified media, different sets of Green's functions for the vector and scalar potentials are possible giving rise to many different MPIE formulations [18], [19]. Among these Green's functions, three useful choices referred as formulations A, B, and C, are given in [20]. In this paper, the formulation C is chosen as the alternative form of the Green's function and given here as

$$\bar{G}_{A,F} = (\hat{x}\hat{x} + \hat{y}\hat{y})G_{xx} + \hat{z}\hat{x}G_{zx} + \hat{z}\hat{y}G_{zy} + \hat{x}\hat{z}G_{zx} + \hat{y}\hat{z}G_{yz} + \hat{z}\hat{z}G_{zz} \quad (30)$$

and $G^{q,m}$ as the Green's function for the scalar potential for both horizontal and vertical dipoles, Fig. 1. Note that the difficulties encountered in the traditional formulation due to the difference between the scalar potentials of HED (HMD) and VED (VMD) are alleviated in this formulation. In the above form of the Green's function, the terms associated with the horizontal dipoles ($G_{xx}^{A,F}$, $G_{yy}^{A,F}$, $G_{zz}^{A,F}$, $G_{zy}^{A,F}$, $G_x^{q,m}$, and $G_y^{q,m}$) remain the same as in the traditional form (2)–(7); two new entries, $G_{xz}^{A,F}$ and $G_{yz}^{A,F}$, are introduced and $G_{zz}^{A,F}$ is modified for the vertical dipoles. For an x -oriented HED and a z -oriented VED, the Green's function components used with the alternative form are adopted to the formulation given in Section II-A as

$$\tilde{G}_{zz}^A = \frac{1}{jk_{zi}} \left[\frac{\mu_i}{2} e^{-jk_{zi}|z|} + e^{-jk_{zi}z} \left[\frac{\mu_i}{2} A_v^e - \frac{k_{zi}^2}{2\omega^2\epsilon_i} \cdot \left[A_v^e - \frac{k_i^2 C_h^e - k_{zi}^2 D_h^e}{k_p^2} \right] + e^{jk_{zi}z} \left[\frac{\mu_i}{2} B_v^e + \frac{k_{zi}^2}{2\omega^2\epsilon_i} \cdot \left[-B_v^e + \frac{k_{zi}^2 B_h^e + k_i^2 A_h^e}{k_p^2} \right] \right] \right] \quad (31)$$

$$\tilde{G}_{xz}^A = \frac{-j - k_x k_{zi}}{k_{zi} 2\omega^2\epsilon_i} \left[e^{-jk_{zi}z} \left[A_v^e - \frac{k_i^2 C_h^e - k_{zi}^2 D_h^e}{k_p^2} \right] + e^{jk_{zi}z} \left[-B_v^e + \frac{k_{zi}^2 B_h^e + k_i^2 A_h^e}{k_p^2} \right] \right] \quad (32)$$


where \tilde{G}_{zz}^A , \tilde{G}_{xz}^A are the alternative Green's function components in the source layer and $A_{h,v}^e$, $B_{h,v}^e$, C_h^e , D_h^e are given in (12)–(17).

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REFERENCES

- [1] N. K. Das and D. M. Pozar, "A spectral-domain Green's function for multilayer dielectric substrates with application to multilayer transmission lines," *IEEE Trans. Microwave Theory Tech.*, vol. MTT-35, pp. 326–335, Mar. 1987.
- [2] F. Crog and D. M. Pozar, "Multifrequency operation of microstrip antennas using aperture coupled parallel resonators," *IEEE Trans. Antennas Propagat.*, vol. 40, pp. 1367–1374, Nov. 1992.
- [3] L. Barlatey, J. R. Mosig, and T. Spicopoulos, "Analysis of stacked microstrip patches with mixed potential integral equation," *IEEE Trans. Antennas Propagat.*, vol. 18, pp. 608–615, May 1990.
- [4] A. N. Tulinseff, S. M. Ali, and J. A. Kong, "Input impedance of a probe fed stacked circular microstrip antenna," *IEEE Trans. Antennas Propagat.*, vol. 39, pp. 381–390, Mar. 1991.
- [5] K. R. Carver and J. W. Mink, "Microstrip antenna technology," *IEEE Trans. Antennas Propagat.*, vol. AP-29, pp. 2–24, Jan. 1981.
- [6] D. R. Jackson and N. G. Alexopoulos, "Gain enhancement methods for printed antennas," *IEEE Trans. Antennas Propagat.*, vol. AP-33, pp. 976–987, Sept. 1985.
- [7] C. I. G. Hsu, R. F. Harrington, K. A. Michalski, and D. Zheng, "Analysis of multiconductor transmission lines of arbitrary cross section in multilayered uniaxial media," *IEEE Trans. Microwave Theory Tech.*, vol. 41, pp. 70–78, Jan. 1993.
- [8] W. C. Chew, *Waves and Fields in Inhomogeneous Media*. New York: Van Nostrand Reinhold, 1990.
- [9] M. Gillick, I. D. Robertson, and J. S. Joshi, "Design analysis of novel coupling structures for multilayer MMIC's," *IEEE Trans. Microwave Theory Tech.*, vol. 41, pp. 346–349, Feb. 1993.
- [10] T. Tokumitsu, H. Hiraota, H. Makamoto, and T. Takenaka, "Multilayer MMIC using a 3 $\mu\text{m} \times 3$ -layer dielectric film structure," in *IEEE MTT-S Int. Microwave Symp. Dig.*, 1990, pp. 831–834.
- [11] T. Hasegawa, S. Banba, H. Ogawa, and H. Nakamoto, "Characteristics of valley microstrip lines for use in multilayer MMIC's," *IEEE Microwave Guided Wave Lett.*, vol. 1, Oct. 1991.
- [12] M. I. Aksun and R. Mittra, "Choices of expansion and testing functions for the method of moments applied to a class of electromagnetic problems," *IEEE Trans. Microwave Theory Tech.*, vol. 41, pp. 503–509, Mar. 1993.
- [13] Y. L. Chow, J. J. Yang, and D. F. Fang, and G. E. Howard, "Closed form spatial Green's function for the thick substrate," *IEEE Trans. Microwave Theory Tech.*, vol. 39, pp. 588–592, Mar. 1991.
- [14] M. I. Aksun and R. Mittra, "Derivation of closed-form Green's functions for a general microstrip geometry," *IEEE Trans. Microwave Theory Tech.*, vol. 40, pp. 2055–2062, Nov. 1992.
- [15] ———, "Spurious radiation from microstrip interconnects," *IEEE Trans. Electromagn. Compat.*, vol. 35, pp. 148–158, May 1993.
- [16] S. L. Marple, *Digital Spectral Analysis with Applications*. Englewood Cliffs, NJ: Prentice Hall, 1987.
- [17] Y. Hua and T. K. Sarkar, "Generalized pencil-of-function method for extracting poles of an EM system from its transient response," *IEEE Trans. Antennas Propagat.*, vol. 37, pp. 229–234, Feb. 1989.
- [18] A. Erteza and B. K. Park, "Nonuniqueness of resolution of Hertz vector in presence of a boundary, and a horizontal dipole problem," *IEEE Trans. Antennas Propagat.*, vol. AP-17, pp. 376–378, May 1969.
- [19] K. A. Michalski, "On the scalar potential of a point charge associated with a time-harmonic dipole in a layered medium," *IEEE Trans. Antennas Propagat.*, vol. AP-35, pp. 1299–1301, Nov. 1987.
- [20] K. A. Michalski and D. Zheng, "Electromagnetic scattering and radiation by surfaces of arbitrary shape in layered media, Part I: Theory," *IEEE Trans. Antennas Propagat.*, vol. 38, pp. 335–344, Mar. 1990.
- [21] A. Sommerfeld, *Partial Differential Equations in Physics*. New York: Academic, 1949.
- [22] A. J. Mackay and A. McCowen, "An improved pencil-of-functions method and comparisons with traditional methods of pole extraction," *IEEE Trans. Antennas Propagat.*, vol. AP-35, pp. 435–441, Apr. 1987.



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Comparative Evaluation of Absorbing Boundary Conditions Using Green's Functions for Layered Media

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Abstract—Absorbing boundary conditions are comparatively studied using the Green's functions of the vector and scalar potentials for multilayer geometries and general sources. Since the absorbing boundaries are introduced as additional layers with predefined reflection coefficients into the calculation of the Green's functions, this approach provides an absolute measure of the effectiveness of different absorbing boundaries. The Green's functions are calculated using different reflection coefficients corresponding to different absorbing boundaries and compared to those obtained with no absorbing boundary. It is observed that the perfectly matched layer (PML) is by far the best among the other absorbing boundary conditions whose reflection coefficients are available.

I. INTRODUCTION

APPLICATION of the numerical techniques based on differential equations in unbounded regions, such as the finite-difference time-domain (FDTD) and the finite-element methods (FEM), requires the truncation of the solution domain with artificial boundaries. Ideally, these boundaries are supposed to absorb all the incident waves, that is, there should be no reflected waves, so they are called absorbing or radiation boundaries [1]–[7]. However, there is always some reflected waves due to imperfect cancellation of the impinging waves on these artificial boundaries. The level of the reflection depends upon the absorbing boundaries used and the order of the approximation.

Since different absorbing boundaries give rise to different level of reflected waves, one needs to examine these boundary conditions comparatively to decide on the type and the order of the absorbing boundary condition (ABC) to be used, to improve the accuracy of results. For the purpose of comparison, numerical experiments can be performed [8], [9] on the geometry of interest, but here, we propose the use of Green's functions to assess the level of imperfections of the ABC's for planar geometries. The Green's functions used in the comparative evaluation of ABC's are provided for general sources and planar stratified media by including the reflections from each boundary [10]. The absorbing boundaries are considered as additional layers, for which the reflection coefficients can be derived explicitly, above the original struc-

ture forming a multilayer geometry. The Green's functions of the vector and scalar potentials are then calculated and compared with those obtained for the original geometry (no absorbing boundary) to observe the effect of the ABC's on the Green's functions, providing an absolute measure of merit of the ABC's. The Green's functions used in this approach are calculated in the spatial domain via either numerically integrating the Sommerfeld-type integrals or approximating the integrals in closed form [10]. The technique proposed here eliminates extraneous problems caused by the discretizations required by the techniques used in conjunction with the ABC's and, therefore, gives a true comparison of different types and orders of the ABC's.

In this paper, the Green's function-based comparison of the ABC's is given for the sources of a horizontal electric dipole and a horizontal magnetic dipole in multilayer media. The comparison is based on the absorbing boundaries formulated by [3] for normal incidence, by [4], [5] for arbitrary angle of incidence, and by Berenger [11] as the perfectly matched layer (PML). The main goal of this approach is to compare the ABC's for planar geometries for the purpose of finding an ABC that can be used accurately. Even though the conclusion drawn here may not be directly extended to other geometries (nonplanar), the technique can be applied to any geometry provided that corresponding Green's functions are available.

The Green's functions used in the evaluation of the ABC's are discussed in Section II, including how these Green's functions in the spatial domain are obtained and how the absorbing boundaries are accounted for in the calculation. The reflection coefficients for the absorbing boundaries studied in this paper are presented in Section III, and discussion on the numerical results is given in Section IV.

II. GREEN'S FUNCTIONS FOR MULTILAYER MEDIA

The Green's functions of the vector and scalar potentials used for the evaluation of the ABC's are given in [10] for the multilayer geometry, shown in Fig. 1, and for the sources of horizontal electric dipole (HED), horizontal magnetic dipole (HMD), vertical electric dipole (VED), and vertical magnetic dipole (VMD). Therefore, only a brief outline of the formulation is provided here, and, in addition, the spectral-domain Green's functions of HED and HMD, which are used in the applications presented in this paper, are given in the Appendix.

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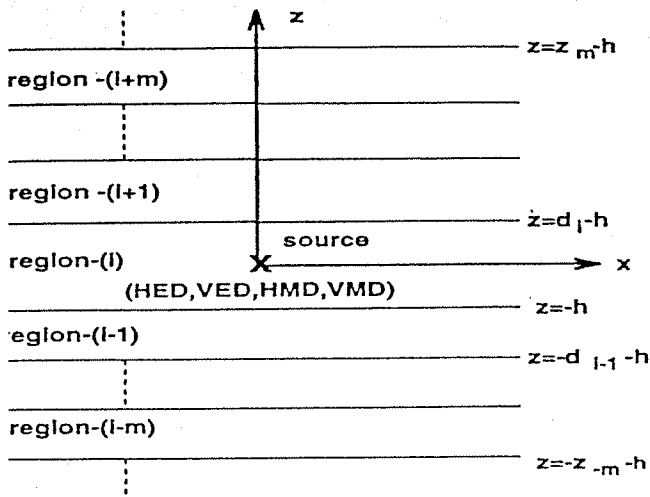


Fig. 1. General multilayer geometry.

The multilayer geometry used in the formulation of the Green's functions (Fig. 1) consists of arbitrary number of planar layers with different electric and magnetic properties (ϵ_i, μ_i) and thicknesses (d_i). The perfect electric and magnetic conducting planes (PEC and PMC) and half-space are also considered as layers for the formulation. The Green's functions are first obtained in the spectral domain, as given in the Appendix, including the reflections from each boundary, then the spatial-domain Green's functions are calculated either with the numerical evaluation of Sommerfeld's integral [1] (exact) or in closed forms (approximate) using the generalized pencil of functions (GPOF) method [10], [13]. Both exact and approximate forms of the Green's functions are used for the purpose of comparison, but the numerical evaluation of the Sommerfeld integral is preferred for the results presented here, in this paper, to eliminate any question regarding the possibility of error in the approximation. The numerical evaluation of the Sommerfeld integral is performed with the method of averages [14], which is considered to be the fastest algorithm available.

These Green's functions can be utilized in the comparative evaluation of the ABC's by introducing the absorbing boundary as an additional layer above the original structure (Fig. 2), forming a multilayer geometry. Since the reflection coefficients associated with different ABC's are available, the Green's functions for the geometry with an absorbing boundary can be obtained by including the reflection coefficients of the ABC's in the formulation. To examine the effect of ABC's, these Green's functions are compared with the Green's functions obtained for the ideal case which corresponds to the original geometry with no absorbing boundary.

III. ABSORBING BOUNDARIES

Various absorbing boundaries have been developed for the purpose of simulating an unbounded region for the solution of differential-equation-based numerical techniques. These absorbing boundaries can be formed as mode annihilating operators, one-way wave equations, numerical approximations, and perfectly matched layers. Although the recent trend was toward

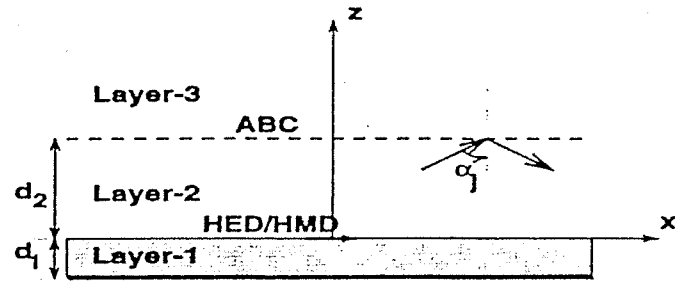


Fig. 2. A typical planar geometry.

numerical simulations of the absorbing boundaries, with the recent introduction of a novel boundary condition by Berenger, PML [11], this approach has gained a flurry of interest. It was numerically demonstrated that the PML absorbing boundary is more accurate than the second-order Mur [3] for 2-D and 3-D geometries [9]. In this paper, the PML absorbing boundary is compared to the other absorbing boundaries given by [3]–[7] for planar geometries. Since comparison given in this paper is based on the Green's functions it has the advantage of being immune to the error introduced by the numerical techniques due to discretizations.

The analytical absorbing boundary conditions discussed in this study are based on one-way wave equations and the corresponding reflection coefficients can be obtained as described in [3], [6]. Expressions for the reflection coefficients are given here for the second- and third-order ABC's as

$$R = \frac{-\frac{k_{zi}}{k_i} + p_0 + p_2 \frac{k_p^2}{k_i^2}}{\frac{k_{zi}}{k_i} + p_0 + p_2 \frac{k_p^2}{k_i^2}} \quad (\text{second order}) \quad (1)$$

$$R = \frac{-q_0 \frac{k_{zi}}{k_i} - q_2 \frac{k_{zi} k_p^2}{k_i^3} + p_0 + p_2 \frac{k_p^2}{k_i^2}}{q_0 \frac{k_{zi}}{k_i} + q_2 \frac{k_{zi} k_p^2}{k_i^3} + p_0 + p_2 \frac{k_p^2}{k_i^2}} \quad (\text{third order}) \quad (2)$$

where the subscript i stands for the layer number, k_p is the wave number in the transverse direction, and p 's and q 's depend upon the type of the approximation used in the derivation of the ABC and are given in [6]. A more general absorbing boundary, which is designed to absorb the plane waves incident at arbitrary angles, can be represented by the following reflection coefficient [4], [5]

$$R = - \prod_{j=1}^{\text{order}} \frac{\cos \alpha_j - \frac{k_{zi}}{k_i}}{\cos \alpha_j + \frac{k_{zi}}{k_i}} \quad (3)$$

where the perfect absorption occurs at the angles of α_j 's.

The PML absorbing boundary is based on the absorption of electromagnetic waves by creating a nonphysical absorbing layer, or perfectly matched layer, that has a wave impedance independent of the angle of incidence and frequency [11]. The PML absorbing boundary consists of a normal free-space computational zone and a PML outer boundary layer backed by a perfectly conducting (PEC) wall. In this approach it is suggested that the loss associated with PML should increase gradually with depth, ρ , within the layer as $\sigma(\delta) =$

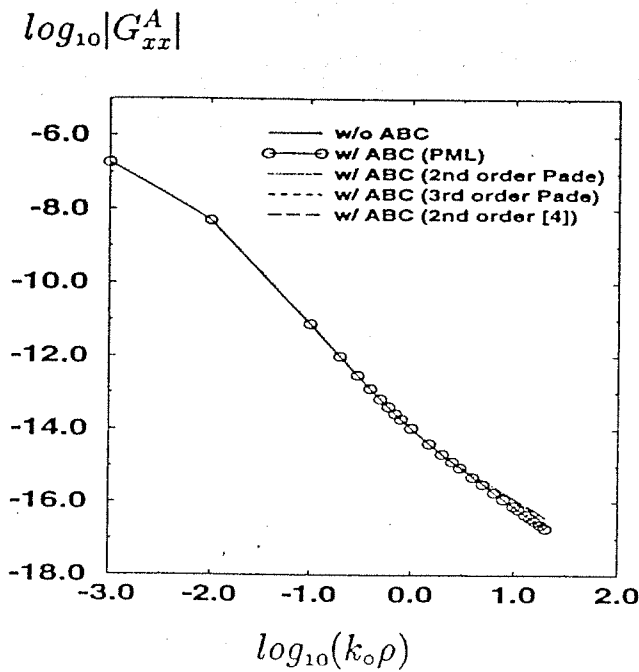


Fig. 3. Magnitude of the Green's function of the vector potential, G_{xx}^A , for an HED. Layer-1: $\epsilon_{r1} = 4.0$, $d_1 = 0.02032$ cm; layer-2: air, $d_2 = 10.0$ cm; layer-3: absorbing boundary, $f = 1.0$ GHz.

$\sigma_{\max}(\rho/\delta)^n$. Hence, it yields a PML reflection factor of

$$R(\theta) = e^{-2\sigma_{\max}\delta \cos\theta/(n+1)\epsilon_0 c} \quad (4)$$

where δ is the PML thickness, σ is the loss associated with the layer, and c is the velocity of light. With the proper choice of δ , σ , and n , the reflection coefficient as low as 1/3000th those of standard second- and third-order ABC's, such as [3], has been reported [11].

IV. RESULTS AND DISCUSSION

The approach discussed in Section II can be applied to any multilayer geometry with arbitrary layer parameters, such as thicknesses, permittivities, and permeabilities. For the sake of illustration, the following parameters have been chosen for the geometry shown in Fig. 2. The dielectric constant of the substrate $\epsilon_{r1} = 4.0$; the thickness of the substrate $d_1 = 0.02032$ cm (8.0 mils); the frequency of operation $f = 1.0$ GHz; the distance of the ABC from the air-dielectric interface $d_2 = 10.0$ cm; layer-0 PEC.

Ideally, absorbing boundaries are supposed to absorb all the waves impinging upon them, but since the ABC's are approximations to the ideal case, inevitably there may be some reflections. Therefore, the ideal absorbing boundary corresponds to, in the case presented here, no absorbing boundary at all. To study the effect of the absorbing boundaries, the vector and scalar potentials at the air-dielectric interface in the presence of the absorbing boundaries are calculated and compared to those obtained with no absorbing boundary. The following Green's functions are employed to study the ABC's: $G_{xx}^{A,F}$ —Green's function of the vector potential for an x oriented HED, HMD, respectively; $G_z^{q,e,m}$ —Green's function

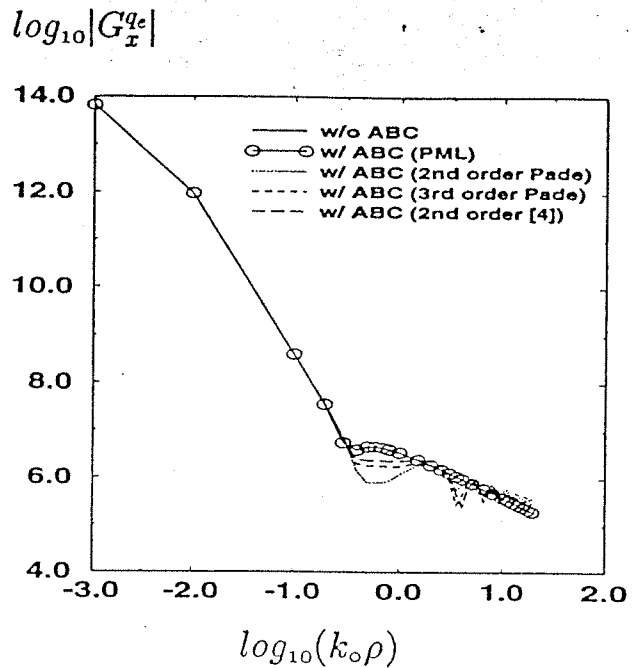


Fig. 4. Magnitude of the Green's function of the scalar potential, G_z^q , for an HED. Layer-1: $\epsilon_{r1} = 4.0$, $d_1 = 0.02032$ cm; layer-2: air, $d_2 = 10.0$ cm; layer-3: absorbing boundary, $f = 1.0$ GHz.

of the scalar potential for an x oriented HED and HMD, respectively.

Figs. 3 and 4 show the magnitudes of the Green's functions of the vector and scalar potentials, G_{xx}^A and G_z^q , respectively, with and without the absorbing boundaries. It is observed that the second-order Padè approximation for the ABC, which only absorbs exactly the normal-incident plane waves, yields sufficiently good results for the vector potential (Fig. 3) as compared to those obtained with the ideal ABC (no ABC). On the other hand, the scalar potential shows some deviation from the ideal case, Fig. 4. Although it is not necessary to use the third-order Padè approximation for the ABC for the vector potential case, significant improvement is observed for the scalar potential which is more evident from the phase information of the scalar potential, as shown in Fig. 5. It might be claimed that if the absorbing boundary annihilates the incoming waves at different angles of incidence, it would improve the overall performance of the ABC without increasing the order of approximation. As a matter of fact, an improvement is observed in the magnitude of the scalar potential, Fig. 4 where the angles of exact absorption are set to 0° and 60° in (3) for the second-order approximation, but the improvement in the phase is not significant. On the other hand, the use of PML absorbing boundary results in perfect agreement with the ideal case in both magnitude and phase, see Figs. 3–5. To assess the level of error introduced by the absorbing boundaries, the plots of percentage error versus distance, corresponding to the above mentioned absorbing boundaries, are given in Fig. 6. As it is observed, the PML absorbing boundary is far superior than the other absorbing boundaries, which is due to very low sensitivity of the reflection coefficient (4) to the incidence angle θ . Furthermore, the performance of the

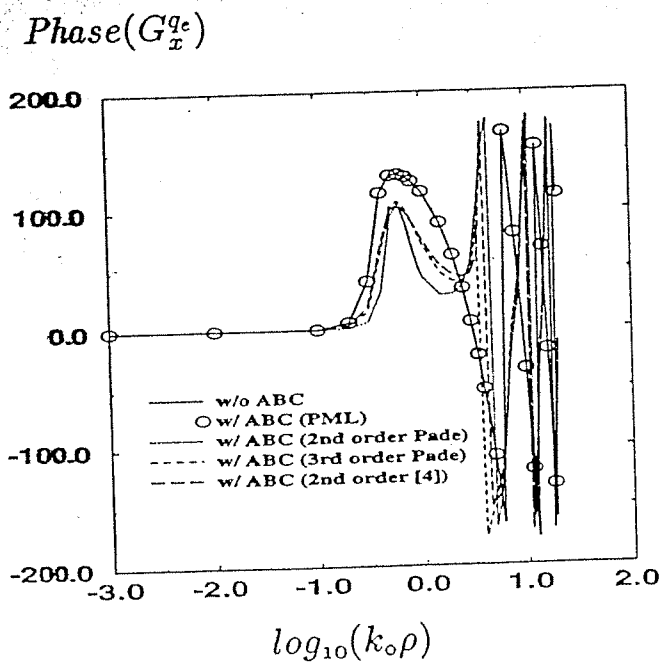


Fig. 5. Phase of the Green's function of the scalar potential, G_x^{qe} for an HED. Layer-1: $\epsilon_{r1} = 4.0$, $d_1 = 0.02032$ cm; layer-2: air, $d_2 = 10.0$ cm; layer-3: absorbing boundary, $f = 1.0$ GHz.

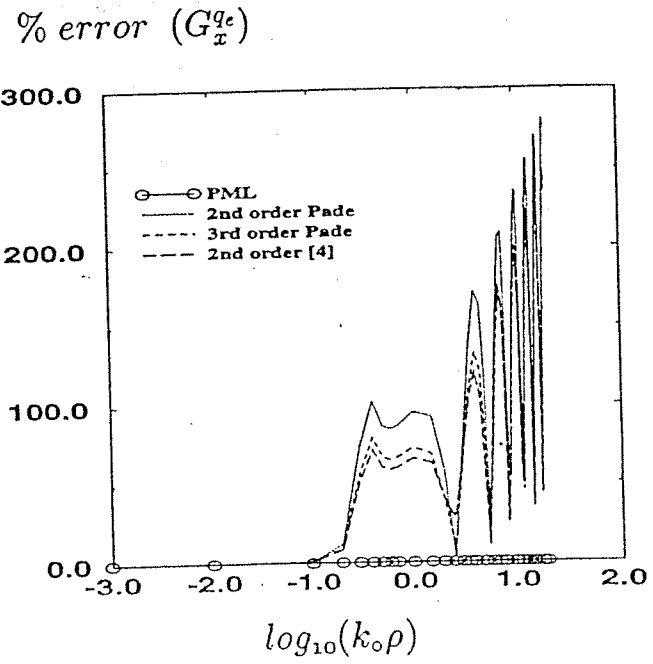


Fig. 6. Percentage error for G_x^{qe} . Layer-1: $\epsilon_{r1} = 4.0$, $d_1 = 0.02032$ cm; layer-2: air, $d_2 = 10.0$ cm; layer-3: absorbing boundary, $f = 1.0$ GHz.

PML can be easily improved by varying the depth, δ , and the conductivity, $\sigma(\rho)$ of the PML. It should be noted that the starting edge of the PML is positioned where the other absorbing boundaries are placed. Due to the finite thickness of the PML, this positioning might be considered as giving an unfair advantage to the PML over other ABC's. However, since the thickness of the PML is usually much smaller, or can be made smaller with the proper choice of the conductivity, than the distance where the PML is located, this positioning can have only a slight effect on the results presented here.

$\% \text{ error } (G_x^{qe})$

In practice, it is desirable to bring the outer boundary as close to the original geometry as possible to reduce the number of mesh points, and hence the computation time. On the other hand, when the distance of the absorbing boundary is reduced, the error introduced by the reflections from the absorbing boundary becomes significant. To demonstrate the effect of the distance of the PML, the percentage error of $|G_x^{qe}|$ is given for the PML distances of $d_2 = 10$ cm and $d_2 = 1$ cm in Fig. 7. It is observed that when the PML distance is as low as 1 cm ($1/30\lambda$) the maximum error is less than 3%, which could even be reduced by adjusting the parameters of the PML.

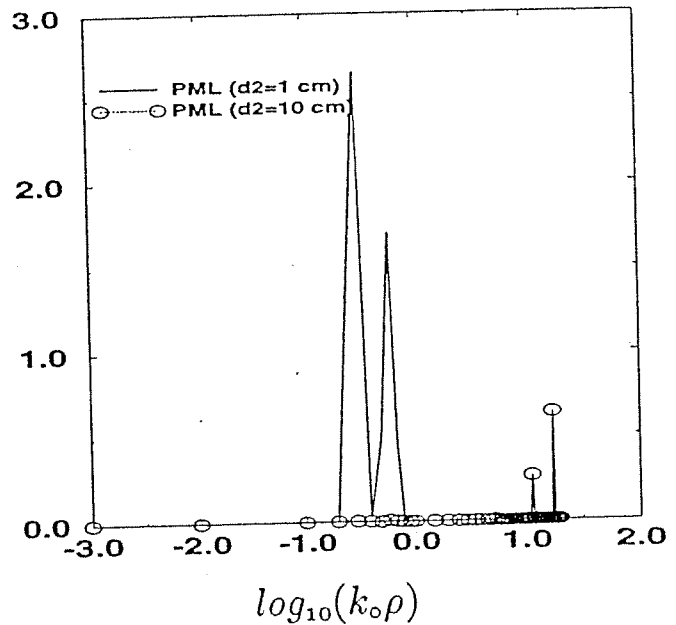


Fig. 7. Percentage error for G_x^{qe} for two different PML distances: $d_2 = 10$ cm and $d_2 = 1$ cm. Layer-1: $\epsilon_{r1} = 4.0$, $d_1 = 0.02032$ cm; layer-2: air; layer-3: PML, $f = 1.0$ GHz.

The HMD is also studied as for the horizontal electric source case given above, and it is observed that the same arguments are valid for the HMD source as well.

V. CONCLUSION

The use of the Green's functions for the study of the ABC's have been demonstrated for planar media. Two different analytical ABC's and PML absorbing boundary have been compared with each other and with the ideal case, but this approach can also be applied to other ABC's provided that the associated reflection coefficients are available. The strength

of this approach over the numerical comparison of the ABC's is the analytical nature of the comparison, which does not depend on the numerical technique used, and is to provide an absolute comparison between different ABC's. Among the compared absorbing boundaries, the error introduced by the PML absorbing boundary is much less than those of the others.

APPENDIX A

Green's functions of the vector and scalar potentials for the planar multilayer media shown in Fig. 1 are first derived in the spectral domain then transformed in to the spatial domain either in closed forms using an approximation technique such as GPOF [13], or with the numerical evaluation of Sommerfeld's integral. The spectral-domain Green's functions are first obtained in the source layer by including the reflections at each interface [12], then the Green's functions of the observation layer are obtained using an iterative algorithm applied to each TE and TM component of the Green's functions in the source layer. The spectral-domain Green's functions in the source layer are given for the sources of an HED and an HMD as [10], HED

$$\tilde{G}_{xx}^A = \frac{\mu_i}{2jk_{z_i}} \left[e^{-jk_{z_i}|z|} + A_h^e e^{jk_{z_i}z} + C_h^e e^{-jk_{z_i}z} \right] \quad (5)$$

$$\tilde{G}_{zx}^A = \frac{-\mu_i}{2jk_{z_i}} \left[\frac{k_x k_{z_i}}{k_p^2} (A_h^e + B_h^e) e^{jk_{z_i}z} + \frac{k_x k_{z_i}}{k_p^2} (D_h^e - C_h^e) e^{-jk_{z_i}z} \right] \quad (6)$$

$$\tilde{G}_x^{q_c} = \frac{1}{j2\epsilon_i k_{z_i}} \left[e^{-jk_{z_i}|z|} + \frac{k_{z_i}^2 B_h^e + k_i^2 A_h^e}{k_p^2} e^{jk_{z_i}z} + \frac{k_i^2 C_h^e - k_{z_i}^2 D_h^e}{k_p^2} e^{-jk_{z_i}z} \right] \quad (7)$$

HMD:

$$\tilde{G}_{xx}^F = \frac{\epsilon_i}{2jk_{z_i}} \left[e^{-jk_{z_i}|z|} + A_h^m e^{jk_{z_i}z} + C_h^m e^{-jk_{z_i}z} \right] \quad (8)$$

$$\tilde{G}_{zx}^F = \frac{-\epsilon_i}{2jk_{z_i}} \left[\frac{k_x k_{z_i}}{k_p^2} (A_h^m + B_h^m) e^{jk_{z_i}z} + \frac{k_x k_{z_i}}{k_p^2} (D_h^m - C_h^m) e^{-jk_{z_i}z} \right] \quad (9)$$

$$\tilde{G}_x^{q_m} = \frac{1}{j2\mu_i k_{z_i}} \left[e^{-jk_{z_i}|z|} + \frac{k_{z_i}^2 B_h^m + k_i^2 A_h^m}{k_p^2} e^{jk_{z_i}z} + \frac{k_i^2 C_h^m - k_{z_i}^2 D_h^m}{k_p^2} e^{-jk_{z_i}z} \right] \quad (10)$$

where the coefficients A, B, C, D , are functions of the generalized reflection coefficients, parameters of the geometry, and the source point, z' .

REFERENCES

- [1] A. Sommerfeld, *Partial Differential Equations in Physics*. New York: Academic, 1949.
- [2] B. Engquist and A. Majda, "Absorbing boundary conditions for the numerical simulation of waves," *Math. Comput.*, vol. 31, pp. 629-651, July 1977.
- [3] G. Mur, "Absorbing boundary conditions for the finite difference approximation of time-domain electromagnetic field equations," *IEEE Trans. Electromag. Compat.*, vol. EMC-23, pp. 377-382, Nov. 1981.
- [4] R. L. Higdon, "Absorbing boundary conditions for difference approximations to the multidimensional wave equation," *Math. Comput.*, vol. 47, pp. 437-459, Oct. 1986.
- [5] R. Mittra and J.-F. Lee, "Direct Maxwell's equation solvers in time and frequency domains—A review," in *Directions in Electromagnetic Wave*

Modeling, H. L. Bertoni and L. B. Felsen, Eds. New York: Plenum, 1991.

- [6] T. G. Moore, J. G. Blashchak, A. Taflove, and G. A. Kriegsmann, "Theory and application of radiation boundary operators," *IEEE Trans. Antennas Propagat.*, vol. 36, pp. 1797-1812, Dec. 1988.
- [7] R. Mittra and O. Ramahi, "Absorbing boundary conditions for the direct solution of partial differential equations arising in electromagnetic scattering problems," in *PIER 2: Finite Element and Finite Difference Methods in Electromagnetic Scattering*, M. A. Morgan, Ed. New York: Elsevier, 1990.
- [8] J. G. Blaschak and G. A. Kriegsmann, "A comparative study of absorbing boundary conditions," *J. Comput. Phys.*, vol. 77, pp. 109-139, July 1988.
- [9] D. S. Katz, E. T. Thiele, and A. Taflove, "Validation and extension to three dimensions of the Berenger PML absorbing boundary condition for FDTD Meshes," *IEEE Microwave Guide Wave Lett.*, vol. 4, pp. 268-270, Aug. 1994.
- [10] G. Dural and M. I. Aksun "Closed-form Green's functions for general sources and stratified media," *IEE Trans. Microwave Theory Tech.*, vol. 43, pp. 1545-1552, July 1995.
- [11] J. Berenger, "A perfectly matched layer for the absorption of electromagnetic waves," *J. Computat. Phys.*, vol. 114, pp. 185-200, Oct. 1994.
- [12] W. C. Chew, *Waves and Fields in Inhomogeneous Media*. New York: Van Nostrand Reinhold, 1990.
- [13] Y. Hua and T. Sarkar, "Generalized pencil-of-function method for extracting poles of an EM system from its transient response," *IEEE Trans. Antennas Propagat.*, vol. 37, pp. 229-234, May 1989.
- [14] J. R. Mosig and F. Gardiol, "A dynamical radiation model for microstrip structures," *Adv. Electron. Electron Phys.*, vol. 59, pp. 139-233, 1982.
- [15] M. I. Aksun and R. Mittra, "Derivation of closed-form Green's functions for general microstrip geometries," *IEEE Trans. Microwave Theory Tech.*, vol. 40, pp. 2055-2062, Nov. 1992.



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DESIGN OF AN ACTIVE MICROSTRIP ARRAY USING A MICROWAVE CIRCUIT SIMULATOR

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Abstract

Active antenna array design and simulation of this with a microwave circuit simulator are presented. Active antenna array is a TV receive only (TVRO) operating at 10 GHz. It is a 8x4 array of planar microstrip patch antennas. Eight low noise transistors are placed in the antenna. Passive antenna characteristics are usually obtained by analytical methods or using special softwares for this purpose. The analytical representation as well as the nonreciprocal of the active device necessitates the use of a circuit simulator. In this work, both the antenna and the active characteristics are obtained in the same medium, microwave circuit simulator LIBRA. The array structure is simulated with LIBRA for gain, noise figure, radiation pattern, directivity and bandwidth.

Microstrip Patch Antenna

Active antenna array will work at a single polarization. Therefore, the microstrip patch antenna is designed as a rectangular patch rather than a square patch. This gives the degree of freedom in the patch design. The shape of the patch is chosen considering its input impedance and patch length is dictated by the resonance frequency at 10 GHz. The substrate of the microstrip antenna is RT Duroid 5880. Parameters of this substrate are given in Table I.

h	Loss tangent	Cladding
0.787 mm	0.0009	70 µm gold plated copper

Table I. Substrate parameters (RT Duroid 5880)

Microstrip patch is modeled using Pues and Van de Polder model [1]. The element values of this model have frequency dependence. It is observed that this dependence is linear in the vicinity of center frequency. The microwave circuit simulator LIBRA allows defining the element values as simple functions. Using this property of the simulator, frequency dependence of the patch model is modeled in the simulations as first order polynomial functions of the frequency.

Antenna Array

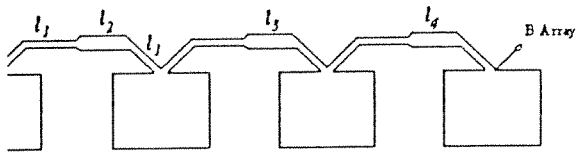
The microstrip antenna array is a parallel fed structure. Four parallel fed patch antennas are taken as a sub array and called as B array. Overall antenna array is consisted of eight parallel fed B arrays, and called as A array. Antenna structure and related dimensions are given in figure 1. Quarter wave impedance transformers are used between the patch antennas in order to make amplitude tapering and also, to decrease the loading of antennas with preceding elements.

The planar antenna array structure is designed for narrow beam and low side lobe level in H-plane. To maintain this criteria, the antenna structure in this dimension is not altered, whereas dimensions and structure of the feedline in the perpendicular dimension are kept as variables of design for active circuit integration.

Active Circuit

G/T ratio of the active antenna is intended to be kept high. An important way to reach this goal is to use low noise active devices. NEC 32484A pHEMTs are the low noise transistors used in the design. Scattering and noise parameters of this transistor at the frequency of interest, 10 GHz, are given in Table II. This transistor has a noise figure as low as 0.51 dB at 10 GHz when input impedance is selected as the optimum noise impedance. The active circuit is placed between each B array and the feedline, thus 8 low noise transistors are used in total. NEC 32484A is a packaged transistor, therefore, it is possible to make a hybrid design.

The transistors are self biased at $V_{DS}=2V$ and $I_D=10mA$ for low noise operation. This is achieved by connecting a capacitor in one of the two source terminals of the pHEMT, and a resistor in the other one. Drain terminals of all the transistors are connected to the feedline. Therefore drain voltage is given from a single point and RF output is DC blocked using a coaxial capacitor. With this configuration total DC power consumption will be about 0.16 W.



Line	Width	Length
1	150	5.82
2	429	5.72
3	326	5.75
4	240	5.79

length : 9.5 mm
width : 10.0 mm

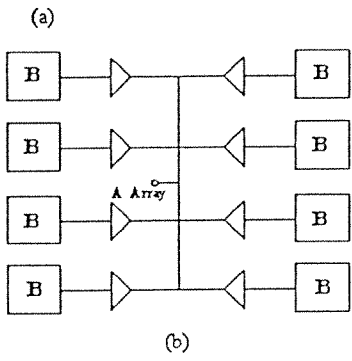


Figure 1. Structure and dimensions of microstrip patch in array. (a) Microstrip patch and B array (b) Structure of A array.

Frequency	NF _{opt}	Γ _{opt}	r _n
GHz	0.51 dB	0.40 131°	0.09

(a)

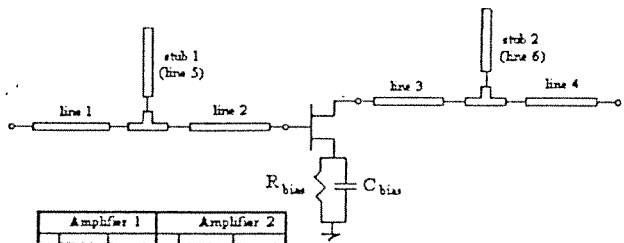
S ₁₁	S ₁₂	S ₂₁	S ₂₂
-142°	0.096 14°	3.03 40°	0.485 -95°

(b)

Table II. (a) Noise and (b) scattering parameters of NEC 32484A.

temperature of the passive antenna is about 25 K space noise is not counted for. Optimum noise of the active device is given as 0.51dB. This figure corresponds approximately to 36 K. Comparison of optimum noise figure of the active device and the passive antenna noise temperature shows that noise contribution of the active device is an important quantity in determining the noise temperature of the active antenna. Therefore, active device should be operated at or close to optimum noise figure.

Microstrip transmission lines and open circuited stubs are used for impedance transforming and will simply be used as matching sections. Line width and lengths of matching elements are the design variables. Transistor and the matching sections should fit onto the area between a B array and the feedline. Also none of the microstrip lines should be close to each other because otherwise parasitic coupling will occur. These considerations limited the electrical and physical sizes of elements used for matching. Amplifier topology is given in figure 2.



Amplifier 1			Amplifier 2		
#	Width	Length	#	Width	Length
1	0.181	1.280	1	0.171	1.276
2	0.486	2.306	2	0.455	2.321
3	0.796	2.128	3	0.797	2.145
4	0.540	7.108	4	0.515	7.368
5	0.150	4.724	5	0.151	4.704
6	0.592	3.949	6	0.600	3.875

Figure 2. Amplifier topology and dimensions of matching elements

Short circuit stubs are not used because no accurate characterization of the production process exists for short circuits. Thus, open circuited stubs are preferred and the open circuit end-effects which are easier to characterize are included in the simulations [2].

In the active array design input impedance of the amplifier is the input impedance of B array and the output impedance is the impedance seen looking towards the feedline at the point of junction. Because of feedline structure and the loading effects, the output impedance as defined above is different for amplifiers at different positions. Observing the symmetry of the feedline structure it is easily seen that there are two different output impedances, consequently there should be two similar but different output matching circuits. One amplifier is effective in determining the load of other amplifier. Therefore an iterative optimization procedure is followed.

Noise figure of an amplifier is strongly dependent on its input impedance. Therefore the input impedance of the B array should be transformed to the optimum noise impedance of the active device in order to reach its optimum noise figure. It should be noted that the matching microstrip elements are lossy. Henceforth, noise figure of the active circuit is greater than the optimum noise figure of the active device.

Moreover, in order to be able to take the available power from a source, input impedance of the amplifier should be conjugately matched to the input impedance of the source. The input power to the amplifier from B array is related to antenna efficiency, that is, efficiency of the B array is less than one if the delivered power from B array is less than the available power of the B array. Therefore, input matching circuit should not only transform the input impedance of the B array to the optimum noise impedance of the active device but also transform the input impedance of the active device to the conjugate impedance of the input impedance of B array. On the otherhand,

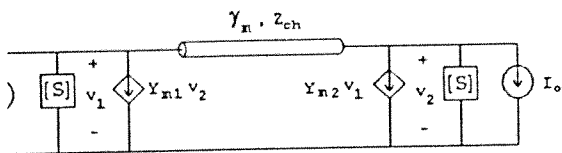


Figure 3. Microstrip patch model in receive mode.

impedance of the amplifier should be adjusted to maximum gain from the amplifier. In practice, constraints may not be satisfied simultaneously.

Impedance of the B array is real and about 105Ω at z. The input impedance of the amplifier is matched input impedance of the B array and under above conditions matching circuits are optimized to yield a figure of 0.58 dB and about 8 dB gain at 10 GHz. A point to be considered is the frequency bandwidth of antenna. In order not to limit this bandwidth, both gain and performance of the amplifiers should have enough frequency bandwidths.

Active Antenna Simulation Results

To simulate the array in receive mode, hypothetical current sources are connected to the patch antennas to represent received electromagnetic wave. The patch antenna element receives electromagnetic power from two sources therefore two current sources equal in amplitude and out of phase are connected to each antenna element. Magnitudes of the current sources for antenna elements in different positions are taken to be the same as a uniform illumination of the array is assumed and the antenna elements are identical. The absolute value of currents depends on effective length of the slots and intensity of the incident field. The receive mode operation of the patch antenna is given in figure 3.

In simulations, a load impedance of 50Ω is connected to the output of the A array. Output power of the active antenna is defined as the power delivered to this load impedance. Input power is the sum of the power delivered to each antenna element when all current sources, amplifiers etc. are present in the system. Amplification of the active system is defined as the ratio of output power to input power. The amplification term takes the place of efficiency term in the gain definition of an antenna. It is, for a passive antenna, directivity times the efficiency of the antenna. With this definition, amplification is 15.2dB at 10 GHz.

Noise temperature of the active system is calculated by the author using the noise correlation matrices. Current sources representing the received power are disconnected, and the noise current delivered to the load impedance from the n-port A array is calculated. The noise power due to

this noise current is converted to noise temperature using the well-known relation:

$$P_n = \bar{i}_n^2 R_L = kTB \quad (1)$$

The resultant noise at the load impedance is due to the losses in the active system and the noise generated by the active device. Noise temperature calculated in this manner is about 29.2 dB-K at 10 GHz. The ratio of amplification of the active system to the noise temperature is -14 dB. In order to find the antenna gain to noise temperature ratio, G/T, effect of directivity should be included. Simulation results for amplification, noise temperature and output power when 10 μA current sources are connected, are given in figure 4. Since amplification is defined as the ratio of output power to the input power, frequency dependence of output power is also important; i.e.; although amplification remains constant, output power may decrease.

In order to obtain the radiation pattern, progressive phase shift is introduced to the hypothetical current sources. The magnitude of the phase shift is a function of element spacing, free space wavelength, physical position of the element in the array and angle of incidence. Output power as a function of angle of incidence gives the radiation pattern of the array which does not include the dependence of effective length of the microstrip patch on angle of incidence. Magnitude of the hypothetical current sources can be set as a function of angle of incidence which will count for the dependence of effective length on angle of incidence. Array factor which is much more rapidly changing than this dependence dominates in determining the radiation pattern in low angles of incidence. Therefore dependence of effective length on angle of incidence is neglected. H-plane radiation pattern which is obtained by this way is given in figure 5. Side lobe level is below 19 dB in H-plane. E-plane radiation pattern is also obtained and directivity is calculated using the approximate formula of Krauss for directivity. Directivity of the active array is about 22 dB at 10 GHz.

The frequency dependence of the array characteristics is also investigated. Frequency bandwidth for output power is about 600 MHz. However, the dependence of radiation pattern on frequency is much more higher. As frequency deviates from the center frequency in either direction, side-lobe level increases rapidly. Therefore, frequency bandwidth of the antenna is mainly determined with radiation pattern bandwidth.

Stability of both the amplifiers and the active system are investigated. All over the simulation frequency range, real part of amplifier output impedances and the A array output impedance are positive. Therefore, for any passive load, this one port system is stable.

Conclusion

The array simulation method using a microwave simulator is described. The designed active array is an antenna and since there are nonreciprocal elements in the system, the array cannot be analysed as a passive antenna which is the usual case for passive arrays. To simulate the array in receive mode, ideal current sources are connected to the patch to represent the induced short circuit currents.

The method described here is applicable not only to the active arrays but to the passive arrays as well. By this method of simulation, efficiency (amplification), noise figure, radiation pattern, directivity, gain and

frequency bandwidth of antenna arrays can be obtained in the same computational environment.

Acknowledgement

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Reference:

- [1] Pues, H., Van de Capelle, A., "Accurate transmission line model for the rectangular microstrip antenna", IEE Proceedings, vol. 131, Pt. H, No. 6, Dec. 1984.
- [2] J.R. James, P.S. Hall (Ed.), *Handbook of Microstrip Antennas*, Peter Peregrinus Ltd., London, 1989.

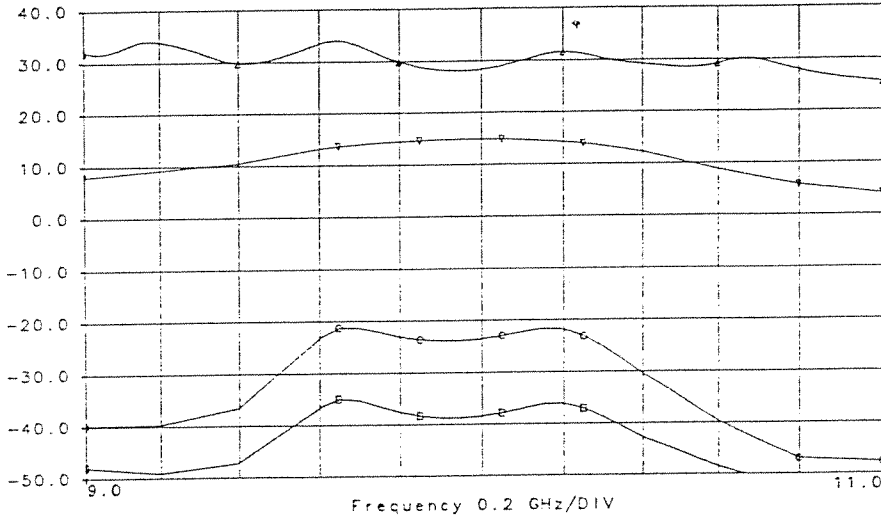


Figure 4. Amplification, noise and output power responses of the active system. \square : Input power, \circ : Output power, ∇ : Amplification (dB), \triangle : Noise temperature (dB-K)

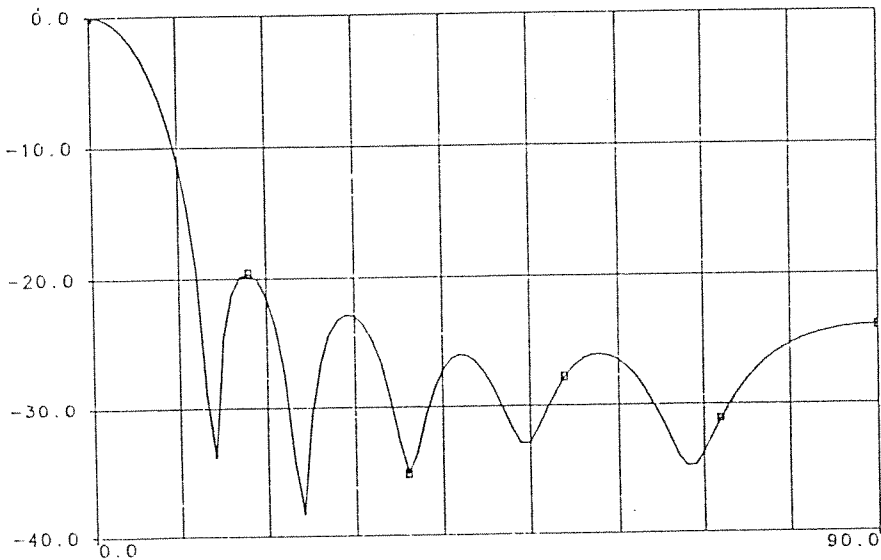


Figure 5. H-plane radiation pattern of the active array.

A NOVEL LOW NOISE ACTIVE CIRCUIT REPLACEMENT CRITERIA FOR PARALLEL FED LARGE SCALE ACTIVE ANTENNA ARRAYS

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Abstract: In this work noise analysis of parallel feed structures for active antenna arrays are presented. Signal and noise behaviour of the feed structures are signified by the newly introduced concepts of "coherent" and "incoherent" impedance match of power combining structures. It is also shown that a feed structure can be re-designed for low noise operation without affecting its radiation characteristics. Optimum design of parallel feed structures for low noise operation is explained. Also an optimum use of active elements in such structures is investigated to have a low overall noise temperature of the antenna array with minimum number of active elements. In the analysis a new method is introduced where a "noise equivalent line length" is defined. This definition which unifies the contribution of noise from different array elements, is used in the design of a parallel feed structure and as an active circuit replacement criteria in passive arrays.

I. INTRODUCTION

An important figure of merit for receive antennas is noise performance. Since 1960's antenna arrays have been investigated for better signal-to-noise ratios, Lo et al. (1), including the recent active antenna structures, Grabherr and Menzel (2). However, in these analysis, feed lines are not studied for their noise performance. Moreover, explicit methods for low noise design of feed structures do not appear in the literature.

Receive antenna array design for certain radiation characteristics is related to the case where all elements receive coherent signal. Feed structure designs that are appearing in the literature are mainly concerned with impedance matching for coherent excitation. However, impedance matching for coherent excitation does not imply the incoherent impedance matching which is the case where the signal that are combined in the structure are incoherent. The response of a feed structure to excitations from incoherent sources such as internal noise of the antenna array, is totally different and such a concept is not considered previously. In our work, incoherent matching of the feed structures is accounted for the first time. Moreover, a novel concept, 'noise equivalent line length', is introduced and utilized for noise analysis of feed structures. Without loss of generality, feed structures that are constructed by transmission lines are investigated.

Using analysis above a low noise large scale antenna array design guide is presented where the critical point to insert a low noise gain element for improved noise performance is identified. In our analysis, it is also shown that insertion of low noise active elements in an antenna array improves the noise performance, however where to insert the active elements is a design problem from point of view of labor, cost and improvement in performance. We defined node, branch, virtual node, virtual branch, and level concepts for parallel feed structures. A weighted equivalent line length function is introduced. This novel function which carefully combines the analysis results of the previous works, stands for the noise contribution of a line segment in a parallel feed structure to the output noise power and utilized for comparing different feed network structures of large scale antenna arrays.

II. PARALLEL FEED STRUCTURE NOISE ANALYSIS

The noise analysis of feed structures is based on the noise analysis of a low loss transmission line, Collin (3). Characteristic impedance, Z_{ch} , attenuation per unit length, α , and length of the line, l , and the ambient temperature, T , determine the generated noise power. The attenuation factor of the line introduces an imaginary part to the Z_{ch} but it is assumed that line is low loss and therefore, Z_{ch} remains, practically, real. The source and load reflection coefficients are defined with respect to the characteristic impedance of the line. Available noise power of a low loss transmission line is obtained for $Z_L = Z_{out}$, where $L = e^{2\alpha l}$:

$$P_{n,available} = kT\Delta f \frac{L - |\Gamma_g|^2/L - 1 + |\Gamma_g|^2}{(1 - |\Gamma_g/L|^2)L} \quad (1)$$

Available noise power of a low loss transmission line is a function of source mismatch and loss factor. This power increases with increasing magnitude of source reflection coefficient. The upper limit of this available power is:

$$P_{n,available,max} = kT\Delta f \quad (2)$$

This means that in the limit of mismatch, a low loss transmission line introduces an available noise power equal to the available noise power of a resistor. Therefore matching is of ultimate importance from point of view of noise

generation which corresponds to incoherent impedance matching of the feed structure of the antenna array.

Above noise analysis is used towards the definition of a noise equivalent line length which simplifies the noise performance evaluation of the feed structures considerably. In doing so, the noise contributions from different elements of a feed structure to the output noise power is expressed in terms of a single parameter which puts explicitly the strength of the contribution relative to the theoretical minimum. Simple addition of these equivalent line lengths is a good comparison criteria for the overall noise performance of the feed structure. Moreover, this uncomplicated parameter, is used as a replacement criteria of active circuits in an antenna array for the optimum noise performance.

Let L be the loss factor of the line under investigation which has a source reflection coefficient, Γ_g , and loss coefficient, α , then its available noise power, P_{line} , is given by (1). Let L_{neqv} be the loss factor of a line which has a line length l_{neqv} and has the same loss coefficient, α . Furthermore let this line be impedance matched at its source side, then its available noise power is given by:

$$P_{eqv} = k T \Delta f \frac{L_{neqv} - 1}{L_{neqv}} \quad (3)$$

For the line under investigation, let us define an equivalent line which is matched and therefore has the available noise power in (3). If L_{neqv} is obtained such that $P_{eqv} = P_{line}$, then L_{neqv} turns out to be:

$$L_{neqv} = \frac{L^2 - |\Gamma_g|^2}{(L^2 - |\Gamma_g|^2) - (L-1)(L + |\Gamma_g|^2)} \quad (4)$$

Consequently, noise equivalent line length, l_{neqv} , of the line turns out to be:

$$l_{neqv} = \frac{1}{2\alpha} \ln \left(\frac{L^2 - |\Gamma_g|^2}{(L^2 - |\Gamma_g|^2) - (L-1)(L + |\Gamma_g|^2)} \right) \quad (5)$$

Using the equivalent line length, output noise temperature can be obtained through (3). Noise equivalent length of a mismatched line is longer than its physical length where minimum noise equivalent length which corresponds to matched case is equal to its physical length. Without comparing the actual noise temperatures, one can deduce the effect of mismatch on noise generation by comparing the noise equivalent and physical lengths. In Fig. 1, noise equivalent line length normalized with its physical line length is given as a function of the source reflection coefficient.

Noise contributions of different segments can be superposed in terms of their noise equivalent line lengths to give an approximate value for the total noise equivalent length. Let us consider two line segments with noise equivalent line length, loss factor and noise power which are represented with l_1 , L_1 and P_1 and l_2 , L_2 and P_2 , respectively. Noise power of the first line section will be attenuated in the second one and the resultant noise power of cascaded connection is given by:

$$\begin{aligned} P_{total} &= kT\Delta f \frac{L_1 - 1}{L_1 \cdot L_2} + kT\Delta f \frac{L_2 - 1}{L_2} \\ &= kT\Delta f \frac{L_{eqv} - 1}{L_{eqv}} \end{aligned} \quad (6)$$

That is:

$$\begin{aligned} L_{eqv} &= L_1 \cdot L_2 \\ l_{eqv} &= l_1 + l_2 \end{aligned} \quad (7)$$

A parallel feed structure is composed of a number of transmission line sections which sometimes function as impedance transformers, and junction points of line sections which function as power combiners. Noise equivalent line lengths of these individual structures can be added to find the overall noise equivalent line length of the feed structure. For a $1 : g^2$ double section quarter wave impedance transformer, noise equivalent line length is obtained through the generated noise power by the line segments:

$$P_{n_1} = kT\Delta f \left(1 - \frac{L((Z_g - Z_1)^2 - (Z_g + Z_1)^2)}{(Z_g - Z_1)^2 - L^2(Z_g + Z_1)^2} \right)$$

$$P_{n_2} = kT\Delta f \left(1 - \frac{L((Z_g - qZ_1)^2 - (Z_g + qZ_1)^2)}{(Z_g - qZ_1)^2 - L^2(Z_g + qZ_1)^2} \right) \quad (8)$$

The total noise power at the output is:

$$P_{Total} = \frac{P_{n_1}}{L_2} + P_{n_2} \quad (9)$$

and noise equivalent line length of the impedance transformer is given by:

$$l_{neqv, tr} = \frac{1}{2\alpha} \ln \left(\frac{1}{1 - P_{Total}/kT\Delta f} \right) \quad (10)$$

For a $1:p^2$ power combiner structure, the equivalent line length is calculated based on the noise power at the output port. For a transmission line power combiner, the output power is the sum of the available power at the input ports if the input signals are coherent and have the proper power ratio Parad and Moynihan (4). Otherwise, if the signals are incoherent, the output power is the weighted summation of the input powers where the weights are the power combination ratios. The following is the noise equivalent line length of the power combiner where port 1 is the output arm, and port 2 and 3 are the input arms:

$$l_{neqv, comb} = l_{neqv, 1} + \frac{1}{1+p^2} l_{neqv, 2} + \frac{p^2}{1+p^2} l_{neqv, 3} \quad (11)$$

For the case, where the thermal noise powers of the two arms are equal, the noise equivalent line length is given by:

$$l_{neqv, comb} = l_{neqv, 1} + l_{arm} \quad (12)$$

These individual structures are used to construct a parallel feed structure. The main frame of a parallel feed structure is a parallel arm where sub arrays are connected to form an array. The sub arrays might be antenna elements and the formed array might be a sub array to be used in the successive level of the parallel feed network. The line segment between the sub array and the parallel arm is named as a *Branch* (Br). The junction point of a branch and the parallel arm is the *Connection Point* (CP) of the sub array and a *Virtual Connection Point* (VCP) of the parallel arm. The sections of the parallel arm between consecutive VCPs are named as *Virtual Branches* (VBr). A parallel arm array has a single branch and a single connection point at its output side, but, have more than one VCP and VBr depending on the number of antenna elements connected to the arm. In a parallel feed structure, all the antenna elements are virtually connected to the same point, output of the array, with complex weights to create the required radiation pattern. The Br's are used to obtain the necessary complex weight of the antenna element (sub array) and VBr are usually of $n\lambda/2$ length and used to supply the connectivity of the antenna elements. VBr's can be used to create a tapered feed by means of quarter-wave-length impedance transformers.

Contribution of available noise power of a lossy line segment, P_{line} , to the output noise power depends on signal power contribution weight factor of the line, w , to the output signal power. Hence, the noise contribution of a line to the noise power at the output is:

$$P_{out, line} = w \times P_{line} \quad (13)$$

For this noise power at the output, a weighted noise equivalent line length ${}^w L_{neqv}$, is defined similar to the noise equivalent line length definition as:

$${}^w l_{neqv} = \frac{1}{2\alpha} \ln \left(\frac{L^2 - |\Gamma_g|^2}{(L^2 - |\Gamma_g|^2) - w(L-1)(L + |\Gamma_g|^2)} \right) \quad (14)$$

By this definition weighted equivalent length of each line segment in a structure can be calculated. These weighted equivalent lengths explicitly give the strength of each noise source in the structure, which enables the designer to see the relatively noisy parts of the feed structure. Summation of noise temperatures corresponding to these noise equivalent line lengths will give the overall noise temperature. On the other hand, the sum of the individual noise equivalent lengths yields the noise equivalent line length of the feed structure.

The impedance at the output of the array decreases rapidly with the increasing number of parallel connected antenna elements, which makes it difficult to match for coherent and incoherent operation. This situation is prevented by

implementing impedance transformers at the connection points of sub arrays. In a corporate feed the number of these connection points is a maximum. Therefore, coherent and incoherent matching is solved with less problem in a corporate feed structure. Weighted noise equivalent line length formulation is applied to a $N = 2^n$ element uniform corporate fed microstrip rectangular patch antenna array which is incoherent impedance matched. The following is the noise equivalent line length for this structure based on (7):

$$\begin{aligned} l_{total, n \text{ even}} &= \sum_{k=1}^{n/2} \lambda \cdot 2^{k-1} - \lambda/4 \\ &= \lambda \cdot 2^{n/2} - \frac{5}{4} \lambda \\ l_{total, n \text{ odd}} &= l_{total, n-1} + \frac{1}{2} \lambda \cdot 2^{(n-1)/2} \end{aligned} \quad (15)$$

Because of spurious radiation losses and conductor losses, realizable microstrip transmission lines widths are limited. Consequently, characteristic impedances required for incoherent impedance match in parallel arm structures are impractical and incoherent mismatch is unavoidable. Such a structure may be coherent impedance matched but because of incoherent impedance mismatch its noise equivalent line length will be much worse than minimum attainable length. Weighted noise equivalent line length of a $2 \times p$ element uniform fed parallel arm structure has the following approximate noise equivalent line length, including the incoherent mismatch:

$$l_{total} = \sum_{k=1}^{p/2-1} \frac{1}{2\alpha} \ln \left(\frac{L^2 - |\Gamma_{g,k}|^2}{L^2 - |\Gamma_{g,k}|^2 - w(L-1)(L + |\Gamma_{g,k}|^2)} \right) \quad (16)$$

where,

$$\begin{aligned} w &= \frac{2k}{p} \\ \Gamma_{g,k} &= \frac{Z_{ant}/2k - Z_{ch,k}}{Z_{ant}/2k + Z_{ch,k}} \end{aligned} \quad (17)$$

A two level parallel arm structure has the shortest physical line length but because of the incoherent mismatch, the noise equivalent line length might be several times longer than the physical line length. For a corporate feed structure, the total physical line length is a maximum, but because of easy integration of impedance transformers, incoherent impedance can be attained, and noise equivalent line length can be made a minimum. The noise equivalent line length is a measure to decide the structure of the array for low noise operation from this point of view.

III. ACTIVE ANTENNA ARRAY DESIGN

For the line segments in the structure, line lengths are determined with phasing requirements and characteristic impedances should be chosen for the incoherent impedance match. However, in the cases where incoherent impedance match is not attained, noise performance will be degraded. For a large antenna array, active circuit integration might be a solution for low noise operation. In that case l_{noise} will be a design guide to determine the insertion level of the active devices in the feed structure. This level will depend on the noise figure and gain of the active circuit and the loss of the line segments. Fig. 2 shows schematically, levels in a corporate feed structure where active elements are placed at one of them. Replacing active devices at level 1 is the best for lowest noise performance at the expense of large number of active circuits, i.e., 2^n . However, there will be a level in the structure where noise improvement is just achieved with decreased number of active elements compared to a passive antenna array.

In order to see this fact let us consider the two cases given in Fig. 3. In this figure the connection point, A, of two successive levels, k and $k+1$ are shown with noise equivalent length l_{noise1} corresponding to levels 1 to k of the structure shown in Fig. 2, and noise equivalent length l_{noise2} corresponding to levels $k+1$ to n . A feed structure with noise temperature, T_f and efficiency, η_f , can be partitioned into two consecutive sections with noise temperatures and efficiencies, T_1, η_1 and T_2, η_2 , respectively, where $T_f = T_1 \times \eta_2 + T_2$ and $\eta_f = \eta_1 \times \eta_2$, and to improve the performance, an LNA can be placed between these two partitions as shown in the Fig. 3.b. Depending on η_2 and T_2 distributed amplification may yield even a better G/T compared to $(G/T)_{passive}$. Notice that, when comparing noise powers of these two systems, active system's noise power should be normalized since signal power of active system is G times more than the passive system's. Distributed amplification yields a better G/T than the passive case when the following equation yields a result greater than zero :

$$\begin{aligned}
P_{out,passive} - \frac{P_{out,dist}}{G} &= T_f - \eta_2(T_{LNA} + T_1) - \frac{T_2}{G} \\
&= T_2\left(1 - \frac{1}{G}\right) - \eta_2 T_{LNA}
\end{aligned}
\tag{18}$$

To satisfy this condition, high G and low T_{LNA} are required. This equation also implies that active circuit integration is necessary for low efficiency systems. Using this calculation maximum length of noise equivalent line of the second partition of the feed structure can be determined, where an active circuit with a certain G and T_{LNA} should be inserted for better noise performance. This point will be the optimum point where the number of required LNAs is a minimum and the noise performance of the passive array is improved.

IV. ACTIVE ARRAY

A 16×16 corporate fed microstrip antenna array on a RT-DUROID 5880 substrate is designed. Quarter-wave-line impedance transformers are placed according to the results of section III, to the feed structure to decrease the noise generation by the lossy feed lines. The rectangular patch antennas are resonant at 10 GHz having a 276Ω resistive input impedance. The uniform fed antennas are equi-separated by a distance, d , which is determined by radiation pattern considerations. The total weighted equivalent line length of this 16×16 patch array is calculated to be about 14.8λ which corresponds to $T = 101^\circ K$ for $T_{amb} = 290^\circ K$. Using microstrip matching elements and an ultra low noise pHEMT, NEC 32484A, a low noise amplifier is designed. The noise figure of the amplifier is 0.6dB and gain is 14dB. It is assumed, and shown that appropriate matching circuits whose total physical length will be about $\lambda/2$ can be designed independent of wherever the amplifier is inserted in the feed structure, Demir et al. (5). In case, this amplifier is connected to the output of the 16×16 passive array, noise temperature at the output of the amplifier turns out to be $T = 35.6dB-K$. Using weighted equivalent line length method and the results of section V, the noise temperatures corresponding to different amplifier placement levels are calculated and presented in Table 1. The improvement of noise performance with the added number of amplifiers is clearly seen from this table.

Using Table 1, above equations yield that active antenna has a better G/T than the passive antenna for connection level 7 which is also implied by (18). It can be said that for this structure and the amplifiers concerned, the level where the improvement is just achieved is level 7 where four active elements are required. Further improvements can be achieved using more active elements at the different levels as can be seen from Table 1.

Level	1	2	3	4	5	6	7	8	output
# of amp.	256	128	64	32	16	8	4	2	1
T_{level} (dB-K)	30.7	30.9	31.1	31.7	32.1	32.9	33.6	34.7	35.6

Table 1: Number of amplifiers and the output noise temperature for different levels as connection points of amplifiers.

V. CONCLUSION

Noise analysis of feed structures of antenna arrays are not considered in detail, previously. In this work, noise analysis of low loss transmission lines are given and a new concept named as "noise equivalent line length" is introduced. Through the signification of coherent and incoherent impedance matching concepts, noise sources in a parallel feed antenna array are identified and strength of these sources are expressed in terms of their noise equivalent line lengths. This provided the means to apply the noise equivalent line length as a low noise parallel feed structure design guide. Coherent impedance matching which is important for efficient radiation characteristics does not imply incoherent impedance matching which is important for noise generation of the feed structure. Moreover, noise equivalent line length is also utilized as an active circuit replacement criteria in antenna arrays which showed that G/T performance of a passive antenna array may be improved by inserting active circuits to certain levels in the feed structure.

References

- [1] Y. T. Lo, S. W. Lee and Q.H. Lee, 'Optimization of directivity and signal-to-noise ratio of an arbitrary antenna array', Aug. 1966, Proc. IEEE, vol. 54, pp 1033-1045.
- [2] W. Grabherr and W. Menzel, 'Broadband, low noise active receiving microstrip antenna', in Proc. 24th European Microwave Conf., Sep. 1994, pp 1785-1790.
- [3] R. E. Collin, Antennas and Radiowave Propagation, New York, McGraw Hill Int. Ed., 1985.
- [4] L. I. Parad and R. L. Moynihan, 'Split-Tee power divider', Jan. 1965, IEEE Trans. Microwave Theory Tech., vol. MTT-13, no. 1, pp 91-95.
- [5] S. Demir, C. Toker and A. Hizal, 'Design of an active microstrip array using a microwave circuit simulator', in Proc. IEEE MTT-S Top. Symp. on Tech. for Wireless Appl., Vancouver, Canada, Feb. 1997, pp 103-106.

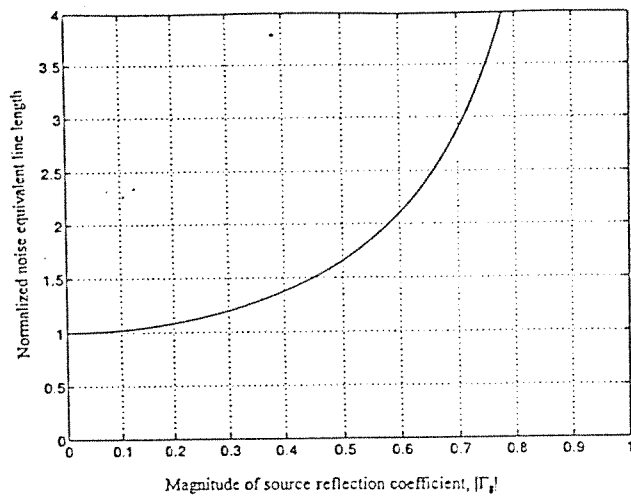


Fig. 1. Variation of noise equivalent line length with the source reflection coefficient, normalized with its physical line length.

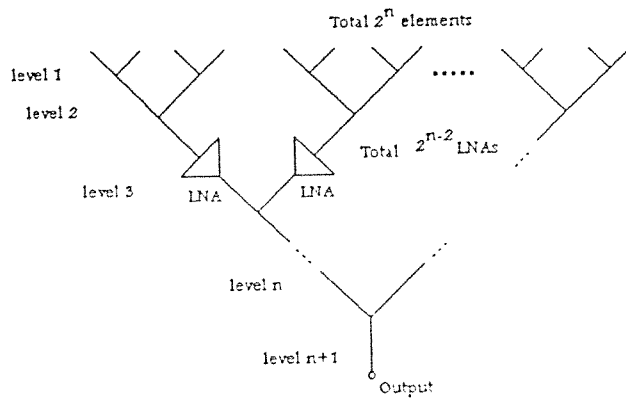


Fig. 2. Schematic representation of a $N=2^n$ element corporate feed structure.

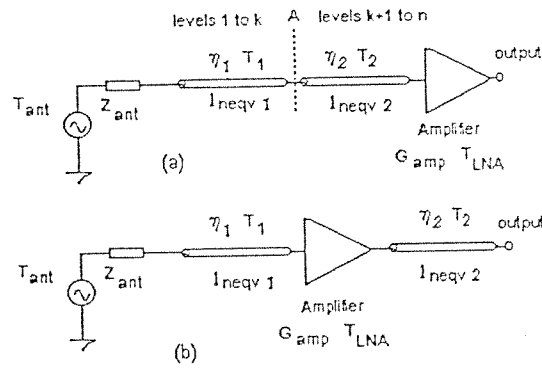


Fig. 3. Active circuit integration with antenna arrays: (a) LNA connected to level $n+1$ (b) LNAs connected to level $k+1$.

USE OF COMPUTATIONALLY EFFICIENT SPATIAL-DOMAIN METHOD OF MOMENTS IN CAD OF MICROSTRIP ANTENNAS

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Abstract

An efficient and rigorous technique, based on the spatial-domain MoM in conjunction with the closed-form Green's functions, is presented for the analysis and the design of printed geometries in a multilayer environment. The derivation of the closed-form Green's functions and the analytical evaluation of the MoM matrix entries have alleviated the most of the computational burden of the spatial-domain MoM. By performing non-uniform meshing, fine adjustment of the dimensions of the analyzed geometry is made possible without increasing the number of unknowns. In addition, with the use of the order-recursive Gaussian elimination in the solution of the MoM matrix equation when the original geometry is modified, the computational efficiency of the spatial-domain MoM is further improved. The assessment of this improvement is demonstrated here in the optimization of the dimensions of an inset-fed patch antenna.

1 Introduction

Since printed geometries in layered media are widely used in the applications of microstrip antennas and monolithic millimeterwave and microwave integrated circuits, efficient and accurate modeling of such structures has gained a lot of interest. There are basically two approaches for the modeling of printed geometries; i) using a simple equivalent model such as transmission line model, cavity model in the analysis of microstrip antennas, and quasi-TEM, quasi-static approaches for the characterization of interconnects, transmission line discontinuities, ii) using a full-wave method like the method of moments, the finite difference time domain method and finite element method. Since the equivalent models are numerically efficient, they might be preferred in the computer-aided-design procedures involving optimization, but they often lack accuracy and are valid for specific geometries. In the case of microstrip antennas, for example, when stubs, parasitic elements or discontinuities are introduced, a full-wave analysis method has to be employed. Therefore, one needs to improve the numerical efficiency of these rigorous techniques without sacrificing the accuracy. After a series of studies, the spatial-domain MoM has become a computationally efficient method which can be used in CAD applications. These studies involve casting the spatial-domain Green's functions into closed forms[1, 2] and analytically evaluating the MoM matrix elements[3]. The analytical evaluation of the integrals are performed by using the Taylor series expansion of the integrands. Consequently, the elimination of the numerical integrals, involved in the traditional spatial-domain MoM, results in a significant improvement in the matrix fill-time.

When the analyzed geometry is large, most of the computation time is dedicated for the solution of the matrix equation. However, in interactive design or optimization, the whole geometry is not changed at each iteration but some part of it is deleted or added, so at each step some few rows and columns are added to or deleted from the previous matrix. For this type of applications, order recursive Gaussian elimination (ORGE) method[4], developed to improve the computational efficiency of solving matrix equations for modified geometries, can be utilized very efficiently. This method provides the solution of the modified matrix with the use of the solution in the previous iteration, hence eliminates the repeated solution of the whole matrix equation. Since the computation time is reduced significantly, the real time assessment of the results, due to small changes in the geometry, becomes possible.

The improvements in the matrix fill-time and in the matrix solution time, make the MoM an efficient numerical method which can be used in conjunction with an optimization procedure. However, when the method is performed with equal subintervals, very small cell sizes, which lead to a large number of unknowns, should be preferred in order to be able to optimize the dimensions of the desired geometry. Hence, instead of uniform meshing, the dimensions of one or two subintervals are made variable, and they are optimized to obtain the desired specifications.

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The numerically efficient procedure presented in this paper is employed to optimize the dimensions of an inset-fed patch antenna and the results are presented in Section 2.

2 Results and Discussions

In this section, an inset-fed patch antenna shown in Fig.1 is analyzed. The permittivity and the thickness of the substrate are 2.2 and 0.7874 mm, respectively and the operation frequency is 10GHz. The dimensions of the patch antenna are 0.9488cm×0.9488cm. This geometry is analyzed by using the Galerkin's MoM and the basis and testing functions are chosen to be the rooftop functions which are triangular functions in the longitudinal direction and uniform in the transverse direction. The input impedance of the antenna which is normalized with respect to the impedance of the feed line is calculated to be 3.39 Ω .

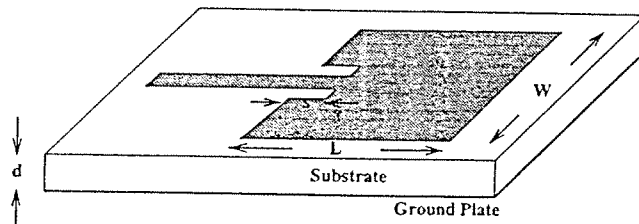


Figure 1: Inset-fed patch antenna configuration

For typical patch widths ($\approx \lambda/2$), the input impedance of the antenna is so high that it is required to feed the antenna with a very narrow transmission line to decrease the mismatch between the antenna and the feed network. To eliminate this problem, the antenna feed point should be shifted towards the center of the patch by inserting notches.

The depth of the notch changes both the real and imaginary parts of the input impedance and this variation is given in Table 1. During the analysis, the unknowns are ordered in such a way that the matrix entries corresponding to the notch region are placed at the end of the MoM matrix, so the effect of the changes in the notch depth can be observed immediately by applying the ORGE method. In obtaining the results, the width of the notch is chosen to be equal to the width of the feed line which is 0.10542cm. The input impedances are

depth of the notch	input impedance of the antenna
0. cm	3.39+j0.0
0.06325 cm	3.36+j0.46
0.12650 cm	2.70+j1.53
0.18975 cm	2.11+j1.94
0.25300 cm	1.75+j2.17

Table 1: Variation of the input impedance with the notch depth

From the table it can be seen that, when the inset-fed configuration is used, it is desired to re-tune the antenna. This tuning can be achieved either by changing the length of the patch or by adding stubs to proper locations. In this study changing the length of the patch is preferred and the results are given in Table 2. To this end, the method is performed by using uniform meshing, at this point, a vertical division with variable width (Section 1 shown in Fig.2) is added in order to be able to tune the length of the patch.

length of the patch	depth of the notch	input impedance of the antenna
0.96600	0.18975 cm	2.81+j0.0
0.97075	0.25300 cm	2.31+j0.0

Table 2: Input impedance of tuned antennas for different notch depths

If it is desired to obtain a specific input impedance level, the width of the Section 2 shown in Fig.3, should also be made variable and the width of the two sections (1 and 2) should be optimized. In this case, the shaded region

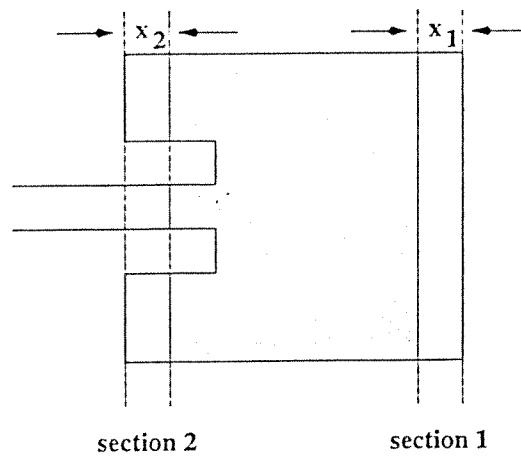


Figure 2: Non-uniform meshing with variable widths x_1 and x_2

shown in Fig.2, is analyzed first and the other sections are added to this region in order to apply the ORGE method efficiently. The width of the two regions are optimized to obtain input impedance of 1.8 and 1.6, the results are given in Table 3.

input impedance of the antenna	length of the patch	depth of the notch
$1.8+j0.0$	0.9755 cm	0.283 cm
$1.6+j0.0$	0.9775 cm	0.291 cm

Table 3: The depth of the notch and the length of the patch for the desired input impedance levels

These results show that the input impedance of the patch antenna can be decreased and adjusted to a desired value by increasing the depth of the notch. However, the depth of the notch can not be chosen arbitrarily large since it degrades the radiation pattern[5].

3 Conclusion

An efficient and accurate numerical modeling of printed structures is presented and employed in the characterization of an inset-fed microstrip antenna. It is observed that the use of the order recursive Gaussian elimination in addition to the closed-form Green's functions has improved the computational efficiency of the spatial-domain MoM. When non-uniform meshing is used, the width of the variable section can be utilized as a parameter of the optimization procedure and the design of the printed geometry with specific properties can be efficiently performed.

References

- [1] Y. L. Chow, J. J. Yang, and D. F. Fang and G. E. Howard, "Closed form spatial Green's function for the thick substrate," *IEEE Trans. Microwave Theory Tech.*, vol. MTT-39, pp. 588-592, Mar. 1991.
- [2] M. I. Aksun, "A robust approach for the derivation of the closed-form Green's functions," *IEEE Trans. Microwave Theory Tech.*, in press.
- [3] L. Alatan, M. I. Aksun, K. Mahadevan, and M. T. Birand, "Analytical evaluation of the MoM matrix elements," *IEEE Trans. Microwave Theory Tech.*, in press.
- [4] K. Naishadham, and P. Misra, "Order recursive Gaussian elimination and efficient CAD of microwave circuits," *Proceedings of IEEE MTT-S International Microwave Symposium*, vol. 3, pp. 1435-1438, Orlando, May 16-20, 1995.
- [5] S. C. Wu, M. G. Alexopoulos, and O. Fordham, "Feeding Structure contribution to radiation by patch antennas with rectangular boundaries," *IEEE Trans. Antennas and Prop.*, vol. APS-40, pp. 1245-1249, Oct. 1992.

PERFORMANCE OF A 10 GHz 32 ELEMENTS RECEIVING PLANAR MICROSTRIP ANTENNA ARRAY

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ABSTRACT

4 by 8 planar receiving arrays are designed for the operating frequency of 10 GHz, having rectangular microstrip patch elements. For a low sidelobe level, amplitude tapering is implemented by using double-section transmission-line transformers. The losses of these feed lines are also used beneficially which leads to a very low noise temperature for the total array. An appreciable amount of the generated thermal noise is radiated to outer space which is further responsible for the low noise temperature. Sensitivity analyses are performed against several manufacturing tolerances. The input return loss, gain, and the pattern of the array are measured and compared with our theoretical predictions. To reduce the stray radiation from feeder lines and to improve the matching of patch radiators, the design is also repeated with narrow microstrip feed lines.

1. INTRODUCTION

Planar microstrip antenna arrays are in current demand due to their low profiles and costs together with their compatibility with electronic circuits. This is especially the case for *receiving* arrays where power requirements are moderate. From the engineering point of view, the design of receiving planar microstrip antenna arrays with a large number of elements is a challenging task. Inaccuracies in the radiating and feeder element models together with manufacturing tolerances can accumulate leading to poor performance of the array at the initial design frequency.

In this work we present the design and the performance of a 32 element microstrip receiving antenna array for the 10 GHz centre frequency. For a satisfactory result, we followed a systematic study in both theoretical and experimental aspects. The details of the procedure and the results are explained in the next sections.

2. DESIGN OF THE ARRAY

2.1 Models

The success of the array design relies predominantly on an accurate modeling of the radiating elements and feeder lines. For the former we use the improved transmission-line model due to Pues and Van de Capelle (Ref. 1) that takes into account the mutual coupling of radiating slots and with accurate slot admittance expressions. The microstrip transmission-lines are modeled using planar waveguide model (Ref. 2). This approach favors the computer-aided design (CAD) procedure in contrast to full-wave treatments which are at the moment not very suitable to CAD. To assess the accuracy of our models we first designed two single patches for 3 GHz and 10 GHz frequencies and compared with our measurements. It is observed that centre frequency can be attained to an accuracy of 20 MHz at 10 GHz. This is repeated for a 4-element linear array that actually forms the sub-array of the full (4x8) array and a very good agreement with measurement is obtained.

2.2 Array

To reduce the side lobe levels a Gaussian amplitude tapering is used along both orthogonal directions. This is achieved using double-section microstrip transformers between the elements. With the advantage of the centre fed topology, the losses of the feed lines are used beneficially, aiding the amplitude tapering and this, in turn, resulted in a high efficiency of the array. The layout of the design is given in Fig. 1. In the implementation RT-Duroid 5880 substrate is used having the parameters: $\epsilon_r = 2.2 \pm 0.015$, $h = 0.7874$ mm, $t = 0.035$ mm, $\tan \delta = 0.0009$.

The thermal noise analysis of the array is performed and resulted in a low noise temperature: $T \approx 26^\circ\text{K}$ at 10 GHz. This is mainly due to the fact that generated noise contributions from lossy transmission-lines and patches are radiated before reaching the load at the output.

3. THEORETICAL SENSITIVITY ANALYSIS

The uncertainties in the models used and manufacturing tolerances need to be systematically accounted for to identify the critical parts in the design. To investigate the sensitivity to patch slot admittances we introduced an additional $\pm 10\%$ slot susceptance but the effect was seen to be marginal. For the geometrical dimensions we introduced $\pm 30\mu\text{m}$ deterministic errors and this only slightly affected the input matching of the antenna. Furthermore, the inclusion of step discontinuity capacitances yielded minor changes and can be neglected in the design. Finally the substrate permittivity is changed within the specifications of the manufacturer ($\epsilon = 2.185 - 2.215$). It is seen that the centre frequency deviates ± 40 MHz around 10 GHz. We further identified that permittivity change primarily affects the patches rather than microstrip feed lines.

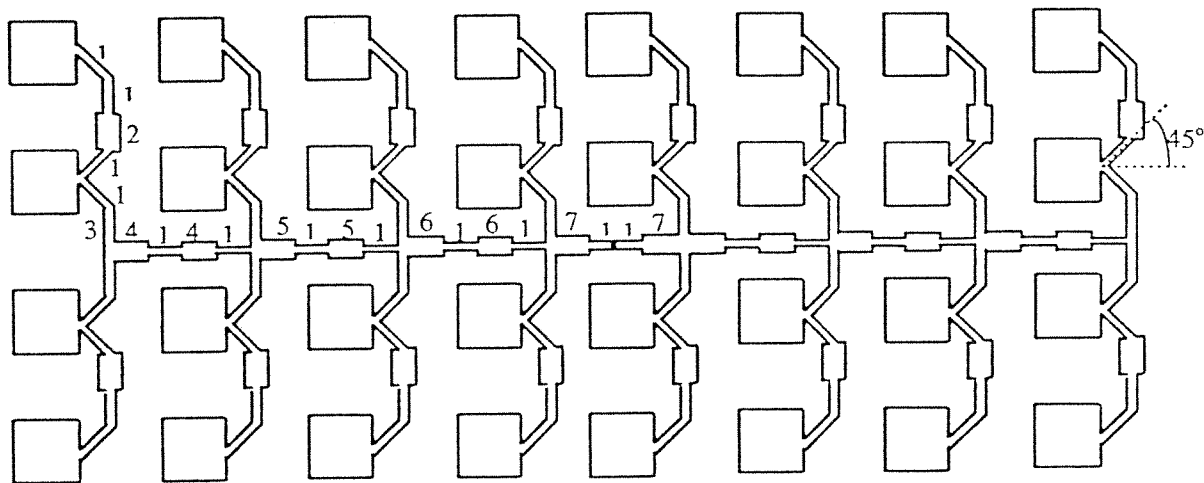


Fig. 1 Schematic layout of the 32 element microstrip array.

4. MEASUREMENTS

Against manufacturing tolerances, three separate arrays with square patch elements (of size 9.488×9.488 mm²) were manufactured having slightly different dimensions. Their measured centre frequencies were slightly shifted (10.14 GHz to 10.2 GHz). However, the exact centre frequency (10 GHz) is obtained easily by means of very thin dielectric coating. This also proves that the array design is sensitive to the permittivity of the substrate and the superstrate. It should be mentioned that this method of tuning must be marginal in frequency as the radiation pattern can deteriorate due to mis-phasing of the elements.

Line No.	Width (μm)	Length (mm)	
1	150.0	5.787	
2	748.0	5.626	Length of Patch: 9.451 mm
3	99.0	5.818	
4	266.0	5.741	Width of Patch: 10 mm
5	224.1	5.755	
6	186.3	5.771	Width of Patch Feeder Line (W_f):
7	551.0	5.666	$\sqrt{2} 150 = 212 \mu\text{m}$

Table I: Geometrical dimensions of the narrow strip array design; see also Fig. 1.

5. NARROW STRIP DESIGN AND MEASUREMENT RESULTS

The 4×8 element array is also realized with rectangular patches and narrow microstrip lines having $150 \mu\text{m}$ width. Geometrical dimensions of the design are given in Table I. The narrow feed lines have higher characteristic impedances ($Z_{cb} \cong 159 \Omega$) and the impedance contrast between a patch radiator ($Z_{patch} = 275 \Omega$) and the feed line is reduced, enabling an easier match. Furthermore, the stray radiation from the feed lines is reduced. Unfortunately, the performance of thin lines are more vulnerable to manufacturing tolerances. The resulting small deviations in the centre frequency can be tuned by dielectric coating, however, as mentioned previously, this can also deteriorate the radiation characteristics of the antenna. In Figs. 2-5 the measured input VSWR, E-plane, H-plane and cross polarization patterns of the narrow strip design are presented. Gain is measured with respect to a *standard* X-Band horn antenna as 20.2 ± 1 dB, which compares well with our theoretically expected value of 21.84 dB.

ACKNOWLEDGMENT

Antennas are manufactured in ASELSAN Military Electronics Industries. The partial support of TUBITAK (Turkish Scientific and Technical Council) is acknowledged.

6. REFERENCES

1. Pues H. & Van de Capelle 1984, Accurate transmission-line model for the rectangular microstrip antenna, IEE Proc. H, 131, 6, 334-339.
2. Collin R. E. 1992, *Foundations for Microwave Engineering*, Second Ed., McGraw Hill, New York.

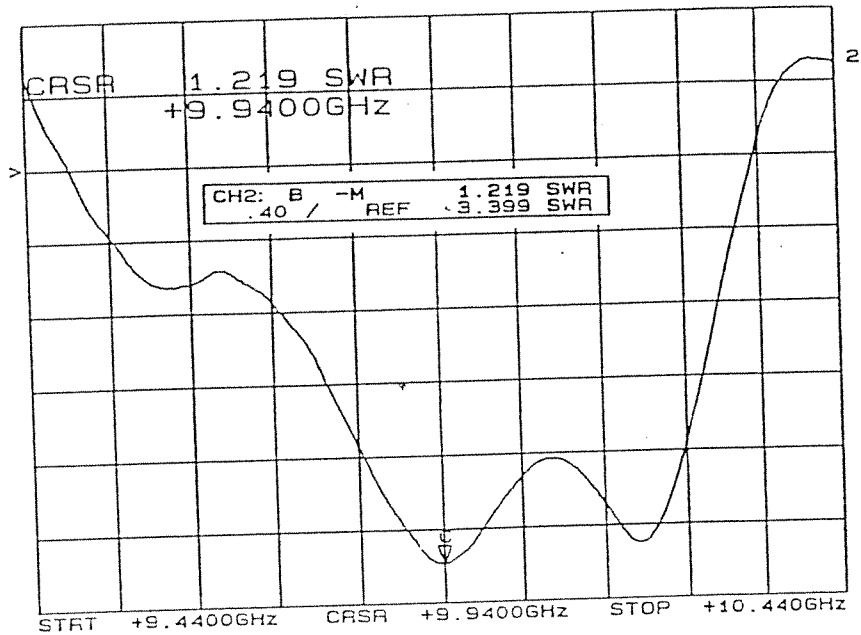


Fig. 2: Input VSWR of the narrow strip array.

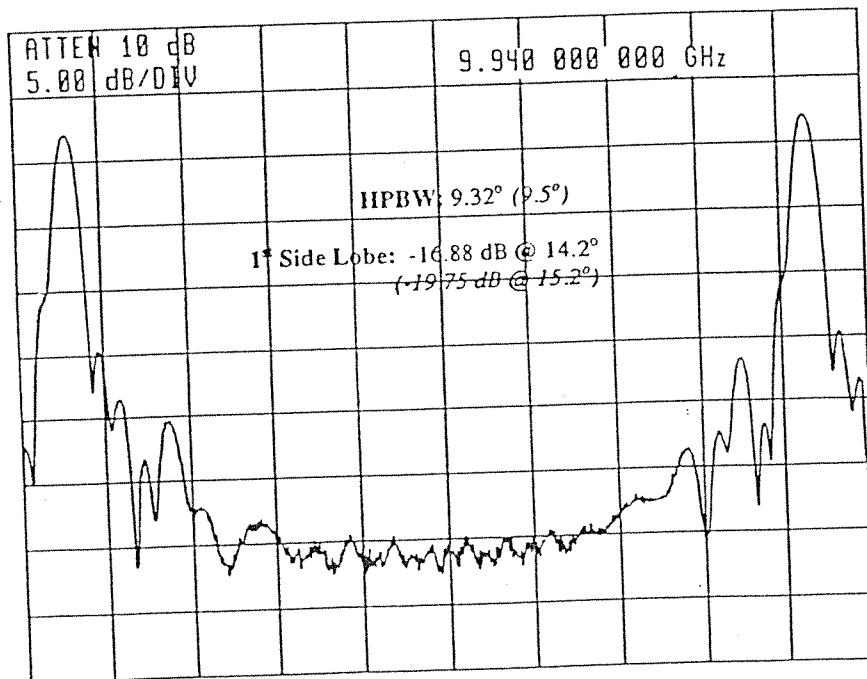


Fig. 3: E-Plane power radiation pattern. The distance between two main peaks corresponds to 360° . Half power beam width and first side lobe level are indicated; theoretical predictions are given in parentheses.

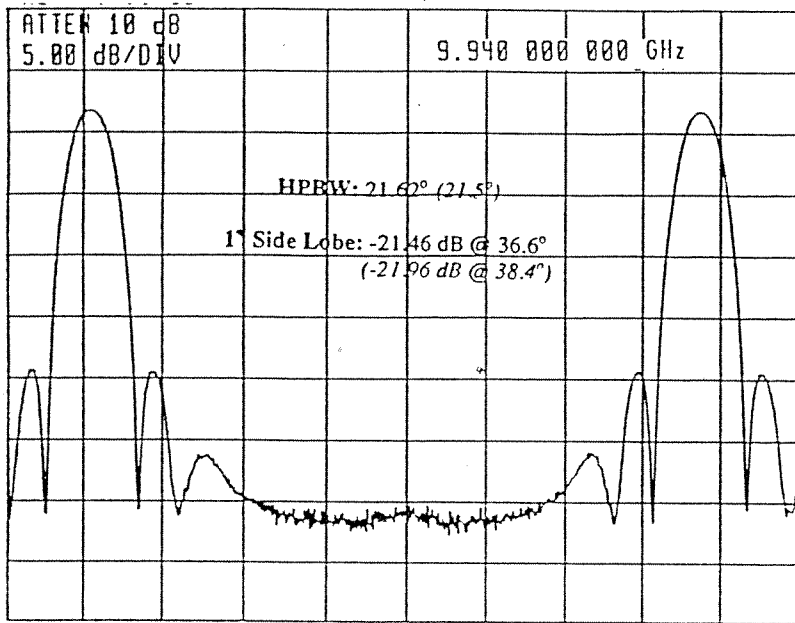


Fig. 4: H-Plane power radiation pattern. The distance between two main peaks corresponds to 360° . Half power beam width and first side lobe level are indicated; theoretical predictions are given in parentheses.

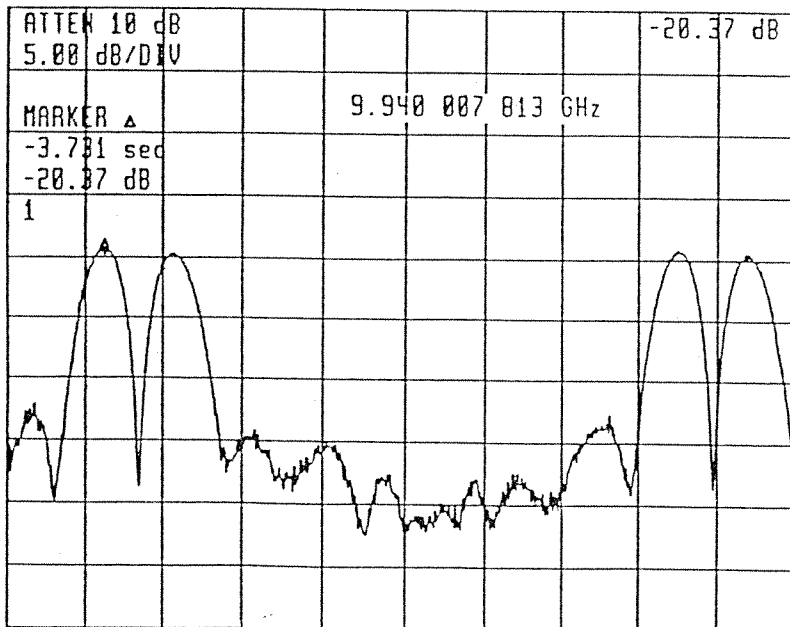


Fig. 5: Cross polarization pattern in the H-plane. The interval corresponding to 360° can be identified from periodic pattern.

Abstract

An efficient and rigorous technique, based on the spatial-domain MoM in conjunction with the closed-form Green's functions, is presented for the analysis and the design of printed geometries in a multilayer environment. The derivation of the closed-form Green's functions and the analytical evaluation of the MoM matrix entries have alleviated the most of the computational burden of the spatial-domain MoM. In addition, with the use of the order recursive Gaussian elimination in the solution of the MoM matrix equation, when the original geometry is modified, the computational efficiency of the spatial-domain MoM is further improved. The assessment of this improvement is demonstrated here, in the characterization of a series-fed microstrip array and an inset-fed microstrip antenna.

1 Introduction

Since printed geometries in layered media are widely used in the applications of microstrip antennas and monolithic millimeterwave and microwave integrated circuits, efficient and accurate modeling of such structures has gained a lot of interest. There are basically two approaches for the modeling of printed geometries; i) using a simple equivalent model such as transmission line model, cavity model in the analysis of microstrip antennas, and quasi-TEM, quasi-static approaches for the characterization of interconnects, transmission line discontinuities, ii) using a full-wave method like the method of moments, the finite difference time domain method and finite element method. Since the equivalent models are numerically efficient, they might be preferred in the computer-aided-design procedures involving optimization, but they often lack accuracy and are valid for specific geometries. In the case of microstrip antennas, for example, when stubs, parasitic elements or discontinuities are introduced, a full-wave analysis method has to be employed. Therefore, one needs to improve the numerical efficiency of these rigorous techniques without sacrificing the accuracy. After a series of studies, the spatial-domain MoM has become a computationally efficient method which can be used in CAD applications. These studies involve casting the spatial-domain Green's functions into closed forms [1, 2] and analytically evaluating the MoM matrix elements [3]. Consequently, the elimination of the numerical integrals, involved in the traditional spatial-domain MoM, results in a significant improvement in the matrix fill-time.

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printed onto this region and the corresponding matrix entries are selected from the stored matrix. As a result, the analysis of any structure printed on this region requires only a solution of a matrix equation whose computation time increases with the dimension of the matrix (usually $O(N^3)$). In interactive design or optimization, the whole geometry is not changed at each iteration but some part of it is deleted or added, so at each step some few rows and columns are added to or deleted from the previous matrix. For this type of applications, order recursive Gaussian elimination method [5], developed to improve the computational efficiency of solving matrix equations for modified geometries, can be utilized very efficiently. This method provides the solution of the modified matrix with the use of the solution in the previous iteration, hence eliminates the repeated solution of the whole matrix equation. Since the computation time is reduced significantly, the real time assessment of the results, due to small changes in the geometry, becomes possible. The numerically efficient procedure presented in this paper is employed to analyze two different geometries and their results are presented in Section 2.

2 Results and Discussions

In this section, two rectangular patch antennas connected in series as shown in Fig. 1a, are analyzed. The permittivity and the thickness of the substrate are 2.55 and 1.59 mm, respectively and the operation frequency is 2.275 GHz. A region of $17.688\text{cm} \times 4.02\text{cm}$, which is chosen to be large enough to incorporate the largest possible circuit that we would like to investigate, is divided into subregions and the corresponding MoM matrix is obtained. Out of this area, a square patch antenna with dimensions $4.02\text{cm} \times 4.02\text{cm}$ is chosen and its normalized (with respect to 50Ω) input impedance is calculated as $6.78 + j0.0$. Since the main goal is to investigate the characteristics of a series-fed array of two elements, the second antenna can easily be printed on the original area for which the corresponding MoM matrix elements have already been calculated. As series-fed antennas are generally used for broadband operation, the length of the transmission line connecting the two patches is adjusted to $\lambda/2(4.623\text{cm})$ by inserting or deleting some cells between the antennas. The current distribution of the geometry shown in Fig. 1a, is given in Fig. 2a and the input impedances of antenna # 1 and # 2 in this configuration are given in Table 1. These results show that the mutual coupling between the antennas shifts the resonant frequencies of the patches. Moreover, the input impedance of the patch # 1 is changed due to the loading of the patch # 2. The coupling and loading effects are observed for different transmission line lengths and the results are also given in Table 1. It is observed that the mutual coupling decreases with increasing the length of the transmission line and the input impedance of the antenna # 2 approaches to that of the resonance condition. On the other hand, when the length of the transmission line is different from $\lambda/2$, antenna # 1 is loaded by different complex loads, consequently the resonance condition of the array can be achieved by readjusting the length of the first antenna. This behavior should be taken into

Table 1: Variation of the input impedances with the length of the transmission line

An other geometry, analyzed by using the method proposed in this paper, is the inset-fed patch antenna shown in Fig.1b. For typical patch widths ($\approx \lambda/2$), the input impedance of the antenna is so high that it is required to feed the antenna with a very narrow transmission line to decrease the mismatch between the antenna and the feed network. To eliminate this problem, the antenna feed point should be shifted towards the center of the patch by inserting notches. The depth of the notch changes both the real and imaginary parts of the input impedance and this variation is given in Table 2. In obtaining the results, the width of the notch is chosen to be equal to the width of the 50Ω feed line which is 0.4467cm. When the

depth of the notch	input impedance of the antenna
0. cm	6.78+j0.0
0.201 cm	1.36+j2.73
0.402 cm	0.42+j1.61

Table 2: Variation of the input impedance with the notch depth

inset-fed configuration is used, it is desired to retune the antenna. This tuning can be achieved either by changing the length of the patch or by adding stubs to proper locations. In this study changing the length of the patch is preferred and the results are given in Table 3. The current distribution corresponding to the antenna with a notch depth of 0.8388cm is shown in Fig.2b. These results show that the input

length of the patch	depth of the notch	input impedance of the antenna
4.132cm	0.4132 cm	5.57+j0.0
4.194cm	0.8388 cm	3.49+j0.0

Table 3: Input impedance of tuned antennas for different notch depths

impedance of the patch antenna can be decreased and adjusted to a desired value by increasing the depth of the notch. However, the depth of the notch can not be chosen arbitrarily large since it degrades the radiation pattern[4].

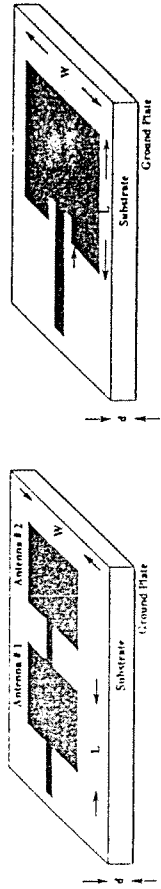


Figure 1: (a) Series-fed antenna array; (b) Inset-fed patch antenna

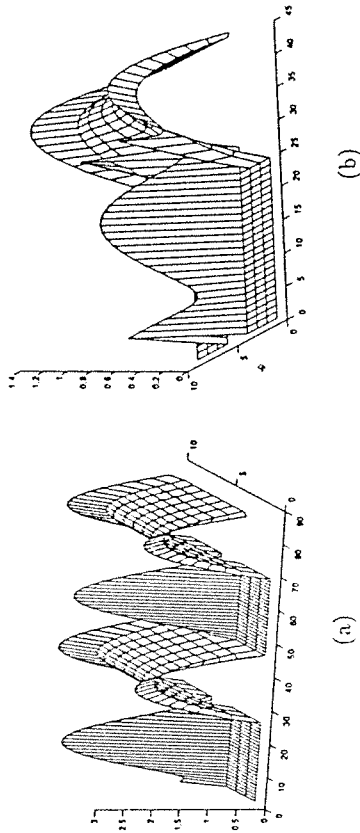


Figure 2: Current distributions for (a) series-fed array; (b) inset-fed patch

References

- [1] Y. L. Chow, J. J. Yang, and D. F. Fang and G. E. Howard, "Closed form spatial Green's function for the thick substrate," *IEEE Trans. Microwave Theory Tech.*, vol. MTT-39, pp. 588-592, Mar. 1991.
- [2] M. I. Aksun, "A robust approach for the derivation of the closed-form Green's functions," *IEEE Trans. Microwave Theory Tech.*, in press.
- [3] L. Alatan, M. I. Aksun, K. Mahadevan, and M. T. Birand, "Analytical evaluation of the MoM matrix elements," *IEEE Trans. Microwave Theory Tech.*, in press.
- [4] S. C. Wu, M. G. Alexopoulos, and O. Fordham, "Feeding Structure contribution to radiation by patch antennas with rectangular boundaries," *IEEE Trans. Antennas and Prop.*, vol. APS-40, pp. 1245-1249, Oct. 1992.
- [5] K. Naishadham, and P. Mista, "Order recursive Gaussian elimination and efficient CAD of microwave circuits," *Proceedings of IEEE MTT-S International Microwave Symposium*, vol. 3, pp. 1435-1438, Orlando, May 16-20, 1995.

RADIATION OF DIPOLES IN MULTILAYERED CYLINDER WITH FERRITE LAYER

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ABSTRACT: Radiation characteristics of infinitesimal dipole in multilayered circular cylindrical structure including gyromagnetic media are investigated. Transversal field equations in spectral domain are obtained for gyromagnetic medium in cylindrical coordinates. These expressions are formed into a set of linear differential equations. The solution at each layer is expressed in terms of state transition matrices. Fields are matched at the interfaces. Far fields are evaluated asymptotically. The effects of changing the bias field, the thickness of the layers, the frequency, and the medium parameters are examined.

INTRODUCTION: In recent years, there is a considerable interest in the interaction of electromagnetic waves with anisotropic media. Scattering from anisotropic circular cylinder has been analyzed in detail by many authors. However, radiation of sources from cylindrically layered structures with anisotropic layers has not been considered in all aspects yet. In [1], fields have been assumed not vary in axial direction, hence nonuniform transmission line expressions have been used. In [2], cylindrical wave functions have been used to analyze radiation from infinite longitudinal slot on an anisotropic dielectric coated conducting cylinder. In both of these papers, sources are infinite in axial direction resulting in no axial variation. The extension to the three dimensions greatly increases the complexity of the problem.

In this paper, far fields of an arbitrarily oriented source in multilayered cylindrical structure with ferrite are found using state-transition matrix approach, [3]. Source can be placed in any layer. All media are assumed linear and homogeneous. Since ferrite as a gyromagnetic material possesses dyadic permeability, more parameters which can affect the far fields, will be introduced. This provides additional degree of freedom to the design of the antenna. $\exp(j\omega t)$ time dependence is assumed and suppressed throughout the formulation.

FORMULATION: Geometry of the problem is shown in Fig.1. The inner layer is a perfect conductor with radius d_0 , the outermost region $\rho > d_N$ is free space. In general, the i 'th layer ($d_{i-1} < \rho < d_i$) is homogeneous gyromagnetic material. Gyromagnetic material can be characterized by dyadic permeability and scalar permittivity.

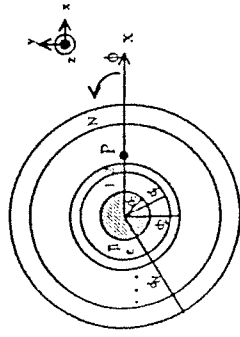


Figure 1. Geometry of the problem

For axially magnetized ferrite, the permeability tensor is given by

$$\vec{\mu} = \mu_0 \begin{bmatrix} 1 + \chi & j\kappa & 0 \\ -j\kappa & 1 + \chi & 0 \\ 0 & 0 & 1 \end{bmatrix}, \quad \chi = \frac{\omega_0 \omega_m}{\omega_0^2 - \omega^2}, \quad \kappa = \frac{\omega \omega_m}{\omega_0^2 - \omega^2}, \quad \omega_m = \gamma \mu_0 M_s, \quad \omega_0 = \gamma B_0, \quad (1)$$

where $\mu_0 M_s$ is the saturation magnetization constant of ferrite, ω is the angular operating frequency, γ is the gyromagnetic ratio, B_0 is the applied magnetic field.

Maxwell's curl equations in gyromagnetic medium are decomposed into longitudinal (ρ) and transversal (transverse to ρ) components. In dielectric coating case, fields can be expressed as a superposition of TE and TM waves. However, in anisotropic coating, field components are coupled. The cylindrical transformation given by

$$\begin{aligned} \vec{E}(n, k_z) &= \frac{1}{2\pi} \int_0^{2\pi} d\phi \int dz \vec{E}(\rho, \phi, z) e^{-j\phi} e^{-jk_z z}, \\ \vec{E}(\rho, \phi, z) &= \sum_{n=-\infty}^{\infty} e^{jn\phi} \frac{1}{2\pi} \int_{-\infty}^{\infty} \vec{E}(n, k_z) e^{jk_z z} dk_z, \end{aligned} \quad (2)$$

is used to transform transversal field components. Transformed field components are formed into a set of linear differential equations

$$\frac{d}{d\rho} \psi(\rho) = \Lambda(\rho) \psi(\rho) + S, \quad (3)$$

where $\psi = [\vec{E}_z \quad \vec{E}_\phi \quad \vec{H}_z \quad \vec{H}_\phi]^T$ and S is 4×1 source vector. Entries of 4×4 matrix Λ depend on the variable ρ . The general solution of this differential equation set can be expressed as, [3],

$$\psi(\rho) = \Phi(\rho, \rho_0) \psi(\rho_0) + \int_{\rho_0}^{\rho} \Phi(\rho, \lambda) S(\lambda) d\lambda, \quad (4)$$

where $\Phi(\rho, \rho_0)$ is the state transition matrix of the source free system. State transition matrix relates the tangential electric and magnetic fields at one interface to the other. Due to the ρ dependence, the state transition matrices are evaluated numerically. Fields in the free space are expressed as a series of Hankel functions of the second kind. Using the boundary conditions at the conductor, and at the interfaces between the layers, fields in free space are found. The inverse Fourier transforms can be evaluated using the Method of Steepest Descents to find far fields, asymptotically.

NUMERICAL RESULTS: The radiation patterns of an infinitesimal dipole in a multilayered cylindrical structure are presented in this section. In the given examples one of the layer is magnetized ferrite and the others are isotropic dielectrics. Radiation patterns for both axially and circumferentially magnetized ferrite layer have been obtained. In Fig. 2, the radiation patterns of a half-wave narrow axial slot on a conducting cylinder coated by circumferentially magnetized ferrite are shown. It is observed that shape of the pattern changes and directivity increases when cylinder is coated by ferrite. Also, main beam direction changes with the strength of the magnetization field.

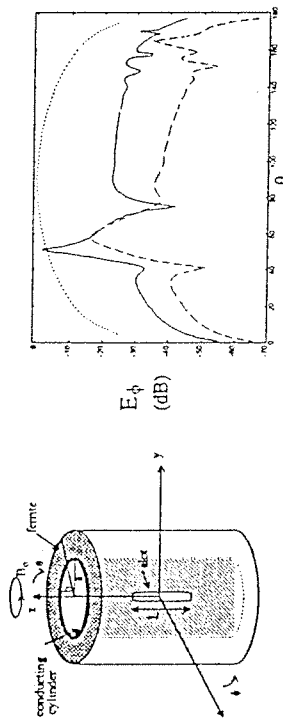


Figure 2. Geometry and radiation patterns of slot on ferrite coated conducting cylinder, $f=18\text{GHz}$, $\mu_r M_r=0.3T$, $d_1=d_2=1.2\text{mm}$, $\epsilon_r=14$, solid line: $\omega_p/\omega=0.75$, dashed line: $\omega_p/\omega=0.78$, dotted line: without ferrite

In Fig. 3 and Fig. 4 the radiation patterns of infinitesimal dipole in the two layer cylindrical structure are shown. First layer is a magnetized ferrite and the second layer is an isotropic dielectric. The dipole is assumed to be placed at the point where $\rho=d_1$ and $\phi=0$ at the interface of ferrite and dielectric. The orientation of the dipole can be \hat{x} , \hat{y} , \hat{z} direction. In Fig. 3, ferrite is magnetized circumferentially, whereas ferrite is magnetized axially in Fig. 4. In circumferentially magnetized case, there is no cross polarized component. However there exists significant cross polarized component in axially magnetized case.

Radiation characteristics as a function of other parameters, such as thickness of layers, saturation magnetization value of ferrite, dielectric constants, have also been examined and will be presented in the symposium.

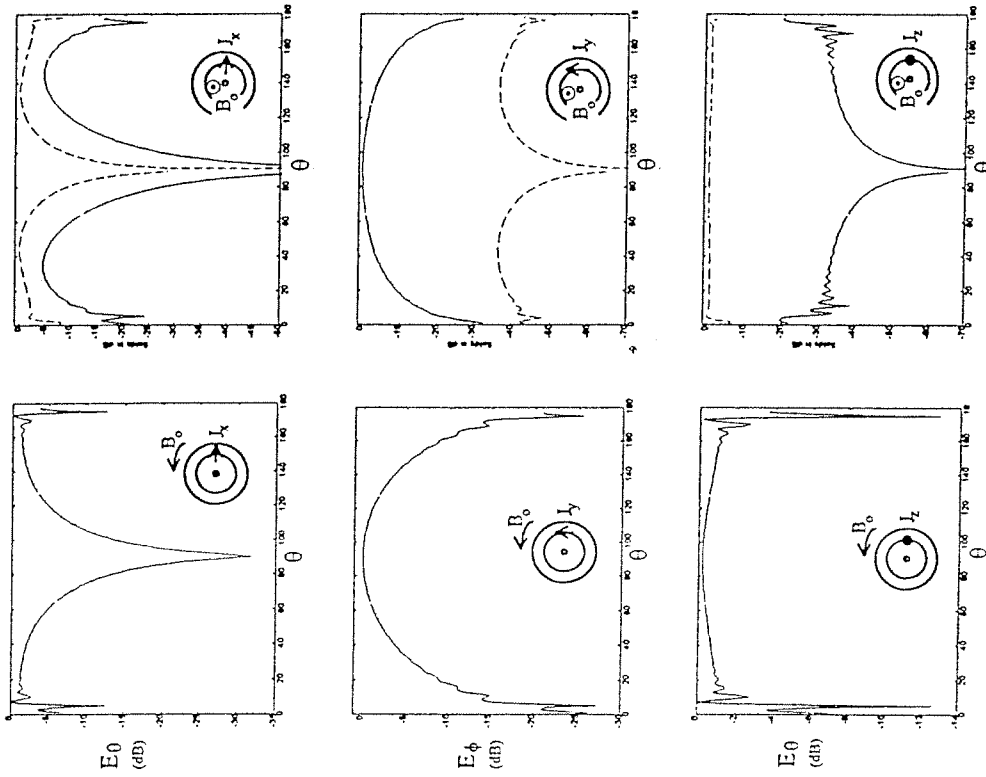


Fig. 3. Far fields for circumferentially mag. ferrite $f=20\text{GHz}$, $\mu_r M_r=0.3T$, $d_1=d_2=1.2\text{mm}$, $d_1=d_2=1.2\text{mm}$, $\epsilon_r=14$, $\epsilon_d=12$, $\omega_p/\omega=0.07$ (in Fig. 4. solid line: E_θ component, dashed line: E_ϕ component)

REFERENCES:

- [1] J.R. Wait, 'Transverse propagation of waveguide modes in a cylindrically stratified magnetoplasma', *Electromagnetic Waves in Stratified Media*, p.529-544, Pergamon Press.
- [2] X.B. Wu and W. Ren, 'Axial slot antenna on an anisotropic dielectric-coated circular cylinder', *IEE Proc., Microwaves, Antennas, Propagation*, vol.141, no.6, p.527-530, Dec. 1994.
- [3] P.M. Deteruso, R.J. Roy and C.M. Close, *State Variables for Engineers*, Ch.6, John Wiley, 1967.

AN IMPROVED DESIGN OF 2-18 GHz VIVALDI ANTENNA AND A NEW DESIGN OF 6-18 GHz ANTENNA ARRAY

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The recent researches on microwave and millimeter wave technologies demand antennas those are compact, low cost, reproducible, planar and can be easily integrated with front end circuits on the same substrate. Vivaldi antenna is a member of the class of aperiodic continuously scaled traveling wave antenna structures and theoretically has an infinite instantaneous frequency bandwidth (1:20). It has a significant gain, low side lobe level, and symmetric end fire beam [1]. It is a planar, compact, low profile, low cost antenna. It is an exponentially tapered slotline antenna. The slotline is double sided and balanced [2]. At the input of the antenna a balun exists for transition from microstrip to balanced slotline.

Vivaldi antenna belongs to the class of slow traveling wave antenna and for that kind of structures radiation occurs only at nonuniformities, curvatures, and discontinuities. Discontinuities, can be distributed or discrete, interrupt a bound wave on the surface of the antenna and cause radiation. For Vivaldi antenna the radiation takes place when the slot width equals to the half of the free space wavelength of the radiation frequency. At that point phase velocity of the traveling wave is equal to the free space wave velocity. Vivaldi antenna is in principal a frequency independent antenna, for it has a scaled geometry, with frequency. However, since it should be truncated physically at a certain point, a lower cut off frequency for the antenna exists.

The feed structure of the antenna consists of an unbalanced microstrip line, then followed by a suspended microstrip tapered balun, and ends with an equal width balanced line. All of them have a 50 Ohm characteristic impedance. Then double sided slotline radiating section follows (Figure1).

The design is the continuation of an earlier work [3] on a single Vivaldi antenna operating in 1-18 GHz frequency band. In this work, first a single antenna which operates on 2-18 GHz frequency band is re-designed. The antenna has a double sided slotline radiating part fed by a microstripline. There is a balun between the microstripline and double sided slotline. The balun has been also re-designed using a finite element program [7,8]. Afterwards the geometric structure is printed on a RT/duroid substrate. The input return loss (Figure2) and radiation characteristics of the antenna has been measured. Secondly a Vivaldi antenna that operates on 6-18 GHz frequency band has been designed using a similar feeding and radiating structure but this time the length of the balun has been decreased. The designed antenna is manufactured on a RT/duroid substrate. The return loss of the antenna is measured (Figure 3). It was observed that the results were not as good as expected. So, some experiments on the structure have been done and it is redesigned having a longer radiating part. The new design is realized in the form of an array by rearranging eight of these elements in a circular geometry. The array is manufactured on a single RT/duroid substrate. The input return loss of the of

the elements of the array has been measured and it is seen that it has better return loss characteristics than the previously designed single 6-18 GHz Vivaldi antenna (Figure 4). Also the radiation pattern and gain of some of the elements of the array have been measured (Figure 5,6,7).

The results of return loss and radiation characteristics measurements are found satisfactory. The designed and manufactured circular array can be used in monopulse amplitude or phase comparison DF systems. Another possible application is pattern configurable antenna. The idea is that a number of the elements of the array are used at a time to form a beam which can be steered by changing the elements of the beam forming array by means of electronic switching. The array design should include the antenna element spacings (antennas and radius) as a design parameter.

References

- [1] Gibson, P.J., " The Vivaldi Aerial ".
9 th European Microwave Conference Proceedings, 1979, pp.101-105.
- [2] Gazit, E., " Improved Design of The Vivaldi Antenna".
IEE Proceedings Vol.-135, 1988 pp.89-92.
- [3] Günalp N., Birant T., Hızal A., "Design of Tapered Slot Antennas with Broadband Feeds".
Contribution by the Turkish COST-223 Working Group METU (Turkey):
Cost 223 Final Report.
- [4] Birant T., et al., "Antennas in 1990's: Active Antenna Array for Future Satellite and Terrestrial Communication".
Project Final Report for TUBITAK within the Frame Work of the
COST-223 Project. January 1993 Ankara.
- [5] Gvozdev, V.I., "Use of The Unbalanced Slotted Line in SHF Microcircuits".
Radio Eng. & Electron Phys., Vol.-27, 1982, pp. 42-47.
- [6] Schiek, B., Köhler, J., " An Improved Microstrip-to-Microslot Transition."
IEEE Trans. Vol. MTT-24, 1976, pp. 231-233.
- [7] Kuzuoğlu, M., " A New Finite Element Method for Electromagnetic Boundary Value Problems in Combined Exterior and Interior Regions".
Ph. D. Thesis in Elec. and Electron. Eng. METU., 1986.
- [8] Akdeniz, T. " Analysis of Microstrip and Microstrip-like Structures by the Finite Element Method ".
A Master's Thesis in Elec. and Electron. Eng. METU., 1989.

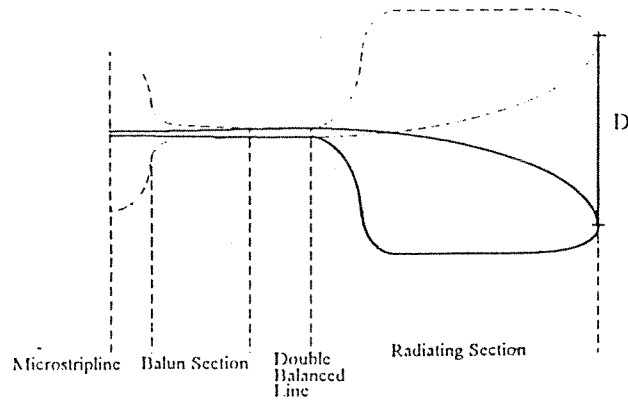


Figure 1 Improved Vivaldi Antenna

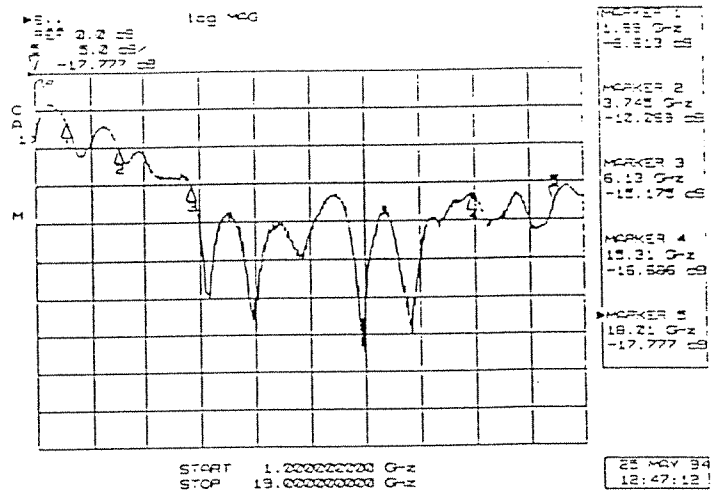


Figure 2 Return Loss Characteristics of 2-18 GHz Vivaldi Antenna

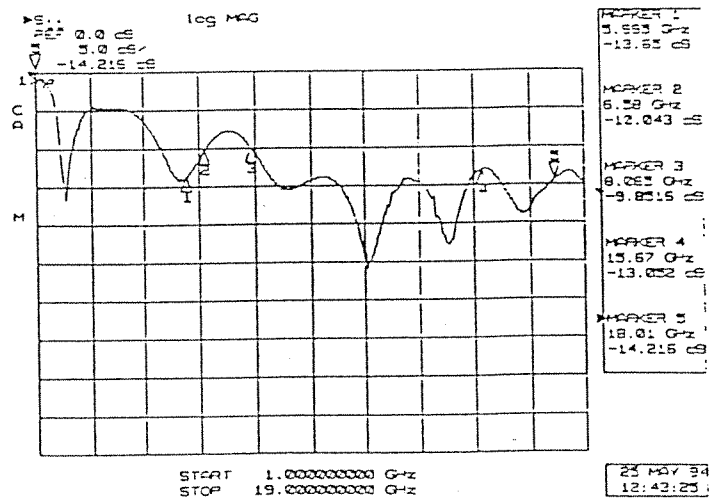


Figure 3 Return Loss Characteristics of 6-18 GHz Vivaldi Antenna

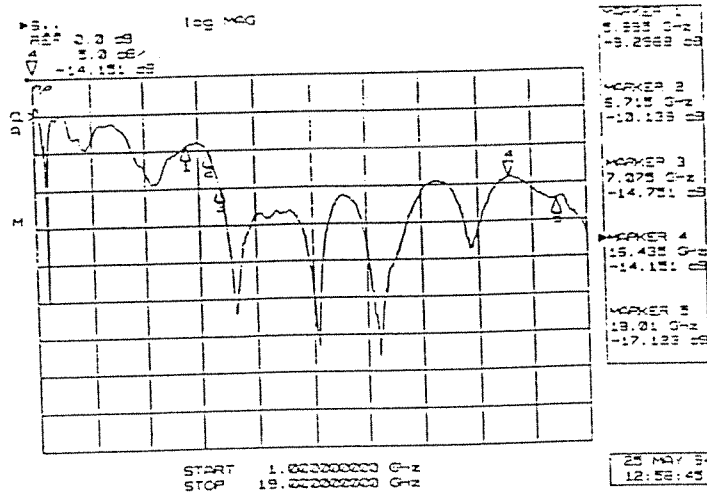


Figure 4 Return Loss Characteristics of an Array Element

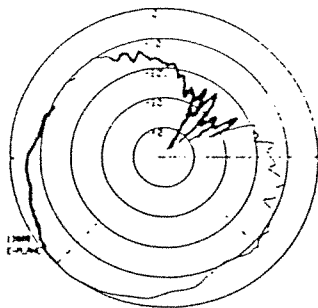


Figure 5 Radiation Pattern of an Array Element at 13 GHz.

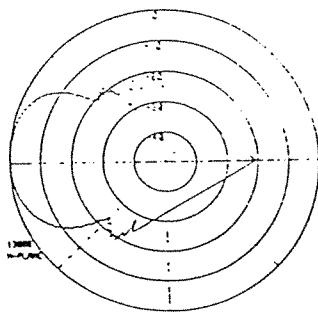


Figure 6 Radiation Pattern of an Array Element at 13 GHz.

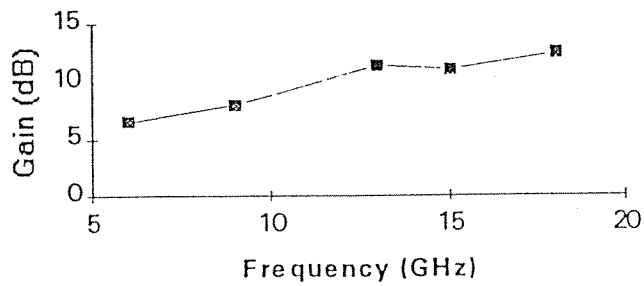


Figure 7 Gain Characteristics of an Array Element

MUTUAL COUPLING EFFECTS of FINITE RECTANGULAR PHASED ARRAYS

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Abstract — A rigorous integral equation formulation for the analysis of a phased array of flange-mounted waveguide apertures is given for a finite number of elements and nonuniform spacings. The resulting set of integral equations is reduced to a matrix equation called the coupling matrix which relates the coefficients of all the modes in all the waveguides to one another. The solution then yields the dominant mode reflection coefficient, coefficients of scattered modes and hence the field in each waveguide. The block-Toeplitz symmetry property for the uniformly spaced linear and rectangular grid arrays is utilized in the solution of the system of equations.

INTRODUCTION

Flange mounted rectangular waveguides are the basic radiating elements of many microwave antennas. They find many applications in aeronautics, phased array systems as well as in diathermy and hyperthermia. They have been investigated both as single radiators and as coupled radiators.

The radiating aperture of the waveguide establishes a discontinuity for the incident dominant waveguide mode TE_{10} . The reflection coefficient of the dominant mode due to the aperture discontinuity depends upon the aperture admittance, which changes with the change in dimensions of the radiating aperture. The dominant mode is also coupled to higher order modes by this discontinuity, which have quite an important effect on the aperture field distribution especially near the edges. Coefficients of these higher order modes are also directly related to the aperture dimensions.

In phased arrays with a large number of elements, almost all of the elements have nearly the same active reflection coefficient. But the reflection coefficients of the elements near the edges are quite different from those of central elements. Infinite array approxima-

tions are valid for the large arrays. However, this approximation becomes less accurate for the smaller arrays. This is because of the mutual coupling characteristics of the elements. In a practical finite sized array, aperture admittance and hence the active reflection coefficient of elements strongly depend on the element location.

In this paper mutual coupling and evanescent mode effects on the performance of the flange-mounted finite rectangular waveguide arrays is presented.

FORMULATION

Consider the $M \times N$ element array of apertures backed by rectangular waveguides flange-mounted on an infinite, conducting ground plane. For the sake of simplicity the elements are spaced in a rectangular grid as shown in Figure 1 and each waveguide is assumed to be fed by the dominant TE_{10} mode phased accordingly with the desired scan angle.

The problem is divided into $M \times N + 1$ regions using the equivalence principle, that is the apertures are covered by a perfect electric conductor. Appropriate dyadic Green's functions are used to represent the fields in both waveguide and half-space regions. Then the solution is achieved by expanding the electric field at the apertures in terms of a linear combination of waveguide modes weighted by unknown coefficients. The continuity of transverse component of the magnetic field is then enforced. After inner multiplying the resulting equation with suitable testing functions (again waveguide mode distributions - essentially Galerkin's Method) a set of algebraic equations are obtained, which are reduced to a matrix equation. The matrix is called coupling matrix and it relates the coefficients of all the modes in all the waveguides to one another. The solution then yields the reflection coefficient for the dominant mode and through it the

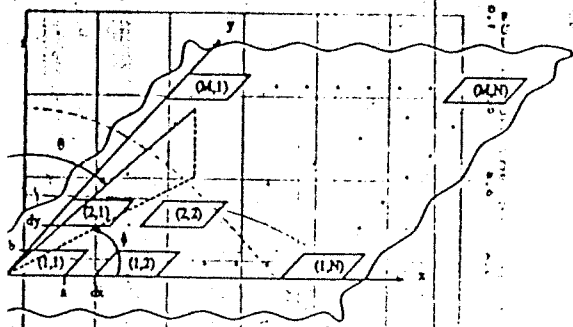


Figure 1: $M \times N$ rectangular grid phased array.

ture admittance and the coefficients of the higher modes excited by the aperture discontinuity of y elements. The detailed derivation of this analysis is given in [1] and [2].

(2.8) COMPUTED RESULTS

In an earlier variational study [3] and in [2] the use of a dominant mode as the aperture distribution has been found to be adequate for predicting the input admittance of a single radiating waveguide. However, this is not the case for the aperture field distribution.

A flange-mounted single rectangular waveguide with $a = 0.7\lambda$ and $b = 2.25$ is solved using different numbers of expansions for the electric field at the aperture to examine the effect of evanescent modes on the equivalent magnetic current $\vec{M} = 2\vec{E} \times \hat{z}$ over the aperture. The coefficients of the 1 (TE_{10}) and 6 ($TE_{10}, TE_{20}, TE_{30}, TE_{40}, TE_{50}, TE_{60}$; TM_{12}, TM_{32}) mode solutions are used to obtain \vec{M} over the aperture as shown in Figures 2 and 3 respectively. It is seen that the magnitude of \vec{M} is particularly near the edges of the waveguide is strongly dependent on the number of the expansion functions in the solution. This is due to the edge singularity having a behaviour of $r^{-1/2}$ where r is the distance from the edge of the aperture. It is expected that the radiation pattern of flange mounted waveguide should be affected by higher order modes excited by the aperture discontinuity.

The scattered mode coefficients (mode voltages) of the flange termination of the same geometry are also calculated and compared with those obtained by Baulk et al. [4] and McPhie et al. [5] in Table 1 where agreement is very good. As expected, the dominant TE_{10} reflected mode amplitude dominates the results. All the quantities in Table 1 are calculated using 15 modes of expansion for the electric field in the waveguide. The same geometry is solved using

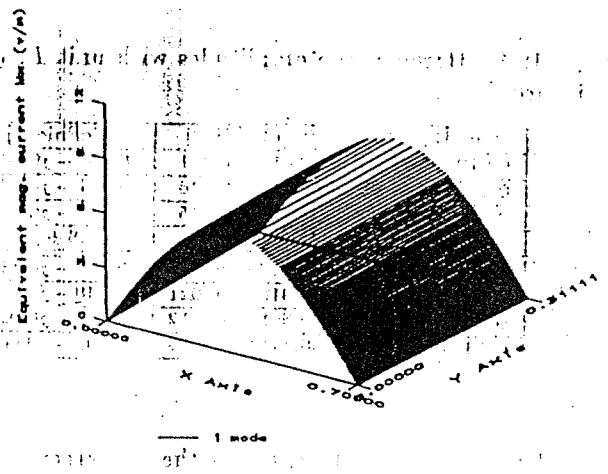


Figure 2: Aperture field distribution of flange mounted rectangular waveguide with 1 mode of expansion.

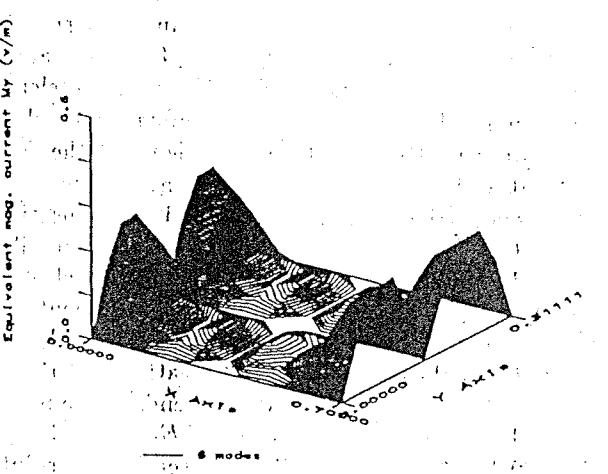
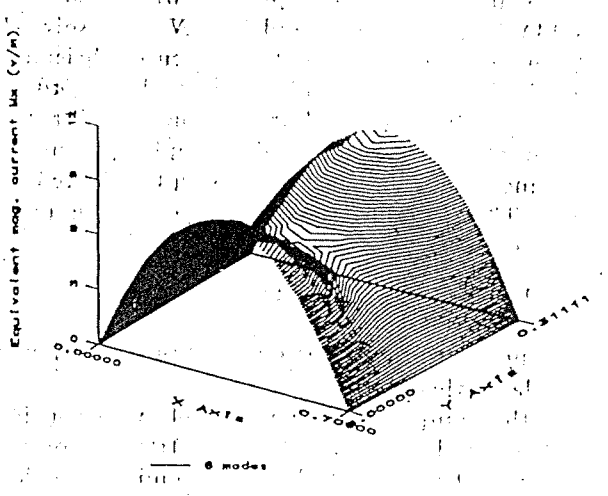


Figure 3: Aperture field distribution of flange mounted rectangular waveguide with 6 modes of expansion.

Table 1: Scattered mode amplitudes with unit TE_{10} incidence

Mode	Our Results	Baudrand [4]	McPhie [5]
E_{10}	$0.079 - j0.237$	$0.066 - j0.271$	$0.063 - j0.240$
E_{30}	$0.026 - j0.049$	$0.022 - j0.046$	$0.027 - j0.049$
E_{50}	$0.018 - j0.017$	$0.012 - j0.015$	$0.015 - j0.018$
E_{42}	$0.035 - j0.011$	$0.031 - j0.011$	$-0.033 + j0.032$
M_{12}	$0.194 - j0.108$	$-0.182 + j0.134$	$0.156 - j0.112$
M_{32}	$0.008 - j0.021$	$-0.010 + j0.021$	$0.048 - j0.020$
M_{52}	$0.007 - j0.011$	$-0.008 + j0.012$	$0.052 - j0.026$
M_{14}	$0.135 - j0.063$	$-0.128 + j0.069$	$0.101 - j0.063$

nodes of expansion to examine the convergence of the formulation. TE_{10} mode amplitude is found as $0.078 - j0.239$ which differs from the 15 modes solution by only about 0.6%.

The array given in Figure 1 with $a = dx = 0.714\lambda$, $b = dy = 0.254\lambda$ and $M = N = 5$ is solved for the dominant mode element reflection coefficients for both the E-plane and H-plane scans. The coordinate system and variables used are also shown in Figure 1. Each waveguide is fed by a unit amplitude dominant TE_{10} mode phased accordingly with the desired scan angle. The (m, n) 'th element of the array is phased to the scan angle (θ, ϕ) by

$$e^{j(n-1)dx \sin \theta \cos \phi} e^{jk(m-1)dy \sin \theta \cos \phi}$$

scanning is done in the H-plane when $\theta = 0$ or π and E-plane when $\theta = \pm \frac{\pi}{2}$.

In the computations 6 modes of expansion functions are used to represent the electric field over the apertures. The magnitude of the dominant mode reflection coefficients of the center element (element 3,3) and corner elements (elements 1,1 and 5,5) are given in Figures 4 and 5 as a function of E-plane and H-plane scan angle, respectively. The effect of element excitation and hence the mutual coupling is seen clearly by comparing the reflection coefficients of the center element and corner elements both in E-plane and H-plane scans given in Figures 4 and 5, respectively. Thus, the radiation pattern of the array also will be affected by the mutual coupling of the array elements.

The tangential electric field in the element apertures is determined for 0° scan angle for the purpose of calculating the radiation pattern. The accuracy of this representation will depend on the number of modes used. Again 1 mode (TE_{10}) and 6 modes ($E_{10,12,30,32}; TM_{12,32}$) are used for the solution of the electric field in the apertures in which the mutual coupling between all the modes in all the waveguides is taken into account to examine the effect of higher order modes excited by the aperture discontinu-

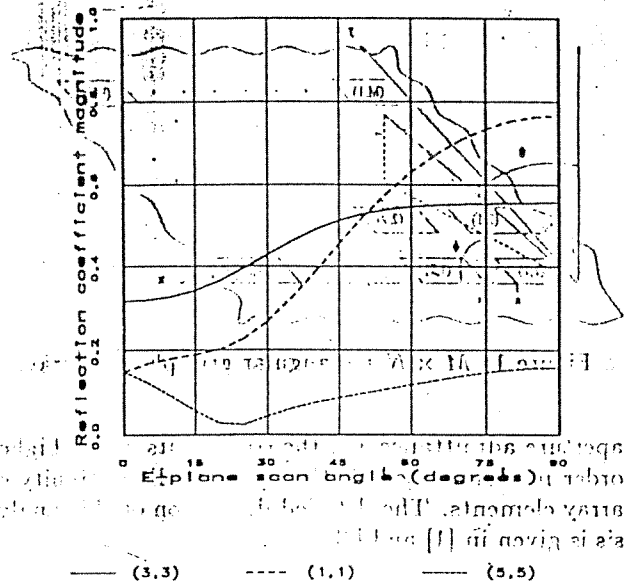


Figure 4: Dominant mode reflection coefficients of elements (1,1), (3,3) and (5,5) of the 5×5 array as a function of E-plane scan angle.

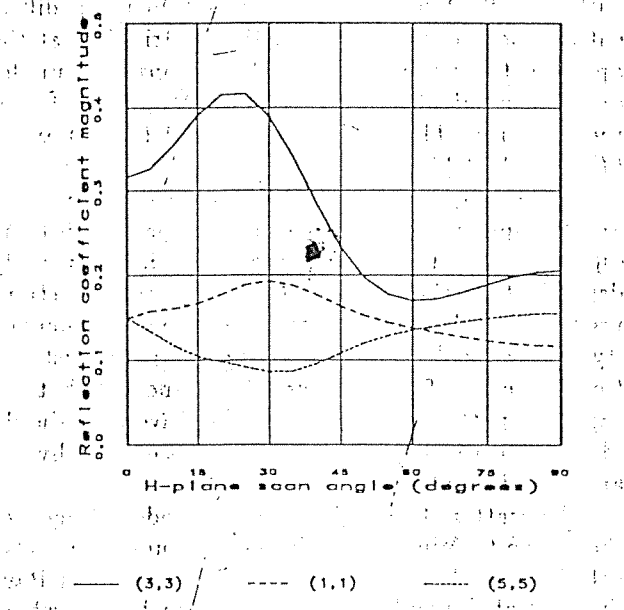


Figure 5: Dominant mode reflection coefficients of elements (1,1), (3,3) and (5,5) of the 5×5 array as a function of H-plane scan angle.

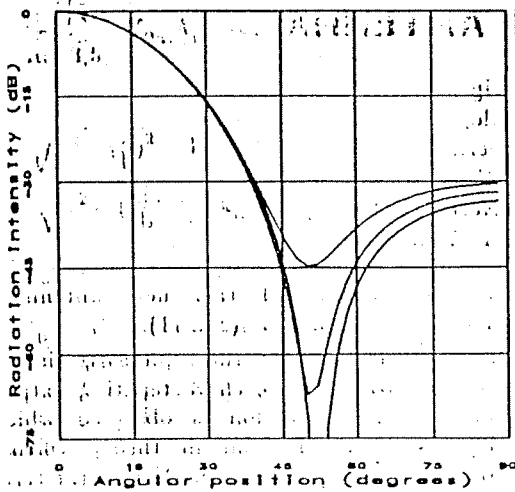


Figure 6: Radiation intensity as a function of angular position θ , $\phi = 90^\circ$ where solid : 1 mode without mutual coupling, dotted : 1 mode and dashed : 6 modes solutions.

to the radiation pattern of the array. In addition to these two types of electric field distribution, dominant mode (TE_{10}) electric field distribution is assumed to exist over the apertures ignoring the mutual coupling between the array elements to show the effect of mutual coupling on the radiation pattern.

Far field radiation intensity $|H_\theta(\theta, \phi)|^2 + |H_\phi(\theta, \phi)|^2$ is calculated for the above three types of aperture field distributions as a function of angular position θ for $\phi = \frac{\pi}{2}$ and presented in Figure 6. In this figure, the solid and dotted lines are obtained using dominant mode aperture field distribution without and with the effect of mutual coupling, respectively, while the dashed line is obtained using 6 modes of excitation for each aperture field distribution. As shown in Figure 6 a notch is seen when mutual coupling between the array elements is ignored while the other two solutions have no such behaviour. This is because of mutual coupling effects. The effect of evanescent modes is also important as shown in Figure 6 where a mode solution (dashed line) is about 20 dB below the mode solution (dotted line) around $\theta = 52^\circ$. This difference is too large to ignore.

CONCLUSION

The most expensive part of the solution is the calculation of the matrix elements via numerical integration. However, if an equally spaced linear or a rectangular grid array is of interest the resulting coupling matrix is block-Toeplitz and each Toeplitz block has also some symmetry. The CPU time and the storage area

required for the solution of the problem are highly reduced when these symmetry properties are used. No matrix inversion is carried out to reduce the numerical errors incurred in the calculations for rectangular grid arrays but a recursive algorithm is used to solve the block-Toeplitz system.

Another important feature of the formulation is that the coupling matrix is independent of excitation of array elements, so it is calculated and inverted only once for the specified geometry of the array. Then the response of the array for any kind of excitation is found using the same matrix.

REFERENCES

- [1] H. Yavuz and O. M. Büyükdura, 'Rigorous analysis of finite rectangular arrays with simultaneous integral equations', Proc. of IEEE APS international symposium, 3, 1262, Ann Arbor MI, (June, 1993).
- [2] H. Yavuz 'Analysis of flange-mounted finite rectangular waveguide arrays', Ph.D Dissertation, Middle East Technical University, December 1993.
- [3] M. H. Cohen et al., 'The aperture admittance of a rectangular waveguide radiating into half-space', Antenna Lab., Ohio State Univ. Res. Foundations, Rep. No. 339-22, Contract USAF W33-038-ac-21114 (November, 1951).
- [4] H. Baudrand et al., 'Study of radiating properties of open-ended rectangular waveguides', IEEE Trans. AP, 36, 1071 (August, 1988).
- [5] R. H. MacPhie and A. I. Zaghoul, 'Radiation from a rectangular waveguide with infinite flange-exact solution by the correlation matrix method', IEEE Trans. AP, 28, 497 (July, 1980).

MMIC TEKNOLOJİSİ KULLANILARAK TASARIMLANMIŞ VOLTAJ KONTROLLÜ OSİLATÖR

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ÖZET: Bir mikrodalga voltaj kontrollü osilatör (VCO) devresi, devre elemanlarının tek bir taban üzerine inşa edilerek gerçekleştirildiği monolitik mikrodalga entegre devre teknolojisi (MMIC) kullanılarak tasarlanmış ve GEC Marconi firmasının F20 tasarım kurallarına uygun olarak bu firmaya imal ettirilmiştir ///. Kontrol voltajı 1V ile -8V arasında değişen VCO, 9.295GHz-11.028GHz bandında osilasyon göstermektedir.

I.GİRİŞ

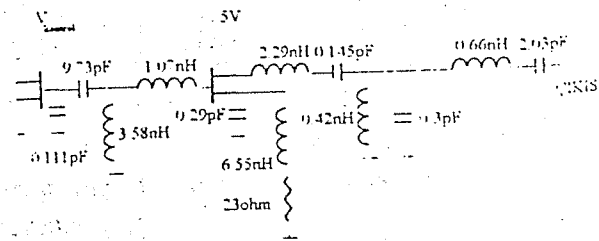
MMIC teknolojisi hızla gelişen bir teknoloji olup, askeri ve ticari alanlardaki mikrodalga sistemlerde önemli ölçüde kullanılmaya başlanmıştır. Bu teknolojide GaAs MESFET'ler ve diğer devre elemanları tek bir GaAs taban üzerinde üretilmektedir. Düşük fiyatlarla çok sayıda üretimlerin yapılabilmesi, yüksek performans, tekrar edilebilir üretim, küçük hacim ve güvenilirlik gibi özellikler MMIC devrelerine büyük avantajlar sağlamaktadır. Bu avantajlar yüzünden çeşitli şoklara, ısı değişimlerine ve sert sarsıntılara dayanabilen MMIC devreleri, uzay bilimleri ve askeri teknolojilerde pek çok uygulama alanı bulabilmektedir //2/.

Bu çalışma bir MMIC voltaj kontrollü osilatörün tasarımını anlatmakta, simülasyon sonuçları ile ölçüm sonuçlarını karşılaştırmaktadır. Osilatör tasarımı negatif direnç teorisine dayanmakta olup, aktif eleman olarak GaAs MESFET transistör seçilmiştir. Tasarımdaki optimizasyon ve analizlerde doğrusal olmayan simülasyon

sonuçları önem taşıdığı için LIBRA simülasyon programının harmonik balans analiz yöntemi kullanılmıştır. Devre elemanlarının taban üzerine yerleşimi (layout) için ise CADENCE (Artist) yazılım programından yararlanılmıştır.

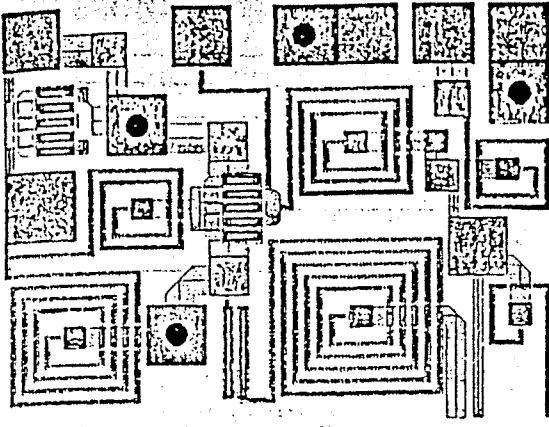
II.VCO TASARIMI

GEC Marconi firmasının elemanlarıyla tasarımı yapılan //3,4/ VCO'nun şematik gösterimi Şekil 1'de, layout gösterimi ise Şekil 2'de verilmiştir. Layout için kullanılan alanın sınırlı olması nedeniyle devre bir MMIC LNA'nın iki toprak viasını kullanmaktadır. Bu negatif direnç osilatöründe toplam 300 µm gate genişliği olan 4 parmaklı (4x75) MESFET aktif eleman olarak kullanılmıştır. Gate girişinde görülen negatif direnç, FET'in source bacağından yapılan kapasitif geri besleme ile elde edilmiştir. Osilasyon frekansını belirleyen değişken kapasite (varaktör) yine Marconi'nin 4x75'lik MESFET'i ile oluşturulmuştur.



Şekil 1. VCO'nun Şematik Gösterimi

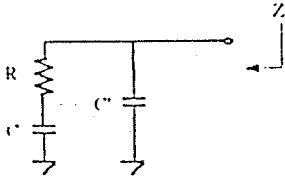
Drain ve source çıkışları birleştirilerek toprağa çekilen transistör, gate girişindeki besleme voltajı ile değişen gate - source.



MMIC Yükselticinin Toprak VIA'larına Bağlanıyor

Şekil 2. VCO'nun Layout Gösterimi

kapasitesi ve eklenen paralel bir kapasite yardımı ile istenen değerlerde değişebilen voltaj kontrollü bir kapasite olarak kullanılmıştır. Gate girişi negatif beslenen MESFET, seri bir direnç R ve kapasite C kombinasyonu ile modellenebilir. Eklenen paralel kapasite C' (Şekil 3) ise girişte görünen empedansı şu şekilde etkilemektedir:



Şekil 3. Varaktör Eşdeğer Devresi

$$\text{Re}\{Z\} = \frac{RC^2}{\omega^2 C^2 C'^2 R^2 + (C + C')^2} \quad (1)$$

$$\text{Im}\{Z\} = \frac{-\omega^2 C^2 C' R^2 - (C + C')}{\omega^3 C^2 C'^2 R^2 + \omega(C + C')^2} \quad (2)$$

Bu empedans yine frekansa bağımlı bir direnç R_v ve ona seri bir kapasite C_v olarak ifade edildiğinde R_v ve C_v değerleri aşağıdaki gibi olur:

$$R_v = \frac{RC^2}{\omega^2 C^2 C'^2 R^2 + (C + C')^2} \quad (3)$$

$$C_v = \frac{\omega^2 C^2 C'^2 R^2 + (C + C')^2}{\omega^3 C^2 C' R^2 + (C + C')} \quad (4)$$

10GHz'deki simülasyon sonuçlarına göre, varaktör devresinin girişinde görülen direnç ve kapasite değerleri Tablo 1'de kontrol voltajının bir fonksiyonu olarak verilmiştir.

Tablo 1. Varaktör Eşdeğer Devresi

V_{gate} (V)	R_v (Ω)	C_v (pF)
0.5	4.59	1.268
0.0	3.49	0.857
-1.0	2.94	0.633
-2.5	2.60	0.532
-10	2.35	0.416

Rezonatör devresi varaktör ile birlikte osilasyon frekansını tayin eder. Besleme devresi, drain akımı $I_{dss}/2$ olacak biçimde ayarlanmıştır. Geri besleme devresindeki kapasite, iki adet polyimide kapasitenin paralellenmesiyle oluşturulmuş, böylelikle parazitik etkiler azaltılmış ve layout alanı daha etkin bir şekilde kullanılmıştır. Çıkıştaki bant geçiren filtre, harmonik frekansları önlemek amacıyla eklenmiştir. LIBRA'da devre simülasyonu yapabilmek için, pasif Marconi elemanlarının parazitik etkilerini de içeren elektriksel modelleri kullanılmıştır. Bu yüzden spiral bobinler, silikon nitrat ve polyimide kapasiteler, ideal elemanlardan oluşan küçük alt devreler halinde simülasyona sokulmuşlardır. MESFET'ler için ise LIBRA'ya uygun, lineer olmayan Curtice-Cubic transistör modeli kullanılmıştır [5]. Tasarımı LIBRA'da incelemek için, programın OSCTEST [6] adlı elemanı ana eleman olarak kullanılmıştır. Bu eleman kullanıcıya bir AC sinyalin asıl bileşenini geri besleme döngüsüne verme imkanı sağlayarak, osilasyon frekansı ve çıkış gücünü bulmaya yarar. Elemanın tasarımı, devrenin doğal durumunu bozmayacak şekilde yapılmıştır.

Yapılan büyük işaret teknikli simülasyon sonuçlarına göre başlangıç (çok küçük bir AC sinyal uygulamasıyla yapılan lineer olmayan simülasyon tekniği ile bulunmuştur) ve kalıcı durum osilasyonları Tablo 2'de görülmektedir.

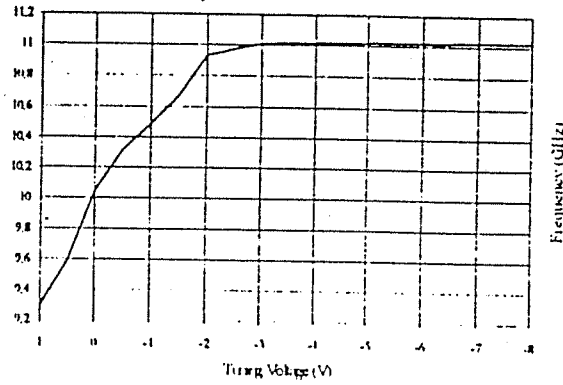
Tablo 2. VCO'nun Osilasyon Durumu

V_{kontrol} (V)	$f_{\text{başlangıç}}$ (GHz)	$f_{\text{osilasyon}}$ (GHz)	Çıkış Gücü (dBm)
0.5	9.46	8.79	12.54
0	9.62	9.27	13.14
-0.5	9.72	9.60	12.70
-1	9.80	9.71	12.45
-1.5	9.83	9.82	12.18
-2	9.88	9.88	12.06
-2.5	9.90	9.92	11.90
-10	10.15	10.15	10.95

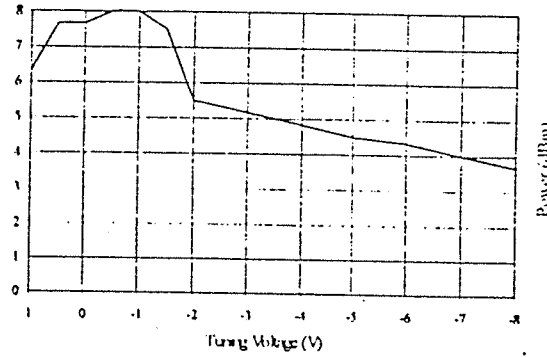
Üretimi tamamlandıktan sonra gelen devre üzerinde BILKENT Üniversitesi'nde yapılan ölçüm sonuçları Tablo 3'de verilmiştir. Bu ölçüm sonuçlarına kablo ve konnektör kayıpları da dahil olduğu için değerlendirme yapılırken çıkış gücüne bu kayıp kadar daha güç eklemek gerekir. Şekil 4 ve 5 kontrol voltajının 0.25V adımlarla 1V ile -10V arasında taratılmasıyla elde edilmiştir. Şekil 6 spektrum analizörde "hold maksimum" modunda kaydedilmiştir. Besleme hatlarında şok bobinler olmadığı için besleme kablolarının etrafına yüksek permeability (μ) 'si olan maddeler konulmuştur.

Tablo 3. VCO'nun Osilasyon Frekansları, Çıkış Güçleri ve Besleme Akımları (Drain Besleme Voltajı 5V)

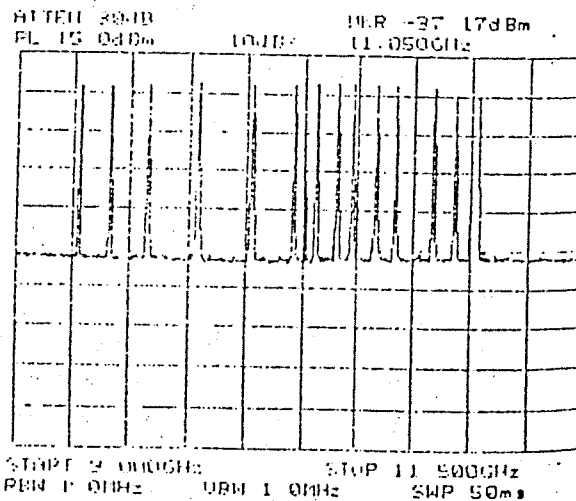
V_{kontrol} (V)	f_{osc} (GHz)	$P_{\text{çıkış}}$ (dBm)	I_{besleme} (mA)
1.0	9.295	6.33	32.7
0.5	9.592	7.67	31.3
0.0	10.040	7.67	29.3
-0.5	10.311	8.00	27.7
-1.0	10.488	8.00	26.6
-1.5	10.674	7.50	25.9
-2.0	10.928	5.50	25.9
-3.0	11.010	5.17	25.9
-4.0	11.016	4.83	25.9
-5.0	11.019	4.50	25.9
-6.0	11.022	4.33	25.85
-8.0	11.028	3.67	25.8



Şekil 4. Kontrol Voltajına Karşılık Osilasyon Frekansı



Şekil 5. Kontrol Voltajına Karşılık Çıkış Gücü



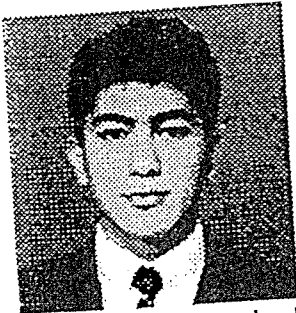
Şekil 6. Hold Maksimum Modunda Spektrum Analizör Çıktısı (Kontrol Voltajı 0.25V Adımlarla 1V ile -10V Arasında Taratıldı)

III.SONUC

Bir MMIC VCO tasarlanıp imal edilmiştir. 9.295GHz ile 11.028GHz arasında osilasyon gösteren VCO, 1V ile -8V arasında değişen DC voltaj ile kontrol edilmektedir.

REFERANSLAR:

- 1/ S. C. Birdir. Design of Microwave Voltage Controlled Oscillators Using MMIC Technology, Ms. Thesis, (1994).
- 2/ A. Sweet. MIC & MMIC Amplifier and Oscillator Design, Artech House, Boston, (1990).
- 3/ K. Kurokawa. "Some Basic Characteristics of Broadband Negative Resistance Oscillator Circuits", The Bell System Technical Journal, 1937, (July-August, 1969).
- 4/ GaAs IC Foundry Design Guide Process F20/F14, GEC Marconi, (1993).
- 5/ S. A. Maas. Nonlinear Microwave Circuits, Artech House, Boston, (1988).
- 6/ EESOF Element Catalog, Version 3.5, (November, 1982).



S.Cüneyt BİRDİR
1970 yılında Ankara'da doğdu. İlk, orta ve lise öğrenimini Ankara'da tamamladı. 1992 yılında ODTÜ Elektrik-Elektronik Mühendisliği Bölümü'nü bitirdi.

1994 yılında MMIC VCO konulu tezi ile yüksek lisans derecesi aldı. 1992-1994 yıllarında ODTÜ' de mikrodalga sistemleri grubunda araştırma görevlisi olarak çalıştı. Halen Aselsan A.Ş.'de elektronik yüksek mühendisi olarak görev yapıyor.

MMIC TEKNOLOJİSİYLE DÜŞÜK GÜRÜLTÜLÜ YÜKSELTEÇ VE ANTEN ANAHTARI TASARIMI

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STRAC

In this work, a low noise amplifier and an antenna T/R switch are designed for a 1.9 GHz wireless communication system in monolithic microwave integrated circuit (MMIC) form. The designed circuits are manufactured abroad. The active matching is used in the design of the LNA. Moreover an asymmetric circuit topology is proposed for the T/R switch. The minimum usage of the wafer area without sacrificing from electrical performance is one of the main purposes. The similarity between the simulation and measurement results shows that this purpose can be realized.

GİRİŞ

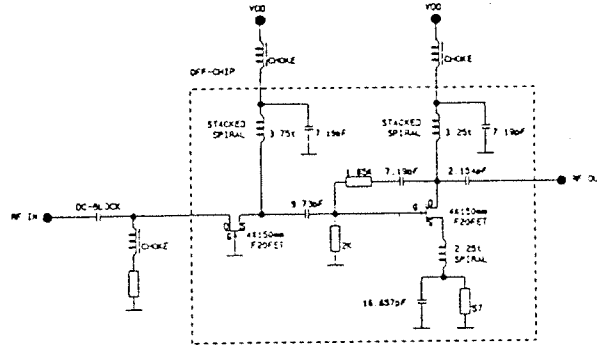
MMIC teknolojisi köken olarak öncelikle X-band ve yukarı frekanslar için GaAs yarı-iletkeninin yüksek frekanstaki üstün özelliklerinden yararlanılarak geliştirilmiştir. Başlangıçta MMIC devreler sadece askeri sistemler için geliştirilmiş, yüksek maliyeti sivil sistemlerde kullanılmasını engellemiştir. Bununla birlikte 90'lı yıllarda gittikçe yaygınlaşmaya başlayan sivil hücreli iletişim sistemlerinin (GSM, PCN, GPRS, CT gibi) tümleşik devreler için büyük pazar yaratması, MMIC teknolojisinin sivil sistemlere de uygulanmasını sağlamıştır. Bu sistemlerde, silikon yarı-iletkeni kullanılarak yapılması oldukça zor olan RF devrelerinin (düşük gürültülü yükselteçler, anten anahtarları, güç yükselticileri, karıştırıcılar, osilatörler) MMIC formunda gerçekleştirilmesi hedeflenmiştir. Bu çalışmada bu yönelimin etkisinde yola çıkılarak 1.9 GHz'de çalışan bir telsiz iletişim sistemi için LNA ve anten anahtarı iki ayrı MMIC devre olarak tasarlanmıştır.

DÜŞÜK GÜRÜLTÜLÜ YÜKSELTEÇ TASARIMI

Amaç

Amaç istenen elektriksel özelliklere en düşük maliyetle ulaşılmaktır. Kazancın 13 dB civarında, gürültü faktörünün ise 3 dB'den az olması hedeflenmiştir. Ayrıca giriş ve çıkış dönüş kayıplarının 1 dB'den iyi olması istenmiştir. İşletim frekansı 1.9 GHz'dir. Devrenin 400 MHz'lik (%20) bir band

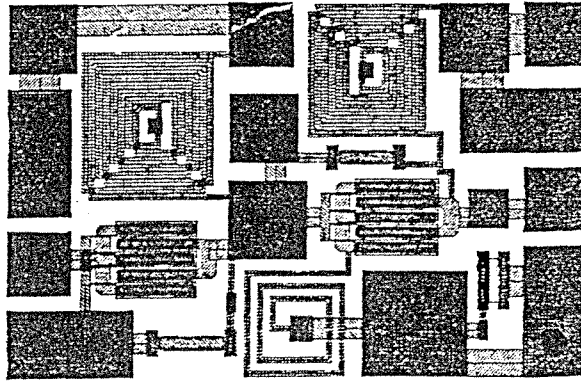
genişliğinde en fazla 1 dB'lik bir değişimle belirlenen kazanç vermesi istenmiştir.



Şekil: 1 Düşük Gürültülü Yükselteç Devre Şeması

b) Tasarım

Devrenin giriş tarafında aktif uyumlama kullanılmıştır. Aktif uyumlama ortak-kapı konfigürasyonundaki FET'in düşük giriş yansıma katsayısı özelliğinin kullanılmasıyla ortaya çıkan bir uyumlama metodudur[1]. GaAs MESFET ortak-kaynak konfigürasyonunda yüksek kazançlı ve düşük gürültülü çalışırken, ortak-kapı konfigürasyonunda iyi bir giriş uyumlama özelliği gösterir.



Şekil: 2 LNA Devre Yerleşim Planı

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Tasarımlanan yükseltici (Şekil 1) iki kattan oluşur: Birinci kat sonraki katın girişini uyumlamak amacıyla kullanılan bir ortak-kapı yapısındadır. İkinci kat bir ortak-kaynak FET şeklindedir ve LNA'nın esas yükseltici kısmını oluşturur. Optimum gürültü uyum empedansını eşlenik giriş uyum empedans seviyesine getirmek için ortak-kaynak FET'in kaynağında seri düktif geri besleme kullanılmıştır[2]. Ayrıca, ortak-kapı FET, savakına bağlanan bir dirençle kararlı hale getirilmiştir. Bir bobin kullanımı yoluyla ortak-kapı katının eşlenik uyumlu çıkış empedansı ortak-kaynak katının eşlenik uyum giriş empedansına getirilmiştir. Ortak-kaynak FET katının çıkışı bir L-tipi yüksek geçirgen yapı kullanılarak sistem empedansına uyumlandırılmıştır. Daha sonraki aşamada, gerçek MIC elemanlar modellenerek devredeki yerlerine konulmuş ve devre belirlenen hedefler çerçevesinde optimize edilmiştir.

Devrenin yerleşim planı Şekil 2'de görülmektedir. İşletim frekansı düşük olduğundan tüm alana düşen eleman yoğunluğu yüksek bulunmuştur. Yonganın boyutları 1.18X0.74 mm (0.9 mm²)'dir.

3) Simülasyon ve Ölçüm Sonuçları

Devre simülasyonu Libra ortamında gerçekleştirilmiştir. Devre tepkeleri HP8510C devre analizörü kullanılarak Bilkent Üniversitesi'nde ölçülmüştür. Simülasyon ve ölçüm sonuçları Şekil 3'de verilmiştir.

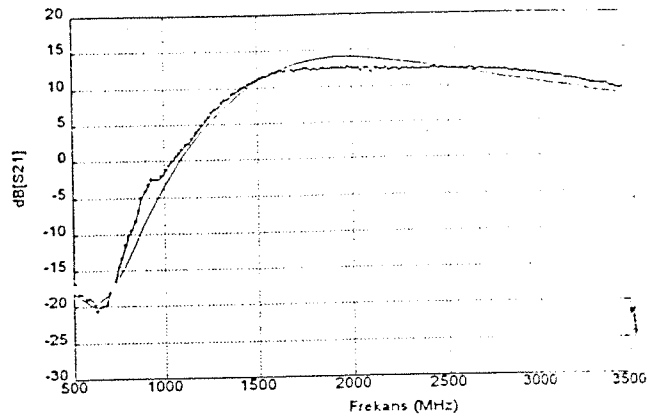
Simülasyon sonuçlarına göre kazancın 0.5 dB seviyesinde değişiklikler gösterdiği band genişliği 600 MHz'dir. Bandın ortasında elde edilen kazanç 14 dB, giriş ve çıkış dönüş kayıpları 14 dB'den daha iyidir. Gürültü seviyesi 3 dB'den iyidir. Kararlılık analizleri sonucu yükselticinin 20 Ghz'e kadar kararlı olduğu görülmüştür.

Ölçüm sonuçlarına göre kazanç yaklaşık 1.5 Ghz'lik bir bandda 12.5 dB civarındadır. Prob kayıplarını göz önüne alırsak, öngörülen kazanç değerinin 0.5 db altına düştüğü, bununla birlikte band genişliğinin 600 Mhz'i aşmış 1.5 Ghz olduğu tesbit edilmiştir. S₁₁ parametresinin simülasyon sonucunu aynen takip ettiği görülmüş, ayrıca öngörülenden çok daha iyi bir sonuca ulaşıldığı tesbit edilmiştir. S₂₂ parametresi için de benzer yorum yapılabilir.

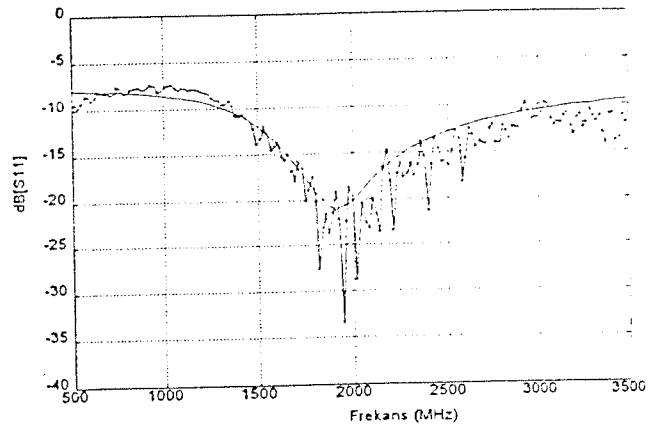
III. ANTEN ANAHTARI

a) Amaç

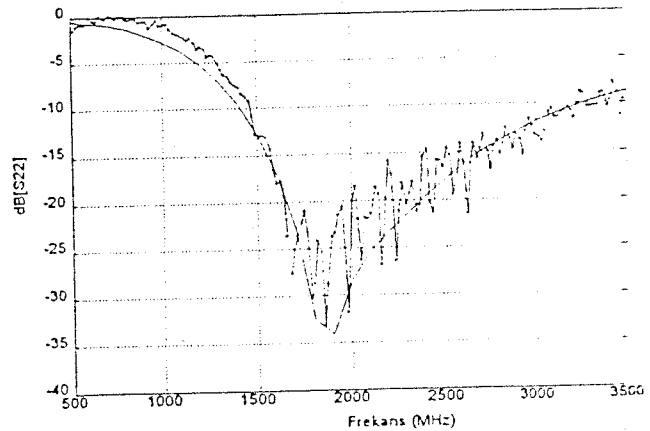
Anten anahtarını tasarımlarken gözetilen amaç yine maliyet etkin yani elektrikselsel performansdan fazla ödün vermeksizin en küçük yonga alanının kullanılması olmuştur.



(a)



(b)



(c)

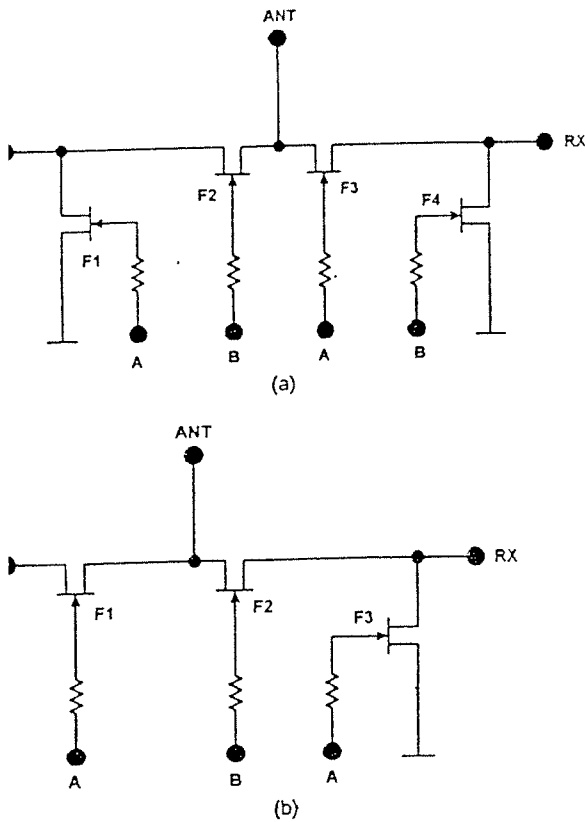
Şekil: 3 Ölçüm (—o—) ve Simülasyon (—) sonuçları

- (a) Kazanç (S₂₁)
- (b) Giriş Dönüş Kaybı (S₁₁)
- (c) Çıkış Dönüş Kaybı (S₂₂)

Bu çalışmamızda, TX-ANT araya girişinin 0.3 dB'den düşük olmasını, ANT-RX araya kaybının 1 dB'den düşük olmasını, TX-RX arasındaki izolasyonun 20 dB'den iyi olmasını ve anahtarın 400 mW gücü üzerinden çalışabilmesi hedeflenmiştir (TX gönderici giriş impedansını, ANT anten terminalini, RX alıcı çıkış impedansını belirtir.)

Yapısal Tasarım

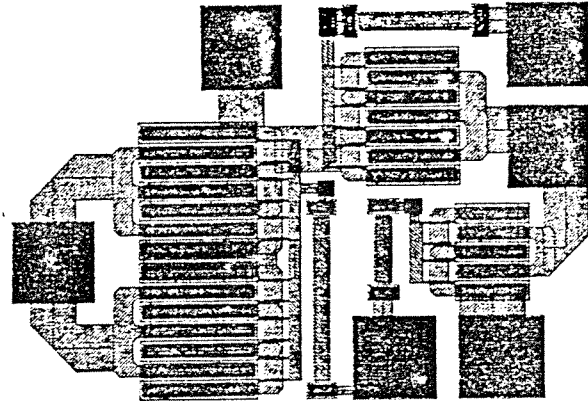
Telsiz sistemi anten anahtarı aslında tek yönlü çift yönlü (SPDT) bir anahtar olarak tasnif edilebilir. SPDT olarak yapılan genel amaçlı MMIC anahtarları ise hem TX hattında hem de RX hattında aynı devre topolojisini (Şekil 4.a) kullanırlar. Bu uygulamalarında, TX-ANT hattındaki araya giriş kaybının azaltılması, ANT-RX hattındaki araya giriş kaybının azaltılmasından daha önemlidir. Bu nedenle Şekil 4.b'de verilen asimetrik devre topolojisi önerilmiştir.



Şekil 4: (a) Genel Amaçlı SPDT RF Anahtarı Yapısı
(b) Önerilen Anten Anahtarı Yapısı

Devre topolojisinin belirlenmesinden sonraki adım olarak kullanılacak FET'lerin eşdeğer devrelerinin açık hem de kapalı konumda) tesbiti ve devre parametrelerinin FET'in kapı genişliğine oranlı değerlerini belirlemek oldu. Anahtarlama elemanı olarak, FET'lerin açık hem de kapalı konumları birbirinin benzeri olarak eşdeğer devre ile modellenmiştir[3,4,5]. Açık

konumda devreyi belirleyen en önemli eleman R_{ON} direncidir. Kapalı konumdaki önemli eleman ise savak ile kaynak arasında oluşan kapasiteyi modelleyen C_{ds} 'dir. Her ne kadar bu iki eleman devrenin elektriksel performansına egemen ise de modellerdeki diğer elemanlarında bulunması devre performansının daha kesin doğrulukta tahmin edilmesini sağlayacağından eldeki FET bilgileri[6] çerçevesinde diğer elemanlarda bulunmuştur. Anahtar çerçevesinde üç FET'in kapı genişlikleri optimize edilmiştir. Bir diğer amaç olan anahtarın 400 mW gücü kaldırabilme yeteneği ise FET'lerin bu güç seviyesinde devredeki akım ve gerilime dayanıklı olmalarıyla ilgilidir. Seçilen ve optimize edilen FET'lerin istenen güç seviyesinin üstünde bir seviyeye dayanıklı oldukları tesbit edilmiştir.



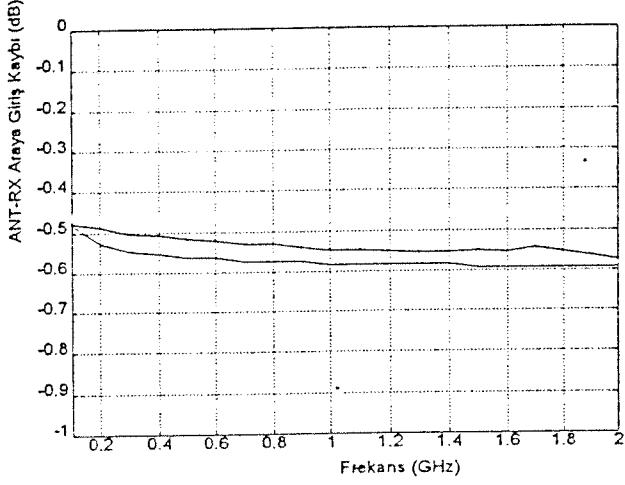
Şekil 5: Anten Anahtarı Yerleşim Planı

Devre yerleşim planı (Şekil 5) 0.86X0.585 mm bir diğer deyişle 0.5 mm²'lik alan kaplamaktadır. 3 numaralı FET'in kaynağı toprağa çekilmemiş böylece devrenin pozitif gerilimle çalışabilmesi mümkün olmuştur.

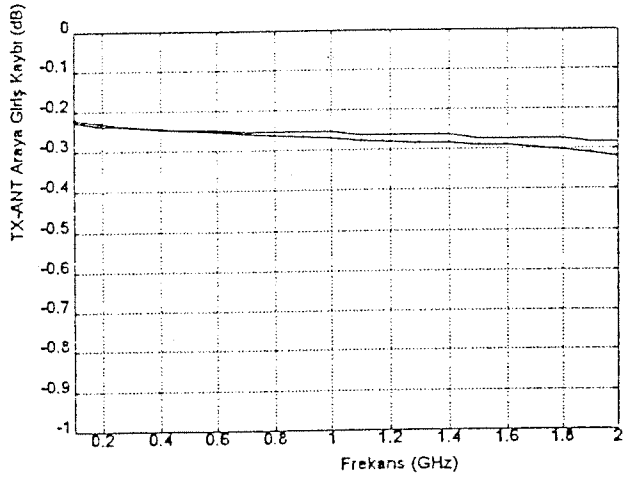
c) Simülasyon ve Ölçüm Sonuçları

5 adet numune devrenin ölçümü devreleri üreten firmanın laboratuvarlarında yapılmıştır. 5 devrede de elde edilen sonuçlar benzerdir. Devrenin TX-ANT araya giriş kaybı simülasyon ve ölçüm sonuçları (Şekil 6) birbirini son derece yakından izlemektedir. Sadece işletim frekansı civarında ölçüm sonucunun beklenenden biraz daha kötü olduğu görülmektedir. ANT-RX araya giriş kaybı ise beklenenden biraz daha iyi çıkmıştır. TX-RX arasındaki izolasyonun simülasyon sonuçları 30 dB'den daha iyi bir dereceye sahip gözükmemektedir. Karşılaştırılabilecek doğrudan bir ölçüm sonucu mevcut değildir. Bununla beraber dolaylı yoldan fikir edinebileceğimiz TX konumunda ANT-RX izolasyonu ölçüm sonucu mevcuttur. TX konumunda TX ve ANT terminallerinin birbirine çok yakın seviyelerde olduğu gözönüne alınırsa karşılaştırmanın gerçekçi olacağı

şüphesizdir. Ölçüm sonucuna göre izolasyon 30 db civarındadır.



(a)



(b)

Şekil: 7 Ölçüm (—o—) ve Simülasyon (—) sonuçları

(a) ANT-RX Araya Giriş Kaybı

(b) TX-ANT Araya Giriş Kaybı

IV. SONUÇ

Elde edilen sonuçlar simülasyonda kullanılan eşdeğer devre modellerinin ve eleman değerlerinin gerçekçi olduğunu göstermiştir. MMIC tasarımında, bilgisayar destekli mühendislik ve tasarım araçları yoğun olarak kullanılır. Ayrıca kullanılan modellerin güvenilirliği büyük önem arzeder. Devrenin üretiminden sonra hibrit veya ayrık RF devrelerde mümkün olan elektriksel performansa müdahale imkanı MMIC'te tektaş yapıdan dolayı imkansızdır. Bununla birlikte bu çalışmada yapılan tasarımların kanıtlandığı gibi, eğer devre elemanlarından ve iletim hatlarından kaynaklanabilecek parazitikler eşdeğer devre elemanlarıyla simülasyon ortamına yansıtılabilirse oldukça tatmin edici sonuçlar alınabilir.

Bu çalışmada elde edilen bir diğer sonuçta aktif uyumlamanın tektaş devre tasarımında başarıyla uygulanabilmesidir. Anten anahtarı için önerilen asimetrik devre yapısı kısıtlı enerjiye sahip telsiz uygulamaları açısından önemlidir.

KAYNAKÇA:

- [1]. Niclas, "Active Matching with Common-gate MESFETS" IEEE MTT-33, no. 6, June 1985, pp.492-499.
- [2]. Engberg, "Simultaneous Input Power Match and Noise Optimization Using Feedback" IV. Euro. Mw. Conf. 1974 pp.385-389.
- [3]. Ayasli, "Microwave Switching with GaAs FETs", Microwave Journal, vol.25, no: 11, pp.61-74, 1982.
- [4]. Jain, Gutmann, "Modeling and design of GaAs MESFET control devices for broad-band applications" IEEE T-MTT-38, pp.109-117, February 1990.
- [5]. Gopinath, Rankin, "GaAs FET RF Switches", IEEE T-ED-32, pp.1272-1278, July 1985.
- [6]. GEC-MARCONI "GaAs Foundry Design Rule Guide F14/F20 Process", 1991

ÇOK KATMANLI SİLİNDİRİK YAPILARDAKİ GENEL AKIM KAYNAKLARI İÇİN GERÇEK UZAYDA KAPALI FORMDA GREEN FONKSİYONLARININ ÇIKARILMASI

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TRACT

A zero-level approximation technique is employed to obtain the closed-form spatial domain Green's functions of the electric and magnetic fields due to electric and magnetic sources of z and ϕ -oriented sources located in an arbitrary layer of a cylindrical, stratified medium. First, the electric and magnetic field components representing the coupled TM and TE modes are derived recursively in the spectral domain at an arbitrary observation layer. Then, the field components are decoupled between the TM and TE modes for the purpose of obtaining the spectral domain Green's functions which are approximated by a complex exponentials in two consecutive steps by using the Generalized Pencil of Function (GPOF) method. For the Green's functions approximated in the first step, the large argument behaviour of zero order Bessel functions is used for the transformation into the spatial domain by the Sommerfeld identity. In the second step, the remaining portion of the Green's functions are approximated and transformed into the spatial domain, analytically.

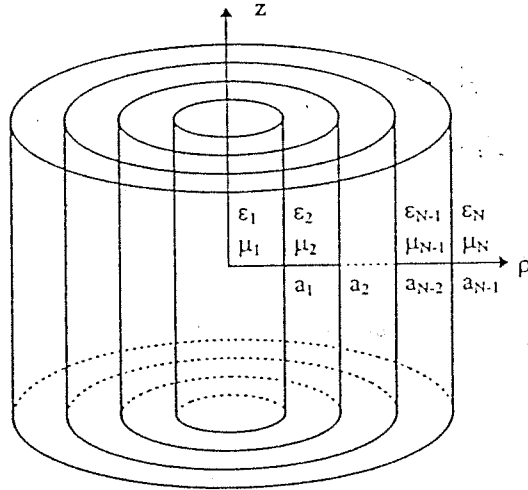
İRİŞ

Elektromagnetik teoremin birçok uygulamasında, enerji taşıyan kompozisyonlara sahip katmanlı yapıların içinde ele alınmaktadır. Bu nedenle, çok katmanlı bir yapıya sınırlı yerleştirilmiş noktasal bir akım kaynağına ait alanlar geniş uygulama alanlarına sahiptir. Bu tür yapıların bazılarında çok katmanlı yapı veya bir devre, katmanlar arasından geçirilen bir akımla çalışmakta, bazılarında ise yapı, katmanların dışında bulunan bir kaynağın oluşturduğu yayılımdan çalışmaktadır. Çok katmanlı yapıların bilhassa iletişim elektroniklerinde ve optikte geniş kullanım alanları vardır.

Çok katmanlı düzlemsel yapılar için gerçek uzayda kapalı formda elde edilen ifadeler daha önce bulunmuştur [1], [2]. Ancak, çok katmanlı silindirik ve küresel yapılar için henüz böyle bir çalışma bulunmamıştır. Bu çalışmada, çok katmanlı silindirik yapılara ait Green fonksiyonlarının gerçek uzayda ve kapalı formda çıkarılması için geliştirilen iki temel bir yöntem anlatılmaktadır.

2. FORMÜLASYON

Bu çalışmada, içiçe silindirik katmanlardan oluşan bir yapının herhangi bir katmanında ve (ρ', ϕ', z') koordinatlarında bulunan z ya da ϕ yönündeki elektrik ya da magnetik noktasal bir akım kaynağının, herhangi bir katmanda bulunan ve (ρ, ϕ, z) koordinatlarına sahip olan bir gözlem noktasında oluşturduğu elektrik ve magnetik alanların Green fonksiyonları, gerçek uzayda ve kapalı formda elde edilmiştir. Bu katmanların sayısında herhangi bir sınırlama olmayıp, herbir katmanın ayrı bir elektrik veya magnetik özelliği olabileceği gibi, katmanlar mükemmel elektrik veya magnetik iletkenlerden oluşabilmektedir. Formülasyonda $e^{j\omega t}$ zaman bağımlılığı kabul edilmiştir. Silindirik ve çok katmanlı genel bir yapı Şekil 1'de gösterilmiştir.



ŞEKİL:1 N katmanlı silindirik yapı modeli

2.1. Green Fonksiyonlarının Spektral Uzayda Hesaplanması:

Düz ve küresel çok katmanlı yapılardan farklı olarak ϕ veya z bağımlılığının olmadığı durumlar hariç, silindirik yapılarda TM ve TE modlardan herhangi biri tek başına katmanlar arasındaki sınır koşullarını sağlayamadığı için, bu modlar kaynak katmanında aynı anda çözümlenerek bu katmandaki elektrik ve magnetik alan ifadeleri bulunur. Gözlem noktası,

aynak katmanından farklı bir katmanda bulunduğu anan, kaynak ve gözlem katmanlarındaki dalgalar rasındaki genlik faktörü iteratif bir yöntemle ulunmalı [3] ve kaynak katmanındaki alan ifadeleri bu ktör ile çarpılarak gözlem katmanına ait alan adeleri şekline dönüştürülmelidir. TM ve TE modların yını anda çözülmesinden dolayı katmanlar arasındaki ansıma ve iletimi temsil eden terimler 2x2 matrisler larak elde edilmektedir. Bulunan ifadelerdeki TM ve E modlara ait terimler birbirinden ayrılarak gözlem atmanına ait Green fonksiyonları kolaylıkla esaplanabilir. Spektral uzayda, z ve ϕ yönündeki oktasal elektrik akım kaynaklarının gözlem atmanında oluşturduğu Green fonksiyonları aşağıda erilmiştir:

$$\begin{aligned} \tilde{G}_{z,z}^E &= -\frac{1}{4\omega} \sum_{n=-\infty}^{\infty} e^{jn(\phi-\phi')} \frac{k_{\rho_j}^2}{\epsilon_j} f_{11} \\ \tilde{G}_{z,z}^H &= -\frac{1}{4\omega} \sum_{n=-\infty}^{\infty} e^{jn(\phi-\phi')} \frac{k_{\rho_j}^2}{\epsilon_j} f_{21} \\ \tilde{G}_{\phi,z}^E &= -\frac{1}{4\omega} \sum_{n=-\infty}^{\infty} e^{jn(\phi-\phi')} \frac{k_{\rho_j}^2}{\epsilon_j} \left[\frac{nk_z}{k_{\rho_j}^2} f_{11} + \frac{j\omega\mu_i}{k_{\rho_j}} \frac{df_{21}}{d(k_{\rho_j}, \rho)} \right] \\ \tilde{G}_{\phi,z}^H &= -\frac{1}{4\omega} \sum_{n=-\infty}^{\infty} e^{jn(\phi-\phi')} \frac{k_{\rho_j}^2}{\epsilon_j} \left[-\frac{j\omega\epsilon_i}{k_{\rho_j}} \frac{df_{11}}{d(k_{\rho_j}, \rho)} + \frac{nk_z}{k_{\rho_j}^2} f_{21} \right] \\ \tilde{G}_{z,\phi}^E &= -\frac{1}{4\omega} \sum_{n=-\infty}^{\infty} e^{jn(\phi-\phi')} \left[\frac{nk_z}{\epsilon_j \rho_j'} f_{11} - j\omega k_{\rho_j} \frac{df_{21}}{d(k_{\rho_j}, \rho')} \right] \\ \tilde{G}_{z,\phi}^H &= -\frac{1}{4\omega} \sum_{n=-\infty}^{\infty} e^{jn(\phi-\phi')} \left[\frac{nk_z}{\epsilon_j \rho_j'} f_{21} - j\omega k_{\rho_j} \frac{df_{22}}{d(k_{\rho_j}, \rho')} \right] \\ \tilde{G}_{\phi,\phi}^E &= -\frac{1}{4\omega} \sum_{n=-\infty}^{\infty} e^{jn(\phi-\phi')} \left\{ \frac{nk_z}{\epsilon_j \rho_j'} \left[\frac{nk_z}{k_{\rho_j}^2} f_{11} + \frac{j\omega\mu_i}{k_{\rho_j}} \frac{df_{21}}{d(k_{\rho_j}, \rho)} \right] \right. \\ &\quad \left. - j\omega k_{\rho_j} \frac{df_{22}}{d(k_{\rho_j}, \rho')} \left[\frac{nk_z}{k_{\rho_j}^2} f_{12} + \frac{j\omega\mu_i}{k_{\rho_j}} \frac{df_{22}}{d(k_{\rho_j}, \rho)} \right] \right\} \\ \tilde{G}_{\phi,\phi}^H &= -\frac{1}{4\omega} \sum_{n=-\infty}^{\infty} e^{jn(\phi-\phi')} \left\{ \frac{nk_z}{\epsilon_j \rho_j'} \left[-\frac{j\omega\epsilon_i}{k_{\rho_j}} \frac{df_{11}}{d(k_{\rho_j}, \rho)} + \frac{nk_z}{k_{\rho_j}^2} f_{21} \right] \right. \\ &\quad \left. - j\omega k_{\rho_j} \frac{df_{22}}{d(k_{\rho_j}, \rho')} \left[-\frac{j\omega\epsilon_i}{k_{\rho_j}} \frac{df_{12}}{d(k_{\rho_j}, \rho)} + \frac{nk_z}{k_{\rho_j}^2} f_{22} \right] \right\} \end{aligned} \quad (1)$$

Yukarıdaki ifadelerde,

$$\begin{aligned} \bar{F}_n(\rho, \rho') &= \begin{bmatrix} f_{11} & f_{12} \\ f_{21} & f_{22} \end{bmatrix} \\ &= \begin{cases} \left[J_n(k_{\rho_j}, \rho) \bar{I} + H_n^{(2)}(k_{\rho_j}, \rho) \bar{\bar{R}}_{i,i-1} \right] \cdot \bar{A}_n, & \rho < \rho', \\ \left[H_n^{(2)}(k_{\rho_j}, \rho) \bar{I} + J_n(k_{\rho_j}, \rho) \bar{\bar{R}}_{i,i+1} \right] \cdot \bar{A}_n, & \rho > \rho', \end{cases} \end{aligned} \quad (2)$$

matrisinin elemanları kullanılmıştır. Burada, birinci tür Bessel ve ikinci tür Hankel fonksiyonları, gözlem katmanında sırasıyla silindirin içine ve dışına doğru ilerleyen dalgaları temsil etmektedir. Yukarıdaki ifadelerde kaynak ve gözlem katmanlarına ait olan terimlerin belirtilmesinde sırasıyla j ve i alt indeksleri kullanılmış olup, k_j ve k_i , sırasıyla, kaynak ve gözlem katmanlarındaki yayılma katsayıları olmak üzere $k_j^2 = k_{\rho_j}^2 + k_z^2$ ve $k_i^2 = k_{\rho_i}^2 + k_z^2$ bağıntıları geçerlidir. Bütün katmanlar için k_z sabit olup, k_{ρ}

değişkendir. Ayrıca, $\bar{\bar{R}}_{i,i-1}$ ve $\bar{\bar{R}}_{i,i+1}$, gözlem katmanından, sırasıyla, alt ve üst katmanlara doğru ilerleyen dalgalara ait genelleştirilmiş yansıma matrisleridir. \bar{A}_n , ise yine bu katmandaki dalgaların genliklerini temsil eden, kaynak ile gözlem katmanları arasındaki genelleştirilmiş iletim matrisini ve kaynak katmanına ait bilgileri içeren bir matristir.

2.2. Green Fonksiyonlarının Gerçek Uzayda Kapalı Formda İfade Edilmesi:

Gerçek uzaydaki Green fonksiyonları, spektral uzaydaki Green fonksiyonları cinsinden aşağıdaki integral dönüşümü ile ifade edilmektedir:

$$G(z) = \frac{1}{2\pi} \int_{-\infty}^{\infty} dk_z e^{-jk_z(z-z')} \tilde{G}(k_z) \quad (3)$$

Bu ifadede G ve \tilde{G} , sırasıyla, gerçek ve spektral uzaydaki Green fonksiyonlarını temsil etmektedirler.

Yukarıdaki integralde k_z değişkeninin izlediği yolun eksi sonsuzdan artı sonsuza kadar gitmesi, integralin hesaplanmasını güçleştirmektedir [4]. Bunun yanında, k_z değişkeninin bu yol üzerinde herhangi bir katmanın yayılma katsayısına eşit olduğu noktalarda, o katmana ait k_{ρ} değişkeni ve dolayısıyla o katmandaki dalgaları temsil eden Hankel fonksiyonlarının argümanları sıfıra gitmektedir. Bu durumda, argümanı sıfır olan Hankel fonksiyonlarının değerleri sonsuza gitmekte ve integralin bu yol üzerinde alınması mümkün olmamaktadır. Integralin izlediği yolun bu noktalardan geçmeyecek ve aynı zamanda da hataya yolaçmayacak şekilde deforme edilmesi, integralin kolayca alınmasını sağlayacaktır.

Bu çalışmada, integralin sayısal olarak hesaplanmasını kolaylaştırmak amacıyla iki aşamalı bir yöntem önerilmektedir. Her iki aşamada da, spektral uzaydan gerçek uzaya dönüşümü analitik olarak yapabilmek ve gerçek uzayda kapalı formda ifadeler bulabilmek amacıyla, spektral uzaydaki Green fonksiyonları Generalized Pencil of Function (GPOF)

temi kullanılarak [5] kompleks üstel terimlerle değiştirilmiştir. Bu aşamalar şu şekilde açıklanabilir:

aşamada, spektral uzayda k_z değişkeninin büyük değerlerine karşılık gelen Green fonksiyonlarının k_p değişkeninin fonksiyonu olan kompleks üstellerle değiştirilmesi amacıyla, Green fonksiyonları bu değişkenin izlediği yol üzerinde eşit aralıklarla aşağıdaki gibi örneklenir;

$$s_j = -jk_p t \quad T_2 \leq t < T_3 \quad (4)$$

Green fonksiyonlarının örneklenen her bir değeri, k_p değişkeninin o örnekleme noktasındaki değerinin kökü ile çarpılarak aşağıda gösterildiği gibi N_3 ile kompleks üstel terimle yaklaştırılır;

$$\overline{G}_{k_p} \cong \sum_{k=1}^{N_3} a_k e^{k_p d_k} \quad (5)$$

Yukarıda, \overline{G}_{k_p} spektral uzaydaki Green fonksiyonlarının yukarıda verilen yol üzerinde örneklenen bölümünü temsil etmektedir.

Yukarıdaki gibi, argümanlarının genliği büyük olduğu için, yukarıdaki Green fonksiyonları kompleks üstel fonksiyonlar gibi davranmaktadırlar;

$$H_0^{(2)}(x) \cong \sqrt{\frac{j2}{\pi}} \frac{e^{-jx}}{\sqrt{x}} \quad (6)$$

Yukarıda tanımlanan örnekleme yolundaki k_p değerlerine karşılık gelen Hankel fonksiyonu argümanlarının genlikleri yeterince büyük olacak şekilde T_2 değeri seçilmelidir. Bu sayede, yukarıda tanımlanan kompleks üstel terimlerle yaklaştırılmış olan Green fonksiyonları Hankel fonksiyonları cinsinden de ifade edilebilmektedir;

$$\overline{G}_{k_p} \cong \sum_{k=1}^{N_3} a_k \frac{e^{k_p d_k}}{\sqrt{k_p}} \cong \sum_{k=1}^{N_3} c_k H_0^{(2)}(k_p, d_k) \quad (7)$$

Yukarıdaki şekilde yaklaştırılan spektral uzaydaki Green fonksiyonlarının analitik olarak gerçek uzaya dönüştürülmesi için aşağıdaki eşitliğin integral dönüşümüne benzerliğinden yararlanılmaktadır.

$$\frac{f(s)|_{\bar{p}-\bar{p}'}}{-\bar{p}'|} = \frac{-j}{2} \int_{-\infty}^{\infty} dk_z e^{-jk_z(z-z')} H_0^{(2)}(k_p, |\bar{p}-\bar{p}'|) \quad (8)$$

Yukarıdaki integral eşitliği kullanıldığında, spektral uzayda Hankel fonksiyonları ile yaklaştırılan Green fonksiyonları kapalı formda gerçek uzaya aktarılabilirler.

Spektral uzayda, yukarıda tanımlanan yolda yaklaştırılan Green fonksiyonları spektral uzayın tümünde tanımlanan Green fonksiyonlarından çıkarılarak bu yolun dışında kalan bölge ile sınırlanmış Green fonksiyonları elde edilir.

$$\tilde{G}_{k_z} = \tilde{G} - \tilde{G}_{k_p} \quad (9)$$

Bu aşamada dikkat edilmesi gereken, k_z değişkeninin yukarıda tanımlanan yol üzerinde bütün katmanların yayılma katsayılarından büyük olmasını sağlayacak bir T_2 değerinin seçilmesidir.

Bu aşamada, k_z değişkeni reel değerlere sahip olacak şekilde örnekleme yapılması durumunda, izlenen yol daha önce bahsedilen ve integralin tanımsız olduğu noktalar üzerinden geçecektir. Bu durumu engellemek ve aynı zamanda k_z değişkenini eşit aralıklarla örnekleyebilmek amacıyla, bu değişkenin izlediği yol deforme edilerek iki kısma bölünmüştür. İlk aşamada Hankel fonksiyonları ile yaklaştırılan Green fonksiyonlarının orijinallerinden çıkarılması ile elde edilen Green fonksiyonları, \tilde{G}_{k_z} , her iki kısımda sırasıyla aşağıdaki gibi örneklenir:

$$k_z = k_j \left[jt + \frac{t}{T_1} \right] \quad 0 \leq t < T_1 \quad (10)$$

$$k_z = k_j \left[\sqrt{1+T_2^2} + (1+jT_1 - \sqrt{1+T_2^2}) \left(\frac{T_2-t}{T_2-T_1} \right) \right] \quad T_1 \leq t < T_2 \quad (11)$$

Örneklenen Green fonksiyonları, her iki bölümde k_z değişkeninin fonksiyonu olan, sırasıyla, N_1 ve N_2 tane kompleks üstel terimle yaklaştırılabilirler;

$$\tilde{G}_{k_z} \cong \sum_{l=1}^{N_1} a_l e^{k_z b_l} + \sum_{m=1}^{N_2} a_m e^{k_z b_m} \quad (12)$$

Bu şekilde yaklaştırılan spektral uzaydaki Green fonksiyonları dönüşüm integraline konulduğunda, bu integral kompleks üstel fonksiyonların sınırlı integrali halini alır ve gerçek uzaydaki Green fonksiyonları analitik olarak kolayca hesaplanabilir. Son olarak, her iki aşamada hesaplanan gerçek uzaydaki Green fonksiyonları toplanarak kapalı formda Green fonksiyonları elde edilmiş olur.

3. UYGULAMALAR

Gerçek uzayda kapalı formda elde edilen yaklaşık sonuçlar, dönüşüm integralinin sayısal hesaplanması ile bulunan kesin sonuçlarla karşılaştırılmış ve sonuçların uyum içinde oldukları gözlenmiştir.

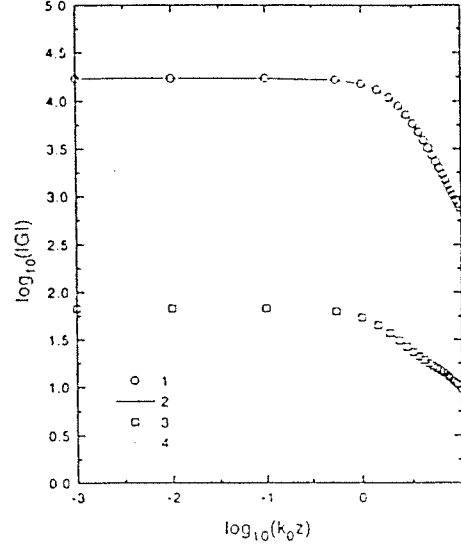
Örnek olarak, mükemmel elektrik iletkenliğine sahip, yarıçapı 20 mm. olan, dış yüzeyinde 1 mm. kalınlığında dielektrik bir katman ($\epsilon_r = 2.3$) bulunan ve hava boşluğu içerisine yerleştirilmiş bir yapı 4.7 GHz'te incelenmiştir. Hava ile dielektrik arasındaki arayüze yerleştirilmiş ($\rho' = 21$ mm., $\phi' = 0, z' = 0$) z ve ϕ yönündeki noktasal elektrik akım kaynaklarının, hava boşluğundaki bir gözlem noktasında ($\rho = 40$ mm., $\phi = 30^\circ, z$) oluşturdukları elektrik alanlara ait Green fonksiyonları gerçek uzayda kapalı formda bulunmuş ve genlik grafikleri Şekil 2 ve 3'te gösterilmiştir.

4. SONUÇ

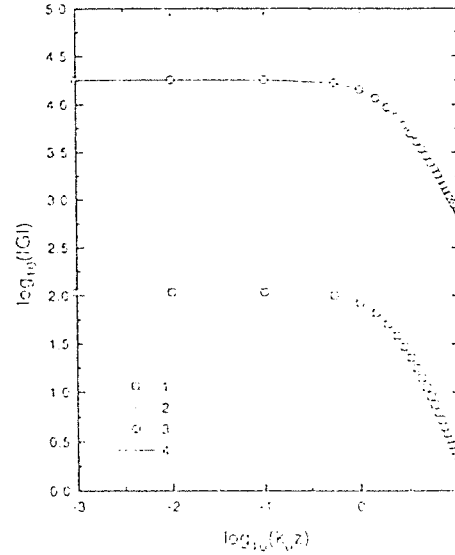
Bu çalışmada, çok katmanlı silindirik bir yapının herhangi bir katmanına yerleştirilen elektrik ya da magnetik noktasal akım kaynaklarının oluşturduğu elektrik ve magnetik alanlara ait Green fonksiyonları gerçek uzayda ve kapalı formda elde edilmiştir. Önerilen yöntem dönüşüm integralinin sayısal olarak hesaplanması güçlüğü ortadan kaldırmakta ve hesaplama süresini önemli ölçüde azaltmaktadır.

KAYNAKÇA

- [1] Gülbin Dural ve M. I. Aksun, "Closed-form Green's functions for general sources and stratified media", *IEEE Trans. Microwave Theory and Tech.* Vol. MTT-43, No.7, pp. 1545-1552, Temmuz 1995
- [2] M. I. Aksun, "A robust approach for the derivation of closed-form Green's functions", *IEEE Trans. Microwave Theory and Tech.* Vol. MTT-44, No.5, pp. 651-658, Mayıs 1996
- [3] W. C. Chew, *Waves and Fields in Inhomogeneous Media*, Piscataway, NJ: IEEE Press, 1995
- [4] W. C. Chew, "The singularities of a Fourier-type integral in a multicylindrical layer problem", *IEEE Trans. Antennas and Prop.* Vol. AP-31, No.4, pp. 653-655, Temmuz 1983
- [5] Y. Hua ve T. K. Sarkar, "Generalized pencil-of-function method for extracting poles of an EM system from its transient response", *IEEE Trans. Antennas and Prop.* Vol. AP-37, No.2, pp. 239-234, Şubat 1989



ŞEKİL:2 G sembolü, z yönündeki noktasal bir elektrik akım kaynağının oluşturduğu $G_{z,z}^E$ ve $\int G_{z,z}^E dz$ Green fonksiyonlarının, 1 ve 3 nolu grafiklerde kesin, 2 ve 4 nolu grafiklerde ise yaklaşık değerlerini temsil etmektedir. Katman-0: toprak, katman-1: $\epsilon_r = 2.3$, katman-2: boşluk, $a_1 = 20$ mm., $a_2 = \rho' = 21$ mm., $\rho = 40$ mm., $\phi = 30^\circ$, $\phi' = z' = 0$, $f=4.7$ GHz.



ŞEKİL:3 G sembolü, ϕ yönündeki noktasal bir elektrik akım kaynağının oluşturduğu $\int G_{z,\phi}^E dz$ ve $G_{z,\phi}^E$ Green fonksiyonlarının, 1 ve 3 nolu grafiklerde kesin, 2 ve 4 nolu grafiklerde ise yaklaşık değerlerini temsil etmektedir. Katman-0: toprak, katman-1: $\epsilon_r = 2.3$, katman-2: boşluk, $a_1 = 20$ mm., $a_2 = \rho' = 21$ mm., $\rho = 40$ mm., $\phi = 30^\circ$, $\phi' = z' = 0$, $f=4.7$ GHz.

Özgün Düşük Gürültülü Aktif Anten Dizisi Analiz ve Tasarım Yöntemi

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ABSTRACT

In this work, noise analysis of active receive antenna systems are given. Noise analysis of low loss transmission lines is given and a new concept, 'noise equivalent line length' is introduced. Importance of incoherent impedance match is shown and based on the noise equivalent line length, noise performance of different antenna array feed structures are also studied. It is shown that an antenna array feed structure can be re-designed without affecting the radiation performance for a lower noise temperature. It is also shown that active antenna arrays may have superior noise performance compared to passive antenna arrays. Application of noise equivalent line length as an active circuit replacement criteria in antenna arrays is given.

1. GİRİŞ

Gürültü, alıcı anten sistemleri için önemli bir tasarım kriteridir. 1960'lardan beri alıcı anten sistemlerinde gürültü faktörlerinin belirlenmesi, hesaplanması konularında çalışmalar yapılmaktadır [1]. Son yıllarda aktif anten yapıları kullanılmaya başlanmıştır. Aktif anten yapıları için de gürültü analizi ve ölçümleri konularında çalışmalar sürmektedir [2]. Ancak, bu çalışmaların hiçbirinde anten besleme yapısının kendi gürültü sıcaklığı hesaba katılmamış, tasarımlarda bu sıcaklığı azaltma konusu dikkate alınmamıştır. Alıcı antenlerde gürültü sıcaklığının ölçülmesi çok zor olduğu için güvenilir bir analiz yöntemi son derece önemlidir. Besleme yapılarında kullanılan iletim hatlarının kayıplı olması gürültü faktörünün hesaba katılmasını gerekli kılmaktadır. Özellikle büyük ölçekli anten dizilerinde besleme yapılarında oluşan kayıplar anten verimliliğini %70'ler seviyesine indirmektedir [3]. Aynı nedenle, kayıp faktörü ile doğrudan ilişkili olan gürültü faktörü de önemli derecede artmaktadır.

Anten dizilerinin gürültü sıcaklığının belirlenmesi ve düşük gürültülü bir besleme yapısının tasarımı ve analizi çalışmaları sürmektedir. Bu çalışmada, aktif anten dizisi tasarımına uygulanması sunulmaktadır. Anten besleme yapıları seri ve paralel tipte olmak üzere iki ayrı grupta incelenebilir. Bu çalışmada daha yaygın kullanıma sahip olan paralel besleme yapıları esas alınmıştır.

Paralel besleme yapıları temel olarak güç birleştirici yapılardır. Işınım örüntüsüne bağlı olarak antenlerden faz ilintili (coherent) gelen işaretler, besleme yapısı üzerinde birleştirilerek anten çıkışına aktarılırlar. Anten dizisi, dışarıdan alınan işaret ve gürültü için aynı biçimde davrandığından, bu biçimdeki çalışma, işaret-gürültü oranı (SNR) analizi çalışmalarına temel oluşturmuştur [4]. Ancak, kayıplı elemanlardan oluşan besleme yapısı kendi başına ısı (thermal) gürültü oluşturduğu için, hem dışarıdan alınan gürültü ile hem yapı içindeki diğer elemanların yarattığı gürültü ile faz ilintili değildir (incoherent). Bu nedenle şimdiye kadar yapılan çalışmalardan tamamen farklı bir çalışmayı gerektirmektedir.

2. KAYIPLI İLETİM HATTI GÜRÜLTÜ HESABI

Anten dizisi besleme yapıları bir çok uygulamada iletim hatları ile oluşturulur. Bu nedenle, kayıplı iletim hatlarının gürültü analizi, besleme yapılarının gürültü analizinde temel oluşturmaktadır. Yaptığımız analizde, iletim hattı kaybının, iletim hattı karakteristik empedansını, Z_{line} gerçel sayı olarak kabul etmemizi engellemeyecek kadar düşük olduğunu kabul ettik. Kaynak ve yük yansıma katsayıları bu empedansa göre tanımlandığında:

$$\Gamma_g = \frac{Z_g - Z_{line}}{Z_g + Z_{line}} \quad (1)$$

ve

$$\Gamma_L = \frac{Z_L - Z_{line}}{Z_L + Z_{line}} \quad (2)$$

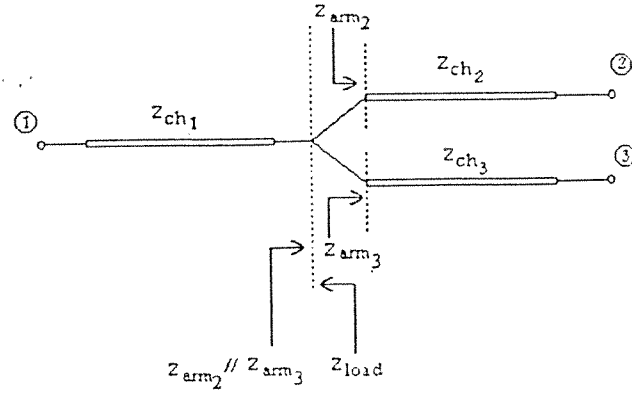
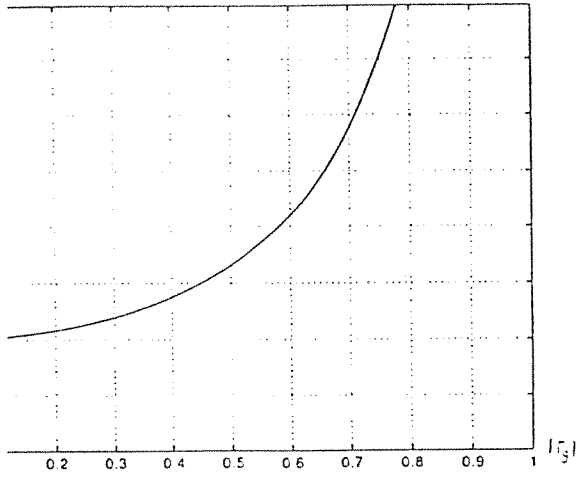
olmaktadır. α iletim hattının zayıflatma faktörünü göstermek üzere, kayıp faktörü, L :

$$L = e^{2\alpha l} \quad (3)$$

olarak tanımlanmıştır. Bu durumda, bu iletim hattının, Z_L yüküne aktaracağı gürültü gücü şöyledir:

$$P_n = kT\Delta f \frac{1 - |\Gamma_L|^2}{|1 - \Gamma_L \Gamma_g|^2 L} \left(L - |\Gamma_g|^2 / L - 1 + |\Gamma_g|^2 \right) \quad (4)$$

Yük empedansı, çıkış empedansının eşleniği olduğu durumda aktarılan güç, en fazla aktarılabilecek güce eşit olduğundan, kayıplı bir iletim hattının aktarabileceği en fazla gürültü gücü şöyledir:



ŞEKİL 2. Güç birleştiricinin şematik gösterimi

bir aktarımların kayıp güç:

olacak eşdeğer

l_{eq}

olacak

3. A

Anten bulukullu

eşdeğer

ve

$l_p =$

olacak

katı

ara

bur

em

sev

bu

gür

yapı

uzun

dal

du

bir

uzun

olacak

1. Eşdeğer hat uzunluğunun kaynak yansımaya göre değişimi

$$\alpha = kT\Delta f \frac{L - |\Gamma_s|^2 / L - 1 + |\Gamma_s|^2}{(1 - |\Gamma_s|^2 / L)^2} L \quad (5)$$

İncelendiğinde görülen odur ki, gürültü gücü yansımaya katsayısının mutlak büyüklüğü ile α ve yansımaya en yüksek değerine ulaştığında:

$$P_{n,max} = kT\Delta f \quad (6)$$

edir. Bu gürültü, bir direncin aktarabileceği en fazla karşılık geldiğinden, uygun tasarlanmamış bir hattın ne kadar çok gürültü yaratabileceği göstermektedir.

Analiz, besleme yapılarındaki farklı elemanların katkılarına veren, besleme yapısının genel olarak değerlendirilmesinde kullanılacak olan, bir eşdeğer hat uzunluğu' tanımında kullanılmıştır. Bu yöntemin kullanıldığı uygulamalar ileriki bölümlerde verilmektedir.

uzunluğu l , kaynak yansımaya katsayısı Γ_0 olan bir iletim hattının kayıp faktörü olsun. Bu durumda aktarabileceği gürültü gücü (5)'de verildiği gibi:

l_{req} aynı kayıp özelliklerine sahip, l_{req} uzunluğunda, kaynak yansımaya katsayısı sıfır olan bir hat olsun. Bu hattın aktarabileceği gürültü:

$$P_{eq} = kT\Delta f \frac{l_{req} - 1}{L_{req}} \quad (7)$$

olacaktır. İncelenen hattın, gürültü özelliklerini bu eşdeğer hat ile gösterebiliriz. L_{req} , $P_{line} = P_{eq}$ olacak şekilde seçildiğinde her iki hat da aynı gürültü gücü yaratacaktır. Bu durumda:

$$l_{req} = \frac{L^2 - |\Gamma_s|^2}{(L^2 - |\Gamma_s|^2) - (L-1)(L + |\Gamma_s|^2)} \quad (8)$$

$$l_{req} = \frac{1}{2\alpha} \ln \left(\frac{L^2 - |\Gamma_s|^2}{(L^2 - |\Gamma_s|^2) - (L-1)(L + |\Gamma_s|^2)} \right) \quad (9)$$

olacaktır. Bu 'eşdeğer hat uzunluğu' gürültü sıcaklığının bulunmasında doğrudan kullanılmaktadır. Eşdeğer hat uzunluğu fiziksel uzunluk birimi ile ifade edilmekte ve en az değeri hattın fiziksel uzunluğuna eşit olmaktadır. Bu biçimde gürültü sıcaklığını hesaplamadan gürültünün yansımaya katsayısından kaynaklanan artışı belirlenebilir, farklı özellikteki iletim hatları gürültü bakımından karşılaştırılabilir. Şekil 1'de fiziksel uzunluk ile normalize edilmiş olarak, gürültü eşdeğer uzunluğunun yansımaya katsayısı ile değişimi verilmiştir.

Bir anten dizisi besleme yapısı güç birleştiriciler, Şekil 2, kullanılarak tanımlanabileceğinden, bu yapıların analizi, anten dizisi besleme yapılarının gürültü analizine temel oluşturmaktadır. Güç birleştirici yapıların analizinden görülebileceği gibi faz ilintili gelen işaretler yansımaya uğramadan eklenmekte, bu nedenle giriş kapılarından alınan toplam güç çıkışı kapısına aktarılabilir. Sadece faz ilintili durum için uyumlanmış olan bu yapılar, aralarında faz ilintisi olmadan gelen işaretler için, giriş empedans uyumu olmadığından, yansımaya yaratmakta ve gelen güç ancak güç birleştirici kollarının birleştirme oranı kadar çıkışa aktarılabilir. $l_{eq,1}$ ve $l_{eq,2}$ eşdeğer uzunluğunda iki kolu olan bir birleştirici, kollar arasındaki birleştirme oranı $1:p^2$ olduğunda:

$$l_{comb} = \frac{1}{1+p^2} l_{eq,1} + \frac{p^2}{1+p^2} l_{eq,2} \quad (10)$$

eşdeğer hat uzunluğuna sahip olacaktır. Kollar aynı özelliklere sahipse, yani $l_{eq,1} = l_{eq,2} = l_{eq}$ ise:

$$l_{comb} = l_{eq} \quad (11)$$

olacaktır. Anten dizisi besleme yapısı içinde arka arkaya bağlanmış olan güç birleştiricilerin birleştirme oranları çarpılarak bulunacak olan bir ağırlık katsayısı, w , bu birleştiricilerin önüne bağlanmış olan

bir yapının ya da anten elemanının, çıkışa aktarabileceği gürlütü gücünün bulunmasında çarpan olarak kullanılacaktır. Gürlütü gücünün takip eden kayıplı yapılarda belli bir kayıp faktörü ile, L_{pro} , zayıflayacağı da dikkate alındığında, çıkışa aktarılan güç:

$$P_{out,line} = w' \times \frac{1}{L_{pro}} \times P_{line} \quad (11)$$

olacaktır. Buna ilişkin olarak tanımlanacak bir ağırlıklı eşdeğer hat uzunluğu, $w' \ell_{neqv}$:

$$w' \ell_{neqv} = \frac{1}{2\alpha} \ln \left(\frac{L^2 - |\Gamma_g|^2}{\left(L^2 - |\Gamma_g|^2 \right) - \frac{w'}{L_{pro}} (L-1) \left(L + |\Gamma_g|^2 \right)} \right) \quad (12)$$

olacaktır.

3. ANTEN BESLEME DİZİSİ GÜRLÜTÜ SICAKLIĞI

Anten besleme dizisinin gürlütü sıcaklığının bulunmasında ağırlıklı eşdeğer hat uzunluğu tanımı kullanılmıştır. $2xp$ elemanlı bir paralel anten dizisinin eşdeğer hat uzunluğu, $w' = \frac{2k}{p}$, $\Gamma_{g,k} = \frac{Z_{ant}/2k - Z_{line,k}}{Z_{ant}/2k + Z_{line,k}}$

ve $L_{pro,k} = L^{p/2-1-k}$ olmak üzere:

$$I_p = \frac{1}{2\alpha} \sum_{k=1}^{p/2-1} \ln \left(\frac{L^2 - |\Gamma_{g,k}|^2}{L^2 - |\Gamma_{g,k}|^2 - \frac{w'}{L_{pro,k}} (L-1) \left(L + |\Gamma_{g,k}|^2 \right)} \right) \quad (13)$$

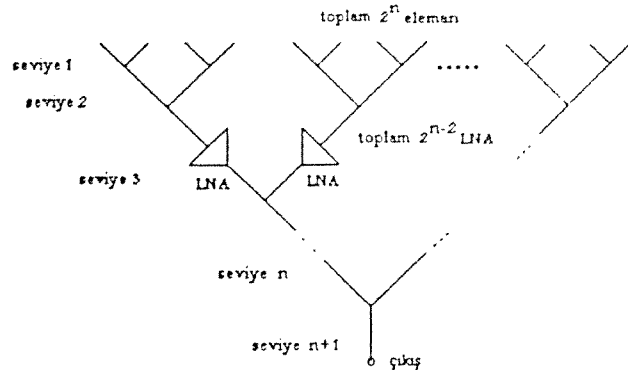
olarak bulunmaktadır. Bu tip yapılarda besleme katsayılarını değiştirmemek için, anten elemanları arasına empedans dönüştürücüler bağlanamamakta, bunun sonucunda paralel bağlanan anten empedansları uyumlaması oldukça güç empedans seviyeleri yaratmaktadır. Eleman sayısı arttıkça artan bu empedans uyumsuzluğu oldukça hızlı artan bir gürlütü sıcaklığı yaratmaktadır. *Corporate* besleme yapılarında böyle bir sorun olmadığından, fiziksel hat uzunluğu daha fazla da olsa, eşdeğer hat uzunluğu daha kısa çıkabilmektedir. Faz ilintili ve ilintisiz durumlar için empedans uyumlu olan $N=2^n$ elemanlı bir *corporate* besleme yapısının eşdeğer hat uzunluğu:

$$I_{n,even} \approx \sum_{k=1}^{n/2} \lambda \cdot 2^{k-1} - \lambda / 4$$

$$\approx \lambda \cdot 2^{n/2} - 5/4 \cdot \lambda \quad (14)$$

$$I_{n,odd} \approx I_{n-1} + 1/2 \cdot \lambda \cdot 2^{(n-1)/2}$$

olarak bulunmaktadır.



ŞEKİL 3. *corporate* besleme yapısı şematik gösterimi

4. AKTİF ANTEN DİZİLERİNDE GÜRLÜTÜ

Alıcı antenlerde gürlütü performansı kazanç gürlütü sıcaklığı oranı (G/T) ile ölçülmektedir. Alıcı anten dizilerinin yüksek kazançlı ve düşük gürlütülü olması için aktif eleman kullanılarak aktif anten dizisi haline getirilmesi başarılı sonuçlar vermektedir [5]. Alıcı sistemlerde pasif bir anten dizisinin çıkışına düşük gürlütülü yükselteç (LNA) bağlanması gereklidir. Ancak, anten dizisine LNA bağlanması, gürlütü faktörüne bağlı olmadan, anten sisteminin gürlütü sıcaklığını artırır. Çıkışına LNA bağlanmış bir anten dizisini, anten dizisi içerisine dağınık olarak yükselteç bağlanarak aktif hale getirilmiş bir anten dizisi ile karşılaştırdığımızda ise görürüz ki, yükselteçler anten elemanlarına ne kadar yakın konulursa gürlütü faktöründeki iyileşme o kadar artar. Hatta, bazı durumlarda pasif antenin G/T oranından daha yüksek oranlar elde edilebilir.

Şekil 3'teki gibi bir *corporate* besleme yapısını göz önüne alalım. η besleme yapısının verimliliğini, T_A anten elemanının gürlütü sıcaklığını, T_{LNA} yükseltecin gürlütü sıcaklığını, T_f besleme yapısının gürlütü sıcaklığını, G yükseltecin kazancını göstermek üzere, sadece çıkışa yükselteç bağlandığında, gürlütü gücü:

$$P_{tek} = k\Delta f \left((\eta T_A + T_{LNA}) + T_f \right) \cdot G \quad (15)$$

olacaktır. Yükselteçler çıkıştan önceki bir seviyeye bağlandığında ise, $T_f = T_1 \eta_2 + T_2$ ve $\eta = \eta_1 \times \eta_2$ olmak üzere, η_1 ve T_1 yükselteç öncesindeki, η_2 ve T_2 yükselteç sonrasındaki besleme yapısının verimlilik ve gürlütü sıcaklığını gösterdiğinde gürlütü gücü:

$$P_{dağınık} = k\Delta f \left(G \eta_2 (\eta_1 T_A + T_1 + T_{LNA}) + T_2 \right) \quad (16)$$

olacaktır. (15) ve (16)'nın karşılaştırmasından, yükselteçlerin anten dizisi besleme yapısında dağınık olarak yerleştirildiğinde daha yüksek bir G/T oranına ulaşıldığı görülmektedir. (16), pasif anten dizisi gürlütü sıcaklığı ile karşılaştırıldığında ise:

$$T_2 \left(1 - \frac{1}{G} \right) - \eta_2 T_{LNA} > 0 \quad (17)$$

olduğu durumda yükselteçlerin dağınık olarak besleme yapısına yerleştirilmesi, pasif anten

den daha yüksek bir G/T oranı oluşturur. Jüğü gibi, anten besleme yapısında kullanılan hatlarının kayıp faktörü arttığında ya da anten elemanı sayısı artması sonucunda hattı uzunluğu arttığında, düşük gürültü faktörlü kazançlı yükselteçler kullanmak antenin gürültü performansını iyileştirecektir.

SARIM ÖRNEĞİ

alışmada gösterilmiş olduğu gibi anten dizisi me yapısının faz ilintili işaretler için empedanslı tasarlandığı gibi yapı içinden kaynaklanan tü gibi faz ilintisi olmayan işaretler için de edans uyumlu tasarlanması gerekmektedir. Böyle tasarım çalışmasında 4x8 corporate beslenmiş bir anten dizisinde sadece besleme dizisinde nılan iletim hatlarının karakteristik empedansları ştirilerek gürültü sıcaklığı yarıya indirilmiştir. ıdaki örnekte 16x16 bir pasif anten dizisi tanmış ve farklı seviyelere yükselteçler anarak gürültü sıcaklıkları hesaplanmıştır.

DUROID 5880 substrat üzerinde mikroşerit örtgen yama anten tasarlanmıştır. Antenlerin giriş edansı 10 GHz'te 276Ω dur. 256 anten corporate eme yapısında düzgün dağılımlı olarak enerek alıcı bir anten dizisi haline getirilmiştir. en elemanları arasındaki fiziksel mesafe ışınım tütüsü özelliklerine göre seçilmiştir. Çeyrek dalga u iletim hatları kullanılarak empedans dönüşümleri ılmış ve besleme yapısı hem faz ilintili hem de faz ili olmayan işaretler için empedans uyumlu hale rtilmiştir. Bu besleme yapısının toplam eşdeğer nluđu, çevre sıcaklığı 290°K olduğu durumda 101°K karşılık gelmek üzere 14.8 λ olarak aplanmıştır.

roşerit empedans uyumlama elemanları ve ultra şük gürültü faktörlü bir pHEMT, NEC 32484A, lanılarak bir yükselteç tasarlanmıştır. Yükseltecin 3GHz'teki gürültü faktörü 0.6dB, kazancı ise 14dB rak hesaplanmıştır. Uyumlamada kullanılan vrelerin antenler arasındaki fiziksel alaına dırılabilirdiği daha önceki bir çalışmada sterilmiştir [5]. Bu yükselteç anten dizisinin çıkışına ğlandığında T=35.6dB-K gürültü sıcaklığı ışımuştur. Ağırlıklı eşdeğer hat uzunluğu ve aktif ten dizisi gürültü analiz yöntemleri kullanılarak kselteçler besleme yapısı üzerinde farklı seviyelere ğlandığında elde edilen gürültü sıcaklıkları saplanmış ve Tablo 1'de verilmiştir. Bu tablodan ıkça görülmektedir ki yükselteçler anten emanlarına yaklaştıkça aktif antenin gürültü caklığı düşmektedir. Ayrıca, (17)'nin sağlanma ışıulu dikkate alındığında görülmektedir ki bu tasarım neğinde, 7. ya da daha önceki seviyelere yükselteç ağılandığında aktif anten dizisi pasif antenden daha ıksek bir G/T oranında çalışacaktır.

TABLO 1. 16x16 aktif anten dizisinde yükselteç yerleştirme seviyesine bağlı gürültü sıcaklığı

Seviye	1	2	3	4	5
Yüks. Sayısı	256	128	64	32	16
T (dB-K)	30.7	30.9	31.1	31.7	32.1

Seviye	6	7	8	ÇIKIŞ
Yüks. Sayısı	8	4	2	1
T (dB-K)	32.9	33.6	34.7	35.6

6. SONUÇ

Bu çalışmada, düşük kayıplı iletim hatlarının kullanıldığı anten dizisi besleme yapılarının analizi verilmiş ve 'eşdeğer hat uzunluğu' kavramı tanıtılmıştır. Besleme yapıları için faz ilintisi olmayan işaretler için de empedans uyumlamanın önemli olduğu gösterilmiştir.

'Eşdeğer hat uzunluğu' kavramı aktif anten dizilerinin analiz ve tasarımında kullanılmış ve anten dizilerinde yükselteç yerleştirilecek noktaların belirlenmesinde bir tasarım kriteri olarak kullanımı gösterilmiştir. Çok düşük gürültü seviyeli aktif elemanların kullanılmaya başlanması ile birlikte, aktif anten dizilerinin alıcı anten yapılarında kullanılma alanları daha da yaygınlaşacaktır.

KAYNAKÇA:

- [1] Y. T. Lo, S. W. Lee and Q.H. Lee, 'Optimization of directivity and signal-to-noise ratio of an arbitrary antenna array', Proc. IEEE, vol. 54, pp. 1033-1045, Aug. 1966.
- [2] H. An, B. Nauwelaers, A. van de Capelle, 'Noise figure measurement of receiving active microstrip antennas', Electron. Lett., vol. 29, no. 18, pp. 1594-1596, Sep. 1993.
- [3] M. A. Weiss, 'Microstrip antennas for millimeter waves', IEEE Trans. Antennas Propagat., vol AP-29, pp. 171-176, Jan. 1981.
- [4] L.P.Winkler and M. Schwartz, 'A fast numerical method for determining the optimum SNR of an array subject to a Q factor constraint', IEEE Trans. Antennas Propagat., vol. AP-20, pp. 503-505, July 1972.
- [5] Ş. Demir, C. Toker and A. Hızal, 'Design of an active microstrip array using a microwave circuit simulator', in Proc. IEEE MTT-S Top. Symp. on Tech. for Wireless Appl., Vancouver, Canada, Feb. 1997, pp. 103-106.

EK II:
COST-245 PROJESİNİN
ULUSLARARASI ORGANİZASYONU

**A SHORT DESCRIPTION OF
THE PROJECT**

COST 245

*ACTIVE ARRAYS
AND
ARRAY FED REFLECTOR ANTENNAS*

1993 - 1997

prepared by Juan R. Mosig, EPF-Lausanne, Switzerland

GOAL

To design, analyze, build and demonstrate new type of ANTENNAS for mobile communications and broadcasting via satellite

MOTIVATION

- Increasing communications traffic via satellite

leads to:

- Increasing technical requirements for antennas

(in satellites, at ground stations, on mobiles)

- ✓ High efficiency

- ✓ Multibeam (fixed and mobile)

- ✓ Reconfigurable

- ✓ Frequency agility and re-use

- ✓ Geographical coverage and footprints

- ✓ Tracking capabilities

A GOOD CANDIDATE

- ❑ **Active or semiactive integrated antennas and phased arrays of these antennas**
 - ⇒ **Also good for cellular base stations and other commercial applications**

PROBLEMS TO BE SOLVED

- ① **Find good basic designs for these antennas and their associated BeamForming Networks**
- ② **Model and analyze these structures and develop CAD packages**
- ③ **Combine with microwave electronics and waveguides to arrive at the active antenna**

COST 245 Project

□ A well conceived working team

⇒ Multidisciplinary

- ✓ Antenna theory
- ✓ Microwave electronics
- ✓ Numerical electromagnetics
- ✓ Satellite/Mobile Telecoms

⇒ Multiprofile

- ✓ Universities (B, CH, CR, D, DK, F, GR, I, I, N, NL, PL, P, S, TR)
- ✓ Telecom companies (Saab-Ericsson, Alcatel Espace, Alenia Spazio, GEC-Marconi, DASA-Dornier, Siemens, CASA, ERA, Ericsson M. S., Dassault)
- ✓ R&D Institutes (CNET-F, VTT-SF, SINTEF-N, DETyCOM-E, FT2-D, TNO-NL, FOA-S)
- ✓ European Space Agency

COST 245 Project

- 17 European Countries + ESA

- 3 Working Groups
 - ✓ WG1 : Antenna modeling and CAD Tools
 - ✓ WG2 : Radiating elements and arrays
 - ✓ WG3 : Active Antenna architectures

- 3 Workshops
 - ✓ CAD for antennas
StGallen, CH, Feb. 1994 hosted by EPFL

 - ✓ MMIC technologies for active antennas
Friedrichshafen, D, Sep. 95
hosted by Siemens-Dornier

 - ✓ Active Antennas
(Noordwijk, NL, June 96, hosted by
ESA-ESTEC, open to a worldwide
audience of 200 attendees

COST 245: Key Achievements

☐ Working Group 1

- ✓ Development of two complementary CAD tools, intended for industrial use, able to deal with technologically relevant printed antennas**
- ✓ Presently developed as stand alone versions, their integration into a general Antenna Design Framework (ADF) is underway.**

☐ Working Group 2

- ✓ Development of dual polarized antennas for satellite communications and broadcasting.**
- ✓ Design and study of radiating elements with generation of very low passive intermodulation**

☐ Working Group 3

- ✓ development and consolidation of the new transmit antenna concept of semi-active multi-matrix antennas, originally introduced in COST Project 223 for multibeam mobile communications satellites**

THE NEAR FUTURE: The COST 260 Project

*“Smart antennas:
computer aided design & technology”*

- ⇒ MoU approved on January 1997
- ⇒ At least, 15 signatory countries expected
- ⇒ Logical follow-up of COST-245
 - ✓ Develop and validate CAD tools
 - ✓ Speed up the demonstration of new antenna concepts in close collaboration with TSUNAMI
 - ✓ Continue to provide an European Forum for exchange and cooperation

The COST 245 Project in Switzerland

- ❑ **Swiss representative: EPF-Lausanne**
(Co-leader of Working Group 1)

- ❑ **Swiss experts**
 - ✓ **Huber+Suhner, Herisau**
 - ✓ **Ascom-Tech, Maegenwil**

- ❑ **Spin-offs**
 - ✓ **EPFL: partner in several european projects**
 - ✓ **CAD softwares for ESA-ESTEC**
 - ✓ **Know-how and technology transfert to swiss industries : H+S, Ascom-Tech, Asulab...**

(antenna designs for commercial applications)

ANNEX III. COST 245 Mailing list

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ROLE: Expert

W.G. : 3

BİBLİYOGRAFİK BİLGİ FORMU	
1- Proje No: COST 245	2- Rapor Tarihi: 31.10.1997
3- Projenin Başlangıç ve Bitiş Tarihleri: 1.1.1994 - 1.7.1997	
4- Projenin Adı: Aktif Faz Taramalı Diziler ve Dizi Beslemeli Antenler (Active Phased Arrays and Array Fed Antennas)	
5- Proje Yürütücüsü ve Yardımcı Araştırmacılar: Proje Yürütücüsü: Prof. Dr. T. Birand. Araştırmacılar: Prof. Dr. C. Toker, Prof. Dr. A. Hızal, Prof. Dr. N. Günalp, Prof. Dr. M. Büyükdura, Doç. Dr. G. Dural, Öğr. Gör. Dr. C. Bulutay, Öğr. Gör. Dr. Ö. Çivi, Öğr. Gör. Dr. L. Alatan, Öğr. Gör. Ş. Demir.	
6- Projenin Yürütüldüğü Kuruluş ve Adresi: ODTÜ Elektrik ve Elektronik Mühendisliği Bölümü	
7- Destekleyen Kuruluş(ların) Adı ve Adresi:	
8- Öz (Abstract): Bu projede faz taramalı anten dizileri, aktif diziler, akıllı antenler, monolitik mikrodalga entegre devreler (MMIC), geniş bantlı antenler ve bu tür yapıların nümerik metotlarla analizi konularında çalışmalar yapılmıştır. Bu çalışmalar, AET üye ülkeleriyle işbirliği ve koordinasyon içerisinde yürütülmüştür. Within the framework of this project, research has been carried out on phased array antennas, active arrays, smart antennas, monolithic microwave integrated circuits (MMIC), wide band antennas and numerical methods for the analysis of these structures. These studies have been conducted in cooperation with the member countries of European Community. Anahtar Kelimeler: Faz taramalı diziler, aktif anten dizileri, mikroşerit antenler, monolitik mikrodalga entegre devreler, moment metodu.	
9- Proje ile ilgili Yayın/Tebliğlerle ilgili Bilgiler Proje kapsamında ortaya çıkan 16 adet yurt dışı ve yurt içi yayın raporun ekinde sunulmuştur.	
10- Bilim Dalı: Elektromanyetik Alanlar ve Mikrodalga Tekniği Doçentlik B. Dalı Kodu: ISIC Kodu: Uzmanlık Alanı Kodu:	
11- Dağıtım (*): <input type="checkbox"/> Sınırlı <input checked="" type="checkbox"/> Sınırsız	
12- Raporun Gizlilik Durumu : <input type="checkbox"/> Gizli <input checked="" type="checkbox"/> Gizli Değil	

(*) Projenizin Sonuç Raporunun ulaştırılmasını istediğiniz kurum ve kuruluşları ayrıca belirtiniz